



## FEATURES

- 4GB of DDR4 with ECC
- e5500 cores built on Power Architecture® technology,
  - QT1040 has four cores and QT1020 has two cores
  - Each core with a private 256KB L2 cache
- 256 KB shared L3 CoreNet platform cache (CPC)
- Hierarchical interconnect fabric
  - CoreNet Coherency manager supporting coherent and non-coherent transactions with prioritization and bandwidth allocation amongst CoreNet end-points
  - 150Gbps coherent read bandwidth Data Path Acceleration Architecture (DPAA) incorporating acceleration for the following functions:
    - Packet parsing, classification, and distribution
    - Queue management for scheduling, packet sequencing, and congestion management
    - Hardware buffer management for buffer allocation and de-allocation
    - Cryptography Acceleration
    - RegEx Pattern Matching Acceleration
    - IEEE Std 1588™ support
- Integrated 8-port Gigabit Ethernet switch
  - 8K MAC addresses, 4K VLANs
  - Static Address provisioning
  - Dynamic learning of MAC addresses and aging
  - Policing with storm control and MC/BC protection
  - Link aggregation (IEEE Std 802.3ad)
  - Spanning Tree Protocol (STP, RSTP and MSTP)
  - Access Control List
  - VLAN editing, translation and remarking
  - Hierarchical QoS with DWRR scheduling
- Parallel Ethernet interfaces
  - Up to two RGMII interface
  - One MII interface
- Eight SerDes lanes for high-speed peripheral interfaces
  - Four PCI Express 2.0 controllers
  - Two Serial ATA (SATA 3Gb/s) controllers
  - Up to two QSGMII interface
- Up to six SGMII interface supporting 1000 Mbps
- Supports 1000Base-KX
- Additional peripheral interfaces
  - Two high-speed USB 2.0 controllers with integrated PHY
  - Enhanced secure digital host controller with support for high capacity memory card (SD/eSDHC/eMMC)
  - Enhanced Serial peripheral interface (eSPI)
  - Four I2C controllers
  - Two DUARTs
  - Integrated flash controller supporting NAND and NOR flash
  - Display interface unit (DIU) with 12-bit dual data rate
  - TDM Interface
  - Four GPIO controllers supporting up to 109 general purpose I/O signals
  - Two 8-channel DMA engines
  - Multicore programmable interrupt controller (MPIC)
- QUICC Engine block
  - 32-bit RISC controller for flexible support of the communications peripherals
  - Serial DMA channel for receive and transmit on all serial channels
  - Two universal communication controllers, supporting TDM, HDLC and UART
- Package: 26 × 44 mm, 1415 solder spheres pitch 0.8 mm

## OVERVIEW

The QT1040 QorIQ advanced multicore processor combines four 64-bit ISA Power Architecture™ processor cores with high-performance data path acceleration and network and peripheral bus interfaces required for networking, telecom/datacom, wireless infrastructure, and military/aerospace applications.

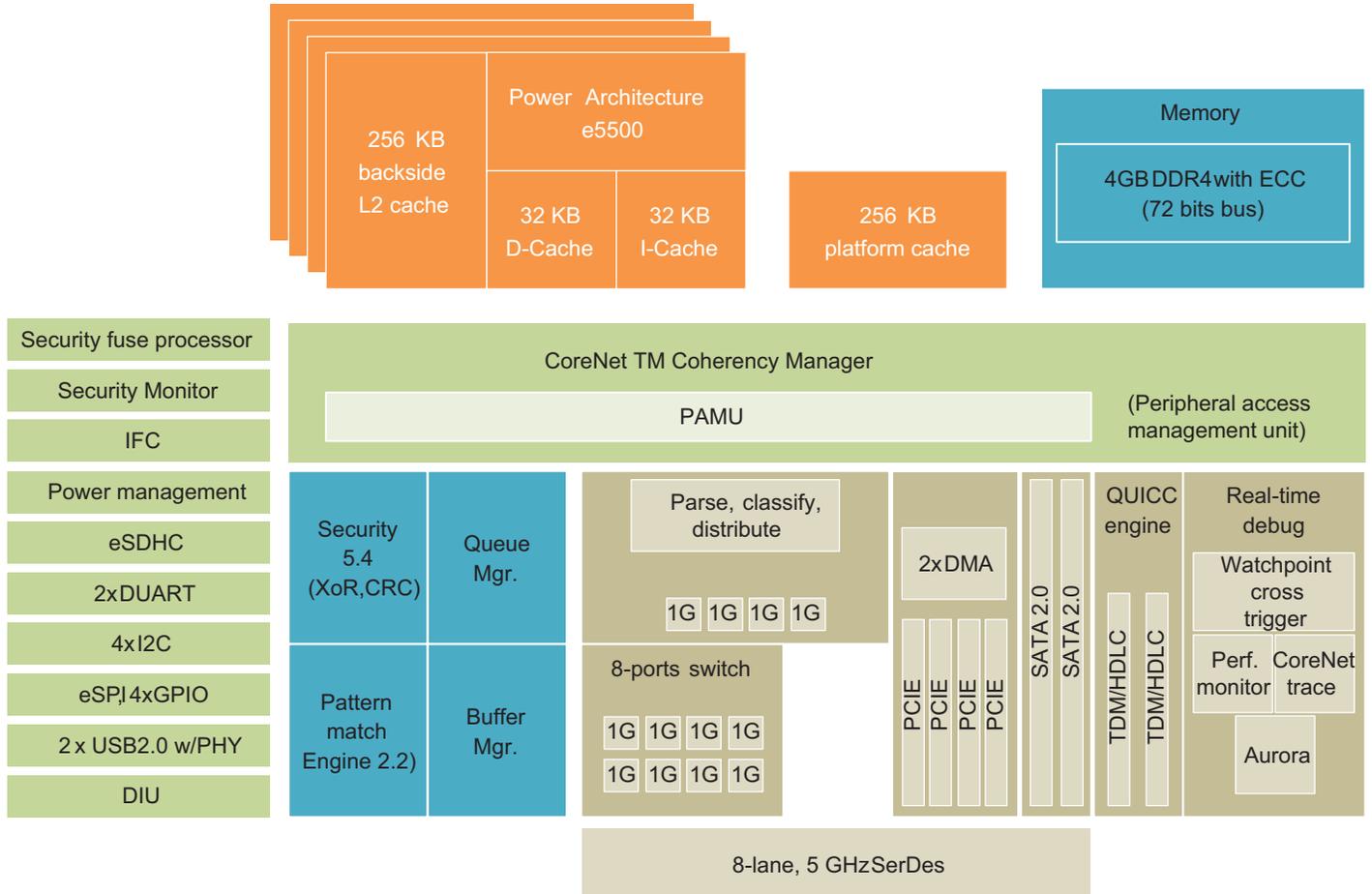
This chip can be used for combined control, data path, and application layer processing in routers, switches, gateways, and general-purpose embedded computing systems. Its high level of integration offers significant performance benefits compared to multiple discrete devices, while also simplifying board design.

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This figure shows the block diagram of the chip.

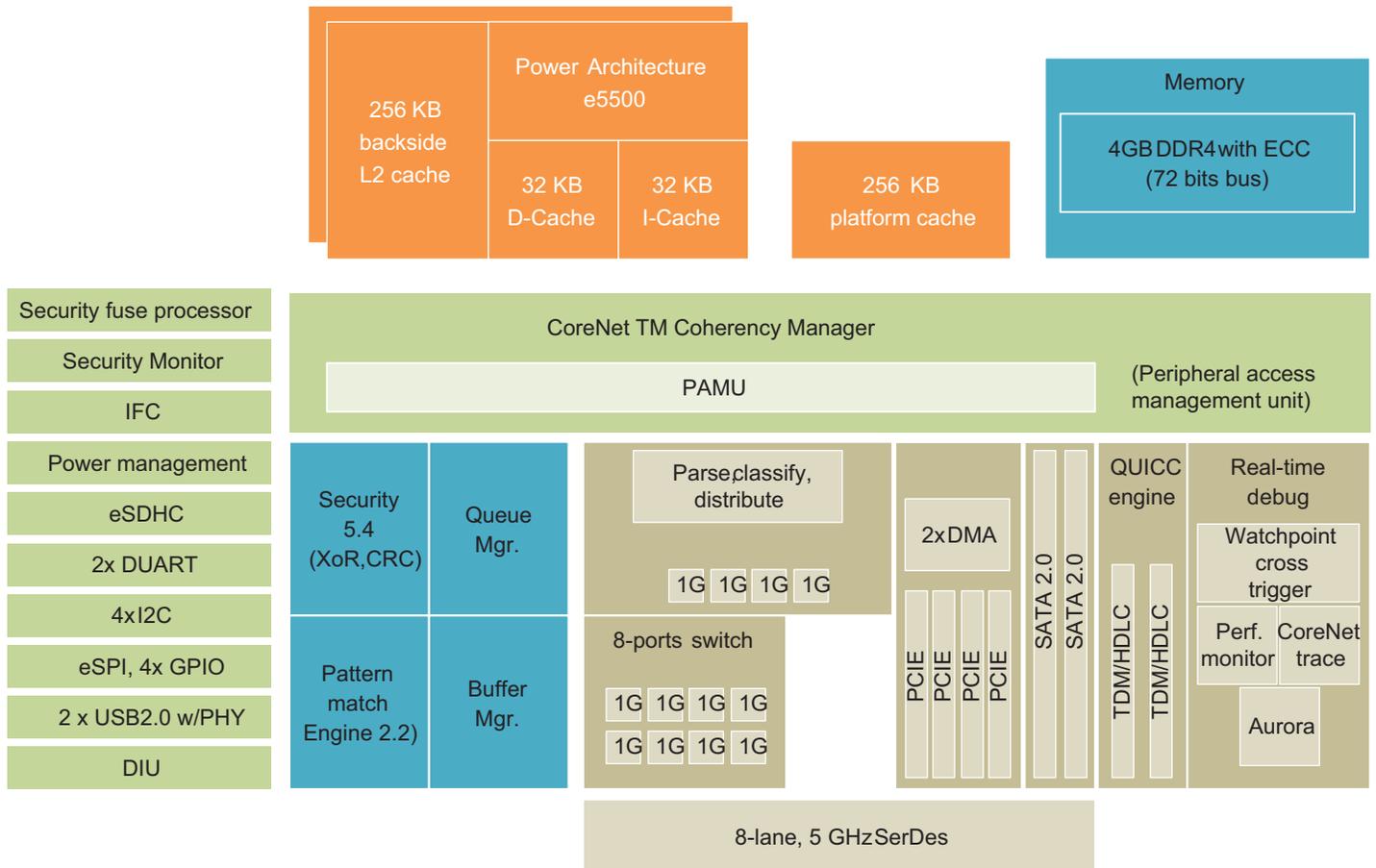
## 1. BLOCK DIAGRAM

Figure 1-1. QT1040 Block diagram



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**Figure 1-2.** QT1020 Block diagram



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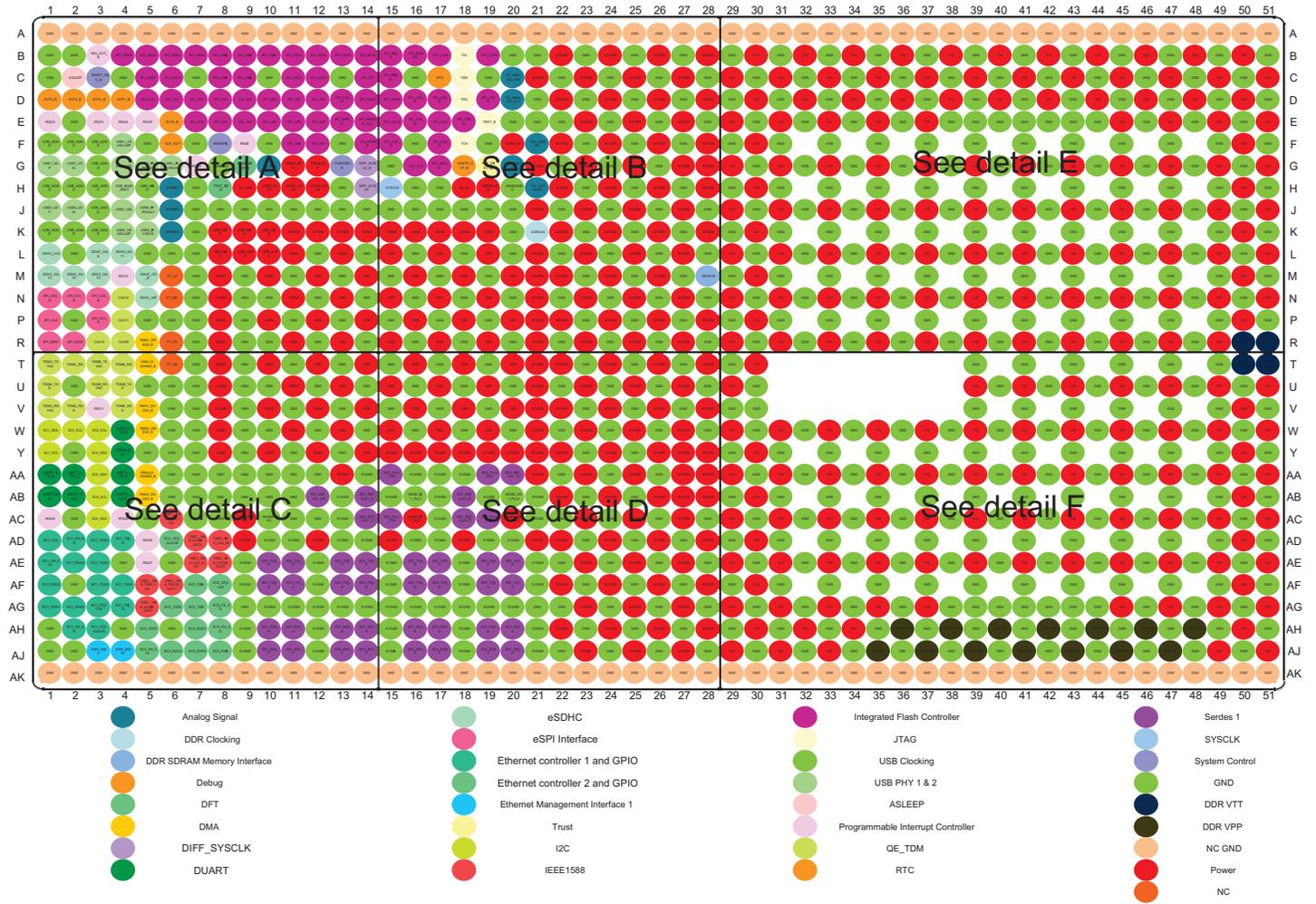
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## 2. PIN ASSIGNMENTS

### 2.1 Layout diagrams

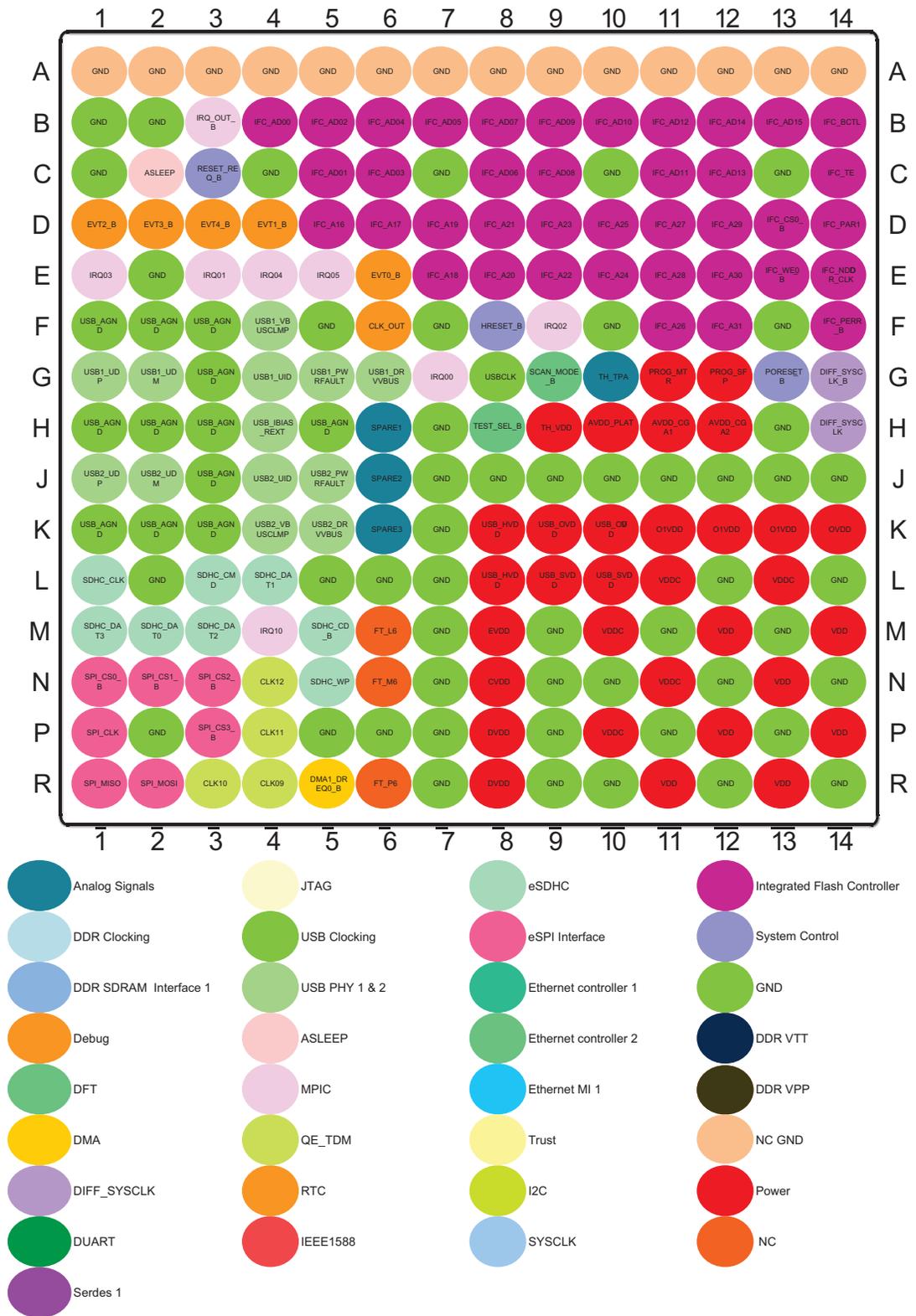
This figure shows the complete view of the QT1040 ball map diagram. [Figure 2-2](#), [Figure 2-3](#), [Figure 2-4](#), and [Figure 2-5](#) show quadrant views.

**Figure 2-1.** Complete BGA Map for the QT1040



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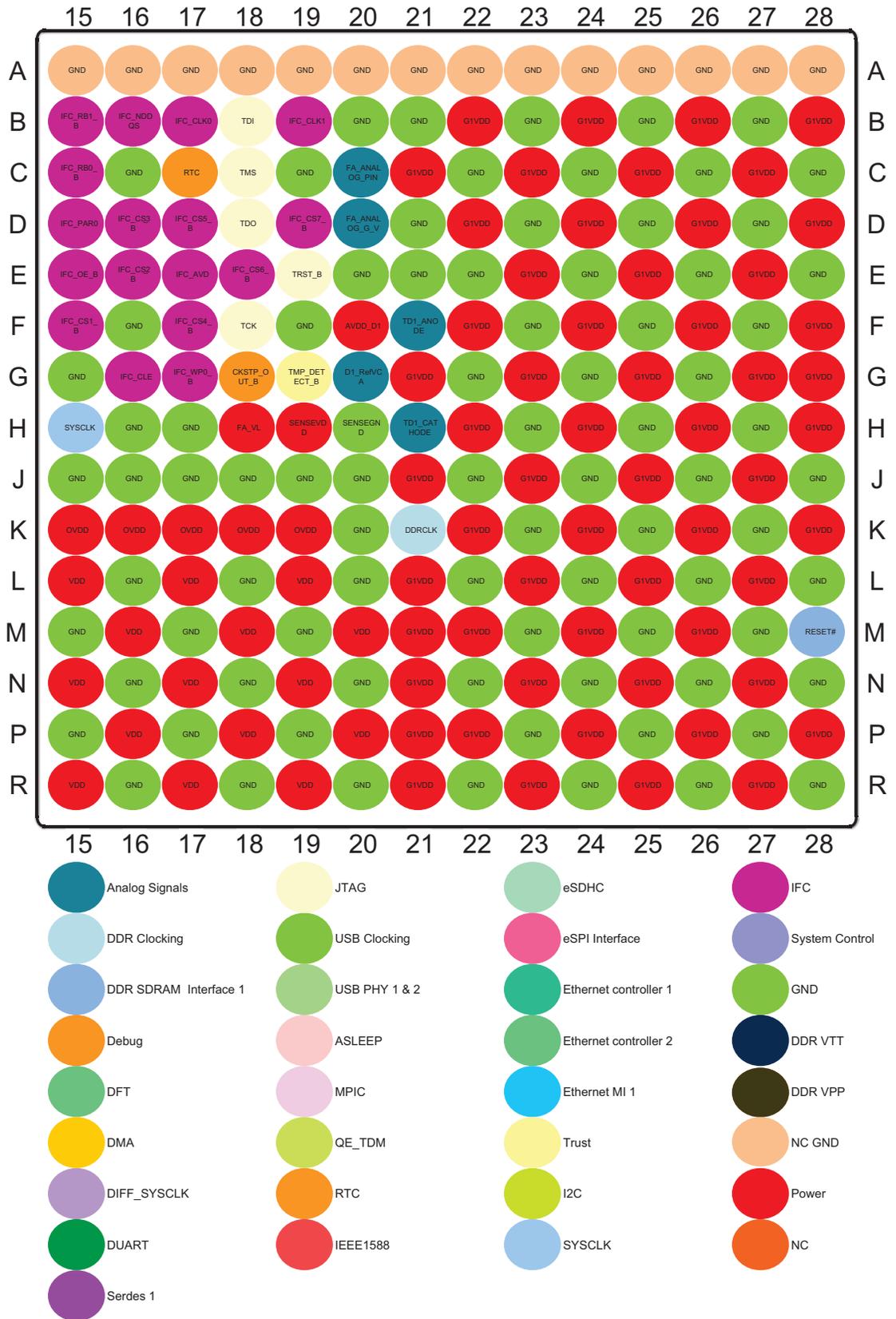
Figure 2-2. Detail A



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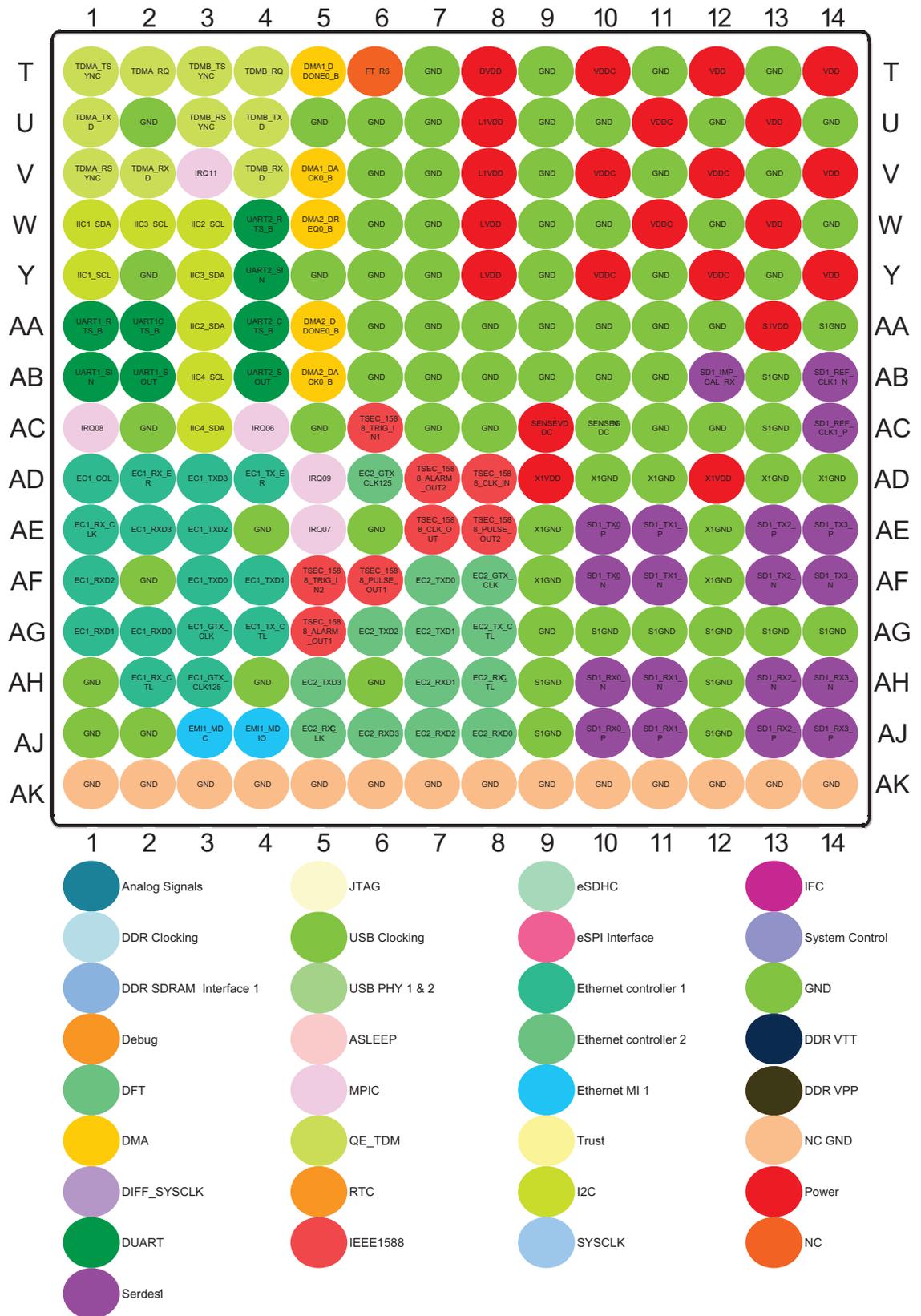
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Figure 2-3. Detail B



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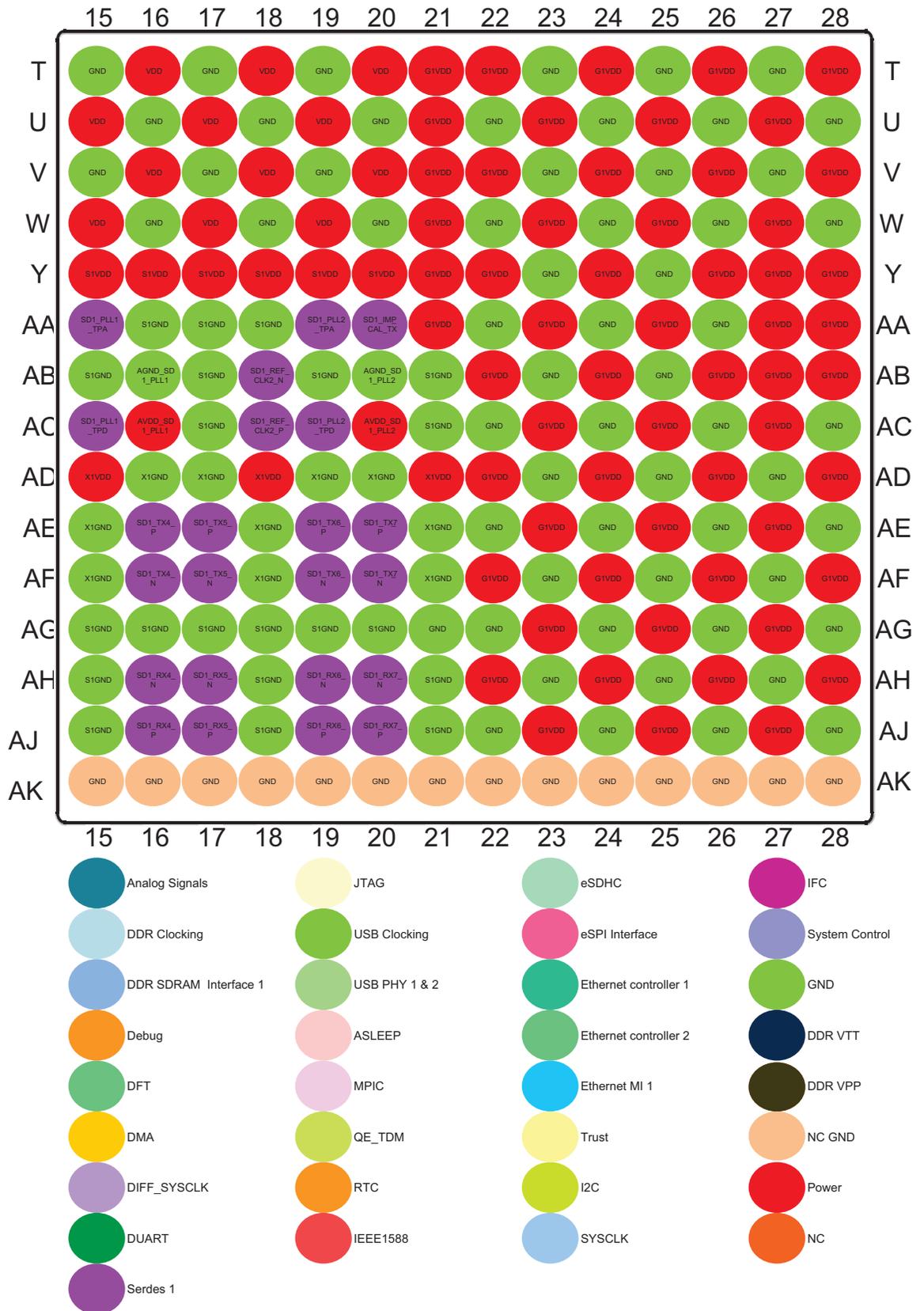
Figure 2-4. Detail C



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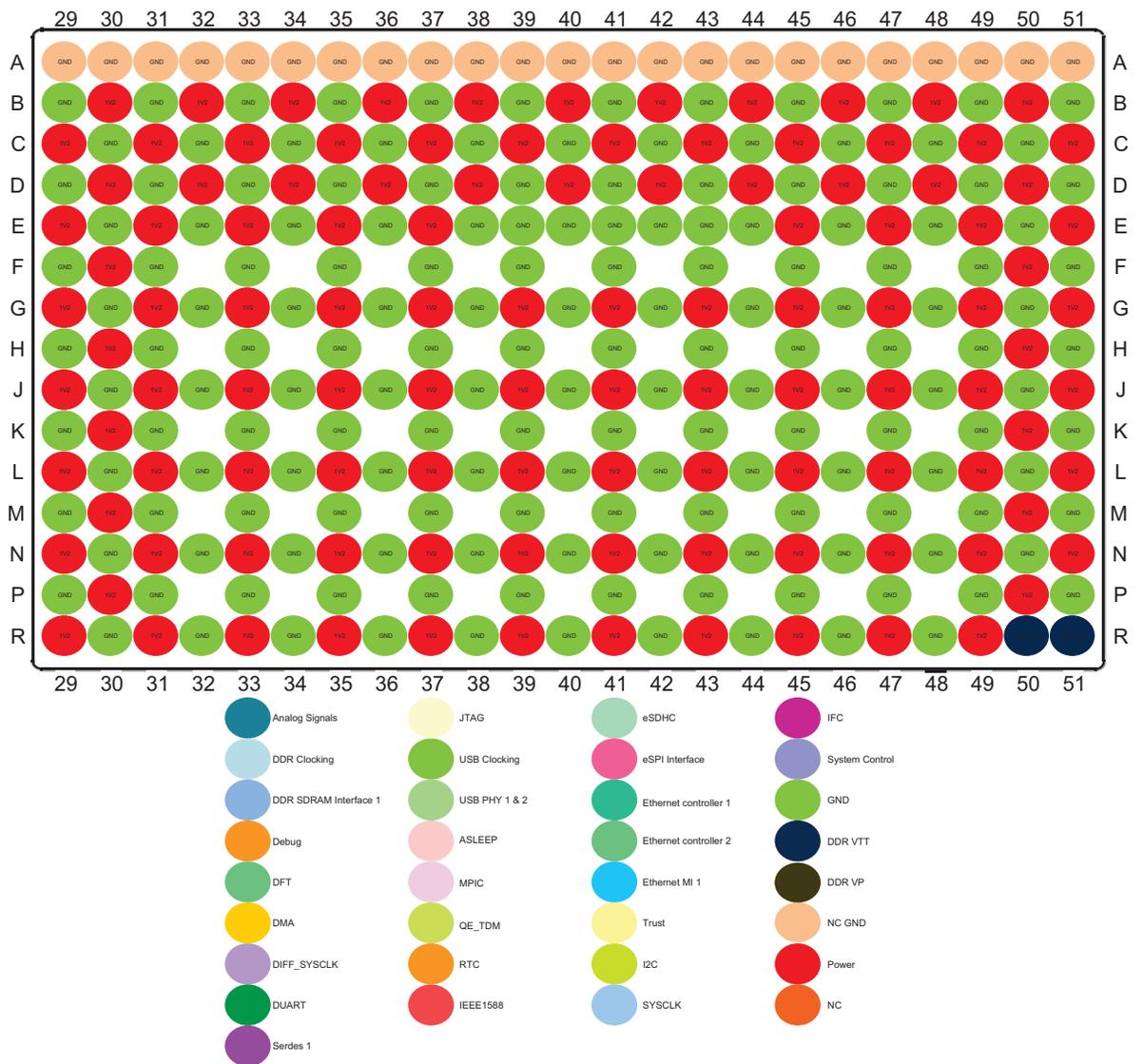
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Figure 2-5. Detail D



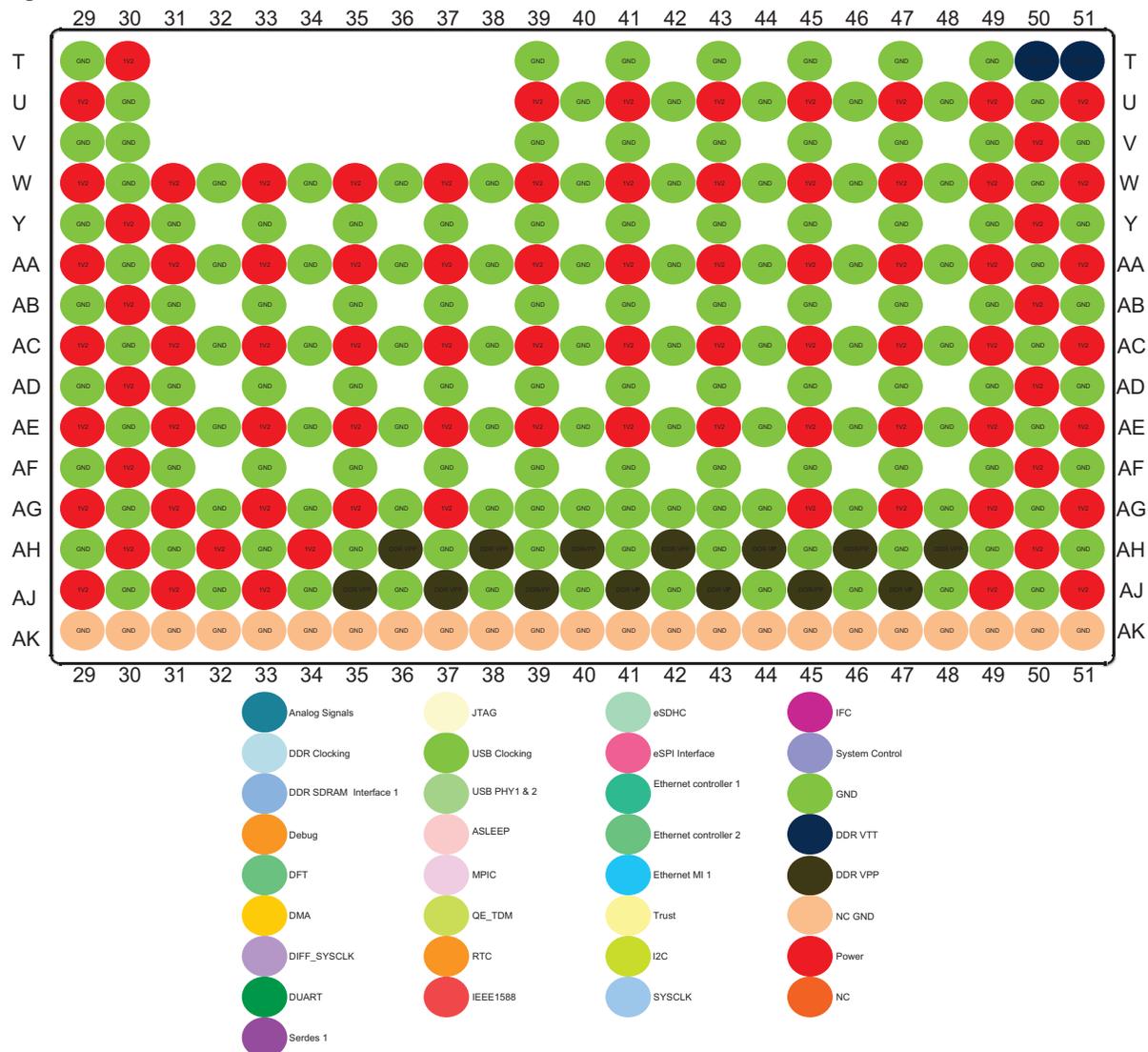
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Figure 2-6. Detail E



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Figure 2-7. Detail F



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2.2 Pinout list

This table provides the pinout listing for the QT1040 by bus. Primary functions are **bolded** in the table.

Table 2-1. Pinout List

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
<b>DDR SDRAM Memory Interface 1</b>					
RESET#	DDR Reset#	M28	I	G1VDD	–
<b>Integrated Flash Controller</b>					
IFC_A16	IFC Address	D5	O	OVDD	(1)(5)
IFC_A17	IFC Address	D6	O	OVDD	(1)(5)
IFC_A18	IFC Address	E7	O	OVDD	(1)(5)
IFC_A19	IFC Address	D7	O	OVDD	(1)(5)
IFC_A20	IFC Address	E8	O	OVDD	(1)(5)
<b>IFC_A21</b> /cfg_dram_type	IFC Address	D8	O	OVDD	(1)(4)
IFC_A22	IFC Address	E9	O	OVDD	(1)
IFC_A23	IFC Address	D9	O	OVDD	(1)
IFC_A24	IFC Address	E10	O	OVDD	(1)
<b>IFC_A25</b> /GPIO2_25/IFC_WP1_B	IFC Address	D10	O	OVDD	(1)
<b>IFC_A26</b> /GPIO2_26/IFC_WP2_B	IFC Address	F11	O	OVDD	(1)
<b>IFC_A27</b> /GPIO2_27/IFC_WP3_B	IFC Address	D11	O	OVDD	(1)
<b>IFC_A28</b> /GPIO2_28	IFC Address	E11	O	OVDD	(1)
<b>IFC_A29</b> /GPIO2_29/IFC_RB2_B	IFC Address	D12	O	OVDD	(1)
<b>IFC_A30</b> /GPIO2_30/IFC_RB3_B	IFC Address	E12	O	OVDD	(1)
<b>IFC_A31</b> /GPIO2_31/IFC_RB4_B	IFC Address	F12	O	OVDD	(1)
<b>IFC_AD00</b> /cfg_gpinput0	IFC Address / Data	B4	IO	OVDD	(4)
<b>IFC_AD01</b> /cfg_gpinput1	IFC Address / Data	C5	IO	OVDD	(4)
<b>IFC_AD02</b> /cfg_gpinput2	IFC Address / Data	B5	IO	OVDD	(4)
<b>IFC_AD03</b> /cfg_gpinput3	IFC Address / Data	C6	IO	OVDD	(4)
<b>IFC_AD04</b> /cfg_gpinput4	IFC Address / Data	B6	IO	OVDD	(4)
<b>IFC_AD05</b> /cfg_gpinput5	IFC Address / Data	B7	IO	OVDD	(4)
<b>IFC_AD06</b> /cfg_gpinput6	IFC Address / Data	C8	IO	OVDD	(4)
<b>IFC_AD07</b> /cfg_gpinput7	IFC Address / Data	B8	IO	OVDD	(4)
<b>IFC_AD08</b> /cfg_rcw_src0	IFC Address / Data	C9	IO	OVDD	(4)
<b>IFC_AD09</b> /cfg_rcw_src1	IFC Address / Data	B9	IO	OVDD	(4)
<b>IFC_AD10</b> /cfg_rcw_src2	IFC Address / Data	B10	IO	OVDD	(4)
<b>IFC_AD11</b> /cfg_rcw_src3	IFC Address / Data	C11	IO	OVDD	(4)
<b>IFC_AD12</b> /cfg_rcw_src4	IFC Address / Data	B11	IO	OVDD	(4)
<b>IFC_AD13</b> /cfg_rcw_src5	IFC Address / Data	C12	IO	OVDD	(4)
<b>IFC_AD14</b> /cfg_rcw_src6	IFC Address / Data	B12	IO	OVDD	(4)
<b>IFC_AD15</b> /cfg_rcw_src7	IFC Address / Data	B13	IO	OVDD	(4)
IFC_AVDD	IFC Address Valid	E17	O	OVDD	(1)(5)
IFC_BCTL	IFC Buffer control	B14	O	OVDD	(1)

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
IFC_CLE/cfg_rcw_src8	IFC Command Latch Enable	G16	O	OVDD	(1)(4)
IFC_CLK0	IFC Clock	B17	O	OVDD	(1)
IFC_CLK1	IFC Clock	B19	O	OVDD	(1)
IFC_CS0_B	IFC Chip Select	D13	O	OVDD	(1)(6)
IFC_CS1_B/GPIO2_10	IFC Chip Select	F15	O	OVDD	(1)(6)
IFC_CS2_B/GPIO2_11	IFC Chip Select	E16	O	OVDD	(1)(6)
IFC_CS3_B/GPIO2_12	IFC Chip Select	D16	O	OVDD	(1)(6)
IFC_CS4_B/GPIO1_09	IFC Chip Select	F17	O	OVDD	(1)(6)
IFC_CS5_B/GPIO1_10	IFC Chip Select	D17	O	OVDD	(1)(6)
IFC_CS6_B/GPIO1_11	IFC Chip Select	E18	O	OVDD	(1)(6)
IFC_CS7_B/GPIO1_12	IFC Chip Select	D19	O	OVDD	(1)(6)
IFC_NDDDR_CLK	IFC NAND DDR Clock	E14	O	OVDD	(1)
IFC_NDDQS	IFC DQS Strobe	B16	IO	OVDD	–
IFC_OE_B/cfg_eng_use1	IFC Output Enable	E15	O	OVDD	(1)(22)
IFC_PAR0/GPIO2_13	IFC Address & Data Parity	D15	IO	OVDD	–
IFC_PAR1/GPIO2_14	IFC Address & Data Parity	D14	IO	OVDD	–
IFC_PERR_B/GPIO2_15	IFC Parity Error	F14	I	OVDD	(1)(6)
IFC_RB2_B/IFC_A29/GPIO2_29	IFC Ready / Busy CS 2	D12	I	OVDD	(1)
IFC_RB3_B/IFC_A30/GPIO2_30	IFC Ready / Busy CS 3	E12	I	OVDD	(1)
IFC_RB4_B/IFC_A31/GPIO2_31	IFC Ready / Busy CS 4	F12	I	OVDD	(1)
IFC_RB0_B	IFC Ready / Busy CS0	C15	I	OVDD	(6)
IFC_RB1_B	IFC Ready / Busy CS1	B15	I	OVDD	(6)
IFC_TE/cfg_ifc_te	IFC External Transceiver Enable	C14	O	OVDD	(1)(4)
IFC_WE0_B/cfg_eng_use0	IFC Write Enable	E13	O	OVDD	(1)(22)
IFC_WP1_B/IFC_A25/GPIO2_25	IFC Write Protect	D10	O	OVDD	(1)
IFC_WP2_B/IFC_A26/GPIO2_26	IFC Write Protect	F11	O	OVDD	(1)
IFC_WP3_B/IFC_A27/GPIO2_27	IFC Write Protect	D11	O	OVDD	(1)
IFC_WP0_B/cfg_eng_use2	IFC Write Protect	G17	O	OVDD	(1)(22)
<b>DUART</b>					
UART1_CTS_B/GPIO1_21/UART3_SIN	Clear To Send	AA2	I	DVDD	(1)
UART1_RTS_B/GPIO1_19/UART3_SOUT	Ready to Send	AA1	O	DVDD	(1)
UART1_SIN/GPIO1_17	Receive Data	AB1	I	DVDD	(1)
UART1_SOUT/GPIO1_15	Transmit Data	AB2	O	DVDD	(1)
UART2_CTS_B/GPIO1_22/UART4_SIN	Clear To Send	AA4	I	DVDD	(1)
UART2_RTS_B/GPIO1_20/UART4_SOUT	Ready to Send	W4	O	DVDD	(1)
UART2_SIN/GPIO1_18	Receive Data	Y4	I	DVDD	(1)
UART2_SOUT/GPIO1_16	Transmit Data	AB4	O	DVDD	(1)
UART3_SIN/UART1_CTS_B/GPIO1_21	Receive Data	AA2	I	DVDD	(1)
UART3_SOUT/UART1_RTS_B/GPIO1_19	Transmit Data	AA1	O	DVDD	(1)
UART4_SIN/UART2_CTS_B/GPIO1_22	Receive Data	AA4	I	DVDD	(1)

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
UART4_SOUT/UART2_RTS_B/GPIO1_20	Transmit Data	W4	O	DVDD	(1)
<b>I2C</b>					
IIC1_SCL	Serial Clock (supports PBL)	Y1	IO	DVDD	(7)(8)
IIC1_SDA	Serial Data (supports PBL)	W1	IO	DVDD	(7)(8)
IIC2_SCL	Serial Clock	W3	IO	DVDD	(7)(8)
IIC2_SDA	Serial Data	AA3	IO	DVDD	(7)(8)
<b>eSPI Interface</b>					
SPI_CLK	SPI Clock	P1	O	CVDD	(1)
SPI_CS0_B/GPIO2_00/SDHC_DAT4	SPI Chip Select	N1	O	CVDD	(1)
SPI_CS1_B/GPIO2_01/SDHC_DAT5/SDHC_CMD_DIR	SPI Chip Select	N2	O	CVDD	(1)
SPI_CS2_B/GPIO2_02/SDHC_DAT6/SDHC_DAT0_DIR	SPI Chip Select	N3	O	CVDD	(1)
SPI_CS3_B/GPIO2_03/SDHC_DAT7/SDHC_DAT123_DIR/SDHC_CLK_SYNC_OUT	SPI Chip Select	P3	O	CVDD	(1)
SPI_MISO	Master In Slave Out	R1	I	CVDD	(1)
SPI_MOSI	Master Out Slave In	R2	IO	CVDD	–
<b>Programmable Interrupt Controller</b>					
IRQ00	External Interrupt	G7	I	O1VDD	(1)
IRQ01	External Interrupt	E3	I	O1VDD	(1)
IRQ02	External Interrupt	F9	I	O1VDD	(1)
IRQ03/GPIO1_23/SDHC_VS	External Interrupt	E1	I	O1VDD	(1)
IRQ04/GPIO1_24	External Interrupt	E4	I	O1VDD	(1)
IRQ05/GPIO1_25	External Interrupt	E5	I	O1VDD	(1)
IRQ06/GPIO1_26	External Interrupt	AC4	I	L1VDD	(1)
IRQ07/GPIO1_27	External Interrupt	AE5	I	L1VDD	(1)
IRQ08/GPIO1_28	External Interrupt	AC1	I	L1VDD	(1)
IRQ09/GPIO1_29	External Interrupt	AD5	I	L1VDD	(1)
IRQ10/GPIO1_30/SDHC_CLK_SYNC_IN	External Interrupt	M4	I	CVDD	(1)
IRQ11/GPIO1_31	External Interrupt	V3	I	DVDD	(1)
IRQ_OUT_B/EVT9_B	Interrupt Output	B3	O	O1VDD	(1)(6)(7)
<b>Trust</b>					
TMP_DETECT_B	Tamper Detect	G19	I	OVDD	(1)
<b>System Control</b>					
HRESET_B	Hard Reset	F8	IO	O1VDD	(7)(27)
PORESET_B	Power On Reset	G13	I	O1VDD	(26)
RESET_REQ_B	Reset Request (POR or Hard)	C3	O	O1VDD	(1)(5)
<b>Power Management</b>					
ASLEEP/GPO1_13	Asleep	C2	O	O1VDD	(1)
<b>SYSCLK</b>					
SYSCLK	System Clock	H15	I	O1VDD	(1)(7)
<b>DDR Clocking</b>					

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
DDRCLK	DDR Controller Clock	K21	I	OVDD	(1)(7)
<b>RTC</b>					
RTC/GPIO1_14	Real Time Clock	C17	I	OVDD	(1)
<b>Debug</b>					
CKSTP_OUT_B	Checkstop Out	G18	O	OVDD	(1)(6)(7)
CLK_OUT	Clock Out	F6	O	O1VDD	–
EVT5_B/IIC4_SCL/GPIO4_02/DIU_HSYNC	Event 5	AB3	IO	DVDD	–
EVT6_B/IIC4_SDA/GPIO4_03/DIU_VSYNC	Event 6	AC3	IO	DVDD	–
EVT7_B/DMA2_DACK0_B/GPIO4_08/TDM_RFS	Event 7	AB5	IO	DVDD	–
EVT8_B/DMA2_DDONE0_B/GPIO4_09/TDM_RCK	Event 8	AA5	IO	DVDD	–
EVT9_B/IRQ_OUT_B	Event 9	B3	IO	O1VDD	–
EVT0_B	Event 0	E6	IO	O1VDD	(9)
EVT1_B	Event 1	D4	IO	O1VDD	–
EVT2_B	Event 2	D1	IO	O1VDD	(6)(22)
EVT3_B	Event 3	D2	IO	O1VDD	–
EVT4_B	Event 4	D3	IO	O1VDD	–
<b>DFT</b>					
SCAN_MODE_B	Reserved	G9	I	O1VDD	(10)
TEST_SEL_B	Reserved	H8	I	O1VDD	(23)
<b>JTAG</b>					
TCK	Test Clock	F18	I	OVDD	–
TDI	Test Data In	B18	I	OVDD	(9)
TDO	Test Data Out	D18	O	OVDD	–
TMS	Test Mode Select	C18	I	OVDD	(9)
TRST_B	Test Reset	E19	I	OVDD	(9)
<b>Analog Signals</b>					
D1_MVREF	SSTL Reference Voltage	G20	IO	G1VDD/2	–
FA_ANALOG_G_V	Reserved for internal use only	D20	IO	–	(15)
FA_ANALOG_PIN	Reserved for internal use only	C20	IO	–	(15)
SPARE1	Reserved for internal use only	H6	–	–	(12)
SPARE2	Reserved for internal use only	J6	–	–	(12)
SPARE3	Reserved for internal use only	K6	–	–	(12)
TD1_ANODE	Thermal diode anode	F21	IO		(19)
TD1_CATHODE	Thermal diode cathode	H21	IO		(19)
TH_TPA	Reserved for internal use only	G10	–	–	(12)
<b>Serdes 1</b>					
SD1_IMP_CAL_RX	SerDes Receive Impedance Calibration	AB12	I	S1VDD	(11)
SD1_IMP_CAL_TX	SerDes Transmit Impedance Calibration	AA20	I	X1VDD	(16)
SD1_PLL1_TPA	Reserved for internal use only	AA15	O	AVDD_SD1_PL L1	(12)

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
SD1_PLL1_TPD	Reserved for internal use only	AC15	O	X1VDD	(12)
SD1_PLL2_TPA	Reserved for internal use only	AA19	O	AVDD_SD1_PL L2	(12)
SD1_PLL2_TPD	Reserved for internal use only	AC19	O	X1VDD	(12)
SD1_REF_CLK1_N	SerDes PLL 1 Reference Clock Complement	AB14	I	S1VDD	–
SD1_REF_CLK1_P	SerDes PLL 1 Reference Clock	AC14	I	S1VDD	–
SD1_REF_CLK2_N	SerDes PLL 2 Reference Clock Complement	AB18	I	S1VDD	–
SD1_REF_CLK2_P	SerDes PLL 2 Reference Clock	AC18	I	S1VDD	–
SD1_RX0_N	SerDes Receive Data (negative)	AH10	I	S1VDD	–
SD1_RX0_P	SerDes Receive Data (positive)	AJ10	I	S1VDD	–
SD1_RX1_N	SerDes Receive Data (negative)	AH11	I	S1VDD	–
SD1_RX1_P	SerDes Receive Data (positive)	AJ11	I	S1VDD	–
SD1_RX2_N	SerDes Receive Data (negative)	AH13	I	S1VDD	–
SD1_RX2_P	SerDes Receive Data (positive)	AJ13	I	S1VDD	–
SD1_RX3_N	SerDes Receive Data (negative)	AH14	I	S1VDD	–
SD1_RX3_P	SerDes Receive Data (positive)	AJ14	I	S1VDD	–
SD1_RX4_N	SerDes Receive Data (negative)	AH16	I	S1VDD	–
SD1_RX4_P	SerDes Receive Data (positive)	AJ16	I	S1VDD	–
SD1_RX5_N	SerDes Receive Data (negative)	AH17	I	S1VDD	–
SD1_RX5_P	SerDes Receive Data (positive)	AJ17	I	S1VDD	–
SD1_RX6_N	SerDes Receive Data (negative)	AH19	I	S1VDD	–
SD1_RX6_P	SerDes Receive Data (positive)	AJ19	I	S1VDD	–
SD1_RX7_N	SerDes Receive Data (negative)	AH20	I	S1VDD	–
SD1_RX7_P	SerDes Receive Data (positive)	AJ20	I	S1VDD	–
SD1_TX0_N	SerDes Transmit Data (negative)	AF10	O	X1VDD	–
SD1_TX0_P	SerDes Transmit Data (positive)	AE10	O	X1VDD	–
SD1_TX1_N	SerDes Transmit Data (negative)	AF11	O	X1VDD	–
SD1_TX1_P	SerDes Transmit Data (positive)	AE11	O	X1VDD	–
SD1_TX2_N	SerDes Transmit Data (negative)	AF13	O	X1VDD	–
SD1_TX2_P	SerDes Transmit Data (positive)	AE13	O	X1VDD	–
SD1_TX3_N	SerDes Transmit Data (negative)	AF14	O	X1VDD	–
SD1_TX3_P	SerDes Transmit Data (positive)	AE14	O	X1VDD	–
SD1_TX4_N	SerDes Transmit Data (negative)	AF16	O	X1VDD	–
SD1_TX4_P	SerDes Transmit Data (positive)	AE16	O	X1VDD	–
SD1_TX5_N	SerDes Transmit Data (negative)	AF17	O	X1VDD	–
SD1_TX5_P	SerDes Transmit Data (positive)	AE17	O	X1VDD	–
SD1_TX6_N	SerDes Transmit Data (negative)	AF19	O	X1VDD	–
SD1_TX6_P	SerDes Transmit Data (positive)	AE19	O	X1VDD	–
SD1_TX7_N	SerDes Transmit Data (negative)	AF20	O	X1VDD	–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
SD1_TX7_P	SerDes Transmit Data (positive)	AE20	O	X1VDD	–
<b>USB PHY 1 &amp; 2</b>					
USB1_DRVVBUS	USB PHY Digital signal – Drive VBUS	G6	O	USB_HVDD	–
USB1_PWRFAULT	USB PHY Digital signal – Power Fault	G5	I	USB_HVDD	–
USB1_UDM	USB PHY Data Minus	G2	IO	USB_HVDD	–
USB1_UDP	USB PHY Data Plus	G1	IO	USB_HVDD	–
USB1_UID	USB PHY ID Detect	G4	I	USB_OVDD	–
USB1_VBUSCLMP	USB PHY VBUS	F4	I	USB_HVDD	–
USB2_DRVVBUS	USB PHY Digital signal – Drive VBUS	K5	O	USB_HVDD	–
USB2_PWRFAULT	USB PHY Digital signal – Power Fault	J5	I	USB_HVDD	–
USB2_UDM	USB PHY Data Minus	J2	IO	USB_HVDD	–
USB2_UDP	USB PHY Data Plus	J1	IO	USB_HVDD	–
USB2_UID	USB PHY ID Detect	J4	I	USB_OVDD	–
USB2_VBUSCLMP	USB PHY VBUS	K4	I	USB_HVDD	–
USB_IBIAS_REXT	USB PHY Impedance Calibration	H4	IO	USB_OVDD	(20)
<b>IEEE1588</b>					
TSEC_1588_ALARM_OUT1/GPIO3_03	Alarm Out 1	AG5	O	LVDD	(1)
TSEC_1588_ALARM_OUT2/GPIO3_04/EMI1_MDC	Alarm Out 2	AD7	O	LVDD	(1)
TSEC_1588_CLK_IN/GPIO3_00	Clock In	AD8	I	LVDD	(1)
TSEC_1588_CLK_OUT/GPIO3_05	Clock Out	AE7	O	LVDD	(1)
TSEC_1588_PULSE_OUT1/GPIO3_06	Pulse Out 1	AF6	O	LVDD	(1)
TSEC_1588_PULSE_OUT2/GPIO3_07	Pulse Out 2	AE8	O	LVDD	(1)
TSEC_1588_TRIG_IN1/GPIO3_01	Trigger In 1	AC6	I	LVDD	(1)
TSEC_1588_TRIG_IN2/GPIO3_02/EMI1_MDIO	Trigger In 2	AF5	I	LVDD	(1)
<b>Ethernet Management Interface 1</b>					
EMI1_MDC	Management Data Clock	AJ3	O	L1VDD	–
EMI1_MDC/TSEC_1588_ALARM_OUT2/GPIO3_04	Management Data Clock	AD7	O	LVDD	(1)
EMI1_MDIO	Management Data In/Out	AJ4	IO	L1VDD	–
EMI1_MDIO/TSEC_1588_TRIG_IN2/GPIO3_02	Management Data In/Out	AF5	IO	LVDD	–
<b>Ethernet controller 1 and GPIO</b>					
EC1_COL/GPIO3_10/MII_COL/MAC2_MII_COL	Collison Detect	AD1	IO	L1VDD	–
EC1_GTX_CLK/GPIO3_16/MII_TX_CLK/MAC2_GTX_CLK/MAC2_MII_TX_CLK	Transmit Clock Out	AG3	O	L1VDD	(1)
EC1_GTX_CLK125/GPIO3_17/MII_CRX/MAC2_GTX_CLK125/MAC2_MII_CRX	Reference Clock	AH3	I	L1VDD	(1)
EC1_RXD0/GPIO3_21/MII_RXD0/MAC2_RXD0/MAC2_MII_RXD0	Receive Data	AG2	I	L1VDD	(1)
EC1_RXD1/GPIO3_20/MII_RXD1/MAC2_RXD1/MAC2_MII_RXD1	Receive Data	AG1	I	L1VDD	(1)
EC1_RXD2/GPIO3_19/MII_RXD2/MAC2_RXD2/MAC2_MII_RXD2	Receive Data	AF1	I	L1VDD	(1)
EC1_RXD3/GPIO3_18/MII_RXD3/MAC2_RXD3/MAC2_MII_RXD3	Receive Data	AE2	I	L1VDD	(1)

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
EC1_RX_CLK/GPIO3_23/MII_RX_CLK/MAC2_RX_CLK/MAC2_MII_RX_CLK	Receive Clock	AE1	I	L1VDD	(1)
EC1_RX_CTL/GPIO3_22/MII_RX_DV/MAC2_RX_CTL/MAC2_MII_RX_DV	Receive Data Valid	AH2	I	L1VDD	(1)
EC1_RX_ER/GPIO3_09/MII_RX_ER/MAC2_MII_RX_ER	Receive Error	AD2	IO	L1VDD	–
EC1_TXD0/GPIO3_14/MII_TXD0/MAC2_TXD0/MAC2_MII_TXD0	Transmit Data	AF3	O	L1VDD	(1)
EC1_TXD1/GPIO3_13/MII_TXD1/MAC2_TXD1/MAC2_MII_TXD1	Transmit Data	AF4	O	L1VDD	(1)
EC1_TXD2/GPIO3_12/MII_TXD2/MAC2_TXD2/MAC2_MII_TXD2	Transmit Data	AE3	O	L1VDD	(1)
EC1_TXD3/GPIO3_11/MII_TXD3/MAC2_TXD3/MAC2_MII_TXD3	Transmit Data	AD3	O	L1VDD	(1)
EC1_TX_CTL/GPIO3_15/MII_TX_EN/MAC2_TX_CTL/MAC2_MII_TX_EN	Transmit Enable	AG4	O	L1VDD	(1)(14)
EC1_TX_ER/GPIO3_08/MII_TX_ER/MAC2_MII_TX_ER	Transmit Error	AD4	IO	L1VDD	(14)
<b>Ethernet controller 2 and GPIO</b>					
EC2_GTX_CLK/GPIO4_28	Transmit Clock Out	AF8	O	LVDD	(1)
EC2_GTX_CLK125/GPIO4_29	Reference Clock	AD6	I	LVDD	(1)
EC2_RXD0/GPIO3_31	Receive Data	AJ8	I	LVDD	(1)
EC2_RXD1/GPIO3_30	Receive Data	AH7	I	LVDD	(1)
EC2_RXD2/GPIO3_29	Receive Data	AJ7	I	LVDD	(1)
EC2_RXD3/GPIO3_28	Receive Data	AJ6	I	LVDD	(1)
EC2_RX_CLK/GPIO4_31	Receive Clock	AJ5	I	LVDD	(1)
EC2_RX_CTL/GPIO4_30	Receive Data Valid	AH8	I	LVDD	(1)
EC2_TXD0/GPIO3_27	Transmit Data	AF7	O	LVDD	(1)
EC2_TXD1/GPIO3_26	Transmit Data	AG7	O	LVDD	(1)
EC2_TXD2/GPIO3_25	Transmit Data	AG6	O	LVDD	(1)
EC2_TXD3/GPIO3_24	Transmit Data	AH5	O	LVDD	(1)
EC2_TX_CTL/GPIO4_27	Transmit Enable	AG8	O	LVDD	(1)(14)
<b>DSYSCLK</b>					
DIFF_SYSCLK	"Single Oscillator Source" Reference Clock Differential (positive)	H14	I	O1VDD	(18)
DIFF_SYSCLK_B	"Single Oscillator Source" Reference Clock Differential (negative)	G14	I	O1VDD	(18)
<b>USB Clocking</b>					
USBCLK	USB PHY Clock In	G8	I	O1VDD	(17)
<b>I2C 3 &amp; 4</b>					
IIC3_SCL/GPIO4_00	Serial Clock	W2	IO	DVDD	(7)(8)
IIC3_SDA/GPIO4_01	Serial Data	Y3	IO	DVDD	(7)(8)
IIC4_SCL/GPIO4_02/EVT5_B/DIU_HSYNC	Serial Clock	AB3	IO	DVDD	(7)(8)
IIC4_SDA/GPIO4_03/EVT6_B/DIU_VSYNC	Serial Data	AC3	IO	DVDD	(7)(8)
<b>DMA</b>					
DMA1_DACK0_B/GPIO4_05/TDM_TFS	DMA1 channel 0 acknowledge	V5	O	DVDD	(1)

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
DMA1_DDONE0_B/GPIO4_06/TDM_TCK	DMA1 channel 0 done	T5	O	DVDD	(1)
DMA1_DREQ0_B/GPIO4_04/TDM_TXD	DMA1 channel 0 request	R5	I	DVDD	(1)
DMA2_DACK0_B/GPIO4_08/EVT7_B/TDM_RFS	DMA2 channel 0 acknowledge	AB5	O	DVDD	(1)
DMA2_DDONE0_B/GPIO4_09/EVT8_B/TDM_RCK	DMA2 channel 0 done	AA5	O	DVDD	(1)
DMA2_DREQ0_B/GPIO4_07/TDM_RXD	DMA2 channel 0 request	W5	I	DVDD	(1)
<b>QE_TDM</b>					
CLK09/GPIO4_15/BRGO2/DIU_D10	External Clock	R4	I	DVDD	(1)
CLK10/GPIO4_22/BRGO3/DIU_D11	External Clock	R3	I	DVDD	(1)
CLK11/GPIO4_16/BRGO4/DIU_DE	External Clock	P4	I	DVDD	(1)
CLK12/GPIO4_23/BRGO1/DIU_CLK_OUT	External Clock	N4	I	DVDD	(1)(24)
TDMA_RQ/GPIO4_14/UC1_CDB_RXER/DIU_D4	Request	T2	O	DVDD	(1)
TDMA_RSYNC/GPIO4_11/UC1_CTSB_RXDV/DIU_D1	Receive Sync	V1	I	DVDD	(1)
TDMA_RXD/GPIO4_10/UC1_RXD7/DIU_D0/TDMA_TXD	Receive Data	V2	I	DVDD	(1)
TDMA_TSYNC/GPIO4_13/UC1_RTSB_TXEN/DIU_D3	Transmit Sync	T1	I	DVDD	(1)
TDMA_TXD/GPIO4_12/UC1_TXD7/DIU_D2/ TDMA_RXD_EXC	Transmit Data	U1	O	DVDD	(1)
TDMB_RQ/GPIO4_21/UC3_CDB_RXER/DIU_D9	Request	T4	O	DVDD	(1)
TDMB_RSYNC/GPIO4_18/UC3_CTSB_RXDV/DIU_D6	Receive Sync	U3	I	DVDD	(1)
TDMB_RXD/GPIO4_17/UC3_RXD7/DIU_D5/TDMB_TXD	Receive Data	V4	I	DVDD	(1)
TDMB_TSYNC/GPIO4_20/UC3_RTSB_TXEN/DIU_D8	Transmit Sync	T3	I	DVDD	(1)
TDMB_TXD/GPIO4_19/UC3_TXD7/DIU_D7/ TDMB_RXD_EXC	Transmit Data	U4	O	DVDD	(1)
<b>eSDHC</b>					
SDHC_CD_B/GPIO4_24	SDHC Card Detect	M5	I	CVDD	(1)
SDHC_CLK/GPIO2_09	Host to Card Clock	L1	IO	EVDD	–
SDHC_CLK_SYNC_IN/IRQ10/GPIO1_30	Clock Sync	M4	I	CVDD	(1)
SDHC_CLK_SYNC_OUT/SPI_CS3_B/GPIO2_03/ SDHC_DAT7/SDHC_DAT123_DIR	Clock Sync	P3	O	CVDD	(1)
SDHC_CMD/GPIO2_04	Command/Response	L3	IO	EVDD	–
SDHC_CMD_DIR/SPI_CS1_B/GPIO2_01/SDHC_DAT5	CMD direction control	N2	O	CVDD	(1)
SDHC_DAT0/GPIO2_05	Data	M2	IO	EVDD	–
SDHC_DAT0_DIR/SPI_CS2_B/GPIO2_02/SDHC_DAT6	Data	N3	O	CVDD	(1)
SDHC_DAT1/GPIO2_06	Data	L4	IO	EVDD	–
SDHC_DAT123_DIR/SPI_CS3_B/GPIO2_03/SDHC_DAT7/ SDHC_CLK_SYNC_OUT	Data	P3	O	CVDD	(1)
SDHC_DAT2/GPIO2_07	Data	M3	IO	EVDD	–
SDHC_DAT3/GPIO2_08	Data	M1	IO	EVDD	–
SDHC_DAT4/SPI_CS0_B/GPIO2_00	Data	N1	IO	CVDD	–
SDHC_DAT5/SPI_CS1_B/GPIO2_01/SDHC_CMD_DIR	Data	N2	IO	CVDD	–
SDHC_DAT6/SPI_CS2_B/GPIO2_02/SDHC_DAT0_DIR	Data	N3	IO	CVDD	–
SDHC_DAT7/SPI_CS3_B/GPIO2_03/SDHC_DAT123_DIR/ SDHC_CLK_SYNC_OUT	Data	P3	IO	CVDD	–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
SDHC_VS/IRQ03/GPIO1_23	Voltage Select	E1	IO	O1VDD	–
SDHC_WP/GPIO4_25	SDHC Write Protect	N5	I	CVDD	(1)
<b>Power-On-Reset Configuration</b>					
cfg_dram_type/IFC_A21	Power-On-Reset Configuration Signal	D8	I	OVDD	(1)(4)
cfg_eng_use0/IFC_WE0_B	Power-On-Reset Configuration Signal	E13	I	OVDD	(1)(21)
cfg_eng_use1/IFC_OE_B	Power-On-Reset Configuration Signal	E15	I	OVDD	(1)(21)
cfg_eng_use2/IFC_WP0_B	Power-On-Reset Configuration Signal	G17	I	OVDD	(1)
cfg_gpinput0/IFC_AD00	Power-On-Reset Configuration Signal	B4	I	OVDD	(1)(4)
cfg_gpinput1/IFC_AD01	Power-On-Reset Configuration Signal	C5	I	OVDD	(1)(4)
cfg_gpinput2/IFC_AD02	Power-On-Reset Configuration Signal	B5	I	OVDD	(1)(4)
cfg_gpinput3/IFC_AD03	Power-On-Reset Configuration Signal	C6	I	OVDD	(1)(4)
cfg_gpinput4/IFC_AD04	Power-On-Reset Configuration Signal	B6	I	OVDD	(1)(4)
cfg_gpinput5/IFC_AD05	Power-On-Reset Configuration Signal	B7	I	OVDD	(1)(4)
cfg_gpinput6/IFC_AD06	Power-On-Reset Configuration Signal	C8	I	OVDD	(1)(4)
cfg_gpinput7/IFC_AD07	Power-On-Reset Configuration Signal	B8	I	OVDD	(1)(4)
cfg_ifc_te/IFC_TE	Power-On-Reset Configuration Signal	C14	I	OVDD	(1)(4)
cfg_rcw_src0/IFC_AD08	Power-On-Reset Configuration Signal	C9	I	OVDD	(1)(4)
cfg_rcw_src1/IFC_AD09	Power-On-Reset Configuration Signal	B9	I	OVDD	(1)(4)
cfg_rcw_src2/IFC_AD10	Power-On-Reset Configuration Signal	B10	I	OVDD	(1)(4)
cfg_rcw_src3/IFC_AD11	Power-On-Reset Configuration Signal	C11	I	OVDD	(1)(4)
cfg_rcw_src4/IFC_AD12	Power-On-Reset Configuration Signal	B11	I	OVDD	(1)(4)
cfg_rcw_src5/IFC_AD13	Power-On-Reset Configuration Signal	C12	I	OVDD	(1)(4)
cfg_rcw_src6/IFC_AD14	Power-On-Reset Configuration Signal	B12	I	OVDD	(1)(4)
cfg_rcw_src7/IFC_AD15	Power-On-Reset Configuration Signal	B13	I	OVDD	(1)(4)
cfg_rcw_src8/IFC_CLE	Power-On-Reset Configuration Signal	G16	I	OVDD	(1)(4)
<b>General Purpose Input/Output</b>					
GPIO1_09/IFC_CS4_B	General Purpose Input/Output	F17	IO	OVDD	–
GPIO1_10/IFC_CS5_B	General Purpose Input/Output	D17	IO	OVDD	–
GPIO1_11/IFC_CS6_B	General Purpose Input/Output	E18	IO	OVDD	–
GPIO1_12/IFC_CS7_B	General Purpose Input/Output	D19	IO	OVDD	–
GPO1_13/ASLEEP	General Purpose Input/Output	C2	O	O1VDD	(1)
GPIO1_14/RTC	General Purpose Input/Output	C17	IO	OVDD	–
GPIO1_15/UART1_SOUT	General Purpose Input/Output	AB2	IO	DVDD	–
GPIO1_16/UART2_SOUT	General Purpose Input/Output	AB4	IO	DVDD	–
GPIO1_17/UART1_SIN	General Purpose Input/Output	AB1	IO	DVDD	–
GPIO1_18/UART2_SIN	General Purpose Input/Output	Y4	IO	DVDD	–
GPIO1_19/UART1_RTS_B/UART3_SOUT	General Purpose Input/Output	AA1	IO	DVDD	–
GPIO1_20/UART2_RTS_B/UART4_SOUT	General Purpose Input/Output	W4	IO	DVDD	–
GPIO1_21/UART1_CTS_B/UART3_SIN	General Purpose Input/Output	AA2	IO	DVDD	–
GPIO1_22/UART2_CTS_B/UART4_SIN	General Purpose Input/Output	AA4	IO	DVDD	–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GPIO1_23/IRQ03/SDHC_VS	General Purpose Input/Output	E1	IO	O1VDD	–
GPIO1_24/IRQ04	General Purpose Input/Output	E4	IO	O1VDD	–
GPIO1_25/IRQ05	General Purpose Input/Output	E5	IO	O1VDD	–
GPIO1_26/IRQ06	General Purpose Input/Output	AC4	IO	L1VDD	–
GPIO1_27/IRQ07	General Purpose Input/Output	AE5	IO	L1VDD	–
GPIO1_28/IRQ08	General Purpose Input/Output	AC1	IO	L1VDD	–
GPIO1_29/IRQ09	General Purpose Input/Output	AD5	IO	L1VDD	–
GPIO1_30/IRQ10/SDHC_CLK_SYNC_IN	General Purpose Input/Output	M4	IO	CVDD	–
GPIO1_31/IRQ11	General Purpose Input/Output	V3	IO	DVDD	–
GPIO2_00/SPI_CS0_B/SDHC_DAT4	General Purpose Input/Output	N1	IO	CVDD	–
GPIO2_01/SPI_CS1_B/SDHC_DAT5/SDHC_CMD_DIR	General Purpose Input/Output	N2	IO	CVDD	–
GPIO2_02/SPI_CS2_B/SDHC_DAT6/SDHC_DAT0_DIR	General Purpose Input/Output	N3	IO	CVDD	–
GPIO2_03/SPI_CS3_B/SDHC_DAT7/SDHC_DAT123_DIR/SDHC_CLK_SYNC_OUT	General Purpose Input/Output	P3	IO	CVDD	–
GPIO2_04/SDHC_CMD	General Purpose Input/Output	L3	IO	EVDD	–
GPIO2_05/SDHC_DAT0	General Purpose Input/Output	M2	IO	EVDD	–
GPIO2_06/SDHC_DAT1	General Purpose Input/Output	L4	IO	EVDD	–
GPIO2_07/SDHC_DAT2	General Purpose Input/Output	M3	IO	EVDD	–
GPIO2_08/SDHC_DAT3	General Purpose Input/Output	M1	IO	EVDD	–
GPIO2_09/SDHC_CLK	General Purpose Input/Output	L1	IO	EVDD	–
GPIO2_10/IFC_CS1_B	General Purpose Input/Output	F15	IO	OVDD	–
GPIO2_11/IFC_CS2_B	General Purpose Input/Output	E16	IO	OVDD	–
GPIO2_12/IFC_CS3_B	General Purpose Input/Output	D16	IO	OVDD	–
GPIO2_13/IFC_PAR0	General Purpose Input/Output	D15	IO	OVDD	–
GPIO2_14/IFC_PAR1	General Purpose Input/Output	D14	IO	OVDD	–
GPIO2_15/IFC_PERR_B	General Purpose Input/Output	F14	IO	OVDD	–
GPIO2_25/IFC_A25/IFC_WP1_B	General Purpose Input/Output	D10	IO	OVDD	–
GPIO2_26/IFC_A26/IFC_WP2_B	General Purpose Input/Output	F11	IO	OVDD	–
GPIO2_27/IFC_A27/IFC_WP3_B	General Purpose Input/Output	D11	IO	OVDD	–
GPIO2_28/IFC_A28	General Purpose Input/Output	E11	IO	OVDD	–
GPIO2_29/IFC_A29/IFC_RB2_B	General Purpose Input/Output	D12	IO	OVDD	–
GPIO2_30/IFC_A30/IFC_RB3_B	General Purpose Input/Output	E12	IO	OVDD	–
GPIO2_31/IFC_A31/IFC_RB4_B	General Purpose Input/Output	F12	IO	OVDD	–
GPIO3_00/TSEC_1588_CLK_IN	General Purpose Input/Output	AD8	IO	LVDD	–
GPIO3_01/TSEC_1588_TRIG_IN1	General Purpose Input/Output	AC6	IO	LVDD	–
GPIO3_02/TSEC_1588_TRIG_IN2/EMI1_MDIO	General Purpose Input/Output	AF5	IO	LVDD	–
GPIO3_03/TSEC_1588_ALARM_OUT1	General Purpose Input/Output	AG5	IO	LVDD	–
GPIO3_04/TSEC_1588_ALARM_OUT2/EMI1_MDC	General Purpose Input/Output	AD7	IO	LVDD	–
GPIO3_05/TSEC_1588_CLK_OUT	General Purpose Input/Output	AE7	IO	LVDD	–
GPIO3_06/TSEC_1588_PULSE_OUT1	General Purpose Input/Output	AF6	IO	LVDD	–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GPIO3_07/TSEC_1588_PULSE_OUT2	General Purpose Input/Output	AE8	IO	LVDD	–
GPIO3_08/EC1_TX_ER/MII_TX_ER/MAC2_MII_TX_ER	General Purpose Input/Output	AD4	IO	L1VDD	–
GPIO3_09/EC1_RX_ER/MII_RX_ER/MAC2_MII_RX_ER	General Purpose Input/Output	AD2	IO	L1VDD	–
GPIO3_10/EC1_COL/MII_COL/MAC2_MII_COL	General Purpose Input/Output	AD1	IO	L1VDD	–
GPIO3_11/EC1_TXD3/MII_TXD3/MAC2_TXD3/MAC2_MII_TXD3	General Purpose Input/Output	AD3	IO	L1VDD	–
GPIO3_12/EC1_TXD2/MII_TXD2/MAC2_TXD2/MAC2_MII_TXD2	General Purpose Input/Output	AE3	IO	L1VDD	–
GPIO3_13/EC1_TXD1/MII_TXD1/MAC2_TXD1/MAC2_MII_TXD1	General Purpose Input/Output	AF4	IO	L1VDD	–
GPIO3_14/EC1_TXD0/MII_TXD0/MAC2_TXD0/MAC2_MII_TXD0	General Purpose Input/Output	AF3	IO	L1VDD	–
GPIO3_15/EC1_TX_CTL/MII_TX_EN/MAC2_TX_CTL/MAC2_MII_TX_EN	General Purpose Input/Output	AG4	IO	L1VDD	–
GPIO3_16/EC1_GTX_CLK/MII_TX_CLK/MAC2_GTX_CLK/MAC2_MII_TX_CLK	General Purpose Input/Output	AG3	IO	L1VDD	–
GPIO3_17/EC1_GTX_CLK125/MII_CRS/MAC2_GTX_CLK125/MAC2_MII_CRS	General Purpose Input/Output	AH3	IO	L1VDD	–
GPIO3_18/EC1_RXD3/MII_RXD3/MAC2_RXD3/MAC2_MII_RXD3	General Purpose Input/Output	AE2	IO	L1VDD	–
GPIO3_19/EC1_RXD2/MII_RXD2/MAC2_RXD2/MAC2_MII_RXD2	General Purpose Input/Output	AF1	IO	L1VDD	–
GPIO3_20/EC1_RXD1/MII_RXD1/MAC2_RXD1/MAC2_MII_RXD1	General Purpose Input/Output	AG1	IO	L1VDD	–
GPIO3_21/EC1_RXD0/MII_RXD0/MAC2_RXD0/MAC2_MII_RXD0	General Purpose Input/Output	AG2	IO	L1VDD	–
GPIO3_22/EC1_RX_CTL/MII_RX_DV/MAC2_RX_CTL/MAC2_MII_RX_DV	General Purpose Input/Output	AH2	IO	L1VDD	–
GPIO3_23/EC1_RX_CLK/MII_RX_CLK/MAC2_RX_CLK/MAC2_MII_RX_CLK	General Purpose Input/Output	AE1	IO	L1VDD	–
GPIO3_24/EC2_TXD3	General Purpose Input/Output	AH5	IO	LVDD	–
GPIO3_25/EC2_TXD2	General Purpose Input/Output	AG6	IO	LVDD	–
GPIO3_26/EC2_TXD1	General Purpose Input/Output	AG7	IO	LVDD	–
GPIO3_27/EC2_TXD0	General Purpose Input/Output	AF7	IO	LVDD	–
GPIO3_28/EC2_RXD3	General Purpose Input/Output	AJ6	IO	LVDD	–
GPIO3_29/EC2_RXD2	General Purpose Input/Output	AJ7	IO	LVDD	–
GPIO3_30/EC2_RXD1	General Purpose Input/Output	AH7	IO	LVDD	–
GPIO3_31/EC2_RXD0	General Purpose Input/Output	AJ8	IO	LVDD	–
GPIO4_00/IIC3_SCL	General Purpose Input/Output	W2	IO	DVDD	–
GPIO4_01/IIC3_SDA	General Purpose Input/Output	Y3	IO	DVDD	–
GPIO4_02/IIC4_SCL/EVT5_B/DIU_HSYNC	General Purpose Input/Output	AB3	IO	DVDD	–
GPIO4_03/IIC4_SDA/EVT6_B/DIU_VSYNC	General Purpose Input/Output	AC3	IO	DVDD	–
GPIO4_04/DMA1_DREQ0_B/TDM_TXD	General Purpose Input/Output	R5	IO	DVDD	–
GPIO4_05/DMA1_DACK0_B/TDM_TFS	General Purpose Input/Output	V5	IO	DVDD	–
GPIO4_06/DMA1_DDONE0_B/TDM_TCK	General Purpose Input/Output	T5	IO	DVDD	–
GPIO4_07/DMA2_DREQ0_B/TDM_RXD	General Purpose Input/Output	W5	IO	DVDD	–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GPIO4_08/DMA2_DACK0_B/EVT7_B/TDM_RFS	General Purpose Input/Output	AB5	IO	DVDD	–
GPIO4_09/DMA2_DDONE0_B/EVT8_B/TDM_RCK	General Purpose Input/Output	AA5	IO	DVDD	–
GPIO4_10/TDMA_RXD/UC1_RXD7/DIU_D0	General Purpose Input/Output	V2	IO	DVDD	–
GPIO4_11/TDMA_RSXNC/UC1_CTSB_RXDV/DIU_D1	General Purpose Input/Output	V1	IO	DVDD	–
GPIO4_12/TDMA_TXD/UC1_TXD7/DIU_D2	General Purpose Input/Output	U1	IO	DVDD	–
GPIO4_13/TDMA_TSYNC/UC1_RTSB_TXEN/DIU_D3	General Purpose Input/Output	T1	IO	DVDD	–
GPIO4_14/TDMA_RQ/UC1_CDB_RXER/DIU_D4	General Purpose Input/Output	T2	IO	DVDD	–
GPIO4_15/CLK09/BRGO2/DIU_D10	General Purpose Input/Output	R4	IO	DVDD	–
GPIO4_16/CLK11/BRGO4/DIU_DE	General Purpose Input/Output	P4	IO	DVDD	–
GPIO4_17/TDMB_RXD/UC3_RXD7/DIU_D5	General Purpose Input/Output	V4	IO	DVDD	–
GPIO4_18/TDMB_RSXNC/UC3_CTSB_RXDV/DIU_D6	General Purpose Input/Output	U3	IO	DVDD	–
GPIO4_19/TDMB_TXD/UC3_TXD7/DIU_D7	General Purpose Input/Output	U4	IO	DVDD	–
GPIO4_20/TDMB_TSYNC/UC3_RTSB_TXEN/DIU_D8	General Purpose Input/Output	T3	IO	DVDD	–
GPIO4_21/TDMB_RQ/UC3_CDB_RXER/DIU_D9	General Purpose Input/Output	T4	IO	DVDD	–
GPIO4_22/CLK10/BRGO3/DIU_D11	General Purpose Input/Output	R3	IO	DVDD	–
GPIO4_23/CLK12/BRGO1/DIU_CLK_OUT	General Purpose Input/Output	N4	IO	DVDD	–
GPIO4_24/SDHC_CD_B	General Purpose Input/Output	M5	IO	CVDD	–
GPIO4_25/SDHC_WP	General Purpose Input/Output	N5	IO	CVDD	–
GPIO4_27/EC2_TX_CTL	General Purpose Input/Output	AG8	IO	LVDD	–
GPIO4_28/EC2_GTX_CLK	General Purpose Input/Output	AF8	IO	LVDD	–
GPIO4_29/EC2_GTX_CLK125	General Purpose Input/Output	AD6	IO	LVDD	–
GPIO4_30/EC2_RX_CTL	General Purpose Input/Output	AH8	IO	LVDD	–
GPIO4_31/EC2_RX_CLK	General Purpose Input/Output	AJ5	IO	LVDD	–
<b>DIU</b>					
DIU_CLK_OUT/CLK12/GPIO4_23/BRGO1	Pixel Clock	N4	O	DVDD	(1)
DIU_D0/TDMA_RXD/GPIO4_10/UC1_RXD7	DIU Data	V2	O	DVDD	(1)
DIU_D1/TDMA_RSXNC/GPIO4_11/UC1_CTSB_RXDV	DIU Data	V1	O	DVDD	(1)
DIU_D10/CLK09/GPIO4_15/BRGO2	DIU Data	R4	O	DVDD	(1)
DIU_D11/CLK10/GPIO4_22/BRGO3	DIU Data	R3	O	DVDD	(1)
DIU_D2/TDMA_TXD/GPIO4_12/UC1_TXD7	DIU Data	U1	O	DVDD	(1)
DIU_D3/TDMA_TSYNC/GPIO4_13/UC1_RTSB_TXEN	DIU Data	T1	O	DVDD	(1)
DIU_D4/TDMA_RQ/GPIO4_14/UC1_CDB_RXER	DIU Data	T2	O	DVDD	(1)
DIU_D5/TDMB_RXD/GPIO4_17/UC3_RXD7	DIU Data	V4	O	DVDD	(1)
DIU_D6/TDMB_RSXNC/GPIO4_18/UC3_CTSB_RXDV	DIU Data	U3	O	DVDD	(1)
DIU_D7/TDMB_TXD/GPIO4_19/UC3_TXD7	DIU Data	U4	O	DVDD	(1)
DIU_D8/TDMB_TSYNC/GPIO4_20/UC3_RTSB_TXEN	DIU Data	T3	O	DVDD	(1)
DIU_D9/TDMB_RQ/GPIO4_21/UC3_CDB_RXER	DIU Data	T4	O	DVDD	(1)
DIU_DE/CLK11/GPIO4_16/BRGO4	Data Enable	P4	O	DVDD	(1)
DIU_HSYNC/IIC4_SCL/GPIO4_02/EVT5_B	Horizontal sync	AB3	O	DVDD	(1)
DIU_VSYNC/IIC4_SDA/GPIO4_03/EVT6_B	Vertical sync	AC3	O	DVDD	(1)

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
<b>TDM</b>					
TDM_RCK/DMA2_DDONE0_B/GPIO4_09/EVT8_B	Receive clock	AA5	IO	DVDD	–
TDM_RFS/DMA2_DACK0_B/GPIO4_08/EVT7_B	Receive frame sync	AB5	IO	DVDD	–
TDM_RXD/DMA2_DREQ0_B/GPIO4_07	Receive data	W5	I	DVDD	(1)
TDM_TCK/DMA1_DDONE0_B/GPIO4_06	Transmit clock	T5	IO	DVDD	–
TDM_TFS/DMA1_DACK0_B/GPIO4_05	Transmit frame sync	V5	IO	DVDD	–
TDM_TXD/DMA1_DREQ0_B/GPIO4_04	Transmit data	R5	O	DVDD	(1)
<b>QE</b>					
BRGO1/CLK12/GPIO4_23/DIU_CLK_OUT	Baud rate generator	N4	O	DVDD	(1)
BRGO2/CLK09/GPIO4_15/DIU_D10	Baud rate generator	R4	O	DVDD	(1)
BRGO3/CLK10/GPIO4_22/DIU_D11	Baud rate generator	R3	O	DVDD	(1)
BRGO4/CLK11/GPIO4_16/DIU_DE	Baud rate generator	P4	O	DVDD	(1)
UC1_CDB_RXER/TDMA_RQ/GPIO4_14/DIU_D4	Receive Error	T2	I	DVDD	(1)
UC1_CTSB_RXDV/TDMA_RSYNC/GPIO4_11/DIU_D1	Receive DV	V1	I	DVDD	(1)
UC1_RTSB_TXEN/TDMA_TSYNC/GPIO4_13/DIU_D3	Transmit Enable	T1	O	DVDD	(1)
UC1_RXD7/TDMA_RXD/GPIO4_10/DIU_D0	Receive Data	V2	I	DVDD	(1)
UC1_TXD7/TDMA_TXD/GPIO4_12/DIU_D2	Transmit Data	U1	O	DVDD	(1)
UC3_CDB_RXER/TDMB_RQ/GPIO4_21/DIU_D9	Receive Error	T4	I	DVDD	(1)
UC3_CTSB_RXDV/TDMB_RSYNC/GPIO4_18/DIU_D6	Receive DV	U3	I	DVDD	(1)
UC3_RTSB_TXEN/TDMB_TSYNC/GPIO4_20/DIU_D8	Transmit Enable	T3	O	DVDD	(1)
UC3_RXD7/TDMB_RXD/GPIO4_17/DIU_D5	Receive Data	V4	I	DVDD	(1)
UC3_TXD7/TDMB_TXD/GPIO4_19/DIU_D7	Transmit Data	U4	O	DVDD	(1)
<b>Power and Ground Signals</b>					
GND	GND	AA10			–
GND	GND	AA11			–
GND	GND	AA12			–
GND	GND	AA22			–
GND	GND	AA24			–
GND	GND	AA26			–
GND	GND	AA30			–
GND	GND	AA32			–
GND	GND	AA34			–
GND	GND	AA36			–
GND	GND	AA38			–
GND	GND	AA40			–
GND	GND	AA42			–
GND	GND	AA44			–
GND	GND	AA46			–
GND	GND	AA48			–
GND	GND	AA50			–

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**Table 2-1.** Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GND	GND	AA6			–
GND	GND	AA7			–
GND	GND	AA8			–
GND	GND	AA9			–
GND	GND	AB10			–
GND	GND	AB11			–
GND	GND	AB23			–
GND	GND	AB25			–
GND	GND	AB29			–
GND	GND	AB31			–
GND	GND	AB33			–
GND	GND	AB35			–
GND	GND	AB37			–
GND	GND	AB39			–
GND	GND	AB41			–
GND	GND	AB43			–
GND	GND	AB45			–
GND	GND	AB47			–
GND	GND	AB49			–
GND	GND	AB51			–
GND	GND	AB6			–
GND	GND	AB7			–
GND	GND	AB8			–
GND	GND	AB9			–
GND	GND	AC11			–
GND	GND	AC12			–
GND	GND	AC2			–
GND	GND	AC22			–
GND	GND	AC24			–
GND	GND	AC26			–
GND	GND	AC28			–
GND	GND	AC30			–
GND	GND	AC32			–
GND	GND	AC34			–
GND	GND	AC36			–
GND	GND	AC38			–
GND	GND	AC40			–
GND	GND	AC42			–
GND	GND	AC44			–
GND	GND	AC46			–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GND	GND	AC48			–
GND	GND	AC5			–
GND	GND	AC50			–
GND	GND	AC7			–
GND	GND	AC8			–
GND	GND	AD23			–
GND	GND	AD25			–
GND	GND	AD27			–
GND	GND	AD29			–
GND	GND	AD31			–
GND	GND	AD33			–
GND	GND	AD35			–
GND	GND	AD37			–
GND	GND	AD39			–
GND	GND	AD41			–
GND	GND	AD43			–
GND	GND	AD45			–
GND	GND	AD47			–
GND	GND	AD49			–
GND	GND	AD51			–
GND	GND	AE22			–
GND	GND	AE24			–
GND	GND	AE26			–
GND	GND	AE28			–
GND	GND	AE30			–
GND	GND	AE32			–
GND	GND	AE34			–
GND	GND	AE36			–
GND	GND	AE38			–
GND	GND	AE4			–
GND	GND	AE40			–
GND	GND	AE42			–
GND	GND	AE44			–
GND	GND	AE46			–
GND	GND	AE48			–
GND	GND	AE50			–
GND	GND	AE6			–
GND	GND	AF2			–
GND	GND	AF23			–
GND	GND	AF25			–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GND	GND	AF27			–
GND	GND	AF29			–
GND	GND	AF31			–
GND	GND	AF33			–
GND	GND	AF35			–
GND	GND	AF37			–
GND	GND	AF39			–
GND	GND	AF41			–
GND	GND	AF43			–
GND	GND	AF45			–
GND	GND	AF47			–
GND	GND	AF49			–
GND	GND	AF51			–
GND	GND	AG21			–
GND	GND	AG22			–
GND	GND	AG24			–
GND	GND	AG26			–
GND	GND	AG28			–
GND	GND	AG30			–
GND	GND	AG32			–
GND	GND	AG34			–
GND	GND	AG36			–
GND	GND	AG38			–
GND	GND	AG39			–
GND	GND	AG40			–
GND	GND	AG41			–
GND	GND	AG42			–
GND	GND	AG43			–
GND	GND	AG44			–
GND	GND	AG46			–
GND	GND	AG48			–
GND	GND	AG50			–
GND	GND	AG9			–
GND	GND	AH1			–
GND	GND	AH23			–
GND	GND	AH25			–
GND	GND	AH27			–
GND	GND	AH29			–
GND	GND	AH31			–
GND	GND	AH33			–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GND	GND	AH35			–
GND	GND	AH37			–
GND	GND	AH39			–
GND	GND	AH4			–
GND	GND	AH41			–
GND	GND	AH43			–
GND	GND	AH45			–
GND	GND	AH47			–
GND	GND	AH49			–
GND	GND	AH51			–
GND	GND	AH6			–
GND	GND	AJ1			–
GND	GND	AJ2			–
GND	GND	AJ22			–
GND	GND	AJ24			–
GND	GND	AJ26			–
GND	GND	AJ28			–
GND	GND	AJ30			–
GND	GND	AJ32			–
GND	GND	AJ34			–
GND	GND	AJ36			–
GND	GND	AJ38			–
GND	GND	AJ40			–
GND	GND	AJ42			–
GND	GND	AJ44			–
GND	GND	AJ46			–
GND	GND	AJ48			–
GND	GND	AJ50			–
GND	GND	B1			–
GND	GND	B2			–
GND	GND	B20			–
GND	GND	B21			–
GND	GND	B23			–
GND	GND	B25			–
GND	GND	B27			–
GND	GND	B29			–
GND	GND	B31			–
GND	GND	B33			–
GND	GND	B35			–
GND	GND	B37			–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GND	GND	B39			–
GND	GND	B41			–
GND	GND	B43			–
GND	GND	B45			–
GND	GND	B47			–
GND	GND	B49			–
GND	GND	B51			–
GND	GND	C1			–
GND	GND	C10			–
GND	GND	C13			–
GND	GND	C16			–
GND	GND	C19			–
GND	GND	C22			–
GND	GND	C24			–
GND	GND	C26			–
GND	GND	C28			–
GND	GND	C30			–
GND	GND	C32			–
GND	GND	C34			–
GND	GND	C36			–
GND	GND	C38			–
GND	GND	C4			–
GND	GND	C40			–
GND	GND	C42			–
GND	GND	C44			–
GND	GND	C46			–
GND	GND	C48			–
GND	GND	C50			–
GND	GND	C7			–
GND	GND	D21			–
GND	GND	D23			–
GND	GND	D25			–
GND	GND	D27			–
GND	GND	D29			–
GND	GND	D31			–
GND	GND	D33			–
GND	GND	D35			–
GND	GND	D37			–
GND	GND	D39			–
GND	GND	D41			–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GND	GND	D43			–
GND	GND	D45			–
GND	GND	D47			–
GND	GND	D49			–
GND	GND	D51			–
GND	GND	E2			–
GND	GND	E20			–
GND	GND	E21			–
GND	GND	E22			–
GND	GND	E24			–
GND	GND	E26			–
GND	GND	E28			–
GND	GND	E30			–
GND	GND	E32			–
GND	GND	E34			–
GND	GND	E36			–
GND	GND	E38			–
GND	GND	E39			–
GND	GND	E40			–
GND	GND	E41			–
GND	GND	E42			–
GND	GND	E43			–
GND	GND	E44			–
GND	GND	E46			–
GND	GND	E48			–
GND	GND	E50			–
GND	GND	F10			–
GND	GND	F13			–
GND	GND	F16			–
GND	GND	F19			–
GND	GND	F23			–
GND	GND	F25			–
GND	GND	F27			–
GND	GND	F29			–
GND	GND	F31			–
GND	GND	F33			–
GND	GND	F35			–
GND	GND	F37			–
GND	GND	F39			–
GND	GND	F41			–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GND	GND	F43			–
GND	GND	F45			–
GND	GND	F47			–
GND	GND	F49			–
GND	GND	F5			–
GND	GND	F51			–
GND	GND	F7			–
GND	GND	G15			–
GND	GND	G22			–
GND	GND	G24			–
GND	GND	G26			–
GND	GND	G30			–
GND	GND	G32			–
GND	GND	G34			–
GND	GND	G36			–
GND	GND	G38			–
GND	GND	G40			–
GND	GND	G42			–
GND	GND	G44			–
GND	GND	G46			–
GND	GND	G48			–
GND	GND	G50			–
GND	GND	H13			–
GND	GND	H16			–
GND	GND	H17			–
GND	GND	H23			–
GND	GND	H25			–
GND	GND	H27			–
GND	GND	H29			–
GND	GND	H31			–
GND	GND	H33			–
GND	GND	H35			–
GND	GND	H37			–
GND	GND	H39			–
GND	GND	H41			–
GND	GND	H43			–
GND	GND	H45			–
GND	GND	H47			–
GND	GND	H49			–
GND	GND	H51			–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GND	GND	H7			–
GND	GND	J10			–
GND	GND	J11			–
GND	GND	J12			–
GND	GND	J13			–
GND	GND	J14			–
GND	GND	J15			–
GND	GND	J16			–
GND	GND	J17			–
GND	GND	J18			–
GND	GND	J19			–
GND	GND	J20			–
GND	GND	J22			–
GND	GND	J24			–
GND	GND	J26			–
GND	GND	J28			–
GND	GND	J30			–
GND	GND	J32			–
GND	GND	J34			–
GND	GND	J36			–
GND	GND	J38			–
GND	GND	J40			–
GND	GND	J42			–
GND	GND	J44			–
GND	GND	J46			–
GND	GND	J48			–
GND	GND	J50			–
GND	GND	J7			–
GND	GND	J8			–
GND	GND	J9			–
GND	GND	K20			–
GND	GND	K23			–
GND	GND	K25			–
GND	GND	K27			–
GND	GND	K29			–
GND	GND	K31			–
GND	GND	K33			–
GND	GND	K35			–
GND	GND	K37			–
GND	GND	K39			–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GND	GND	K41			–
GND	GND	K43			–
GND	GND	K45			–
GND	GND	K47			–
GND	GND	K49			–
GND	GND	K51			–
GND	GND	K7			–
GND	GND	L12			–
GND	GND	L14			–
GND	GND	L16			–
GND	GND	L18			–
GND	GND	L2			–
GND	GND	L20			–
GND	GND	L22			–
GND	GND	L24			–
GND	GND	L26			–
GND	GND	L28			–
GND	GND	L30			–
GND	GND	L32			–
GND	GND	L34			–
GND	GND	L36			–
GND	GND	L38			–
GND	GND	L40			–
GND	GND	L42			–
GND	GND	L44			–
GND	GND	L46			–
GND	GND	L48			–
GND	GND	L5			–
GND	GND	L50			–
GND	GND	L6			–
GND	GND	L7			–
GND	GND	M11			–
GND	GND	M13			–
GND	GND	M15			–
GND	GND	M17			–
GND	GND	M19			–
GND	GND	M23			–
GND	GND	M25			–
GND	GND	M27			–
GND	GND	M29			–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GND	GND	M31			–
GND	GND	M33			–
GND	GND	M35			–
GND	GND	M37			–
GND	GND	M39			–
GND	GND	M41			–
GND	GND	M43			–
GND	GND	M45			–
GND	GND	M47			–
GND	GND	M49			–
GND	GND	M51			–
GND	GND	M7			–
GND	GND	M9			–
GND	GND	N10			–
GND	GND	N12			–
GND	GND	N14			–
GND	GND	N16			–
GND	GND	N18			–
GND	GND	N20			–
GND	GND	N22			–
GND	GND	N24			–
GND	GND	N26			–
GND	GND	N28			–
GND	GND	N30			–
GND	GND	N32			–
GND	GND	N34			–
GND	GND	N36			–
GND	GND	N38			–
GND	GND	N40			–
GND	GND	N42			–
GND	GND	N44			–
GND	GND	N46			–
GND	GND	N48			–
GND	GND	N50			–
GND	GND	N7			–
GND	GND	N9			–
GND	GND	P11			–
GND	GND	P13			–
GND	GND	P15			–
GND	GND	P17			–

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**Table 2-1.** Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GND	GND	P19			–
GND	GND	P2			–
GND	GND	P23			–
GND	GND	P25			–
GND	GND	P27			–
GND	GND	P29			–
GND	GND	P31			–
GND	GND	P33			–
GND	GND	P35			–
GND	GND	P37			–
GND	GND	P39			–
GND	GND	P41			–
GND	GND	P43			–
GND	GND	P45			–
GND	GND	P47			–
GND	GND	P49			–
GND	GND	P5			–
GND	GND	P51			–
GND	GND	P6			–
GND	GND	P7			–
GND	GND	P9			–
GND	GND	R10			–
GND	GND	R12			–
GND	GND	R14			–
GND	GND	R16			–
GND	GND	R18			–
GND	GND	R20			–
GND	GND	R22			–
GND	GND	R24			–
GND	GND	R26			–
GND	GND	R28			–
GND	GND	R30			–
GND	GND	R32			–
GND	GND	R34			–
GND	GND	R36			–
GND	GND	R38			–
GND	GND	R40			–
GND	GND	R42			–
GND	GND	R44			–
GND	GND	R46			–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GND	GND	R48			–
GND	GND	R7			–
GND	GND	R9			–
GND	GND	T11			–
GND	GND	T13			–
GND	GND	T15			–
GND	GND	T17			–
GND	GND	T19			–
GND	GND	T23			–
GND	GND	T25			–
GND	GND	T27			–
GND	GND	T29			–
GND	GND	T39			–
GND	GND	T41			–
GND	GND	T43			–
GND	GND	T45			–
GND	GND	T47			–
GND	GND	T49			–
GND	GND	T7			–
GND	GND	T9			–
GND	GND	U10			–
GND	GND	U12			–
GND	GND	U14			–
GND	GND	U16			–
GND	GND	U18			–
GND	GND	U2			–
GND	GND	U20			–
GND	GND	U22			–
GND	GND	U24			–
GND	GND	U26			–
GND	GND	U28			–
GND	GND	U30			–
GND	GND	U40			–
GND	GND	U42			–
GND	GND	U44			–
GND	GND	U46			–
GND	GND	U48			–
GND	GND	U5			–
GND	GND	U50			–
GND	GND	U6			–

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**Table 2-1.** Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GND	GND	U7			–
GND	GND	U9			–
GND	GND	V11			–
GND	GND	V13			–
GND	GND	V15			–
GND	GND	V17			–
GND	GND	V19			–
GND	GND	V23			–
GND	GND	V25			–
GND	GND	V27			–
GND	GND	V29			–
GND	GND	V30			–
GND	GND	V39			–
GND	GND	V41			–
GND	GND	V43			–
GND	GND	V45			–
GND	GND	V47			–
GND	GND	V49			–
GND	GND	V51			–
GND	GND	V6			–
GND	GND	V7			–
GND	GND	V9			–
GND	GND	W10			–
GND	GND	W12			–
GND	GND	W14			–
GND	GND	W16			–
GND	GND	W18			–
GND	GND	W20			–
GND	GND	W22			–
GND	GND	W24			–
GND	GND	W26			–
GND	GND	W28			–
GND	GND	W30			–
GND	GND	W32			–
GND	GND	W34			–
GND	GND	W36			–
GND	GND	W38			–
GND	GND	W40			–
GND	GND	W42			–
GND	GND	W44			–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GND	GND	W46			–
GND	GND	W48			–
GND	GND	W50			–
GND	GND	W6			–
GND	GND	W7			–
GND	GND	W9			–
GND	GND	Y11			–
GND	GND	Y13			–
GND	GND	Y2			–
GND	GND	Y23			–
GND	GND	Y25			–
GND	GND	Y29			–
GND	GND	Y31			–
GND	GND	Y33			–
GND	GND	Y35			–
GND	GND	Y37			–
GND	GND	Y39			–
GND	GND	Y41			–
GND	GND	Y43			–
GND	GND	Y45			–
GND	GND	Y47			–
GND	GND	Y49			–
GND	GND	Y5			–
GND	GND	Y51			–
GND	GND	Y6			–
GND	GND	Y7			–
GND	GND	Y9			–
GND	NC/GND	A1			(28)
GND	NC/GND	A10			(28)
GND	NC/GND	A11			(28)
GND	NC/GND	A12			(28)
GND	NC/GND	A13			(28)
GND	NC/GND	A14			(28)
GND	NC/GND	A15			(28)
GND	NC/GND	A16			(28)
GND	NC/GND	A17			(28)
GND	NC/GND	A18			(28)
GND	NC/GND	A19			(28)
GND	NC/GND	A2			(28)
GND	NC/GND	A20			(28)

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**Table 2-1.** Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GND	NC/GND	A21			(28)
GND	NC/GND	A22			(28)
GND	NC/GND	A23			(28)
GND	NC/GND	A24			(28)
GND	NC/GND	A25			(28)
GND	NC/GND	A26			(28)
GND	NC/GND	A27			(28)
GND	NC/GND	A28			(28)
GND	NC/GND	A29			(28)
GND	NC/GND	A3			(28)
GND	NC/GND	A30			(28)
GND	NC/GND	A31			(28)
GND	NC/GND	A32			(28)
GND	NC/GND	A33			(28)
GND	NC/GND	A34			(28)
GND	NC/GND	A35			(28)
GND	NC/GND	A36			(28)
GND	NC/GND	A37			(28)
GND	NC/GND	A38			(28)
GND	NC/GND	A39			(28)
GND	NC/GND	A4			(28)
GND	NC/GND	A40			(28)
GND	NC/GND	A41			(28)
GND	NC/GND	A42			(28)
GND	NC/GND	A43			(28)
GND	NC/GND	A44			(28)
GND	NC/GND	A45			(28)
GND	NC/GND	A46			(28)
GND	NC/GND	A47			(28)
GND	NC/GND	A48			(28)
GND	NC/GND	A49			(28)
GND	NC/GND	A5			(28)
GND	NC/GND	A50			(28)
GND	NC/GND	A51			(28)
GND	NC/GND	A6			(28)
GND	NC/GND	A7			(28)
GND	NC/GND	A8			(28)
GND	NC/GND	A9			(28)
GND	NC/GND	AK1			(28)
GND	NC/GND	AK10			(28)

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GND	NC/GND	AK11			(28)
GND	NC/GND	AK12			(28)
GND	NC/GND	AK13			(28)
GND	NC/GND	AK14			(28)
GND	NC/GND	AK15			(28)
GND	NC/GND	AK16			(28)
GND	NC/GND	AK17			(28)
GND	NC/GND	AK18			(28)
GND	NC/GND	AK19			(28)
GND	NC/GND	AK2			(28)
GND	NC/GND	AK20			(28)
GND	NC/GND	AK21			(28)
GND	NC/GND	AK22			(28)
GND	NC/GND	AK23			(28)
GND	NC/GND	AK24			(28)
GND	NC/GND	AK25			(28)
GND	NC/GND	AK26			(28)
GND	NC/GND	AK27			(28)
GND	NC/GND	AK28			(28)
GND	NC/GND	AK29			(28)
GND	NC/GND	AK3			(28)
GND	NC/GND	AK30			(28)
GND	NC/GND	AK31			(28)
GND	NC/GND	AK32			(28)
GND	NC/GND	AK33			(28)
GND	NC/GND	AK34			(28)
GND	NC/GND	AK35			(28)
GND	NC/GND	AK36			(28)
GND	NC/GND	AK37			(28)
GND	NC/GND	AK38			(28)
GND	NC/GND	AK39			(28)
GND	NC/GND	AK4			(28)
GND	NC/GND	AK40			(28)
GND	NC/GND	AK41			(28)
GND	NC/GND	AK42			(28)
GND	NC/GND	AK43			(28)
GND	NC/GND	AK44			(28)
GND	NC/GND	AK45			(28)
GND	NC/GND	AK46			(28)
GND	NC/GND	AK47			(28)

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**Table 2-1.** Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
GND	NC/GND	AK48			(28)
GND	NC/GND	AK49			(28)
GND	NC/GND	AK5			(28)
GND	NC/GND	AK50			(28)
GND	NC/GND	AK51			(28)
GND	NC/GND	AK6			(28)
GND	NC/GND	AK7			(28)
GND	NC/GND	AK8			(28)
GND	NC/GND	AK9			(28)
1V2	DDR4 module power supply	AA29			–
1V2	DDR4 module power supply	AA31			–
1V2	DDR4 module power supply	AA33			–
1V2	DDR4 module power supply	AA35			–
1V2	DDR4 module power supply	AA37			–
1V2	DDR4 module power supply	AA39			–
1V2	DDR4 module power supply	AA41			–
1V2	DDR4 module power supply	AA43			–
1V2	DDR4 module power supply	AA45			–
1V2	DDR4 module power supply	AA47			–
1V2	DDR4 module power supply	AA49			–
1V2	DDR4 module power supply	AA51			–
1V2	DDR4 module power supply	AB30			–
1V2	DDR4 module power supply	AB50			–
1V2	DDR4 module power supply	AC29			–
1V2	DDR4 module power supply	AC31			–
1V2	DDR4 module power supply	AC33			–
1V2	DDR4 module power supply	AC35			–
1V2	DDR4 module power supply	AC37			–
1V2	DDR4 module power supply	AC39			–
1V2	DDR4 module power supply	AC41			–
1V2	DDR4 module power supply	AC43			–
1V2	DDR4 module power supply	AC45			–
1V2	DDR4 module power supply	AC47			–
1V2	DDR4 module power supply	AC49			–
1V2	DDR4 module power supply	AC51			–
1V2	DDR4 module power supply	AD30			–
1V2	DDR4 module power supply	AD50			–
1V2	DDR4 module power supply	AE29			–
1V2	DDR4 module power supply	AE31			–
1V2	DDR4 module power supply	AE33			–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
1V2	DDR4 module power supply	AE35			–
1V2	DDR4 module power supply	AE37			–
1V2	DDR4 module power supply	AE39			–
1V2	DDR4 module power supply	AE41			–
1V2	DDR4 module power supply	AE43			–
1V2	DDR4 module power supply	AE45			–
1V2	DDR4 module power supply	AE47			–
1V2	DDR4 module power supply	AE49			–
1V2	DDR4 module power supply	AE51			–
1V2	DDR4 module power supply	AF30			–
1V2	DDR4 module power supply	AF50			–
1V2	DDR4 module power supply	AG29			–
1V2	DDR4 module power supply	AG31			–
1V2	DDR4 module power supply	AG33			–
1V2	DDR4 module power supply	AG35			–
1V2	DDR4 module power supply	AG37			–
1V2	DDR4 module power supply	AG45			–
1V2	DDR4 module power supply	AG47			–
1V2	DDR4 module power supply	AG49			–
1V2	DDR4 module power supply	AG51			–
1V2	DDR4 module power supply	AH30			–
1V2	DDR4 module power supply	AH32			–
1V2	DDR4 module power supply	AH34			–
1V2	DDR4 module power supply	AH50			–
1V2	DDR4 module power supply	AJ29			–
1V2	DDR4 module power supply	AJ31			–
1V2	DDR4 module power supply	AJ33			–
1V2	DDR4 module power supply	AJ49			–
1V2	DDR4 module power supply	AJ51			–
1V2	DDR4 module power supply	B30			–
1V2	DDR4 module power supply	B32			–
1V2	DDR4 module power supply	B34			–
1V2	DDR4 module power supply	B36			–
1V2	DDR4 module power supply	B38			–
1V2	DDR4 module power supply	B40			–
1V2	DDR4 module power supply	B42			–
1V2	DDR4 module power supply	B44			–
1V2	DDR4 module power supply	B46			–
1V2	DDR4 module power supply	B48			–
1V2	DDR4 module power supply	B50			–

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**Table 2-1.** Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
1V2	DDR4 module power supply	C29			–
1V2	DDR4 module power supply	C31			–
1V2	DDR4 module power supply	C33			–
1V2	DDR4 module power supply	C35			–
1V2	DDR4 module power supply	C37			–
1V2	DDR4 module power supply	C39			–
1V2	DDR4 module power supply	C41			–
1V2	DDR4 module power supply	C43			–
1V2	DDR4 module power supply	C45			–
1V2	DDR4 module power supply	C47			–
1V2	DDR4 module power supply	C49			–
1V2	DDR4 module power supply	C51			–
1V2	DDR4 module power supply	D30			–
1V2	DDR4 module power supply	D32			–
1V2	DDR4 module power supply	D34			–
1V2	DDR4 module power supply	D36			–
1V2	DDR4 module power supply	D38			–
1V2	DDR4 module power supply	D40			–
1V2	DDR4 module power supply	D42			–
1V2	DDR4 module power supply	D44			–
1V2	DDR4 module power supply	D46			–
1V2	DDR4 module power supply	D48			–
1V2	DDR4 module power supply	D50			–
1V2	DDR4 module power supply	E29			–
1V2	DDR4 module power supply	E31			–
1V2	DDR4 module power supply	E33			–
1V2	DDR4 module power supply	E35			–
1V2	DDR4 module power supply	E37			–
1V2	DDR4 module power supply	E45			–
1V2	DDR4 module power supply	E47			–
1V2	DDR4 module power supply	E49			–
1V2	DDR4 module power supply	E51			–
1V2	DDR4 module power supply	F30			–
1V2	DDR4 module power supply	F50			–
1V2	DDR4 module power supply	G29			–
1V2	DDR4 module power supply	G31			–
1V2	DDR4 module power supply	G33			–
1V2	DDR4 module power supply	G35			–
1V2	DDR4 module power supply	G37			–
1V2	DDR4 module power supply	G39			–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
1V2	DDR4 module power supply	G41			–
1V2	DDR4 module power supply	G43			–
1V2	DDR4 module power supply	G45			–
1V2	DDR4 module power supply	G47			–
1V2	DDR4 module power supply	G49			–
1V2	DDR4 module power supply	G51			–
1V2	DDR4 module power supply	H30			–
1V2	DDR4 module power supply	H50			–
1V2	DDR4 module power supply	J29			–
1V2	DDR4 module power supply	J31			–
1V2	DDR4 module power supply	J33			–
1V2	DDR4 module power supply	J35			–
1V2	DDR4 module power supply	J37			–
1V2	DDR4 module power supply	J39			–
1V2	DDR4 module power supply	J41			–
1V2	DDR4 module power supply	J43			–
1V2	DDR4 module power supply	J45			–
1V2	DDR4 module power supply	J47			–
1V2	DDR4 module power supply	J49			–
1V2	DDR4 module power supply	J51			–
1V2	DDR4 module power supply	K30			–
1V2	DDR4 module power supply	K50			–
1V2	DDR4 module power supply	L29			–
1V2	DDR4 module power supply	L31			–
1V2	DDR4 module power supply	L33			–
1V2	DDR4 module power supply	L35			–
1V2	DDR4 module power supply	L37			–
1V2	DDR4 module power supply	L39			–
1V2	DDR4 module power supply	L41			–
1V2	DDR4 module power supply	L43			–
1V2	DDR4 module power supply	L45			–
1V2	DDR4 module power supply	L47			–
1V2	DDR4 module power supply	L49			–
1V2	DDR4 module power supply	L51			–
1V2	DDR4 module power supply	M30			–
1V2	DDR4 module power supply	M50			–
1V2	DDR4 module power supply	N29			–
1V2	DDR4 module power supply	N31			–
1V2	DDR4 module power supply	N33			–
1V2	DDR4 module power supply	N35			–

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**Table 2-1.** Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
1V2	DDR4 module power supply	N37			–
1V2	DDR4 module power supply	N39			–
1V2	DDR4 module power supply	N41			–
1V2	DDR4 module power supply	N43			–
1V2	DDR4 module power supply	N45			–
1V2	DDR4 module power supply	N47			–
1V2	DDR4 module power supply	N49			–
1V2	DDR4 module power supply	N51			–
1V2	DDR4 module power supply	P30			–
1V2	DDR4 module power supply	P50			–
1V2	DDR4 module power supply	R29			–
1V2	DDR4 module power supply	R31			–
1V2	DDR4 module power supply	R33			–
1V2	DDR4 module power supply	R35			–
1V2	DDR4 module power supply	R37			–
1V2	DDR4 module power supply	R39			–
1V2	DDR4 module power supply	R41			–
1V2	DDR4 module power supply	R43			–
1V2	DDR4 module power supply	R45			–
1V2	DDR4 module power supply	R47			–
1V2	DDR4 module power supply	R49			–
1V2	DDR4 module power supply	T30			–
1V2	DDR4 module power supply	U29			–
1V2	DDR4 module power supply	U39			–
1V2	DDR4 module power supply	U41			–
1V2	DDR4 module power supply	U43			–
1V2	DDR4 module power supply	U45			–
1V2	DDR4 module power supply	U47			–
1V2	DDR4 module power supply	U49			–
1V2	DDR4 module power supply	U51			–
1V2	DDR4 module power supply	V50			–
1V2	DDR4 module power supply	W29			–
1V2	DDR4 module power supply	W31			–
1V2	DDR4 module power supply	W33			–
1V2	DDR4 module power supply	W35			–
1V2	DDR4 module power supply	W37			–
1V2	DDR4 module power supply	W39			–
1V2	DDR4 module power supply	W41			–
1V2	DDR4 module power supply	W43			–
1V2	DDR4 module power supply	W45			–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
1V2	DDR4 module power supply	W47			–
1V2	DDR4 module power supply	W49			–
1V2	DDR4 module power supply	W51			–
1V2	DDR4 module power supply	Y30			–
1V2	DDR4 module power supply	Y50			–
DDR VTT	DDR4 termination	R50			–
DDR VTT	DDR4 termination	R51			–
DDR VTT	DDR4 termination	T50			–
DDR VTT	DDR4 termination	T51			–
DDR VPP	DDR4 activating power supply	AH36			–
DDR VPP	DDR4 activating power supply	AH38			–
DDR VPP	DDR4 activating power supply	AH40			–
DDR VPP	DDR4 activating power supply	AH42			–
DDR VPP	DDR4 activating power supply	AH44			–
DDR VPP	DDR4 activating power supply	AH46			–
DDR VPP	DDR4 activating power supply	AH48			–
DDR VPP	DDR4 activating power supply	AJ35			–
DDR VPP	DDR4 activating power supply	AJ37			–
DDR VPP	DDR4 activating power supply	AJ39			–
DDR VPP	DDR4 activating power supply	AJ41			–
DDR VPP	DDR4 activating power supply	AJ43			–
DDR VPP	DDR4 activating power supply	AJ45			–
DDR VPP	DDR4 activating power supply	AJ47			–
USB_AGND01	USB PHY Transceiver GND	F1	–	–	–
USB_AGND02	USB PHY Transceiver GND	F2	–	–	–
USB_AGND03	USB PHY Transceiver GND	F3	–	–	–
USB_AGND04	USB PHY Transceiver GND	G3	–	–	–
USB_AGND05	USB PHY Transceiver GND	H1	–	–	–
USB_AGND06	USB PHY Transceiver GND	H2	–	–	–
USB_AGND07	USB PHY Transceiver GND	H3	–	–	–
USB_AGND08	USB PHY Transceiver GND	H5	–	–	–
USB_AGND09	USB PHY Transceiver GND	J3	–	–	–
USB_AGND10	USB PHY Transceiver GND	K1	–	–	–
USB_AGND11	USB PHY Transceiver GND	K2	–	–	–
USB_AGND12	USB PHY Transceiver GND	K3	–	–	–
X1GND01	Serdes 1 transceiver GND	AD10	–	–	–
X1GND02	Serdes 1 transceiver GND	AD11	–	–	–
X1GND03	Serdes 1 transceiver GND	AD13	–	–	–
X1GND04	Serdes 1 transceiver GND	AD14	–	–	–
X1GND05	Serdes 1 transceiver GND	AD16	–	–	–

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**Table 2-1.** Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
X1GND06	Serdes 1 transceiver GND	AD17	–	–	–
X1GND07	Serdes 1 transceiver GND	AD19	–	–	–
X1GND08	Serdes 1 transceiver GND	AD20	–	–	–
X1GND09	Serdes 1 transceiver GND	AE9	–	–	–
X1GND10	Serdes 1 transceiver GND	AE12	–	–	–
X1GND11	Serdes 1 transceiver GND	AE15	–	–	–
X1GND12	Serdes 1 transceiver GND	AE18	–	–	–
X1GND13	Serdes 1 transceiver GND	AE21	–	–	–
X1GND14	Serdes 1 transceiver GND	AF9	–	–	–
X1GND15	Serdes 1 transceiver GND	AF12	–	–	–
X1GND16	Serdes 1 transceiver GND	AF15	–	–	–
X1GND17	Serdes 1 transceiver GND	AF18	–	–	–
X1GND18	Serdes 1 transceiver GND	AF21	–	–	–
S1GND01	Serdes 1 core logic GND	AA14	–	–	–
S1GND02	Serdes 1 core logic GND	AA16	–	–	–
S1GND03	Serdes 1 core logic GND	AA17	–	–	–
S1GND04	Serdes 1 core logic GND	AA18	–	–	–
S1GND05	Serdes 1 core logic GND	AB13	–	–	–
S1GND06	Serdes 1 core logic GND	AB15	–	–	–
S1GND07	Serdes 1 core logic GND	AB17	–	–	–
S1GND08	Serdes 1 core logic GND	AB19	–	–	–
S1GND09	Serdes 1 core logic GND	AB21	–	–	–
S1GND10	Serdes 1 core logic GND	AC13	–	–	–
S1GND11	Serdes 1 core logic GND	AC17	–	–	–
S1GND12	Serdes 1 core logic GND	AC21	–	–	–
S1GND13	Serdes 1 core logic GND	AG10	–	–	–
S1GND14	Serdes 1 core logic GND	AG11	–	–	–
S1GND15	Serdes 1 core logic GND	AG12	–	–	–
S1GND16	Serdes 1 core logic GND	AG13	–	–	–
S1GND17	Serdes 1 core logic GND	AG14	–	–	–
S1GND18	Serdes 1 core logic GND	AG15	–	–	–
S1GND19	Serdes 1 core logic GND	AG16	–	–	–
S1GND20	Serdes 1 core logic GND	AG17	–	–	–
S1GND21	Serdes 1 core logic GND	AG18	–	–	–
S1GND22	Serdes 1 core logic GND	AG19	–	–	–
S1GND23	Serdes 1 core logic GND	AG20	–	–	–
S1GND24	Serdes 1 core logic GND	AH9	–	–	–
S1GND25	Serdes 1 core logic GND	AH12	–	–	–
S1GND26	Serdes 1 core logic GND	AH15	–	–	–
S1GND27	Serdes 1 core logic GND	AH18	–	–	–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
S1GND28	Serdes 1 core logic GND	AH21	–	–	–
S1GND29	Serdes 1 core logic GND	AJ9	–	–	–
S1GND30	Serdes 1 core logic GND	AJ12	–	–	–
S1GND31	Serdes 1 core logic GND	AJ15	–	–	–
S1GND32	Serdes 1 core logic GND	AJ18	–	–	–
S1GND33	Serdes 1 core logic GND	AJ21	–	–	–
AGND_SD1_PLL1	Serdes 1 PLL 1 GND	AB16	–	–	–
AGND_SD1_PLL2	Serdes 1 PLL 2 GND	AB20	–	–	–
SENSEGND	GND Sense pin	H20	–	–	–
SENSEGNDC	GND Sense pin for VDDC domain	AC10	–	–	–
O1VDD1	General I/O supply – Always on	K11	–	O1VDD	–
O1VDD2	General I/O supply – Always on	K12	–	O1VDD	–
O1VDD3	General I/O supply – Always on	K13	–	O1VDD	–
OVDD1	General I/O supply – Switchable	K14	–	OVDD	–
OVDD2	General I/O supply – Switchable	K15	–	OVDD	–
OVDD3	General I/O supply – Switchable	K16	–	OVDD	–
OVDD4	General I/O supply – Switchable	K17	–	OVDD	–
OVDD5	General I/O supply – Switchable	K18	–	OVDD	–
OVDD6	General I/O supply – Switchable	K19	–	OVDD	–
DVDD1	UART/I2C/DMA/TDM supply – Switchable	P8	–	DVDD	–
DVDD2	UART/I2C/DMA/TDM supply – Switchable	R8	–	DVDD	–
DVDD3	UART/I2C/DMA/TDM supply – Switchable	T8	–	DVDD	–
CVDD	SPI supply – Switchable	N8	–	CVDD	–
EVDD	eSDHC supply – Switchable	M8	–	EVDD	–
L1VDD1	Ethernet controller 1 and GPIO supply- Always ON	U8	–	L1VDD	–
L1VDD2	Ethernet controller 1 and GPIO supply- Always ON	V8	–	L1VDD	–
LVDD1	Ethernet controller 2, 1588 and GPIO supply- Switchable	W8	–	LVDD	–
LVDD2	Ethernet controller 2, 1588 and GPIO supply- Switchable	Y8	–	LVDD	–
S1VDD1	SerDes 1 core logic supply – Switchable	Y15	–	S1VDD	–
S1VDD2	SerDes 1 core logic supply – Switchable	Y16	–	S1VDD	–
S1VDD3	SerDes 1 core logic supply – Switchable	Y17	–	S1VDD	–
S1VDD4	SerDes 1 core logic supply – Switchable	Y18	–	S1VDD	–
S1VDD5	SerDes 1 core logic supply – Switchable	Y19	–	S1VDD	–
S1VDD6	SerDes 1 core logic supply – Switchable	Y20	–	S1VDD	–
S1VDD7	SerDes 1 core logic supply – Switchable	AA13	–	S1VDD	–
X1VDD1	SerDes 1 transceiver supply – Switchable	AD9	–	X1VDD	–

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**Table 2-1.** Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
X1VDD2	SerDes 1 transceiver supply – Switchable	AD12	–	X1VDD	–
X1VDD3	SerDes 1 transceiver supply – Switchable	AD15	–	X1VDD	–
X1VDD4	SerDes 1 transceiver supply – Switchable	AD18	–	X1VDD	–
X1VDD5	SerDes 1 transceiver supply – Switchable	AD21	–	X1VDD	–
PROG_SFP	SFP Fuse Programming supply	G12	–	PROG_SFP	–
PROG_MTR	Reserved for Internal Use Only	G11	–	PROG_MTR	(15)
FA_VL	Reserved for Internal Use Only	H18	–	FA_VL	(15)
TH_VDD	Thermal Monitor Unit supply – Switchable	H9	–	TH_VDD	–
VDD01	Supply for cores and platform – Switchable	L15	–	VDD	–
VDD02	Supply for cores and platform – Switchable	L17	–	VDD	–
VDD03	Supply for cores and platform – Switchable	L19	–	VDD	–
VDD04	Supply for cores and platform – Switchable	M12	–	VDD	–
VDD05	Supply for cores and platform – Switchable	M14	–	VDD	–
VDD06	Supply for cores and platform – Switchable	M16	–	VDD	–
VDD07	Supply for cores and platform – Switchable	M18	–	VDD	–
VDD08	Supply for cores and platform – Switchable	M20	–	VDD	–
VDD09	Supply for cores and platform – Switchable	N13	–	VDD	–
VDD10	Supply for cores and platform – Switchable	N15	–	VDD	–
VDD11	Supply for cores and platform – Switchable	N17	–	VDD	–
VDD12	Supply for cores and platform – Switchable	N19	–	VDD	–
VDD13	Supply for cores and platform – Switchable	P12	–	VDD	–
VDD14	Supply for cores and platform – Switchable	P14	–	VDD	–
VDD15	Supply for cores and platform – Switchable	P16	–	VDD	–
VDD16	Supply for cores and platform – Switchable	P18	–	VDD	–
VDD17	Supply for cores and platform – Switchable	P20	–	VDD	–
VDD18	Supply for cores and platform – Switchable	R11	–	VDD	–
VDD19	Supply for cores and platform – Switchable	R13	–	VDD	–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
VDD20	Supply for cores and platform – Switchable	R15	–	VDD	–
VDD21	Supply for cores and platform – Switchable	R17	–	VDD	–
VDD22	Supply for cores and platform – Switchable	R19	–	VDD	–
VDD23	Supply for cores and platform – Switchable	T12	–	VDD	–
VDD24	Supply for cores and platform – Switchable	T14	–	VDD	–
VDD25	Supply for cores and platform – Switchable	T16	–	VDD	–
VDD26	Supply for cores and platform – Switchable	T18	–	VDD	–
VDD27	Supply for cores and platform – Switchable	T20	–	VDD	–
VDD28	Supply for cores and platform – Switchable	U13	–	VDD	–
VDD29	Supply for cores and platform – Switchable	U15	–	VDD	–
VDD30	Supply for cores and platform – Switchable	U17	–	VDD	–
VDD31	Supply for cores and platform – Switchable	U19	–	VDD	–
VDD32	Supply for cores and platform – Switchable	V14	–	VDD	–
VDD33	Supply for cores and platform – Switchable	V16	–	VDD	–
VDD34	Supply for cores and platform – Switchable	V18	–	VDD	–
VDD35	Supply for cores and platform – Switchable	V20	–	VDD	–
VDD36	Supply for cores and platform – Switchable	W13	–	VDD	–
VDD37	Supply for cores and platform – Switchable	W15	–	VDD	–
VDD38	Supply for cores and platform – Switchable	W17	–	VDD	–
VDD39	Supply for cores and platform – Switchable	W19	–	VDD	–
VDD40	Supply for cores and platform – Switchable	Y14	–	VDD	–
VDDC01	Always ON supply	L11	–	VDDC	–
VDDC02	Always ON supply	L13	–	VDDC	–
VDDC03	Always ON supply	M10	–	VDDC	–
VDDC04	Always ON supply	N11	–	VDDC	–
VDDC05	Always ON supply	P10	–	VDDC	–
VDDC06	Always ON supply	T10	–	VDDC	–
VDDC07	Always ON supply	U11	–	VDDC	–
VDDC08	Always ON supply	V10	–	VDDC	–

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**Table 2-1.** Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
VDDC09	Always ON supply	V12	–	VDDC	–
VDDC10	Always ON supply	W11	–	VDDC	–
VDDC11	Always ON supply	Y10	–	VDDC	–
VDDC12	Always ON supply	Y12	–	VDDC	–
AVDD_CGA1	e5500 Cluster Group A PLL1 supply (SDHC/Cores fed through this) – Switchable	H11	–	AVDD_CGA1	–
AVDD_CGA2	e5500 Cluster Group A PLL2 supply (Cores are fed through this) – Switchable	H12	–	AVDD_CGA2	–
AVDD_PLAT	Platform PLL supply – Always ON	H10	–	AVDD_PLAT	–
AVDD_D1	DDR1 PLL supply – Switchable	F20	–	AVDD_D1	–
AVDD_SD1_PLL1	SerDes1 PLL 1 supply – Switchable	AC16	–	AVDD_SD1_PL L1	–
AVDD_SD1_PLL2	SerDes1 PLL 2 supply – Switchable	AC20	–	AVDD_SD1_PL L2	–
SENSEVDD	Vdd Sense pin – Switchable	H19	–	SENSEVDD	–
SENSEVDDC	Vddc Sense pin – Always ON	AC9	–	SENSEVDDC	–
USB_HVDD1	USB PHY Transceiver 3.3V Supply – "Optionally Switchable or Always ON"	K8	–	USB_HVDD	–
USB_HVDD2	USB PHY Transceiver 3.3V Supply – "Optionally Switchable or Always ON"	L8	–	USB_HVDD	–
USB_OVDD1	USB PHY Transceiver 1.8V Supply – "Optionally Switchable or Always ON"	K9	–	USB_OVDD	–
USB_OVDD2	USB PHY Transceiver 1.8V Supply – "Optionally Switchable or Always ON"	K10	–	USB_OVDD	–
USB_SVDD1	USB PHY Analog 1.0V Supply – "Optionally Switchable or Always ON"	L9	–	USB_SVDD	–
USB_SVDD2	USB PHY Analog 1.0V Supply – "Optionally Switchable or Always ON"	L10	–	USB_SVDD	–
G1Vdd	DDR supply for port 1 – Switchable	AA21			–
G1Vdd	DDR supply for port 1 – Switchable	AA23			–
G1Vdd	DDR supply for port 1 – Switchable	AA25			–
G1Vdd	DDR supply for port 1 – Switchable	AA27			–
G1Vdd	DDR supply for port 1 – Switchable	AA28			–
G1Vdd	DDR supply for port 1 – Switchable	AB22			–
G1Vdd	DDR supply for port 1 – Switchable	AB24			–
G1Vdd	DDR supply for port 1 – Switchable	AB26			–
G1Vdd	DDR supply for port 1 – Switchable	AB27			–
G1Vdd	DDR supply for port 1 – Switchable	AB28			–
G1Vdd	DDR supply for port 1 – Switchable	AC23			–
G1Vdd	DDR supply for port 1 – Switchable	AC25			–
G1Vdd	DDR supply for port 1 – Switchable	AC27			–
G1Vdd	DDR supply for port 1 – Switchable	AD22			–
G1Vdd	DDR supply for port 1 – Switchable	AD24			–
G1Vdd	DDR supply for port 1 – Switchable	AD26			–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
G1Vdd	DDR supply for port 1 – Switchable	AD28			–
G1Vdd	DDR supply for port 1 – Switchable	AE23			–
G1Vdd	DDR supply for port 1 – Switchable	AE25			–
G1Vdd	DDR supply for port 1 – Switchable	AE27			–
G1Vdd	DDR supply for port 1 – Switchable	AF22			–
G1Vdd	DDR supply for port 1 – Switchable	AF24			–
G1Vdd	DDR supply for port 1 – Switchable	AF26			–
G1Vdd	DDR supply for port 1 – Switchable	AF28			–
G1Vdd	DDR supply for port 1 – Switchable	AG23			–
G1Vdd	DDR supply for port 1 – Switchable	AG25			–
G1Vdd	DDR supply for port 1 – Switchable	AG27			–
G1Vdd	DDR supply for port 1 – Switchable	AH22			–
G1Vdd	DDR supply for port 1 – Switchable	AH24			–
G1Vdd	DDR supply for port 1 – Switchable	AH26			–
G1Vdd	DDR supply for port 1 – Switchable	AH28			–
G1Vdd	DDR supply for port 1 – Switchable	AJ23			–
G1Vdd	DDR supply for port 1 – Switchable	AJ25			–
G1Vdd	DDR supply for port 1 – Switchable	AJ27			–
G1Vdd	DDR supply for port 1 – Switchable	B22			–
G1Vdd	DDR supply for port 1 – Switchable	B24			–
G1Vdd	DDR supply for port 1 – Switchable	B26			–
G1Vdd	DDR supply for port 1 – Switchable	B28			–
G1Vdd	DDR supply for port 1 – Switchable	C21			–
G1Vdd	DDR supply for port 1 – Switchable	C23			–
G1Vdd	DDR supply for port 1 – Switchable	C25			–
G1Vdd	DDR supply for port 1 – Switchable	C27			–
G1Vdd	DDR supply for port 1 – Switchable	D22			–
G1Vdd	DDR supply for port 1 – Switchable	D24			–
G1Vdd	DDR supply for port 1 – Switchable	D26			–
G1Vdd	DDR supply for port 1 – Switchable	D28			–
G1Vdd	DDR supply for port 1 – Switchable	E23			–
G1Vdd	DDR supply for port 1 – Switchable	E25			–
G1Vdd	DDR supply for port 1 – Switchable	E27			–
G1Vdd	DDR supply for port 1 – Switchable	F22			–
G1Vdd	DDR supply for port 1 – Switchable	F24			–
G1Vdd	DDR supply for port 1 – Switchable	F26			–
G1Vdd	DDR supply for port 1 – Switchable	F28			–
G1Vdd	DDR supply for port 1 – Switchable	G21			–
G1Vdd	DDR supply for port 1 – Switchable	G23			–
G1Vdd	DDR supply for port 1 – Switchable	G25			–

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**Table 2-1.** Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
G1Vdd	DDR supply for port 1 – Switchable	G27			–
G1Vdd	DDR supply for port 1 – Switchable	G28			–
G1Vdd	DDR supply for port 1 – Switchable	H22			–
G1Vdd	DDR supply for port 1 – Switchable	H24			–
G1Vdd	DDR supply for port 1 – Switchable	H26			–
G1Vdd	DDR supply for port 1 – Switchable	H28			–
G1Vdd	DDR supply for port 1 – Switchable	J21			–
G1Vdd	DDR supply for port 1 – Switchable	J23			–
G1Vdd	DDR supply for port 1 – Switchable	J25			–
G1Vdd	DDR supply for port 1 – Switchable	J27			–
G1Vdd	DDR supply for port 1 – Switchable	K22			–
G1Vdd	DDR supply for port 1 – Switchable	K24			–
G1Vdd	DDR supply for port 1 – Switchable	K26			–
G1Vdd	DDR supply for port 1 – Switchable	K28			–
G1Vdd	DDR supply for port 1 – Switchable	L21			–
G1Vdd	DDR supply for port 1 – Switchable	L23			–
G1Vdd	DDR supply for port 1 – Switchable	L25			–
G1Vdd	DDR supply for port 1 – Switchable	L27			–
G1Vdd	DDR supply for port 1 – Switchable	M21			–
G1Vdd	DDR supply for port 1 – Switchable	M22			–
G1Vdd	DDR supply for port 1 – Switchable	M24			–
G1Vdd	DDR supply for port 1 – Switchable	M26			–
G1Vdd	DDR supply for port 1 – Switchable	N21			–
G1Vdd	DDR supply for port 1 – Switchable	N23			–
G1Vdd	DDR supply for port 1 – Switchable	N25			–
G1Vdd	DDR supply for port 1 – Switchable	N27			–
G1Vdd	DDR supply for port 1 – Switchable	P21			–
G1Vdd	DDR supply for port 1 – Switchable	P22			–
G1Vdd	DDR supply for port 1 – Switchable	P24			–
G1Vdd	DDR supply for port 1 – Switchable	P26			–
G1Vdd	DDR supply for port 1 – Switchable	P28			–
G1Vdd	DDR supply for port 1 – Switchable	R21			–
G1Vdd	DDR supply for port 1 – Switchable	R23			–
G1Vdd	DDR supply for port 1 – Switchable	R25			–
G1Vdd	DDR supply for port 1 – Switchable	R27			–
G1Vdd	DDR supply for port 1 – Switchable	T21			–
G1Vdd	DDR supply for port 1 – Switchable	T22			–
G1Vdd	DDR supply for port 1 – Switchable	T24			–
G1Vdd	DDR supply for port 1 – Switchable	T26			–
G1Vdd	DDR supply for port 1 – Switchable	T28			–

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Table 2-1. Pinout List (Continued)

Signal	Signal description	Package pin number	Pin type	Power supply	Notes
G1Vdd	DDR supply for port 1 – Switchable	U21			–
G1Vdd	DDR supply for port 1 – Switchable	U23			–
G1Vdd	DDR supply for port 1 – Switchable	U25			–
G1Vdd	DDR supply for port 1 – Switchable	U27			–
G1Vdd	DDR supply for port 1 – Switchable	V21			–
G1Vdd	DDR supply for port 1 – Switchable	V22			–
G1Vdd	DDR supply for port 1 – Switchable	V24			–
G1Vdd	DDR supply for port 1 – Switchable	V26			–
G1Vdd	DDR supply for port 1 – Switchable	V28			–
G1Vdd	DDR supply for port 1 – Switchable	W21			–
G1Vdd	DDR supply for port 1 – Switchable	W23			–
G1Vdd	DDR supply for port 1 – Switchable	W25			–
G1Vdd	DDR supply for port 1 – Switchable	W27			–
G1Vdd	DDR supply for port 1 – Switchable	Y21			–
G1Vdd	DDR supply for port 1 – Switchable	Y22			–
G1Vdd	DDR supply for port 1 – Switchable	Y24			–
G1Vdd	DDR supply for port 1 – Switchable	Y26			–
G1Vdd	DDR supply for port 1 – Switchable	Y27			–
G1Vdd	DDR supply for port 1 – Switchable	Y28			–
NC01	No Connection	M6	–	–	–
NC02	No Connection	N6	–	–	–
NC03	No Connection	R6	–	–	–
NC04	No Connection	T6	–	–	–

- Notes:
- Functionally, this pin is an output or an input, but structurally it is an I/O because it either sample configuration input during reset, is a muxed pin, or has other manufacturing test functions. This pin is therefore be described as an I/O for boundary scan.
  - During reset this output signal is actively driven rather than being tri-stated.
  - MDIC[0] is grounded through a 162Ω precision 1% resistor and MDIC[1] is connected to GV1DD through a 162Ω precision 1% resistor. For either full or half driver strength calibration of DDR IOs, use the same MDIC resistor value of 162Ω. Memory controller register setting can be used to determine automatic calibration is done to full or half drive strength. These pins are used for automatic calibration of the DDR4 IOs. The MDIC[0:1] pins must be connected to 162Ω precision 1% resistors.
  - This pin is a reset configuration pin. It has a weak (~20 kΩ) internal pull-up P-FET that is enabled only when the processor is in its reset state. This pull-up is designed such that it can be overpowered by an external 4.7 kΩ resistor. However, if the signal is intended to be high after reset, and if there is any device on the net that might pull down the value of the net at reset, a pull-up or active driver is needed.
  - Pin must **NOT** be pulled down during power-on reset. This pin may be pulled up, driven high, or if there are any externally connected devices, left in tristate. If this pin is connected to a device that pulls down during reset, an external pull-up is required to drive this pin to a safe state during reset.
  - Recommend that a weak pull-up resistor (2-10 kΩ) be placed on this pin to the respective power supply.
  - This pin is an open-drain signal.
  - Recommend that a weak pull-up resistor (1 kΩ) be placed on this pin to the respective power supply.
  - This pin has a weak (~20 kΩ) internal pull-up P-FET that is always enabled.
  - These are test signals for factory use only and must be pulled up (100Ω to 1-kΩ) to the respective power supply for normal operation.

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11. This pin requires a 200Ω pull-up to respective power-supply.
12. Do not connect. These pins should be left floating.
- 13.
14. This pin requires an external 1-kΩ pull-down resistor to prevent PHY from seeing a valid Transmit Enable before it is actively driven.
15. These pins must be pulled to ground (GND).
16. This pin requires a 698Ω pull-up to respective power-supply.
17. This pin should be connected to ground through 2-10kΩ resistor when not used.
18. This pin should be connected to ground through 2-10kΩ resistor when SYSCLK input is used as system clock.
19. This pin should be tied to ground if the diode is not utilized for temperature monitoring.
20. This pin should be connected to GND through a 10kΩ ± 1% resistor with a low temperature coefficient of ≤ 25ppm/°C for bias generation
21. This pin has a weak (~20 kΩ) internal pull-up P-FET that is enabled only when the processor is in its reset state. This pin should have an optional pull down resistor on board. This is required to support DIFF\_SYSCLOCK/DIFF\_SYSCLOCK\_B
22. This pin should not be sampled until PORESET\_B gets deasserted.
23. This pin must be pulled to O1VDD through a 100-Ω to 1k-Ω resistor for a 4 core QT1040 and tied to ground for a 2 core QT1020 device.
24. External “CLK12” pin is connected internally to both CLK12 and CLK8 pins of QE.
25. The alternate signal in DDR4 configuration is mentioned in QT1040 Reference Manual.
26. PORESET\_B should be asserted zero during the JTAG Boundary scan operation, and is required to be controllable on board.
27. This pin requires a pull-up to the respective power supply so as to meet the timing requirements in [Table 3-21](#).
28. This pin is internally connected to the ground plane. On the PCB it can either be connected to the ground plane, or left floating because of routing constraint.

## Warning

See “[Connection recommendations](#)” for additional details on properly connecting these pins for specific applications.

## 3. ELECTRICAL CHARACTERISTICS

This section provides the AC and DC electrical specifications for the chip. The chip is currently targeted to these specifications, some of which are independent of the I/O cell but are included for a more complete reference. These are not purely I/O buffer design specifications.

### 3.1 Overall DC electrical characteristics

This section describes the ratings, conditions, and other characteristics.

#### 3.1.1 Absolute maximum ratings

This table provides the absolute maximum ratings.

**Table 3-1.** Absolute maximum ratings<sup>(1)</sup>

Characteristic	Symbol	Max Value	Unit	Notes
Core and platform supply voltage	V <sub>DD</sub>	-0.3 to 1.1	V	(9)
Always ON supply voltage	V <sub>DDC</sub>	-0.3 to 1.1	V	–
DDR4 termination	V <sub>TT</sub>	G1V <sub>DD</sub> /2		(11)
DDR4 activating power supply	V <sub>PP</sub>	-0.4 to 3.0		(11)
DDR4 module power supply	1V2	-0.4 to 1.5	V	–

Table 3-1. Absolute maximum ratings<sup>(1)</sup> (Continued)

Characteristic		Symbol	Max Value	Unit	Notes
PLL supply voltage (core PLL/eSDHC, platform, DDR)		AV <sub>DD_CGA1</sub> AV <sub>DD_CGA2</sub> AV <sub>DD_PLAT</sub> AV <sub>DD_D1</sub>	-0.3 to 1.98	V	(10)
PLL supply voltage (SerDes, filtered from X1V <sub>DD</sub> )		AVDD_SD1_PLL1 AVDD_SD1_PLL2	-0.3 to 1.48	V	-
SFP fuse programming		PROG_SFP	-0.3 to 1.98	V	-
Thermal monitor unit supply		TH_V <sub>DD</sub>	-0.3 to 1.98	V	-
MPIC, GPIO, system control and power management, clocking, debug, IFC, DDRCLK supply, and JTAG I/O voltage		OV <sub>DD</sub> O1V <sub>DD</sub>	-0.3 to 1.98	V	-
DUART, I <sup>2</sup> C, DMA, TDM, QE, MPIC, DIU		DV <sub>DD</sub>	-0.3 to 2.75 -0.3 to 1.98 -0.3 to 3.63	V	-
eSPI, SDHC_WP, SDHC_CD, SDHC_DAT[4:7]		CV <sub>DD</sub>	-0.3 to 1.98 -0.3 to 3.63	V	-
eSDHC		EV <sub>DD</sub>	-0.3 to 1.98 -0.3 to 3.63	V	-
DDR4 DRAM I/O voltage	DDR4	G1V <sub>DD</sub>	-0.3 to 1.32	V	-
Main power supply for internal circuitry of SerDes and pad power supply for SerDes receivers		S1V <sub>DD</sub>	-0.3 to 1.1	V	-
Pad power supply for SerDes transmitter		X1V <sub>DD</sub>	-0.3 to 1.48	V	-
Ethernet interface 2, 1588, GPIO		LV <sub>DD</sub>	-0.3 to 1.98 -0.3 to 2.75 -0.3 to 3.63	V	-
Ethernet interface 1, Ethernet management interface 1 (EMI1), GPIO		L1V <sub>DD</sub>	-0.3 to 1.98 -0.3 to 2.75 -0.3 to 3.63	V	-
USB PHY Transceiver supply voltage		USB_HV <sub>DD</sub>	-0.3 to 3.63	V	-
		USB_OV <sub>DD</sub>	-0.3 to 1.98	V	-
USB PHY Analog supply voltage		USB_SV <sub>DD</sub>	-0.3 to 1.1	V	-
Input voltage	DDR4 DRAM signals	MV <sub>IN</sub>	-0.3 to (G1V <sub>DD</sub> + 0.3)	V	(2)
	DDR4 DRAM reference	D1_MVREF	-0.3 to (G1V <sub>DD</sub> /2 + 0.3)	V	(5)
	Ethernet signals	LV <sub>IN</sub> LV1 <sub>IN</sub>	-0.3 to (LnV <sub>DD</sub> + 0.3)	V	(4)(5)
	MPIC, GPIO, system control and power management, clocking, debug, IFC, DDRCLK supply, and JTAG I/O voltage	OV <sub>IN</sub> O1V <sub>IN</sub>	-0.3 to (OnV <sub>DD</sub> + 0.3)	V	(3)(5)
	eSDHC signals	EV <sub>IN</sub>	-0.3 to (EV <sub>DD</sub> + 0.3)	V	(7)(5)
	eSPI signals	CV <sub>IN</sub>	-0.3 to (CV <sub>DD</sub> + 0.3)	V	(8)(5)
	DUART, I <sup>2</sup> C, DMA, TDM, QE, MPIC, DIU	DV <sub>IN</sub>	-0.3 to (DV <sub>DD</sub> + 0.3)	V	(5)(6)
	SerDes signals	S1V <sub>IN</sub>	-0.4 to (S1V <sub>DD</sub> + 0.3)	V	(5)
	USB PHY Transceiver signals	USB_HV <sub>IN</sub>	-0.3 to (USB_HV <sub>DD</sub> + 0.3)	V	(5)
USB_OV <sub>IN</sub>		-0.3 to (USB_OV <sub>DD</sub> + 0.3)	V	(5)	
Storage temperature range		T <sub>STG</sub>	-55 to 150	°C	-

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- Notes:
1. Functional operating conditions are given in Table 3-2. Absolute maximum ratings are stress ratings only, and functional operation at the maximums is not guaranteed. Stresses beyond those listed may affect device reliability or cause permanent damage to the device.
  2. **Caution:**  $MV_{IN}$  must not exceed  $G1V_{DD}$  by more than 0.3V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
  3. **Caution:**  $OV_{IN}$  must not exceed  $OV_{DD}$  by more than 0.3V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
  4. **Caution:**  $LV_{IN}$  must not exceed  $LV_{DD}$  by more than 0.3V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
  5. (S,G,L,O,D,E,C) $V_{IN}$ ,  $USBn\_V_{IN\_3P3}$ ,  $USBn\_V_{IN\_1P8}$  and  $D1\_MVREF$  may overshoot/undershoot to a voltage and for a maximum duration as shown in Figure 3-1.
  6. **Caution:**  $DV_{IN}$  must not exceed  $DV_{DD}$  by more than 0.3V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
  7. **Caution:**  $EV_{IN}$  must not exceed  $EV_{DD}$  by more than 0.3V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
  8. **Caution:**  $CV_{IN}$  must not exceed  $CV_{DD}$  by more than 0.3V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
  9. Supply voltage specified at the voltage sense pin. Voltage input pins should be regulated to provide specified voltage at the sense pin.
  10.  $AVDD\_PLAT$ ,  $AVDD\_CGA1$ ,  $AVDD\_CGA2$  and  $AVDD\_D1$  are measured at the input to the filter (as shown in AN4825) and not at the pin of the device.
  11.  $V_{PP}$  must equal or greater than 1V2 at all times when powered.

## 3.1.2 Recommended operating conditions

This table provides the recommended operating conditions for this chip.

### NOTE

The values shown are the recommended operating conditions and proper device operation outside these conditions is not guaranteed.

**Table 3-2.** Recommended operating conditions

Characteristic	Symbol	Recommended Value	Unit	Status in Deep Sleep <sup>(6)</sup>	Notes
Core and platform supply voltage	$V_{DD}$	$1.0 \pm 30$ mV	V	OFF	(3)(4)(5)
Always ON Core and Platform supply	$V_{DDC}$	$1.0 \pm 30$ mV	V	ON	(3)(4)(5)
DDR4 termination	$V_{TT}$	$G1V_{DD}/2 \pm 1\%$			(7)
DDR4 activating power supply	$V_{PP}$	$2.5V \pm 125$ mV			(8)
DDR4 module power supply	1V2	$1.2 \pm 60$ mV	V	–	–
PLL supply voltage (core PLL/eSDHC, platform, DDR)	$AV_{DD\_CGA1}$	$1.8V \pm 90$ mV	V	OFF	–
	$AV_{DD\_CGA2}$			OFF	
	$AV_{DD\_PLAT}$			ON	
	$AV_{DD\_D1}$			OFF	
PLL supply voltage (SerDes, filtered from $X1V_{DD}$ )	$AV_{DD\_SD1\_PLL1}$ $AV_{DD\_SD1\_PLL2}$	$1.35V \pm 67$ mV	V	OFF	–
SFP fuse programming	PROG_SFP	$1.8V \pm 90$ mV	V	ON	(2)
Thermal monitor unit supply	TH_ $V_{DD}$	$1.8V \pm 90$ mV	V	OFF	–
IFC, GPIO, Trust, DDRCLK supply, RTC and JTAG I/O voltage	$OV_{DD}$	$1.8V \pm 90$ mV	V	OFF	–

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Table 3-2. Recommended operating conditions (Continued)

Characteristic		Symbol	Recommended Value	Unit	Status in Deep Sleep <sup>(6)</sup>	Notes
MPIC, GPIO, system control, debug and SYSCLK supply		O1V <sub>DD</sub>	1.8V ± 90 mV	V	ON	–
DUART, I <sup>2</sup> C, DMA, MPIC, QE, TDM, DIU		DV <sub>DD</sub>	2.5V ± 125 mV 1.8V ± 90 mV 3.3V ± 165 mV	V	OFF	–
eSPI, SDHC_WP, SDHC_CD, SDHC_DAT[4:7]		CV <sub>DD</sub>	3.3V ± 165mV 1.8V ± 90mV	V	OFF	–
eSDHC		EV <sub>DD</sub>	3.3V ± 165 mV 1.8V ± 90 mV	V	OFF	–
DDR DRAM I/O voltage	DDR4	G1V <sub>DD</sub>	1.2V ± 60 mV	V	OFF	–
Main power supply for internal circuitry of SerDes and pad power supply for SerDes receivers		S1V <sub>DD</sub>	1.0V + 50 mV 1.0V – 30 mV	V	OFF	–
Pad power supply for SerDes transmitters		X1V <sub>DD</sub>	1.35V ± 67 mV	V	OFF	–
Ethernet interface 2, 1588, GPIO		LV <sub>DD</sub>	1.8V ± 90 mV 2.5V ± 125 mV 3.3V ± 165 mV	V	OFF	(1)
Ethernet interface 1, Ethernet management interface 1 (EMI1), GPIO		L1V <sub>DD</sub>	1.8V ± 90 mV 2.5V ± 125 mV 3.3V ± 165 mV	V	ON	(1)
USB PHY Transceiver supply voltage		USB_HV <sub>DD</sub>	3.3V ± 165 mV	V	Optionally OFF	–
		USB_OV <sub>DD</sub>	1.8V ± 90 mV	V	Optionally OFF	–
USB PHY Analog supply voltage		USB_SV <sub>DD</sub>	1.0 ± 50mV	V	Optionally OFF	(3)
Input voltage	DDR4 DRAM signals	MV <sub>IN</sub>	GND to G1V <sub>DD</sub>	V	–	–
	DDR4 DRAM reference		G1V <sub>DD</sub> /2 ± 1%	V	–	–
	Ethernet interface, EMI1, 1588, GPIO	LV <sub>IN</sub> L1V	GND to LV <sub>DD</sub> GND to L1V	V	–	–
	MPIC, GPIO, system control and power management, clocking, debug, IFC, DDRCLK supply, and JTAG I/O voltage	OV <sub>IN</sub> O1V <sub>IN</sub>	GND to OnV <sub>DD</sub>	V	–	–
	DUART, I <sup>2</sup> C, DMA, TDM, QE, MPIC, DIU	DV <sub>IN</sub>	GND to DV <sub>DD</sub>	V	–	–
	eSDHC, eSPI	CV <sub>IN</sub> , EV <sub>IN</sub>	GND to CV <sub>DD</sub> /EV <sub>DD</sub>	V	–	–
	SerDes signals	SV <sub>IN</sub>	GND to S1V <sub>DD</sub>	V	–	–
	USB PHY Transceiver signals	USB_HV <sub>IN</sub>	GND to USB_HV <sub>DD</sub>	V	–	–
USB_OV <sub>IN</sub>		GND to USB_OV <sub>DD</sub>	V	–	–	
Operating temperature range	Industrial	T <sub>C</sub> , T <sub>J</sub>	T <sub>C</sub> = –40 (min) to T <sub>J</sub> = 110 (max)	°C	–	–
	Military	T <sub>C</sub> , T <sub>J</sub>	T <sub>C</sub> = –55 (min) to T <sub>J</sub> = 125(max)	°C	–	–
	Secure boot fuse programming	T <sub>A</sub> , T <sub>J</sub>	T <sub>A</sub> = 0 (min) to T <sub>J</sub> = 70 (max)	°C	–	(2)

Notes: 1. Selecting RGMII limits L1VDD and LVDD = 1.8V or 2.5V. L1VDD and LVDD should be configured at same voltage.

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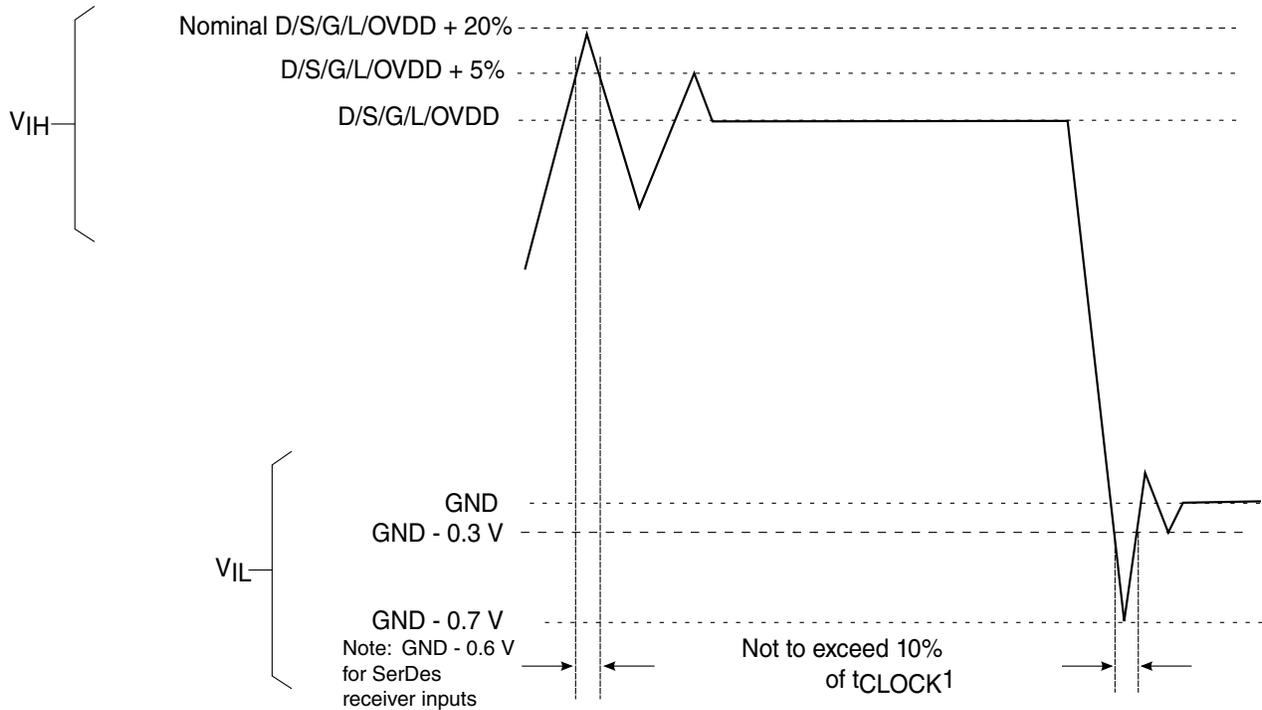
2. PROG\_SFP must be supplied 1.8V and the chip must operate in the specified fuse programming temperature range only during secure boot fuse programming. For all other operating conditions, PROG\_SFP must be tied to GND, subject to the power sequencing constraints shown in Power sequencing.
3. Refer to Core and platform supply voltage filtering for additional information.
4. Supply voltage specified at the voltage sense pin. Voltage input pins should be regulated to provide specified voltage at the sense pin.
5. Operation at 1.1V is allowable for up to 25ms at initial power on.
6. The Power supplies designated as OFF in this column should be switched OFF during Deep Sleep and those designated as ON should not be switched OFF. There are few power supplies which can be optionally switched OFF, for more details refer QT1040 QorIQ Integrated Multicore Communications Processor Reference Manual.
7. This power supply needs a sink and source regulator
8.  $V_{PP}$  must equal or greater than 1V2 at all times when powered.

## Warning

When the device is in Deep Sleep mode, all external voltage supplies applied to any I/O pins, with the exception of wake-up pins, must be turned off. Applying external voltage to any I/O pins, except the wake up pins, while the device is in Deep Sleep mode may cause permanent damage to the device.

This figure shows the undershoot and overshoot voltages at the interfaces of the chip.

**Figure 3-1.** Overshoot/Undershoot voltage for G1V<sub>DD</sub>/L1V<sub>DD</sub>/OV<sub>DD</sub>/SV<sub>DD</sub>/DV<sub>DD</sub>/CV<sub>DD</sub>/LV<sub>DD</sub>/EV<sub>DD</sub>



## Notes:

$t_{CLOCK}$  refers to the clock period associated with the respective interface:

For I<sup>2</sup>C OV<sub>DD</sub>,  $t_{CLOCK}$  references SYSCLK.

For DDR GV<sub>DD</sub>,  $t_{CLOCK}$  references Dn\_MCLK.

For eSPI OV<sub>DD</sub>,  $t_{CLOCK}$  references SPI\_CLK.

For JTAG  $OV_{DD}$ ,  $t_{CLOCK}$  references TCK.

For SerDes SVDD,  $t_{CLOCK}$  references SD\_REF\_CLK.

For Ethernet  $LV_{DD}$ ,  $t_{CLOCK}$  references ECn\_GTX\_CLK125.

See Table 3-2 for actual recommended core voltage. Voltage to the processor interface I/Os are provided through separate sets of supply pins and must be provided at the voltages shown in Table 3-2. The input voltage threshold scales with respect to the associated I/O supply voltage.  $DV_{DD}$ ,  $OV_{DD}$  and  $LV_{DD}$  based receivers are simple CMOS I/O circuits and satisfy appropriate LVCMOS type specifications. The DDR SDRAM interface uses differential receivers referenced by the externally supplied  $Dn\_MV_{REF}$  signal (nominally set to  $G1V_{DD}/2$ ) as is appropriate for the SSTL\_1.35/SSTL\_1.2 electrical signaling standard. The DDR MDQS receivers cannot be operated in single-ended fashion. The complement signal must be properly driven and cannot be grounded.

### 3.1.3 Output driver characteristics

This chip provides information on the characteristics of the output driver strengths.

**NOTE**

These values are preliminary estimates.

**Table 3-3.** Output drive capability

Driver type	Output impedance ( $\Omega$ )			Supply Voltage	Notes
	Minimum <sup>(2)</sup>	Typical	Maximum <sup>(3)</sup>		
DDR4 signal	–	18(full-strength mode) 27(half-strength mode)	–	$G1V_{DD} = 1.2V$	(1)
Ethernet signals	45	–	90	$L1V_{DD} / LV_{DD} = 3.3V$	–
	40	–	90	$L1V_{DD} / LV_{DD} = 2.5V$	–
	40	–	75	$L1V_{DD} / LV_{DD} = 1.8V$	–
MPIC, GPIO, system control and power management, clocking, debug, IFC,DDRCLK supply, and JTAG I/O voltage	23	–	51	$OV_{DD}, O1V_{DD} = 1.8V$	–
DUART, DMA, MPIC, QE, TDM, I <sup>2</sup> C, DIU	45	–	90	$DV_{DD} = 3.3V$	–
	40	–	90	$DV_{DD} = 2.5V$	–
	40	–	75	$DV_{DD} = 1.8V$	–
eSPI, SDHC_WP, SDHC_CD	45	–	90	$CV_{DD} = 3.3V$	–
	40	–	75	$CV_{DD} = 1.8V$	–
eSDHC	45	–	90	$EV_{DD} = 3.3V$	–
	40	–	75	$EV_{DD} = 1.8V$	–

- Notes: 1. The drive strength of the DDR4 interface in half-strength mode is at  $T_j = 105\text{ }^\circ\text{C}$  and at  $G1V_{DD}$  (min).  
 2. Estimated number based on best case processed device.  
 3. Estimated number based on worst case processed device.

## 3.1.4 General AC timing specifications

This table provides AC timing specifications for the sections not covered under the specific interface sections.

**Table 3-4.** AC Timing specifications

Parameter	Symbol	Min	Max	Unit	Notes
Input signal rise and fall times	$t_R/t_F$	–	5	ns	(1)

Note: 1. Rise time refers to signal transitions from 10% to 90% of Supply; fall time refers to transitions from 90% to 10% of supply

## 3.2 Power sequencing

The chip requires that its power rails be applied in a specific sequence in order to ensure proper device operation.

Power up sequence when DDR4 is used

1.  $O1V_{DD}$ ,  $OV_{DD}$ ,  $DV_{DD}$ ,  $CV_{DD}$ ,  $EV_{DD}$ ,  $L1V_{DD}$ ,  $LV_{DD}$ ,  $TH_{VDD}$ ,  $USB_{HVDD}$ ,  $USB_{OVDD}$ ,  $AV_{DD\_CGA1}$ ,  $AV_{DD\_CGA2}$ ,  $AV_{DD\_PLAT}$ ,  $AV_{DD\_D1}$ ,  $X1V_{DD}$ ,  $AV_{DD\_SD1\_PLL1}$ ,  $AV_{DD\_SD1\_PLL2}$ . Drive  $PROG\_SFP = GND$ 
  - a.  $PORESET\_B$  should be driven asserted and held during this step.
2.  $V_{DDC}$ ,  $V_{DD}$ ,  $USB_{SVDD}$ ,  $S1V_{DD}$ 
  - a. When Deep Sleep is not used, it is recommended to source  $V_{DD}$  and  $V_{DDC}$  from same power supply.
  - b. When Deep Sleep is used,  $V_{DDC}$  should ramp up before  $V_{DD}$ . Alternatively  $V_{DD}$  may ramp up together with  $V_{DDC}$  provided that the relative timing between  $V_{DDC}$  and  $V_{DD}$  ramp up conforms to [Figure 3-2](#)
3.  $G1V_{DD}$ ,  $V_{TT}$ ,  $V_{PP}$ ,  $1V2$ 
  - a.  $V_{PP}$  must be equal or greater than  $1V2$  at all times when powered.

The supplies mentioned as OFF in "Status in Deep Sleep" column of [Table 3-2](#) are switched ON while exit from Deep sleep power management mode. These supplies should also follow the same power up sequence as mentioned above.

Items on the same line have no ordering requirement with respect to one another. Items on separate lines must be ordered sequentially such that voltage rails on a previous step must reach 90% of their value before the voltage rails on the current step reach 10% of theirs.

All supplies must be at their stable values within 75 ms.

Negate  $PORESET\_B$  input when the required assertion/hold time has been met per [Table 3-21](#).

### NOTE

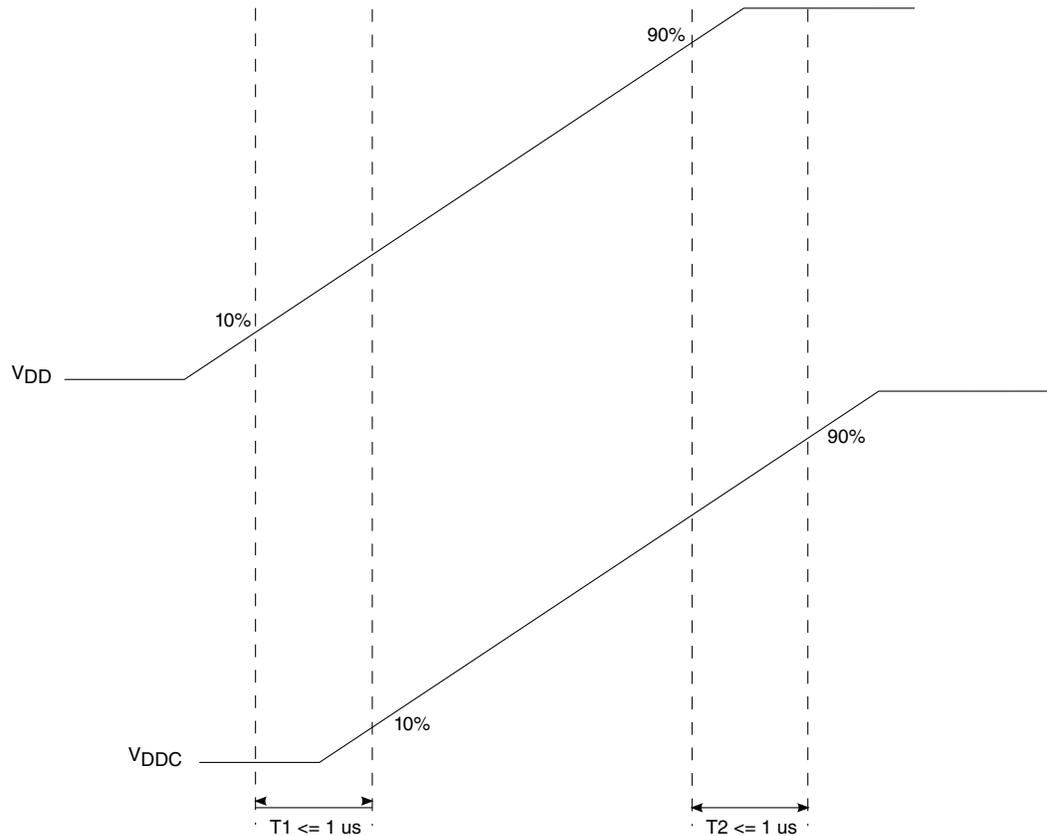
- $EVT2\_B$  may be unstable when  $PORESET\_B$  is asserted. The signal should not be used to enable switchable power supplies during this period.
- Ramp rate requirements should be met per [Table 3-6](#)

### Warning

Only 300,000 POR cycles are permitted per lifetime of a device. Note that this value is based on design estimates and is preliminary.

This figure provides the  $V_{DDC}$  and  $V_{DD}$  ramp up diagram.

**Figure 3-2.**  $V_{DDC}$  and  $V_{DD}$  ramp up diagram



For secure boot fuse programming, use the following steps:

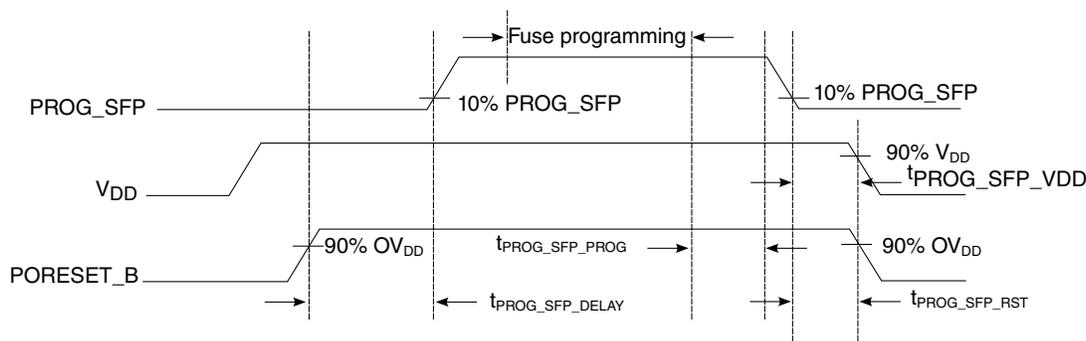
1. After negation of PORESET\_B, drive PROG\_SFP = 1.8V after a required minimum delay per [Table 3-5](#).
2. After fuse programming is completed, it is required to return PROG\_SFP = GND before the system is power cycled (PORESET\_B assertion) or powered down ( $V_{DD}$  ramp down) per the required timing specified in [Table 3-5](#). See “[Security fuse processor](#)”, for additional details.

**Warning**

No activity other than that required for secure boot fuse programming is permitted while PROG\_SFP is driven to any voltage above GND, including the reading of the fuse block. The reading of the fuse block may only occur while PROG\_SFP = GND.

This figure provides the PROG\_SFP timing diagram.

**Figure 3-3.** PROG\_SFP timing diagram



Note: PROG\_SFP must be stable at 1.8V prior to initiating fuse programming.

This table provides information on the power-down and power-up sequence parameters for PROG\_SFP.

**Table 3-5.** PROG\_SFP timing<sup>(5)</sup>

Driver type	Min	Max	Unit	Notes
$t_{\text{PROG\_SFP\_DELAY}}$	100	–	SYSCCLKs	(1)
$t_{\text{PROG\_SFP\_PROG}}$	0	–	$\mu\text{s}$	(2)
$t_{\text{PROG\_SFP\_VDD}}$	0	–	$\mu\text{s}$	(3)
$t_{\text{PROG\_SFP\_RST}}$	0	–	$\mu\text{s}$	(4)

- Notes:
1. Delay required from the deassertion of PORESET\_B to driving PROG\_SFP ramp up. Delay measured from PORESET\_B deassertion at 90%  $OV_{\text{DD}}$  to 10% PROG\_SFP ramp up.
  2. Delay required from fuse programming finished to PROG\_SFP ramp down start. Fuse programming must complete while PROG\_SFP is stable at 1.8V. No activity other than that required for secure boot fuse programming is permitted while PROG\_SFP driven to any voltage above GND, including the reading of the fuse block. The reading of the fuse block may only occur while PROG\_SFP = GND. After fuse programming is completed, it is required to return PROG\_SFP = GND.
  3. Delay required from PROG\_SFP ramp down complete to  $V_{\text{DD}}$  ramp down start. PROG\_SFP must be grounded to minimum 10% PROG\_SFP before  $V_{\text{DD}}$  is at 90%  $V_{\text{DD}}$ .
  4. Delay required from PROG\_SFP ramp down complete to PORESET\_B assertion. PROG\_SFP must be grounded to minimum 10% PROG\_SFP before PORESET\_B assertion reaches 90%  $OV_{\text{DD}}$ .
  5. Only two secure boot fuse programming events are permitted per lifetime of a device.

### 3.3 Power-down requirements

The power-down cycle must complete such that power supply values are below 0.4V before a new power-up cycle can be started.

If performing secure boot fuse programming per [Power sequencing](#), it is required that PROG\_SFP = GND before the system is power cycled (PORESET\_B assertion) or powered down ( $V_{\text{DD}}$  ramp down) per the required timing specified in [Table 3-5](#).

### 3.4 Power-on ramp rate

This section describes the AC electrical specifications for the power-on ramp rate requirements. Controlling the maximum power-on ramp rate is required to avoid excess in-rush current.

This table provides the power supply ramp rate specifications.

**Table 3-6.** Power supply ramp rate

Parameter	Min	Max	Unit	Notes
Required ramp rate for all voltage supplies (including $OV_{DD}/O1V_{DD}/DV_{DD}/G1V_{DD}/S1V_{DD}/X1V_{DD}/LV_{DD}/L1V_{DD}/EV_{DD}/CV_{DD}$ all core and platform $V_{DD}$ supplies, $D1\_MV_{REF}$ and all $AV_{DD}$ supplies.)	–	25	V/ms	(1)(2)
Required ramp rate for PROG_SFP	–	25	V/ms	(1)(2)
Required ramp rate for USB_HV <sub>DD</sub>	–	26.7	V/ms	(1)(2)

- Notes:
1. Ramp rate is specified as a linear ramp from 10% to 90%. If non-linear (for example, exponential), the maximum rate of change from 200 to 500 mV is the most critical as this range might falsely trigger the ESD circuitry.
  2. Over full recommended operating temperature range (see [Table 3-2](#)).

### 3.5 Power characteristics

This table shows the power dissipations of the  $V_{DD}$  and  $V_{DDC}$  supply for various operating platform clock frequencies versus the core and DDR clock frequencies.

**Table 3-7.** QT1040 core power dissipation

Core freq (MHz)	Platform freq (MHz)	DDR data rate (MT/s)	$V_{DD}, V_{DDC}$ (V)	$S1V_{DD}$ (V)	Junction temp. (°C)	Power mode	Power (W)			Total Core and platform power (W) <sup>(1)</sup>	Notes
							$V_{DD}$	$V_{DDC}$	$S1V_{DD}$		
1500	600	1600	1.0	1.0	65	Typical	5.74	0.63	0.41	6.78	(2)(3)
						Thermal	7.51	0.91	0.47	8.89	(5)(7)
					Maximum		8.26	0.91	0.47	9.64	(4)(6)(7)
					125	Thermal	9.29	1.09	0.49	10.87	(5)(7)
Maximum	10.05	1.09	0.49	11.63		(4)(6)(7)					
1400	600	1600	1.0	1.0	65	Typical	5.62	0.63	0.41	6.65	(2)(3)
						Thermal	6.24	0.69	0.41	7.34	(5)(7)
					Maximum		6.97	0.69	0.41	8.07	(4)(6)(7)
					125	Thermal	7.61	0.87	0.43	8.94	(5)(7)
Maximum	8.34	0.87	0.43	9.64		(4)(6)(7)					
1200	500	1600	1.0	1.0	65	Typical	4.86	0.57	0.41	5.83	(2)(3)
						Thermal	5.52	0.63	0.41	6.56	(5)(7)
					Maximum		6.12	0.63	0.41	7.17	(4)(6)(7)
					125	Thermal	6.89	0.81	0.43	8.13	(5)(7)
Maximum	7.49	0.81	0.43	8.73		(4)(6)(7)					

- Notes:
1. Combined power of  $V_{DDC}$ ,  $V_{DD}$  and  $S1V_{DD}$  with platform at power-on reset default state, DDR controller and all SerDes banks active. Does not include I/O power.
  2. Typical power assumes Dhrystone running with activity factor of 70% (on all cores) and is executing DMA on the platform with 100% activity factor.
  3. Typical power based on nominal, processed device.
  4. Maximum power assumes Dhrystone running with activity factor at 100% (on all cores) and is executing DMA on the platform at 115% activity factor.

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- Thermal power assumes Dhrystone running with activity factor of 70% (on all cores) and executing DMA on the platform at 100% activity factor.
- Maximum power is provided for power supply design sizing.
- Thermal and maximum power are based on worst case processed device.

**Table 3-8.** QT1020 core power dissipation

Core freq (MHz)	Platform freq (MHz)	DDR data rate (MT/s)	V <sub>DD</sub> , V <sub>DDC</sub> (V)	S1V <sub>DD</sub> (V)	Junction temp. (°C)	Power mode	Power (W)			Total Core and platform power (W) <sup>(1)</sup>	Notes
							V <sub>DD</sub>	V <sub>DDC</sub>	S1V <sub>DD</sub>		
1500	600	1600	1.0	1.0	65	Typical	4.58	0.63	0.41	5.62	(2)(3)
						Thermal	6.41	0.91	0.47	7.8	(5)(7)
					Maximal		6.99	0.91	0.47	8.37	(4)(6)(7)
					125	Thermal	7.78	1.09	0.49	9.36	(5)(7)
Maximal	8.36	1.09	0.49	9.94		(4)(6)(7)					
1400	600	1600	1.0	1.0	65	Typical	4.52	0.63	0.41	5.55	(2)(3)
						Thermal	5.05	0.69	0.41	6.14	(5)(7)
					Maximum		5.61	0.69	0.41	6.71	(4)(6)(7)
					125	Thermal	6.42	0.87	0.43	7.72	(5)(7)
Maximum	6.98	0.87	0.43	8.28		(4)(6)(7)					
1200	500	1600	1.0	1.0	65	Typical	3.90	0.57	0.41	4.87	(2)(3)
						Thermal	4.42	0.63	0.41	5.46	(5)(7)
					Maximum		4.89	0.63	0.41	5.93	(4)(6)(7)
					125	Thermal	5.79	0.81	0.43	7.03	(5)(7)
Maximum	6.26	0.81	0.43	7.50		(4)(6)(7)					

- Notes:
- Combined power of V<sub>DDC</sub>, V<sub>DD</sub> and S1V<sub>DD</sub> with platform at power-on reset default state, DDR controller and all SerDes banks active. Does not include I/O power.
  - Typical power assumes Dhrystone running with activity factor of 80% (on all cores) and is executing DMA on the platform with 100% activity factor.
  - Typical power based on nominal, processed device.
  - Maximum power assumes Dhrystone running with activity factor at 100% (on all cores) and is executing DMA on the platform at 115% activity factor.
  - Thermal power assumes Dhrystone running with activity factor of 80% (on all cores) and executing DMA on the platform at 100% activity factor.
  - Maximum power is provided for power supply design sizing.
  - Thermal and maximum power are based on worst case processed device.

This table shows the power dissipation in deep sleep mode.

**Table 3-9.** Deep sleep power dissipation, 1.0V, 35°C

Power (W)			Total Core and platform power (W)
V <sub>DD</sub>	V <sub>DDC</sub>	S1V <sub>DD</sub>	
–	0.4	–	0.4

Note: V<sub>DD</sub> and S1V<sub>DD</sub> are switched off during deep sleep mode.

This table provides low power mode saving estimation.

**Table 3-10.** Single core, Single cluster low power mode power savings, 1.0V 65°C<sup>(1)(2)(3)</sup>

Mode	Core Frequency = 1.0 GHz	Core Frequency = 1.2 GHz	Core Frequency = 1.4 GHz	Units	Comment	Notes
PH10	0.19	0.23	0.27	Watts	Saving realized moving from PH00 to PH10 state, single core.	(4)
PH15	0.19	0.23	0.27	Watts	Saving realized moving from PH10 state to PH15 state, single core.	(4)
LPM20	0.32	0.38	0.45	Watts	Saving realized moving from PH15 to LPM20, single core	(4)(5)

- Notes:
1. Power for V<sub>DD</sub> only.
  2. Typical power assumes Dhrystone running (PH00 state) with activity factor of 70%.
  3. Typical power based on nominal process distribution for this device.
  4. PH10, PH15, LPM20 power savings with 1 core. Maximum savings would be N times, where N is the number of used cores.
  5. LPM20 has all platform clocks disabled.

### 3.5.1 DDR4 power consumption

**Table 3-11.** DDR4 power consumption

Symbol	DDR4-1600	Unit
Iddinit : DDR4 initialization current <sup>(5)</sup>	1600	mA
Idd0 : One bank ACTIVATE-to-PRECHARGE current	264	mA
Ipp0 : One bank ACTIVATE-to-PRECHARGE Ipp current	18.4	mA
Idd1 : One bank ACTIVATE-to-READ-to-PRECHARGE current	312	mA
Idd2n : Precharge standby current	176	mA
Idd2nt : Precharge standby ODT current	240	mA
Idd2p : Precharge power-down current	120	mA
Idd2q : Precharge quiet standby current	156	mA
Idd3n : Active standby current	244	mA
Ipp3n : Active standby Ipp current	12	mA
Idd3p : Active power-down current	176	mA
Idd4r : Burst read current	800	mA
Idd4w : Burst write current	984	mA
Idd5b : Burst refresh current (1X REF)	760	mA
Ipp5b : Burst refresh I P P current (1X REF)	88	mA
Idd6n : Self refresh current; 0–85°C <sup>(1)</sup>	80	mA
Idd6e : Self refresh current; 0–95°C <sup>(2)</sup>	108	mA
Idd6r : Self refresh current; 0–45°C <sup>(3)(4)</sup>	40	mA
Idd6a : Auto self refresh current (25°C) <sup>(4)</sup>	36	mA
Idd6a : Auto self refresh current (45°C) <sup>(4)</sup>	40	mA
Idd6a : Auto self refresh current (75°C) <sup>(4)</sup>	64	mA

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**Table 3-11.** DDR4 power consumption (Continued)

Symbol	DDR4-1600	Unit
Idd7 : Bank interleave read current	920	mA
Ipp7 : Bank interleave read Ipp current	48	mA
Idd8 : Maximum power-down current	72	mA

- Notes:
1. Applicable for MR2 settings A7 = 0 and A6 = 0; manual mode with normal temperature range of operation (0–85°C)
  2. Applicable for MR2 settings A7 = 1 and A7 = 0; manual mode with extended temperature range of operation (0–95°C)
  3. Applicable for MR2 settings A7 = 0 and A7 = 1; manual mode with reduced temperature range of operation (0–45°C)
  4. IDD6R and IDD6A values are typical.
  5. Current during initialization of the DDR4 done by the T1040 DDR4 controller during the boot of Qormino (ex : initialization under U-Boot). Maximum duration : 1s.

### 3.5.2 I/O DC power supply recommendation

This table provides the estimated I/O power numbers for each block: DDR, PCI Express, eLBC, eTSEC, SGMII, eSDHC, USB, eSPI, DUART, IIC, DIU, SATA and GPIO. Note that these numbers are based on design estimates only

**Table 3-12.** I/O power supply estimated values

Interface	Parameter	Symbol	Typical	Maximum	Deep Sleep	Unit	Note
DDR4	1600MT/s data rate	G1VDD(1.2V)	660	1000	–	mW	(1)(8)(9)
PCI Express	1x, 2.5 GT/s	X1VDD(1.35V)	50	62	–	mW	(1)(4)(7)
	2x, 2.5 GT/s		81	94			
	4x, 2.5 GT/s		145	158			
	8x, 2.5 GT/s		274	287			
	1x, 5 GT/s		50	70			
	2x, 5 GT/s		90	100			
	4x, 5 GT/s		150	160			
	8x, 5 GT/s		280	290			
SGMII	1x, 1.25 G-baud	X1VDD(1.35V)	50	60	–	mW	(1)(4)(7)
	2x, 1.25 G-baud		70	90			
	4x, 1.25 G-baud		130	140			
SGMII	1x, 5 G-baud	X1VDD(1.35V)	50	70	–	mW	(1)(4)(7)
	2x, 5 G-baud		90	100			
SATA	1x, 3.0 Gbps	X1VDD(1.35V)	50	60	–	mW	(1)(4)(7)
	2x, 3.0 Gbps		70	80			
IFC	16-bit, 100MHz	OVDD(1.8V)	35	61	–	mW	(1)(3)(7)
EC1	RGMII	L1VDD(2.5V)	155	220	13	mW	(1)(3)(7)
	RGMII	L1VDD(1.8V)	115	180	11	mW	(1)(3)(7)
	MII	L1VDD(3.3V)	155	220	18	mW	(1)(3)(7)
EC2	RGMII	LVDD(2.5V)	155	220	–	mW	(1)(3)(7)
	RGMII	LVDD(1.8V)	115	180	–		
eSDHC		EVDD(3.3V)	11	17	–	mW	(1)(3)(7)
		EVDD(1.8V)	7	10	–		

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Table 3-12. I/O power supply estimated values (Continued)

Interface	Parameter	Symbol	Typical	Maximum	Deep Sleep	Unit	Note
USB1, USB2		USB_HVDD(3.3V)	40	60	60	mW	(1)(3)(7)
		USB_OVDD(1.8V)	100	110	100		
eSPI		CVDD(3.3V)	14	22	–	mW	(1)(3)(7)
		CVDD(1.8V)	11	16	–		
DIU		DVDD(3.3V)	70	90	–	mW	(1)(3)(7)
QE		DVDD(3.3V)	15	21	–	mW	(1)(3)(7)
		DVDD(2.5V)	11	17	–		
I2C		DVDD(3.3V)	14	22	–	mW	(1)(3)(7)
		DVDD(2.5V)	10	16	–		
		DVDD(1.8V)	8	13	–		
DUART		DVDD(3.3V)	14	22	–	mW	(1)(3)(5)(7)
		DVDD(2.5V)	10	15	–		
		DVDD(1.8V)	8	12	–		
TDM		DVDD(3.3V)	10	14	–	mW	(1)(3)(7)
IEEE1588		LVDD(2.5V)	16	21	–	mW	(1)(3)(7)
GPIO	x8	3.3V	5	8	–	mW	(1)(3)(7)
	x8	2.5V	4	7	–		
	x8	1.8V	3	5	–		
System Control		O1VDD(1.8V)	45	70	9	mW	(1)(3)(7)
PLL core and system		AVDD_CGA1 (1.8V)	20	20	–	mW	(1)(3)(7)
		AVDD_CGA2 (1.8V)			–		
		AVDD_PLAT(1.8V)			2		
PLL DDR		AVDD_D1(1.8V)	30	40	–	mW	(1)(3)(7)
PLL SerDes		AVDD_SD1_PLL1, AVDD_SD1_PLL2(1.35V)	50	50	–	mW	(1)(3)(7)
PROG_SFP		PROG_SFP (1.8V)	173		–	mW	–
TH_VDD		TH_VDD (1.8V)	1		–	mW	–

- Notes:
1. The typical values are estimates based on simulations 65°C junction temperature.
  2. Typical DDR power numbers are based on 2 Rank DIMM with 40% utilization.
  3. Assuming 15 pF total capacitance load per pin.
  4. The total power numbers of X1VDD is dependent on customer application use case. This table lists all the SerDes configurations possible for the device. To get the X1VDD power numbers, the user should add the combined lanes to match to the total SerDes Lanes used, not simply multiply the power numbers by the number of lanes.
  5. GPIO are supported on OV<sub>DD</sub>, O1V<sub>DD</sub>, L1V<sub>DD</sub>, LV<sub>DD</sub>, DV<sub>DD</sub>, CV<sub>DD</sub> and EV<sub>DD</sub> power rails.
  6. Maximum DDR power numbers are based on 2 Ranks DIMM with 100% utilization.
  7. The maximum values are dependent on actual use case such as what application, external components used, environmental conditions such as temperature voltage and frequency. This is not intended to be the maximum guaranteed power. Expect different results depending on the use case. The maximum values are estimated and they are based on simulations at 105°C junction temperature.
  8. Typical DDR4 power numbers are based on single Rank DIMM with 40% utilization.
  9. Maximum DDR4 power numbers are based on single Rank DIMM with 100% utilization.

## 3.6 Input clocks

### 3.6.1 System clock (SYSCLK) timing specifications

This section provides the system clock DC and AC timing specifications.

#### 3.6.1.1 System clock DC timing specifications

This table provides the system clock (SYSCLK) DC specifications.

**Table 3-13.** SYSCLK DC electrical characteristics<sup>(3)</sup>

Parameter	Symbol	Min	Typical	Max	Unit	Notes
Input high voltage	$V_{IH}$	1.2	–	–	V	(1)
Input low voltage	$V_{IL}$	–	–	0.6	V	(1)
Input capacitance	$C_{IN}$	–	7	12	pF	–
Input current ( $O1V_{IN} = 0V$ or $O1V_{IN} = O1V_{DD}$ )	$I_{IN}$	–	–	$\pm 50$	$\mu A$	(2)

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the respective min and max  $O1V_{IN}$  values found in [Table 3-2](#).
  2. The symbol  $O1V_{IN}$ , in this case, represents the  $O1V_{IN}$  symbol referenced in [Recommended operating conditions](#).
  3. At recommended operating conditions with  $O1V_{DD} = 1.8V$ , see [Table 3-2](#).

#### 3.6.1.2 System clock AC timing specifications

This table provides the system clock (SYSCLK) AC timing specifications.

**Table 3-14.** SYSCLK AC timing specifications<sup>(1)</sup>

Parameter/condition	Symbol	Min	Typ	Max	Unit	Notes
SYSCLK frequency	$f_{SYSCLK}$	64.0	–	133.3	MHz	(2)(5)
SYSCLK cycle time	$t_{SYSCLK}$	7.5	–	15.6	ns	(1)(2)
SYSCLK duty cycle	$t_{KHK}/t_{SYSCLK}$	40	–	60	%	(2)
SYSCLK slew rate	–	1	–	4	V/ns	(3)
SYSCLK peak period jitter	–	–	–	$\pm 150$	ps	–
SYSCLK jitter phase noise at –56 dBc	–	–	–	500	KHz	(4)
AC Input Swing Limits at 1.8V $O1V_{DD}$	$\Delta V_{AC}$	1.08	–	1.8	V	–

- Notes:
1. **Caution:** The relevant clock ratio settings must be chosen such that the resulting SYSCLK frequency does not exceed their respective maximum or minimum operating frequencies.
  2. Measured at the rising edge and/or the falling edge at  $O1V_{DD}/2$ .
  3. Slew rate as measured from  $0.35 \times O1V_{DD}$  to  $0.65 \times O1V_{DD}$ .
  4. Phase noise is calculated as FFT of TIE jitter.
  5. At recommended operating conditions with  $O1V_{DD} = 1.8V$ , see [Table 3-2](#).

### 3.6.2 Spread-spectrum sources

Spread-spectrum clock sources are an increasingly popular way to control electromagnetic interference emissions (EMI) by spreading the emitted noise to a wider spectrum and reducing the peak noise magnitude in order to meet industry and government requirements. These clock sources intentionally add long-term jitter to diffuse the EMI spectral content. The jitter specification given in [Table 3-14](#) considers short-term (cycle-to-cycle) jitter only. The clock generator's cycle-to-cycle output jitter should meet the chip's input cycle-to-cycle jitter requirement. Frequency modulation and spread are separate concerns; the chip is compatible with spread-spectrum sources if the recommendations listed in [Table 3-14](#) are observed.

**Table 3-15.** Spread-spectrum clock source recommendations<sup>(3)</sup>

Parameter	Min	Max	Unit	Notes
Frequency modulation	–	60	kHz	–
Frequency spread	–	1.0	%	(1)(2)

- Notes: 1. SYSCLK frequencies that result from frequency spreading and the resulting core frequency must meet the minimum and maximum specifications given in [Table 3-14](#).  
 2. Maximum spread-spectrum frequency may not result in exceeding any maximum operating frequency of the device.  
 3. At recommended operating conditions with  $O1V_{DD} = 1.8V$ , see [Table 3-2](#).

**CAUTION**

The processor's minimum and maximum SYSCLK and core/ platform/DDR frequencies must not be exceeded regardless of the type of clock source. Therefore, systems in which the processor is operated at its maximum rated core/platform/DDR frequency should avoid violating the stated limits by using down-spreading only.

**3.6.3 Real-time clock timing**

The real-time clock timing (RTC) input is sampled by the platform clock. The output of the sampling latch is then used as an input to the counters of the MPIC and the time base unit of the core; there is no need for jitter specification. The minimum period of the RTC signal should be greater than or equal to 16x the period of the platform clock with a 50% duty cycle. There is no minimum RTC frequency; RTC may be grounded if not needed.

**3.6.4 Gigabit Ethernet reference clock timing**

This table provides the Ethernet gigabit reference clock DC specifications.

**Table 3-16.** ECn\_GTX\_CLK125 DC electrical characteristics (L1V<sub>DD</sub>/LV<sub>DD</sub>=1.8V)

Parameter	Symbol	Min	Typical	Max	Unit	Notes
Input high voltage	V <sub>IH</sub>	0.7 * VDD	–	–	V	(2)(4)
Input low voltage	V <sub>IL</sub>	–	–	0.2 * VDD	V	(2)(4)
Input capacitance	C <sub>IN</sub>	–	–	6	pF	–
Input current (V <sub>IN</sub> = 0V or V <sub>IN</sub> = L1V <sub>DD</sub> )/LV <sub>DD</sub> )	I <sub>IN</sub>	–	–	± 50	µA	(3)

- Notes: 1. At recommended operating conditions with L1V<sub>DD</sub>/LV<sub>DD</sub> = 1.8V  
 2. The min V<sub>IL</sub> and max V<sub>IH</sub> values are based on the respective min and max V<sub>IN</sub> values found in [Table 3-2](#).  
 3. The symbol V<sub>IN</sub>, in this case, represents the L1V<sub>IN</sub>/LV<sub>IN</sub> symbol referenced in [Recommended operating conditions](#).  
 4. ECn\_GTX\_CLK125 is powered by L1V<sub>DD</sub> and LV<sub>DD</sub>. VDD should be replaced by the respective IO power supply.

This table provides the Ethernet gigabit reference clock DC specifications.

**Table 3-17.** ECn\_GTX\_CLK125 DC electrical characteristics ((L1V<sub>DD</sub>/LV<sub>DD</sub>=2.5V)

Parameter	Symbol	Min	Typical	Max	Unit	Notes
Input high voltage	V <sub>IH</sub>	0.7 * VDD	–	–	V	(2)(4)
Input low voltage	V <sub>IL</sub>	–	–	0.2 * VDD	V	(2)(4)
Input capacitance	C <sub>IN</sub>	–	–	6	pF	–
Input current (V <sub>IN</sub> = 0V or V <sub>IN</sub> = L1V <sub>DD</sub> )/LV <sub>DD</sub> )	I <sub>IN</sub>	–	–	± 50	µA	(3)

- Notes: 1. At recommended operating conditions with L1V<sub>DD</sub>/LV<sub>DD</sub> = 2.5V

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- The min  $V_{IL}$  and max  $V_{IH}$  values are based on the respective min and max  $V_{IN}$  values found in [Table 3-2](#).
- The symbol  $V_{IN}$ , in this case, represents the  $L1V_{IN}/LV_{IN}$  symbol referenced in [Recommended operating conditions](#).
- $ECn\_GTX\_CLK125$  is powered by  $L1V_{DD}$  and  $LV_{DD}$ .  $V_{DD}$  should be replaced by the respective IO power supply.

This table provides the Ethernet gigabit reference clocks AC timing specifications.

**Table 3-18.**  $ECn\_GTX\_CLK125$  AC timing specifications<sup>(1)</sup>

Parameter/Condition	Symbol	Min	Typical	Max	Unit	Notes
$ECn\_GTX\_CLK125$ frequency	$t_{G125}$	125 – 100 ppm	125	125 + 100 ppm	MHz	–
$ECn\_GTX\_CLK125$ cycle time	$t_{G125}$	–	8	–	ns	–
$ECn\_GTX\_CLK125$ rise and fall time $L1/LV_{DD} = 1.8V$ $L1/LV_{DD} = 2.5V$	$t_{G125R}/t_{G125F}$	–	–	0.54 0.75	ns	(2)
$ECn\_GTX\_CLK125$ duty cycle 1000Base-T for RGMII	$t_{G125H}/t_{G125}$	40	–	60	%	(3)
$ECn\_GTX\_CLK125$ jitter	–	–	–	± 150	ps	(3)

- Notes:
- At recommended operating conditions with  $L1/LV_{DD} = 1.8V \pm 90mV / 2.5V \pm 125 mV$ .
  - Rise and fall times for  $ECn\_GTX\_CLK125$  are measured from 0.5 and 2.0V for  $L1/LV_{DD} = 2.5V$ .
  - $ECn\_GTX\_CLK125$  is used to generate the GTX clock for the Ethernet transmitter. See [“RGMII AC timing specifications”](#) for duty cycle for 10Base-T and 100Base-T reference clock.

## 3.6.5 DDR clock timing

This section provides the DDR clock DC and AC timing specifications.

### 3.6.5.1 DDR clock DC timing specifications

This table provides the DDR clock (DDRCLK) DC specifications.

**Table 3-19.** DDRCLK DC electrical characteristics<sup>(3)</sup>

Parameter	Symbol	Min	Typical	Max	Unit	Notes
Input high voltage	$V_{IH}$	1.25	–	–	V	(1)
Input low voltage	$V_{IL}$	–	–	0.6	V	(1)
Input capacitance	$C_{IN}$	–	7	12	pF	–
Input current ( $OV_{IN} = 0V$ or $OV_{IN} = OV_{DD}$ )	$I_{IN}$	–	–	± 50	µA	(2)

- Notes:
- The min  $V_{IL}$  and max  $V_{IH}$  values are based on the respective min and max  $OV_{IN}$  values found in [Table 3-2](#).
  - The symbol  $OV_{IN}$ , in this case, represents the  $OV_{IN}$  symbol referenced in [“Recommended operating conditions”](#).
  - At recommended operating conditions with  $OV_{DD} = 1.8V$ , see [Table 3-2](#).

3.6.5.2 *DDR clock AC timing specifications*

This table provides the DDR clock (DDRCLK) AC timing specifications.

**Table 3-20.** DDRCLK AC timing specifications<sup>(5)</sup>

Parameter/Condition	Symbol	Min	Typ	Max	Unit	Notes
DDRCLK frequency	$f_{DDRCLK}$	64.0	–	133.3	MHz	(1)(2)
DDRCLK cycle time	$t_{DDRCLK}$	7.5	–	15.6	ns	(1)(2)
DDRCLK duty cycle	$t_{KHK}/t_{DDRCLK}$	40	–	60	%	(2)
DDRCLK slew rate	–	1	–	4	V/ns	(3)
DDRCLK peak period jitter	–	–	–	± 150	ps	–
DDRCLK jitter phase noise at –56 dBc	–	–	–	500	KHz	(4)
AC Input Swing Limits at 1.8V $OV_{DD}$	$\Delta V_{AC}$	1.08	–	1.8	V	–

- Notes:
- Caution:** The relevant clock ratio settings must be chosen such that the resulting DDRCLK frequency does not exceed their respective maximum or minimum operating frequencies.
  - Measured at the rising edge and/or the falling edge at  $OV_{DD}/2$ .
  - Slew rate as measured from  $0.35 \times OV_{DD}$  to  $0.65 \times OV_{DD}$ .
  - Phase noise is calculated as FFT of TIE jitter.
  - At recommended operating conditions with  $OV_{DD} = 1.8V$ , see [Table 3-2](#).

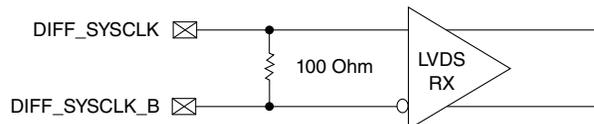
3.6.6 **Differential System clock (DIFF\_SYSCLK/DIFF\_SYSCLK\_B) timing specifications**

"Single Oscillator Source" clocking mode requires single onboard oscillator to provide reference clock input to Differential System clock pair (DIFF\_SYSCLK/ DIFF\_SYSCLK\_B).

This Differential clock pair can be configured to provide clock to Core, Platform, DDR and USB PLL's

This figure shows a receiver reference diagram of the Differential System clock.

**Figure 3-4.** LVDS receiver



This section provides the differential system clock DC and AC timing specifications.

3.6.6.1 *Differential System clock DC timing specifications*

For DC timing specification, see ["DC-level requirement for SerDes reference clocks"](#) .

The Differential System clock receivers core power supply voltage requirements ( $O1V_{DD}$ ) are as specified in [Recommended operating conditions](#).

The Differential system clock can also be single-ended. For this DIFF\_SYSCLK\_B should be connected to  $O1V_{DD}/2$ .

3.6.6.2 *Differential System clock AC timing specifications*

Differential System clock (DIFF\_SYSCLK/DIFF\_SYSCLK\_B) input pair supports input clock frequency of 100 MHz.

For AC timing specification, see ["AC requirements for SerDes reference clocks"](#)

Spread Spectrum clocking is not supported on Differential System clock pair input.

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## 3.6.7 Other input clocks

A description of the overall clocking of this device is available in the chip reference manual in the form of a clock subsystem block diagram. For information about the input clock requirements of functional modules sourced external of the chip, such as SerDes, Ethernet management, eSDHC, IFC, see the specific interface section.

## 3.7 RESET initialization

This section describes the AC electrical specifications for the RESET initialization timing requirements. This table describes the AC electrical specifications for the RESET initialization timing.

**Table 3-21.** RESET Initialization timing specifications

Parameter/Condition	Min	Max	Unit	Notes
Required assertion time of PORESET_B	1	–	ms	(1)
Required input assertion time of HRESET_B	32	–	SYSCLKs	(2)(3)
Maximum rise/fall time of HRESET_B	–	10	SYSCLK	(4)
Maximum rise/fall time of PORESET_B	–	1	SYSCLK	(4)
PLL input setup time with stable SYSCLK before HRESET_B negation	100	–	µs	–
Input setup time for POR configs with respect to negation of PORESET_B	4	–	SYSCLKs	(2)
Input hold time for all POR configs with respect to negation of PORESET_B	2	–	SYSCLKs	(2)
Maximum valid-to-high impedance time for actively driven POR configs with respect to negation of PORESET_B	–	5	SYSCLKs	(2)

- Notes:
1. PORESET\_B must be driven asserted before the core and platform power supplies are powered up.
  2. SYSCLK is the primary clock input for the chip.
  3. The device asserts HRESET\_B as an output when PORESET\_B is asserted to initiate the power-on reset process. The device releases HRESET\_B sometime after PORESET\_B is deasserted. The exact sequencing of HRESET\_B deassertion is documented in section "Power-On Reset Sequence" in the chip reference manual.
  4. System/board must be designed to ensure the input requirement to the device is achieved. Proper device operation is guaranteed for inputs meeting this requirement by design, simulation, characterization, or functional testing.

This table provides the PLL lock times.

**Table 3-22.** PLL lock times

Parameter/Condition	Min	Max	Unit	Notes
PLL lock times (Core, platform, DDR only)	–	100	µs	–

### 3.7.1 Power-Up and Initialization Sequence of the DDR4

The following sequence is required for power-up and initialization:

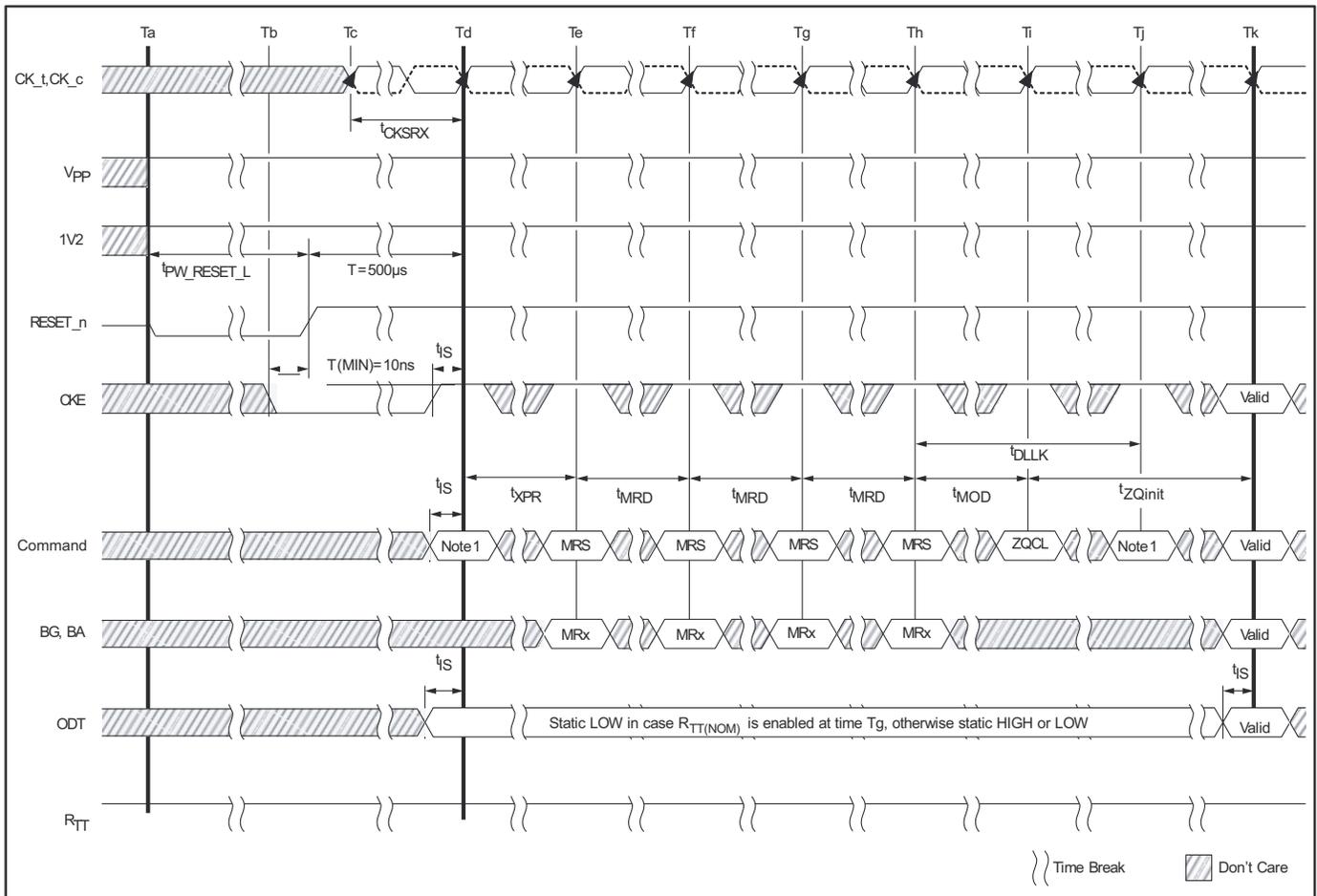
1. Apply power (RESET\_n and TEN must be maintained below  $0.2 \times 1V2$  while supplies ramp up; all other inputs may be undefined). When supplies have ramped to a valid stable level, RESET\_n must be maintained below  $0.2 \times 1V2$  for a minimum of  $t_{PW\_RESET\_L}$  and TEN must be maintained below  $0.2 \times 1V2$  for a minimum of 700 $\mu$ s. CKE is pulled LOW anytime before RESET\_n is de-asserted (minimum time of 10ns). The power voltage ramp time between 300mV to  $1V2_{min}$  must be no greater than 200ms.  $V_{PP}$  must ramp at the same time or before 1V2, and  $V_{PP}$  must be equal to or higher than 1V2 at all times. After 1V2 has ramped and reached the stable level, the initialization sequence must be started within 64ms. During power-up, the following condition must be met:
  - Apply  $V_{PP}$  without any slope reversal before or at the same time as 1V2.
  - 1V2 is driven from a single-power converter output and apply 1V2 without any slope reversal before or at the same time as  $V_{TT}$  and  $V_{REFCA}$ .
  - The voltage levels on all balls of the DDR interface other than 1V2, and GNDs must be less than or equal to 1V2 on one side and must be greater than or equal to GNDs on the other side.
  - $V_{TT}$  is limited to 0.76V MAX when the power ramp is complete.
  - $V_{REFCA}$  tracks 1V2/2.
2. After RESET\_n is de-asserted, wait for another 500ns until CKE becomes active. During this time, the device will start internal state initialization; this will be done independently of external clocks. A reasonable attempt was made in the design to power up with the following default MR settings: gear-down mode (MR3 A[3]): 0 = 1/2 rate; per-DRAM addressability (MR3 A[4]): 0 = disable; maximum power-down (MR4 A[1]): 0 = disable; CS to command/address latency (MR4 A[8:6]): 000 = disable; CA parity latency mode (MR5 A[2:0]): 000 = disable. However, it should be assumed that at power up the MR settings are undefined and should be programmed as shown below.
3. Clocks (CK\_t, CK\_c) need to be started and stabilized for at least 10ns or 5  $t_{CK}$  (whichever is larger) before CKE goes active. Because CKE is a synchronous signal, the corresponding setup time to clock ( $t_{IS}$ ) must be met. Also, a DESELECT command must be registered (with  $t_{IS}$  setup time to clock) at clock edge  $T_d$ . After the CKE is registered HIGH after RESET, CKE needs to be continuously registered HIGH until the initialization sequence is finished, including expiration of  $t_{DLLK}$  and  $t_{ZQINIT}$ .
4. The device keeps its ODT in High-Z state as long as RESET\_n is asserted. Further, the SDRAM keeps its ODT in High-Z state after RESET\_n de-assertion until CKE is registered HIGH. The ODT input signal may be in an undefined state until  $t_{IS}$  before CKE is registered HIGH. When CKE is registered HIGH, the ODT input signal may be statically held either LOW or HIGH. If RTT(NOM) is to be enabled in MR1, the ODT input signal must be statically held LOW. In all cases, the ODT input signal remains static until the power-up initialization sequence is finished, including the expiration of  $t_{DLLK}$  and  $t_{ZQINIT}$ .
5. After CKE is registered HIGH, wait a minimum of RESET CKE EXIT time,  $t_{XPR}$ , before issuing the first MRS command to load mode register ( $t_{XPR} = \text{MAX}(t_{XS}; 5 \times t_{CK})$ ).
6. Issue MRS command to load MR3 with all application settings, wait  $t_{MRD}$ .
7. Issue MRS command to load MR6 with all application settings, wait  $t_{MRD}$ .
8. Issue MRS command to load MR5 with all application settings, wait  $t_{MRD}$ .
9. Issue MRS command to load MR4 with all application settings, wait  $t_{MRD}$ .
10. Issue MRS command to load MR2 with all application settings, wait  $t_{MRD}$ .
11. Issue MRS command to load MR1 with all application settings, wait  $t_{MRD}$ .
12. Issue MRS command to load MR0 with all application settings, wait  $t_{MOD}$ .

13. Issue a ZQCL command to start ZQ calibration.
14. Wait for  $t_{DLLK}$  and  $t_{ZQINIT}$  to complete.
15. The device will be ready for normal operation.

A stable valid 1V2 level is a set DC level (0 Hz to 20 MHz) and must be no less than  $1V2_{min}$  and no greater than  $1V2_{max}$ . If the set DC level is altered anytime after initialization, the DLL reset and calibrations must be performed again after the new set DC level is stable. AC noise of 60mV (greater than 20 MHz) is allowed on 1V2 provided the noise doesn't alter 1V2 to less than  $1V2_{min}$  or greater than  $1V2_{max}$ .

A stable valid  $V_{PP}$  level is a set DC level (0 Hz to 20 MHz) and must be no less than  $V_{PP,min}$  and no greater than  $V_{PP,max}$ . If the set DC level is altered anytime after initialization, the DLL reset and calibrations must be performed again after the new set DC level is stable. AC noise of 120mV (greater than 20 MHz) is allowed on  $V_{PP}$  provided the noise doesn't alter  $V_{PP}$  to less than  $V_{PP,min}$  or greater than  $V_{PP,max}$ .

Figure 3-5. RESET and Initialization Sequence at Power-On Ramping



- Notes:
1. From time point Td until Tk, a DES command must be applied between MRS and ZQCL commands.
  2. MRS commands must be issued to all mode registers that have defined settings.
  3. In general, there is no specific sequence for setting the MRS locations (except for dependent or correlated features, such as ENABLE DLL in MR1 prior to RESET DLL in MR0, for example).
  4. TEN is not shown; however, it is assumed to be held LOW.

### 3.8 DDR4 SDRAM controller

This section describes the DC and AC electrical specifications for the DDR4 SDRAM controller interface. Note that the required  $G1V_{DD}(typ)$  voltage is 1.2V when interfacing to DDR4 SDRAM.

#### 3.8.1 DDR4 SDRAM interface DC electrical characteristics

This table provides the recommended operating conditions for the DDR SDRAM controller when interfacing to DDR4 SDRAM.

**Table 3-23.** DDR4 SDRAM interface DC electrical characteristics ( $G1V_{DD} = 1.2V$ )<sup>(1)(8)</sup>

Parameter	Symbol	Min	Max	Unit	Note
Input low	$V_{IL}$	–	$0.7 \times G1V_{DD} - 0.175$	V	(3)(7)
Input high	$V_{IH}$	$0.7 \times G1V_{DD} + 0.175$	–	V	(3)(7)
Output high current ( $V_{out} = 0.57V$ )	$I_{OH}$	–	–20.7	mA	(4)(5)
Output low current ( $V_{out} = 0.57V$ )	$I_{OL}$	20.7	–	mA	(4)(5)
I/O leakage current	$I_{OZ}$	–100	100	$\mu A$	(6)

- Notes:
- $G1V_{DD}$  is expected to be within 60 mV of the DRAM's voltage supply at all times. The DRAM's and memory controller's voltage supply may or may not be from the same source.
  - VTT and VREFCA are applied directly to the DRAM device. Both VTT and VREFCA voltages must track  $G1V_{DD}/2$ .
  - Input capacitance load for MDQ, MDQS, and MDQS\_B are available in the IBIS models.
  - $I_{OH}$  and  $I_{OL}$  are measured at  $G1V_{DD} = 1.14V$ .
  - Refer to the IBIS model for the complete output IV curve characteristics.
  - Output leakage is measured with all outputs disabled,  $0V \leq V_{out} \leq G1V_{DD}$ .
  - Internal Vref for data bus must be set to  $0.7 \times G1V_{DD}$ .
  - For recommended operating conditions, see [Table 3-2](#).

#### 3.8.2 DDR4 SDRAM interface AC timing specifications

This section provides the AC timing specifications for the DDR4 SDRAM controller interface. The DDR controller supports DDR4 memories. Note that the required  $G1V_{DD}(typ)$  voltage is 1.2V when interfacing to DDR4 SDRAM.

##### 3.8.2.1 DDR4 SDRAM interface input AC timing specifications

This table provides the input AC timing specifications for the DDR controller when interfacing to DDR4 SDRAM.

**Table 3-24.** DDR4 SDRAM interface input AC timing specifications<sup>1</sup>

Parameter		Symbol	Min	Max	Unit	Notes
AC input low voltage	$\leq 1600$ MT/s data rate	$V_{ILAC}$	–	$0.7 \times G1V_{DD} - 0.175$	V	–
AC input high voltage	$\leq 1600$ MT/s data rate	$V_{IHAC}$	$0.7 \times G1V_{DD} + 0.175$	–	V	–

- Note:
- For recommended operating conditions, see [Table 3-2](#).

This table provides the input AC timing specifications for the DDR controller when interfacing to DDR4 SDRAM.

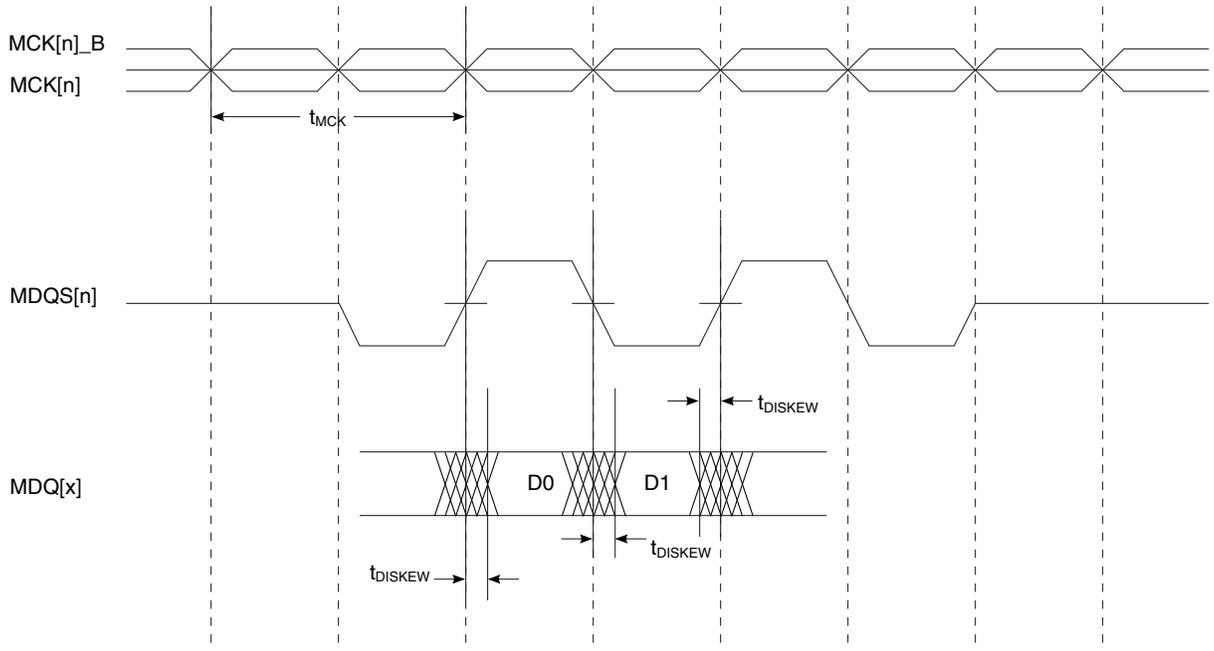
**Table 3-25.** DDR4 SDRAM interface input AC timing specifications<sup>(3)</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Controller Skew for MDQS-MDQ/MECC	$t_{CISKEW}$			ps	
1600 MT/s data rate		-112	112		(1)
1300 MT/s data rate		-125	125		(1)
Tolerated Skew for MDQS-MDQ/MECC	$t_{DISKEW}$			ps	
1600 MT/s data rate		-200	200		(2)
1300 MT/s data rate		-250	250		(2)

- Notes:
- $t_{CISKEW}$  represents the total amount of skew consumed by the controller between MDQS[n] and any corresponding bit that is captured with MDQS[n]. This must be subtracted from the total timing budget.
  - The amount of skew that can be tolerated from MDQS to a corresponding MDQ signal is called  $t_{DISKEW}$ . This can be determined by the following equation:  $t_{DISKEW} = \pm(T \div 4 - \text{abs}(t_{CISKEW}))$  where T is the clock period and  $\text{abs}(t_{CISKEW})$  is the absolute value of  $t_{CISKEW}$ .
  - For recommended operating conditions, see [Table 3-2](#).

This figure shows the DDR4 SDRAM interface input timing diagram.

**Figure 3-6.** DDR4 SDRAM Interface Input Timing Diagram



3.8.2.2 DDR4 SDRAM interface output AC timing specifications

This table contains the output AC timing targets for the DDR4 SDRAM interface.

**Table 3-26.** DDR4 SDRAM interface output AC timing specifications<sup>(7)</sup>

Parameter	Symbol <sup>(1)</sup>	Min	Max	Unit	Notes
MCK[n] cycle time	$t_{MCK}$	1250	1876	ps	(2)
ADDR/CMD output setup with respect to MCK	$t_{DDKHAS}$			ps	
1600 MT/s data rate		495	–		(3)
1300 MT/s data rate		606	–		(3)
ADDR/CMD output hold with respect to MCK	$t_{DDKHAX}$			ps	
1600 MT/s data rate		495	–		(3)
1300 MT/s data rate		606	–		(3)
MCK to MDQS Skew	$t_{DDKMHM}$			ps	(4)
> 1000 MT/s data rate, = 1600 MT/s data rate		–245	245		(6)
MDQ/MECC/MDM output Data eye	$t_{DDKXDEYE}$			ps	
1600 MT/s data rate		400	–		(5)
1300 MT/s data rate		500	–		(5)
MDQS preamble	$t_{DDKHMP}$	$900 \times t_{MCK}$	–	ps	–
MDQS postamble	$t_{DDKHME}$	$400 \times t_{MCK}$	$600 \times t_{MCK}$	ps	–

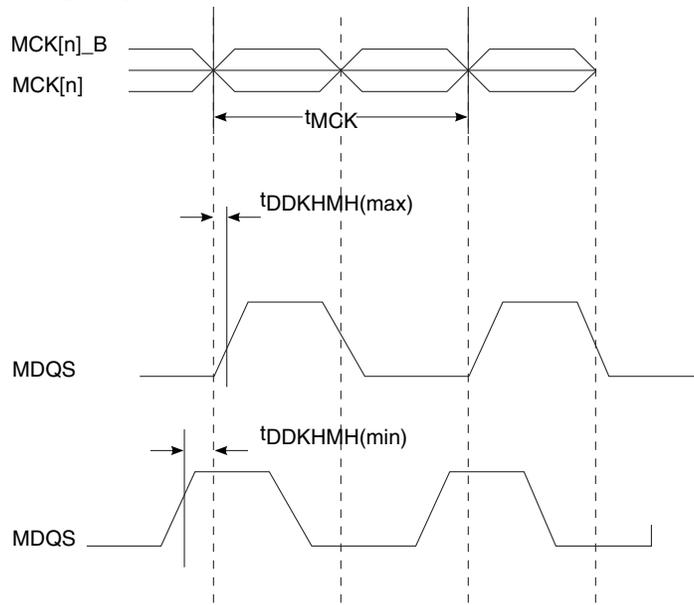
- Notes:
- The symbols used for timing specifications follow the pattern of  $t_{(first\ two\ letters\ of\ functional\ block)(signal)(state)\ (reference)(state)}$  for inputs and  $t_{(first\ two\ letters\ of\ functional\ block)(reference)(state)(signal)(state)}$  for outputs. Output hold time can be read as DDR timing (DD) from the rising or falling edge of the reference clock (KH or KL) until the output went invalid (AX or DX). For example,  $t_{DDKHAS}$  symbolizes DDR timing (DD) for the time  $t_{MCK}$  memory clock reference (K) goes from the high (H) state until outputs (A) are setup (S) or output valid time. Also,  $t_{DDKLDX}$  symbolizes DDR timing (DD) for the time  $t_{MCK}$  memory clock reference (K) goes low (L) until data outputs (D) are invalid (X) or data output hold time.
  - All MCK/MCK\_B and MDQS/MDQS\_B referenced measurements are made from the crossing of the two signals.
  - ADDR/CMD/CNTL includes all DDR SDRAM output signals except MCK/MCK\_B, MCS\_B, and MDQ/MECC/MDM/MDQS.
  - Note that  $t_{DDKMHM}$  follows the symbol conventions described in note 1. For example,  $t_{DDKMHM}$  describes the DDR timing (DD) from the rising edge of the MCK[n] clock (KH) until the MDQS signal is valid (MH).  $t_{DDKMHM}$  can be modified through control of the MDQS override bits (called WR\_DATA\_DELAY) in the TIMING\_CFG\_2 register. This is typically set to the same delay as in DDR\_SDRAM\_CLK\_CNTL[CLK\_ADJUST]. The timing parameters listed in the table assume that these two parameters have been set to the same adjustment value. See the chip reference manual for a description and explanation of the timing modifications enabled by the use of these bits.
  - Available eye for data (MDQ), ECC (MECC), and data mask (MDM) outputs at the pin of the processor. Memory controller will center the strobe (MDQS) in the available data eye at the DRAM (end point) during the initialization.
  - Note that it is required to program the start value of the MDQS adjust for write leveling.
  - For recommended operating conditions, see [Table 3-2](#).

**NOTE**

For the ADDR/CMD/CNTL setup and hold specifications in [Table 3-26](#), it is assumed that the clock control register is set to adjust the memory clocks by ¾ applied cycle.

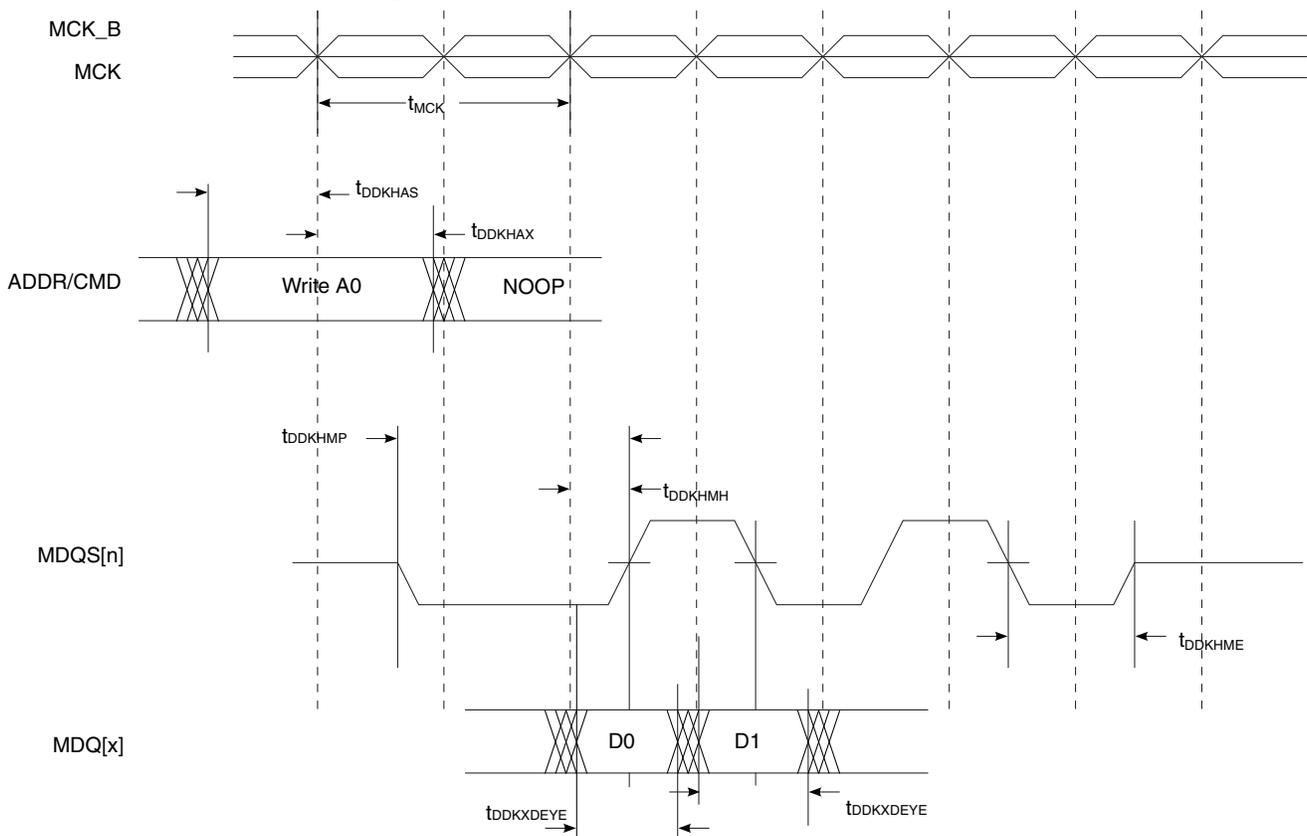
This figure shows the DDR4 SDRAM interface output timing for the MCK to MDQS skew measurement ( $t_{DDKMHM}$ ).

**Figure 3-7.**  $t_{DDKHMH}$  timing diagram



This figure shows the DDR4 SDRAM output timing diagram.

**Figure 3-8.** DDR4 output timing diagram



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### 3.9 eSPI interface

This section describes the DC and AC electrical specifications for the eSPI interface.

#### 3.9.1 eSPI DC electrical characteristics

This table provides the DC electrical characteristics for the eSPI interface operating at  $V_{DD} = 1.8V$ .

**Table 3-27.** eSPI DC electrical characteristics (1.8V)<sup>1</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	$0.7 * CV_{DD}$	–	V	2
Input low voltage	$V_{IL}$	–	$0.2 * CV_{DD}$	V	2
Input current ( $V_{IN} = 0V$ or $V_{IN} = CV_{DD}$ )	$I_{IN}$	–	$\pm 50$	$\mu A$	3
Output high voltage ( $CV_{DD} = \text{min}$ , $I_{OH} = -0.5 \text{ mA}$ )	$V_{OH}$	1.35	–	V	–
Output low voltage ( $CV_{DD} = \text{min}$ , $I_{OL} = 0.5 \text{ mA}$ )	$V_{OL}$	–	0.4	V	–

- Notes:
1. For recommended operating conditions, see [Table 3-2](#).
  2. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the respective min and max  $CV_{IN}$  values found in [Table 3-2](#).
  3. The symbol  $V_{IN}$ , in this case, represents the  $CV_{IN}$  symbol referenced in [Recommended operating conditions](#).

This table provides the DC electrical characteristics for the eSPI interface operating at  $V_{DD} = 3.3V$ .

**Table 3-28.** eSPI DC electrical characteristics (3.3V)<sup>(1)</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	$0.7 * CV_{DD}$	–	V	(2)
Input low voltage	$V_{IL}$	–	$0.2 * CV_{DD}$	V	(2)
Input current ( $V_{IN} = 0V$ or $V_{IN} = CV_{DD}$ )	$I_{IN}$	–	$\pm 50$	$\mu A$	–
Output high voltage ( $CV_{DD} = \text{min}$ , $I_{OH} = -2.0 \text{ mA}$ )	$V_{OH}$	2.4	–	V	–
Output low voltage ( $CV_{DD} = \text{min}$ , $I_{OL} = 2.0 \text{ mA}$ )	$V_{OL}$	–	0.4	V	–

- Notes:
1. For recommended operating conditions, see [Table 3-2](#).
  2. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the respective min and max  $CV_{IN}$  values found in [Table 3-2](#).

## 3.9.2 eSPI AC timing specifications

This table provides the eSPI input and output AC timing specifications.

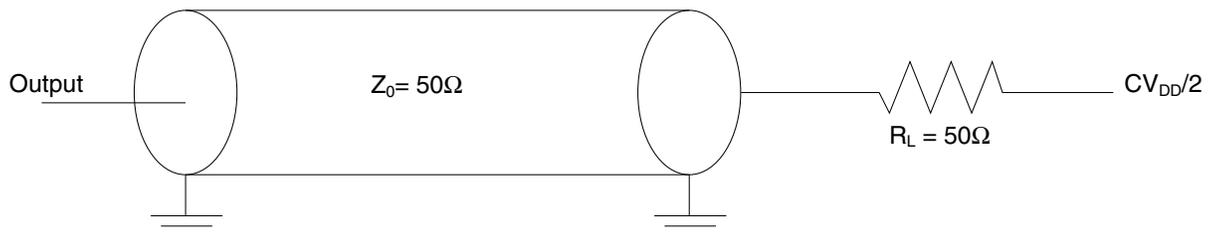
**Table 3-29.** eSPI AC timing specifications<sup>(3)</sup>

Parameter/Condition	Symbol <sup>(2)</sup>	Min	Max	Unit	Notes
SPI_MOSI output-Master data (internal clock) hold time	$t_{\text{NIKHOX}}$	$-0.49 + (t_{\text{PLATFORM\_CLK}/2} * \text{SPMODE}[\text{HO\_ADJ}])$	–	ns	(1)(2)
SPI_MOSI output-Master data (internal clock) delay	$t_{\text{NIKHOV}}$	–	$0.89 + (t_{\text{PLATFORM\_CLK}/2} * \text{SPMODE}[\text{HO\_ADJ}])$	ns	(1)(2)
SPI_CS outputs-Master data (internal clock) hold time	$t_{\text{NIKHOX2}}$	–100	–	ps	(1)
SPI_CS outputs-Master data (internal clock) delay	$t_{\text{NIKHOV2}}$	–	6.0	ns	(1)
SPI inputs-Master data (internal clock) input setup time	$t_{\text{NIIVKH}}$	6.6	–	ns	–
SPI inputs-Master data (internal clock) input hold time	$t_{\text{NIIXKH}}$	0	–	ns	–
Clock-high time	$t_{\text{NIKCKH}}$	4	–	ns	–
Clock-low time	$t_{\text{NIKCKL}}$	4	–	ns	–

- Notes:
1. See the chip reference manual for details about the SPMODE register.
  2. Output specifications are measured from the 50% level of the rising edge of CLKIN to the 50% level of the signal. Timings are measured at the pin.
  3. The symbols used for timing specifications follow the pattern of  $t_{\text{(first two letters of functional block)(signal)(state)(reference)(state)}}$  for inputs and  $t_{\text{(first two letters of functional block)(reference)(state)(signal)(state)}}$  for outputs. For example,  $t_{\text{NIKHOV}}$  symbolizes the NMSI outputs internal timing (NI) for the time  $t_{\text{sp}}$  memory clock reference (K) goes from the high state (H) until outputs (O) are valid (V).
  4. Refer AN4375 to calculate maximum achievable eSPI interface frequency on a system.

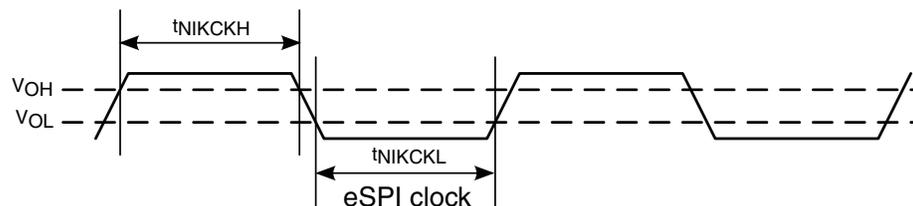
This figure provides the AC test load for the eSPI.

**Figure 3-9.** eSPI AC test load



This figure provides the eSPI clock output timing diagram.

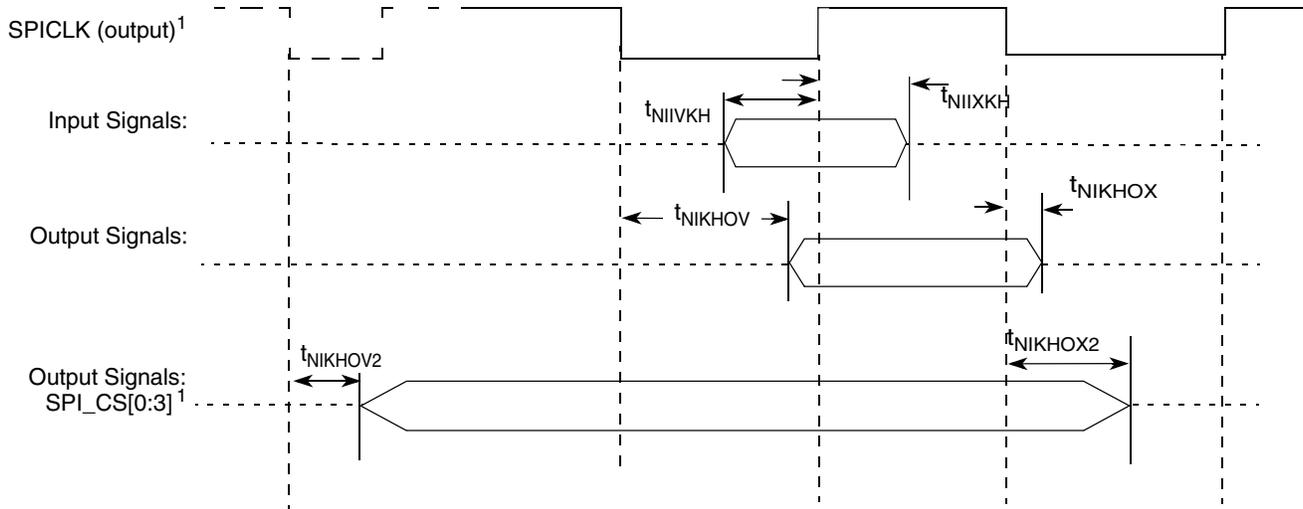
**Figure 3-10.** eSPI clock output timing diagram



- Note:
1. SPICLK appears on the interface only after CS assertion.

This figure represents the AC timing from Table 3-29 in master mode (internal clock). Note that although the specifications generally reference the rising edge of the clock, these AC timing diagrams also apply when the falling edge is the active edge. Also, note that the clock edge is selectable on eSPI.

Figure 3-11. eSPI AC timing in master mode (internal clock) diagram



### 3.10 DUART interface

This section describes the DC and AC electrical specifications for the DUART interface.

#### 3.10.1 DUART DC electrical characteristics

This table provides the DC electrical characteristics for the DUART interface at  $DV_{DD} = 3.3V$ .

Table 3-30. DUART DC electrical characteristics (3.3V)<sup>(3)</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	0.7*VDD	–	V	(1)(4)
Input low voltage	$V_{IL}$	–	0.2*VDD	V	(1)(4)
Input current ( $V_{IN} = 0V$ or $V_{IN} = DV_{DD}$ )	$I_{IN}$	–	±50	µA	(3)
Output high voltage	$V_{OH}$	2.4	–	V	–
( $DV_{DD} = \text{min}$ , $I_{OH} = -2.0 \text{ mA}$ )					
Output low voltage	$V_{OL}$	–	0.4	V	–
( $DV_{DD} = \text{min}$ , $I_{OL} = 2.0 \text{ mA}$ )					

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the min and max  $DV_{IN}$  respective values found in Table 3-2.
  2. The symbol  $DV_{IN}$  represents the input voltage of the supply. It is referenced in Recommended operating conditions.
  3. For recommended operating conditions, see Table 3-2.
  4. VDD should be replaced by the respective IO power supply.

This table provides the DC electrical characteristics for the DUART interface at  $DV_{DD} = 2.5V$ .

**Table 3-31.** DUART DC electrical characteristics(2.5V)<sup>(3)</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	$0.7 \cdot V_{DD}$	–	V	(1)(4)
Input low voltage	$V_{IL}$	–	$0.2 \cdot V_{DD}$	V	(1)(4)
Input current ( $DV_{IN} = 0V$ or $DV_{IN} = DV_{DD}$ )	$I_{IN}$	–	$\pm 50$	$\mu A$	(2)
Output high voltage ( $DV_{DD} = \text{min}$ , $I_{OH} = -1 \text{ mA}$ )	$V_{OH}$	2.0	–	V	–
Output low voltage ( $DV_{DD} = \text{min}$ , $I_{OL} = 1 \text{ mA}$ )	$V_{OL}$	–	0.4	V	–

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the min and max  $DV_{IN}$  respective values found in [Table 3-2](#).
  2. The symbol  $DV_{IN}$  represents the input voltage of the supply. It is referenced in [Recommended operating conditions](#).
  3. For recommended operating conditions, see [Table 3-2](#).
  4. VDD should be replaced by the respective IO power supply.

This table provides the DC electrical characteristics for the DUART interface at  $DV_{DD} = 1.8V$ .

**Table 3-32.** DUART DC electrical characteristics(1.8V)<sup>(3)</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	$0.7 \cdot V_{DD}$	–	V	(1)(4)
Input low voltage	$V_{IL}$	–	$0.2 \cdot V_{DD}$	V	(1)(4)
Input current ( $DV_{IN} = 0V$ or $DV_{IN} = DV_{DD}$ )	$I_{IN}$	–	$\pm 50$	$\mu A$	(2)
Output high voltage ( $DV_{DD} = \text{min}$ , $I_{OH} = -0.5 \text{ mA}$ )	$V_{OH}$	1.35	–	V	–
Output low voltage ( $DV_{DD} = \text{min}$ , $I_{OL} = 0.5 \text{ mA}$ )	$V_{OL}$	–	0.4	V	–

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the min and max  $DV_{IN}$  respective values found in [Table 3-2](#).
  2. The symbol  $DV_{IN}$  represents the input voltage of the supply. It is referenced in [Recommended operating conditions](#).
  3. For recommended operating conditions, see [Table 3-2](#).
  4. VDD should be replaced by the respective IO power supply.

### 3.10.2 DUART AC electrical specifications

This table provides the AC timing parameters for the DUART interface.

**Table 3-33.** DUART AC timing specifications

Parameter	Value	Unit	Notes
Minimum baud rate	$f_{PLAT} / (2 \times 1,048,576)$	baud	(1)(3)
Maximum baud rate	$f_{PLAT} / (2 \times 16)$	baud	(1)(2)

- Notes:
1.  $f_{PLAT}$  refers to the internal platform clock.
  2. The actual attainable baud rate is limited by the latency of interrupt processing.
  3. The middle of a start bit is detected as the eighth sampled 0 after the 1-to-0 transition of the start bit. Subsequent bit values are sampled each 16<sup>th</sup> sample.

**3.11 Ethernet interface, Ethernet management interface, IEEE Std 1588™**

This section provides the AC and DC electrical characteristics for the Ethernet controller and the Ethernet management interface.

**3.11.1 SGMII interface**

Each SGMII port features a 4-wire AC-coupled serial link from the SerDes interface of the chip, as shown in Figure 3-12, where  $C_{TX}$  is the external (on board) AC-coupled capacitor. Each SerDes transmitter differential pair features 100-Ω output impedance. Each input of the SerDes receiver differential pair features 50-Ω on-die termination to XGND<sub>n</sub>. The reference circuit of the SerDes transmitter and receiver is shown in Figure 3-64.

**3.11.1.1 SGMII clocking requirements for SD1\_REF\_CLK<sub>n</sub>\_P and SD1\_REF\_CLK<sub>n</sub>\_N**

When operating in SGMII mode, the EC<sub>n</sub>\_GTX\_CLK125 clock is not required for this port. Instead, a SerDes reference clock is required on SD1\_REF\_CLK[1:2]\_P and SD1\_REF\_CLK[1:2]\_N pins. SerDes lanes may be used for SerDes SGMII configurations based on the RCW Configuration field SRDS\_PRTCL.

For more information on these specifications, see “SerDes reference clocks”.

**3.11.1.2 SGMII DC electrical characteristics**

This section discusses the electrical characteristics for the SGMII interface.

**3.11.1.2.1 SGMII transmit DC specifications**

This table describes the SGMII SerDes transmitter AC-coupled DC electrical characteristics. Transmitter DC characteristics are measured at the transmitter outputs (SD1\_TX<sub>n</sub>\_P and SD1\_TX<sub>n</sub>\_N) as shown in Figure 3-13.

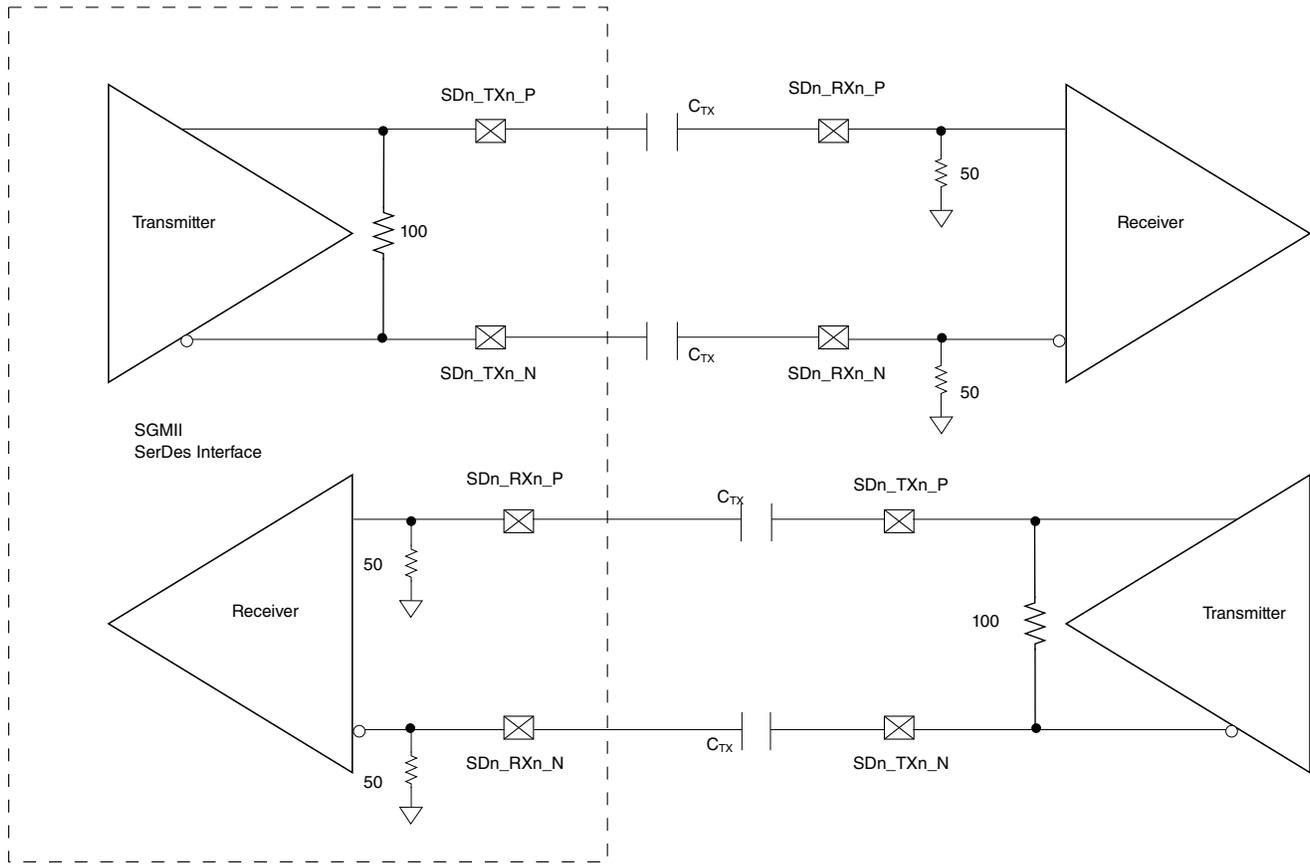
**Table 3-34.** SGMII DC transmitter electrical characteristics (X1V<sub>DD</sub> = 1.35V)<sup>(4)</sup>

Parameter	Symbol	Min	Typ	Max	Unit	Notes
Output high voltage	V <sub>OH</sub>	–	–	$1.5 \times  V_{OD} _{max}$	mV	(1)
Output low voltage	V <sub>OL</sub>	$ V_{OD} _{min}/2$	–	–	mV	(1)
Output differential voltage <sup>(2)(3)(5)</sup> (XV <sub>DD-Typ</sub> at 1.35V)	V <sub>OD</sub>	320	500.0	725.0	mV	TECR0[AMP_RED]=0b00 0000
		293.8	459.0	665.6		TECR0[AMP_RED]=0b00 0001
		266.9	417.0	604.7		TECR0[AMP_RED]=0b00 0011
		240.6	376.0	545.2		TECR0[AMP_RED]=0b00 0010
		213.1	333.0	482.9		TECR0[AMP_RED]=0b00 0110
		186.9	292.0	423.4		TECR0[AMP_RED]=0b00 0111
		160.0	250.0	362.5		TECR0[AMP_RED]=0b01 0000
Output impedance (differential)	R <sub>o</sub>	80	100	120	Ω	–

- Notes:
1. This does not align to DC-coupled SGMII.
  2.  $|V_{OD}| = |V_{SD\_TXn\_P} - V_{SD\_TXn\_N}|$ . |V<sub>OD</sub>| is also referred to as output differential peak voltage. V<sub>TX-DIFFp-p</sub> = 2 × |V<sub>OD</sub>|.
  3. The |V<sub>OD</sub>| value shown in the Typ column is based on the condition of XV<sub>DD</sub>\_SRDS<sub>n</sub>-Typ = 1.35V, no common mode offset variation. SerDes transmitter is terminated with 100-Ω differential load between SD<sub>n</sub>\_TX<sub>n</sub>\_P and SD<sub>n</sub>\_TX<sub>n</sub>\_N.
  4. For recommended operating conditions, see Table 3-2.
  5. Example amplitude reduction setting for SGMII on SerDes1 lane E: SRDS1LN4TECR0[AMP\_RED] = 0b000001 for an output differential voltage of 459 mV typical.

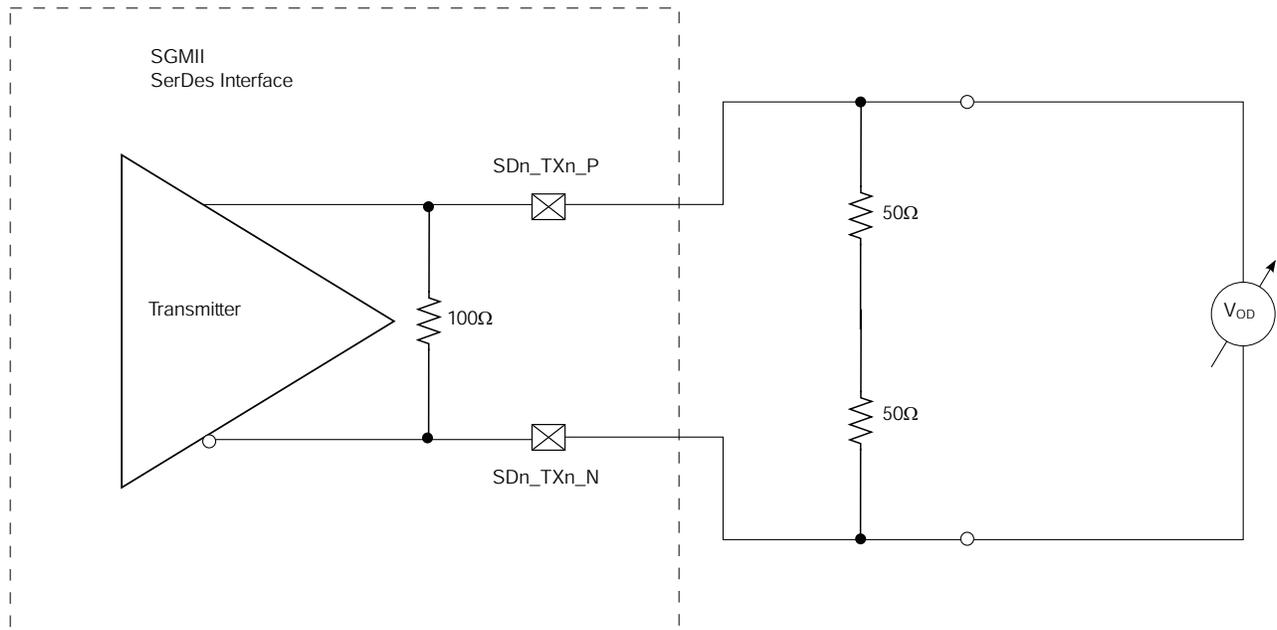
This figure shows an example of a 4-wire AC-coupled SGMII serial link connection.

**Figure 3-12.** 4-wire AC-coupled SGMII serial link connection example



This figure shows the SGMII transmitter DC measurement circuit.

Figure 3-13. SGMII transmitter DC measurement circuit



3.11.1.2.2 SGMII DC receiver electrical characteristics

This table lists the SGMII DC receiver electrical characteristics. Source synchronous clocking is not supported. Clock is recovered from the data.

Table 3-35. SGMII DC receiver electrical characteristics (S1VDD = 1.0V)<sup>(4)</sup>

Parameter	Symbol	Min	Typ	Max	Unit	Notes	
DC input voltage range	–	N/A			–	(1)	
Input differential voltage	REIDL_TH = 001	V <sub>RX_DIFFp-p</sub>	100	–	1200	mV	(2)(5)
	REIDL_TH = 100		175	–			
Loss of signal threshold	REIDL_TH = 001	V <sub>LOS</sub>	30	–	100	mV	(3)(5)
	REIDL_TH = 100		65	–	175		
Receiver differential input impedance	Z <sub>RX_DIFF</sub>	80	–	120	Ω	–	

- Notes:
1. Input must be externally AC coupled.
  2. V<sub>RX\_DIFFp-p</sub> is also referred to as peak-to-peak input differential voltage.
  3. The concept of this parameter is equivalent to the electrical idle detect threshold parameter in PCI Express. See [PCI Express DC physical layer receiver specifications](#), and [PCI Express AC physical layer receiver specifications](#), for further explanation.
  4. For recommended operating conditions, see [Table 3-2](#).
  5. The REIDL\_TH shown in the table refers to the chip's SRDSxLnmGCR1[REIDL\_TH] bit field.

## 3.11.1.3 SGMII AC timing specifications

This section discusses the AC timing specifications for the SGMII interface.

### 3.11.1.3.1 SGMII transmit AC timing specifications

This table provides the SGMII transmit AC timing specifications. A source synchronous clock is not supported. The AC timing specifications do not include RefClk jitter.

**Table 3-36.** SGMII transmit AC timing specifications<sup>4</sup>

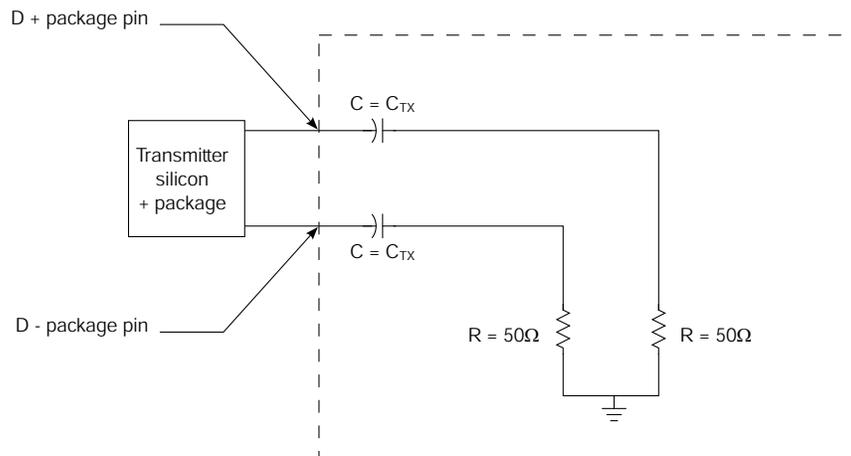
Parameter	Symbol	Min	Typ	Max	Unit	Notes
Deterministic jitter	JD	–	–	0.17	UI p-p	–
Total jitter	JT	–	–	0.35	UI p-p	2
Unit Interval: 1.25 GBaud (SGMII)	UI	800 – 100 ppm	800	800 + 100 ppm	ps	1
AC coupling capacitor	$C_{TX}$	10	–	200	nF	3

- Notes:
- Each UI is 800 ps  $\pm$  100 ppm.
  - See [Figure 3-15](#) for single frequency sinusoidal jitter measurements.
  - The external AC coupling capacitor is required. It is recommended that it be placed near the device transmitter output.
  - For recommended operating conditions, see [Table 3-2](#).

### 3.11.1.3.2 SGMII AC measurement details

Transmitter and receiver AC characteristics are measured at the transmitter outputs (SD1\_TX $n$ \_P and SD1\_TX $n$ \_N) or at the receiver inputs (SD1\_RX $n$ \_P and SD1\_RX $n$ \_N) respectively, as depicted in this figure.

**Figure 3-14.** SGMII AC test/measurement load



**3.11.1.3.3 SGMII receiver AC timing Specification**

This table provides the SGMII receiver AC timing specifications. The AC timing specifications do not include RefClk jitter. Source synchronous clocking is not supported. Clock is recovered from the data.

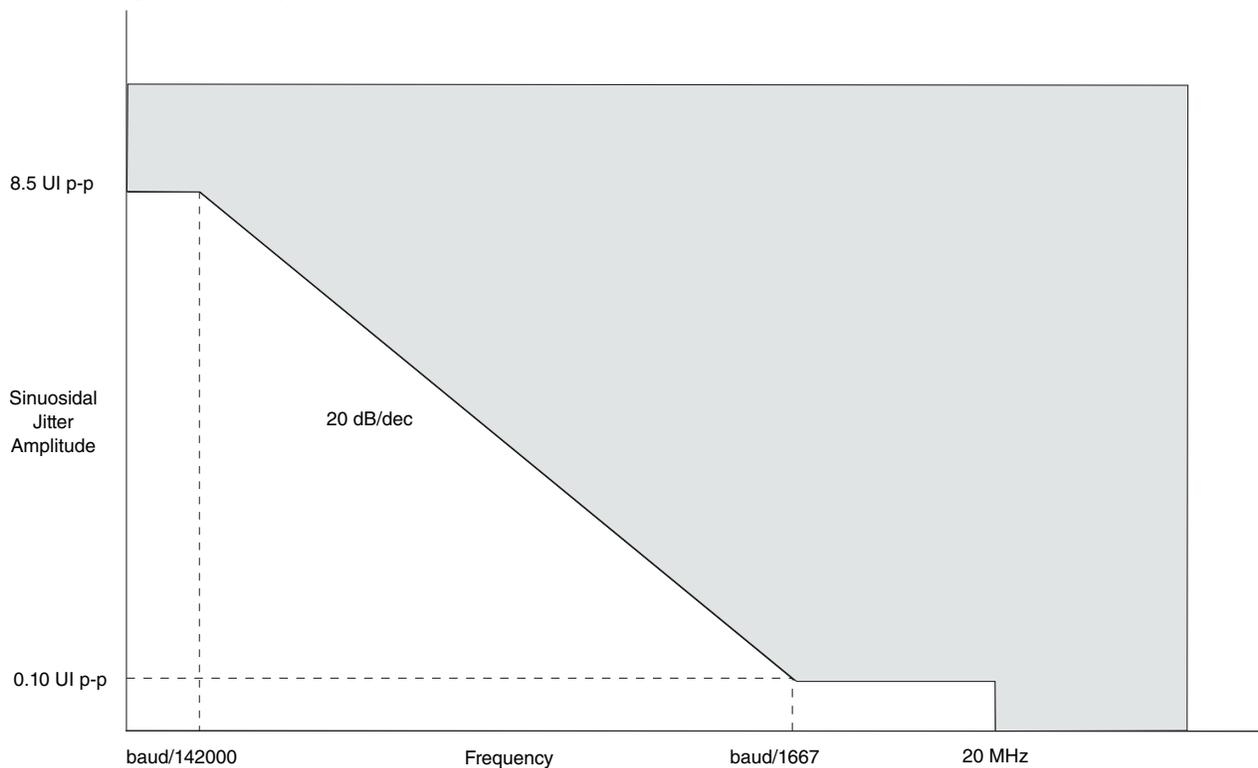
**Table 3-37.** SGMII Receive AC timing specifications<sup>(3)</sup>

Parameter	Symbol	Min	Typ	Max	Unit	Notes
Deterministic jitter tolerance	$J_D$	–	–	0.37	UI p-p	(1)
Combined deterministic and random jitter tolerance	$J_{DR}$	–	–	0.55	UI p-p	(1)
Total jitter tolerance	$J_T$	–	–	0.65	UI p-p	(1)(2)
Bit error ratio	BER	–	–	$10^{-12}$	–	–
Unit Interval: 1.25 GBaud (SGMII)	UI	800 – 100 ppm	800	800 + 100 ppm	ps	(1)

- Notes:
1. Measured at receiver
  2. Total jitter is composed of three components: deterministic jitter, random jitter, and single frequency sinusoidal jitter. The sinusoidal jitter may have any amplitude and frequency in the unshaded region of Figure 3-15. The sinusoidal jitter component is included to ensure margin for low frequency jitter, wander, noise, crosstalk and other variable system effects.
  3. For recommended operating conditions, see Table 3-2.

The sinusoidal jitter in the total jitter tolerance may have any amplitude and frequency in the unshaded region of this figure.

**Figure 3-15.** Single-frequency sinusoidal jitter limits



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## 3.11.2 QSGMII interface

This section describes the QSGMII clocking and its DC and AC electrical characteristics.

### 3.11.2.1 QSGMII clocking requirements for $SDn\_REF\_CLKn$ and $SDn\_REF\_CLKn\_B$

For more information on these specifications, see [SerDes reference clocks](#).

### 3.11.2.2 QSGMII DC electrical characteristics

This section discusses the electrical characteristics for the SGMII interface.

#### 3.11.2.2.1 QSGMII transmitter DC specifications

This table describes the QSGMII SerDes transmitter AC-coupled DC electrical characteristics. Transmitter DC characteristics are measured at the transmitter outputs ( $SDn\_TXn$  and  $SDn\_TXn\_B$ ).

**Table 3-38.** QSGMII DC transmitter electrical characteristics ( $X1V_{DD} = 1.35V$ )<sup>1</sup>

Parameter	Symbol	Min	Typ	Max	Unit	Notes
Output differential voltage	$V_{DIFF}$	400	–	900	mV	–
Differential resistance	$T_{RD}$	80	100	120	$\Omega$	–

Note: 1. For recommended operating conditions, see [Table 3-2](#).

#### 3.11.2.2.2 QSGMII DC receiver electrical characteristics

This table defines the QSGMII receiver DC electrical characteristics.

**Table 3-39.** QSGMII receiver DC timing specifications ( $SV_{DD} = 1.0V$ )<sup>1</sup>

Parameter	Symbol	Min	Typical	Max	Unit	Notes
Input differential voltage	$V_{DIFF}$	100	–	900	mV	–
Differential resistance	$R_{RDIN}$	80	100	120	$\Omega$	–

Note: 1. For recommended operating conditions, see [Table 3-2](#).

### 3.11.2.3 QSGMII AC timing specifications

This section discusses the AC timing specifications for the QSGMII interface.

#### 3.11.2.3.1 QSGMII transmit AC timing specifications

This table provides the QSGMII transmitter AC timing specifications.

**Table 3-40.** QSGMII transmit AC timing specifications<sup>1</sup>

Parameter	Symbol	Min	Typical	Max	Unit	Notes
Transmitter baud rate	$T_{BAUD}$	5.000 – 100 ppm	5.000	5.000 + 100 ppm	Gb/s	–
Uncorrelated high probability jitter	$T_{UHPJ}$	–	–	0.15	UI p-p	–
Total jitter tolerance	$J_T$	–	–	0.30	UI p-p	–

Note: 1. For recommended operating conditions, see [Table 3-2](#).

3.11.2.3.2 QSGMII receiver AC timing Specification

This table provides the QSGMII receiver AC timing specifications.

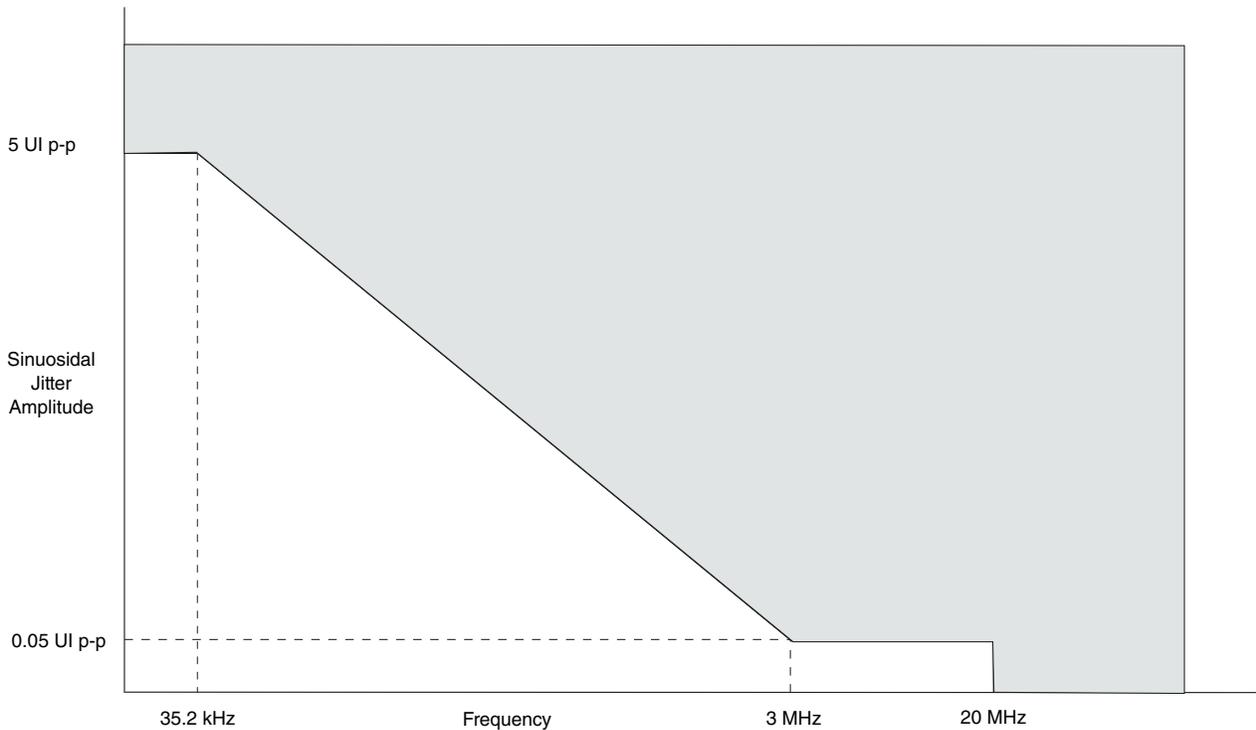
Table 3-41. QSGMII receive AC timing specifications<sup>(2)</sup>

Parameter	Symbol	Min	Typ	Max	Unit	Notes
Receiver baud rate	$R_{BAUD}$	5.000 – 100 ppm	5.000	5.000 + 100 ppm	Gb/s	–
Uncorrelated bounded high probability jitter	$R_{DJ}$	–	–	0.15	UI p-p	–
Correlated bounded high probability jitter	$R_{CBHPJ}$	–	–	0.30	UI p-p	(1)
Bounded high probability jitter	$R_{BHPJ}$	–	–	0.45	UI p-p	–
Sinusoidal jitter, maximum	$R_{SJ-max}$	–	–	5.00	UI p-p	–
Sinusoidal jitter, high frequency	$R_{SJ-hf}$	–	–	0.05	UI p-p	–
Total jitter (does not include sinusoidal jitter)	$R_{Tj}$	–	–	0.60	UI p-p	–

- Notes: 1. The jitter ( $R_{CBHPJ}$ ) and amplitude have to be correlated, for example, by a PCB trace.  
 2. For recommended operating conditions, see Table 3-2.

The sinusoidal jitter may have any amplitude and frequency in the unshaded region of this figure.

Figure 3-16. QSGMII single-frequency sinusoidal jitter limits



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## 3.11.3 1000Base-KX interface

This section discusses the electrical characteristics for the 1000Base-KX. Only AC- coupled operation is supported.

### 3.11.3.1 1000Base-KX DC electrical characteristics

#### 3.11.3.1.1 1000Base-KX Transmitter DC Specifications

This table describes the 1000Base-KX SerDes transmitter DC specification at TP1 per IEEE Std 802.3ap-2007. Transmitter DC characteristics are measured at the transmitter outputs (SD1\_TXn\_P and SD1\_TXn\_N).

**Table 3-42.** 1000Base-KX Transmitter DC Specifications

Parameter	Symbols	Min	Typ	Max	Units	Notes
Output differential voltage	$V_{TX-DIFFp-p}$	800	–	1600	mV	1
Differential resistance	$T_{RD}$	80	100	120	$\Omega$	–

Notes: 1. SRDSxLNmTECR0[AMP\_RED]=00\_0000.  
2. For recommended operating conditions, see [Table 3-2](#).

#### 3.11.3.1.2 1000Base-KX Receiver DC Specifications

Table below provides the 1000Base-KX receiver DC timing specifications.

**Table 3-43.** 1000Base-KX Receiver DC Specifications

Parameter	Symbols	Min	Typical	Max	Units	Notes
Input differential voltage	$V_{RX-DIFFp-p}$	–	–	1600	mV	(1)
Differential resistance	$T_{RDIN}$	80	–	120	$\Omega$	–

Note: 1. For recommended operating conditions, see [Table 3-2](#).

### 3.11.3.2 1000Base-KX AC electrical characteristics

#### 3.11.3.2.1 1000Base-KX Transmitter AC Specifications

Table below provides the 1000Base-KX transmitter AC specification.

**Table 3-44.** 1000Base-KX Transmitter AC Specifications

Parameter	Symbols	Min	Typical	Max	Units	Notes
Baud Rate	$T_{BAUD}$	1.25-100ppm	1.25	1.25+100ppm	Gb/s	–
Uncorrelated High Probability Jitter/ Random Jitter	$T_{UHPJ}T_{RJ}$	–	–	0.15	UI p-p	–
Deterministic Jitter	$T_{DJ}$	–	–	0.10	UI p-p	–
Total Jitter	$T_{TJ}$	–	–	0.25	UI p-p	(1)

Notes: 1. Total jitter is specified at a BER of  $10^{-12}$ .  
2. For recommended operating conditions, [Table 3-2](#).

**3.11.3.2.2 1000Base-KX Receiver AC Specifications**

Table below provides the 1000Base-KX receiver AC specification with parameters guided by IEEE Std 802.3ap-2007.

**Table 3-45.** 1000Base-KX Receiver AC Specifications

Parameter	Symbols	Min	Typical	Max	Units	Notes
Receiver Baud Rate	$T_{BAUD}$	1.25-100ppm	1.25	1.25+100ppm	Gb/s	–
Random Jitter	$R_{RJ}$	–	–	0.15	UI p-p	(1)
Sinusoidal Jitter, maximum	$R_{SJ-max}$	–	–	0.10	UI p-p	(2)
Total Jitter	$R_{TJ}$	–	–	See Note 3	UI p-p	(2)

- Notes:
1. Random jitter is specified at a BER of  $10^{-12}$ .
  2. The receiver interference tolerance level of this parameter shall be measured as described in Annex 69A of the IEEE Std 802.3ap-2007.
  3. Per IEEE 802.3ap-clause 70.
  4. The AC specifications do not include Refclk jitter.
  5. For recommended operating conditions, [Table 3-2](#).

**3.11.4 RGMII electrical specifications**

This section discusses the electrical characteristics for the RGMII interface.

**3.11.4.1 RGMII DC electrical characteristics**

This table shows the DC electrical characteristics for the RGMII interface.

**Table 3-46.** RGMII DC electrical characteristics(LV<sub>DD</sub>, L1V<sub>DD</sub> = 2.5V)<sup>(4)</sup>

Parameters	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	0.7 * LVDD	–	V	(1)
Input low voltage	$V_{IL}$	–	0.2 * LVDD	V	(1)
Input current (LV <sub>IN</sub> = 0V or LV <sub>IN</sub> = LV <sub>DD</sub> )	$I_{IH}$	–	±50	µA	(2)(3)
Output high voltage (LV <sub>DD</sub> = min, I <sub>OH</sub> = –1.0 mA)	$V_{OH}$	2.00	–	V	(3)
Output low voltage (LV <sub>DD</sub> = min, I <sub>OL</sub> = 1.0 mA)	$V_{OL}$	–	0.4	V	(3)

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the respective min and max LV<sub>IN</sub> values found in [Table 3-2](#).
  2. The symbol LV<sub>IN</sub>, in this case, represents the LV<sub>IN</sub> and L1V<sub>IN</sub> symbol referenced in [Recommended operating conditions](#).
  3. The symbol LV<sub>DD</sub>, in this case, represents the LV<sub>DD</sub> and L1V<sub>DD</sub> symbol referenced in [Recommended operating conditions](#).
  4. For recommended operating conditions, see [Table 3-2](#).

# QT1040/QT1020 4GB

This table provides the DC electrical characteristics for the RGMII interface at  $L1V_{DD}/LV_{DD} = 1.8V$ .

**Table 3-47.** RGMII DC electrical characteristics (1.8V)<sup>(4)</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	$0.7 * LV_{DD}$	–	V	(1)
Input low voltage	$V_{IL}$	–	$0.2 * LV_{DD}$	V	(1)
Input current ( $LV_{IN} = 0V$ or $L1V_{IN} = LV_{DD}$ )	$I_{IN}$	–	$\pm 50$	$\mu A$	(2)(3)
Output high voltage ( $LV_{DD} = \text{min}$ , $I_{OH} = -0.5 \text{ mA}$ )	$V_{OH}$	1.35	–	V	(3)
Output low voltage ( $LV_{DD} = \text{min}$ , $I_{OL} = 0.5 \text{ mA}$ )	$V_{OL}$	–	0.4	V	(3)

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the min and max  $LV_{IN}$  values found in [Table 3-2](#).
  2. The symbol  $LV_{IN}$ , in this case, represents the  $LV_{IN}$  and  $L1V_{IN}$  symbol referenced in [Recommended operating conditions](#).
  3. The symbol  $LV_{DD}$ , in this case, represents the  $LV_{DD}$  and  $L1V_{DD}$  symbol referenced in [Recommended operating conditions](#).
  4. For recommended operating conditions, see [Table 3-2](#).

### 3.11.4.2 RGMII AC timing specifications

This table presents the RGMII AC timing specifications.

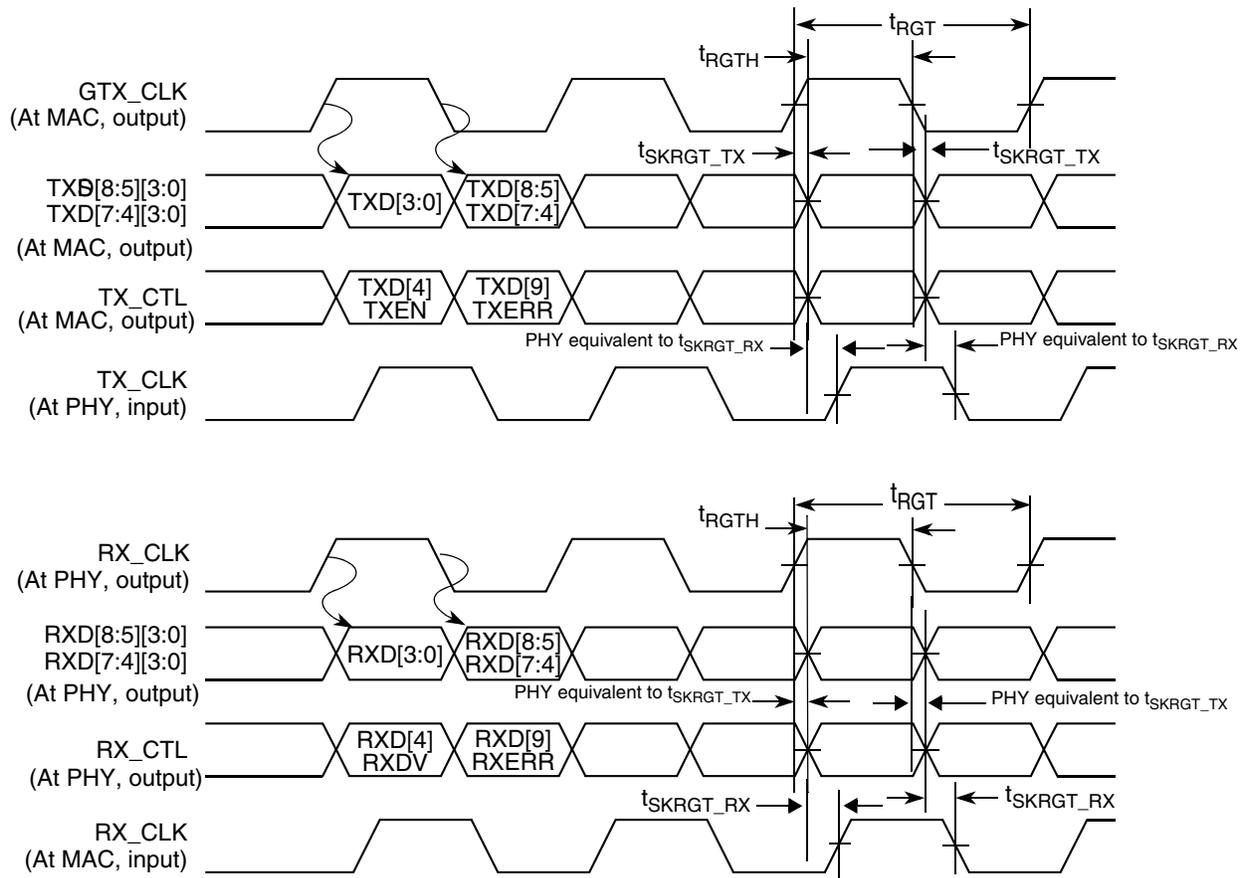
**Table 3-48.** RGMII AC timing specifications ( $LV_{DD} = 2.5 / 1.8V$ )<sup>(8)</sup>

Parameter/Condition	Symbol <sup>(1)</sup>	Min	Typ	Max	Unit	Notes
Data to clock output skew (at transmitter)	$t_{SKRGT\_TX}$	–620	0	520	ps	(7)
Data to clock input skew (at receiver)	$t_{SKRGT\_RX}$	2.0	–	3.0	ns	(2)
Clock period duration	$t_{RGT}$	7.2	8.0	8.8	ns	(3)
Duty cycle for 10BASE-T and 100BASE-TX	$t_{RGTH}/t_{RGT}$	40	50	60	%	(3)(4)
Duty cycle for Gigabit	$t_{RGTH}/t_{RGT}$	45	50	55	%	–
Rise time (20%-80%) $L1/LV_{DD} = 2.5V$ $L1/LV_{DD} = 1.8V$	$t_{RGTR}$	–	–	– 0.75 0.54	ns	(5)(6)
Fall time (20%-80%) $L1/LV_{DD} = 2.5V$ $L1/LV_{DD} = 1.8V$	$t_{RGTF}$	–	–	– 0.75 0.54	ns	(5)(6)

- Notes:
1. In general, the clock reference symbol representation for this section is based on the symbols RGT to represent RGMII timing. Note that the notation for rise (R) and fall (F) times follows the clock symbol that is being represented. For symbols representing skews, the subscript is skew (SK) followed by the clock that is being skewed (RGT).
  2. This implies that PC board design will require clocks to be routed such that an additional trace delay of greater than 2.5 ns is added to the associated clock signal. Many PHY vendors already incorporate the necessary delay inside their device. If so, additional PCB delay is probably not needed.
  3. For 10 and 100 Mbps,  $t_{RGT}$  scales to 400 ns  $\pm$  40 ns and 40 ns  $\pm$  4 ns, respectively.
  4. Duty cycle may be stretched/shrunk during speed changes or while transitioning to a received packet's clock domains as long as the minimum duty cycle is not violated and stretching occurs for no more than three  $t_{RGT}$  of the lowest speed transitioned between.
  5. Applies to inputs and outputs.
  6. System/board must be designed to ensure this input requirement to the chip is achieved. Proper device operation is guaranteed for inputs meeting this requirement by design, simulation, characterization, or functional testing.
  7. The frequency of  $ECn\_RX\_CLK$  (input) should not exceed the frequency of  $ECn\_GTX\_CLK$  (output) by more than 300 ppm.
  8. For recommended operating conditions, see [Table 3-2](#).

This figure shows the RGMII AC timing and multiplexing diagrams.

Figure 3-17. RGMII AC timing and multiplexing diagrams



**Warning**

Teledyne e2v guarantees timings generated from the MAC. Board designers must ensure delays needed at the PHY or the MAC.

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## 3.11.5 MII electrical specifications

This section discusses the electrical characteristics for the MII interface.

### 3.11.5.1 MII DC electrical characteristics

This table shows the MII DC electrical characteristics when operating from a 3.3V supply.

**Table 3-49.** MII DC electrical characteristics

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	$0.7 * L1VDD$	–	V	(1)
Input low voltage	$V_{IL}$	–	$0.2 * L1VDD$	V	(1)
Input high current ( $V_{IN} = L1V_{DD}$ )	$I_{IH}$	–	50	$\mu A$	(2)
Input low current ( $V_{IN} = GND$ )	$I_{IL}$	–50	–	$\mu A$	(2)
Output high voltage ( $L1V_{DD} = \text{min}$ , $I_{OH} = -2.0 \text{ mA}$ )	$V_{OH}$	2.4	–	V	–
Output low voltage ( $L1V_{DD} = \text{min}$ , $I_{OL} = 2.0 \text{ mA}$ )	$V_{OL}$	–	0.40	V	–

Notes: 1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the respective min and max  $L1V_{IN}$  values found in [Table 3-2](#)  
 2. The symbol  $V_{IN}$ , in this case, represents the  $L1V_{IN}$  symbols referenced in Table for "Absolute Maximum Ratings"

This table shows the MII DC electrical characteristics when operating from a 2.5V supply.

**Table 3-50.** MII DC electrical characteristics

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	$0.7 * L1VDD$	–	V	(1)
Input low voltage	$V_{IL}$	–	$0.2 * L1VDD$	V	(1)
Input high current ( $V_{IN} = L1V_{DD}$ )	$I_{IH}$	–	50	$\mu A$	(2)
Input low current ( $V_{IN} = GND$ )	$I_{IL}$	–50	–	$\mu A$	(2)
Output high voltage ( $L1V_{DD} = \text{min}$ , $I_{OH} = -1.0 \text{ mA}$ )	$V_{OH}$	2.0	–	V	–
Output low voltage ( $L1V_{DD} = \text{min}$ , $I_{OL} = 1.0 \text{ mA}$ )	$V_{OL}$	–	0.40	V	–

### 3.11.5.2 MII AC timing specifications

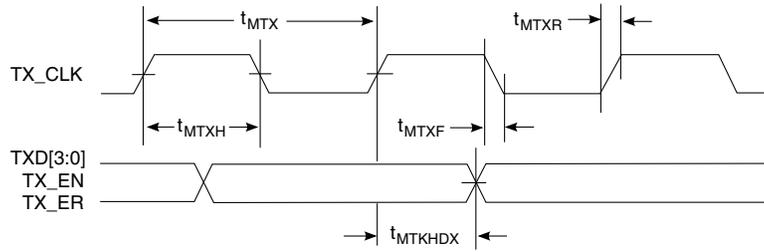
This section describes the MII transmit and receive AC timing specifications.

**Table 3-51.** MII transmit AC timing specifications

Parameter	Symbol	Min	Typ	Max	Unit
TX_CLK clock period 10 Mbps	$t_{MTX}$	–	400	–	ns
TX_CLK clock period 100 Mbps	$t_{MTX}$	–	40	–	ns
TX_CLK duty cycle	$t_{MTXH}/t_{MTX}$	35	–	65	%
TX_CLK to MII data TXD[3:0], TX_ER, TX_EN delay	$t_{MTKHDX}$	0	–	25	ns
TX_CLK data clock rise (20%–80%)	$t_{MTXR}$	1.0	–	4.0	ns
TX_CLK data clock fall (80%–20%)	$t_{MTXF}$	1.0	–	4.0	ns

This figure shows the MII transmit AC timing diagram.

**Figure 3-18.** MII transmit AC timing diagram



This table provides the MII receive AC timing specifications.

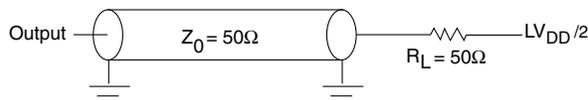
**Table 3-52.** MII receive AC timing specifications

Parameter	Symbol	Min	Typ	Max	Unit
RX_CLK clock period 10 Mbps	$t_{MRX}$	–	400	–	ns
RX_CLK clock period 100 Mbps	$t_{MRX}$	–	40	–	ns
RX_CLK duty cycle	$t_{MRXH}/t_{MRX}$	35	–	65	%
RXD[3:0], RX_DV, RX_ER setup time to RX_CLK	$t_{MRDVKH}$	10.0	–	–	ns
RXD[3:0], RX_DV, RX_ER hold time to RX_CLK	$t_{MRDXKH}$	10.0	–	–	ns
RX_CLK clock rise (20%–80%)	$t_{MRXR}$	1.0	–	4.0	ns
RX_CLK clock fall time (80%–20%)	$t_{MRXF}$	1.0	–	4.0	ns

- Notes:
1. The frequency of RX\_CLK (input) should not exceed the frequency of TX\_CLK (input) by more than 300 ppm.
  2. For recommended operating conditions, see [Table 3-2](#)

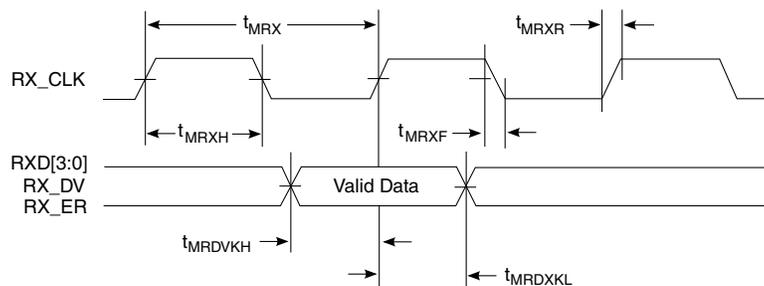
This figure provides the AC test load for the Ethernet controller.

**Figure 3-19.** Ethernet controller AC test load



This figure shows the MII receive AC timing diagram.

**Figure 3-20.** MII receive AC timing diagram



## 3.11.6 Ethernet management interface (EMI)

This section discusses the electrical characteristics for the EMI1 interface. The EMI1 interface timing is compatible with IEEE Std 802.3<sup>o</sup> clause 22.

### 3.11.6.1 Ethernet management interface 1 DC electrical characteristics

The DC electrical characteristics for EMI1\_MDIO and EMI1\_MDC are provided in this section. The pins are available on LV<sub>DD</sub> and L1V<sub>DD</sub>. Refer to [Table 3-2](#) for operating voltages.

**Table 3-53.** Ethernet management interface 1 DC electrical characteristics (L1V<sub>DD</sub> = 3.3V)<sup>(3)</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	V <sub>IH</sub>	0.7 * L1VDD	–	V	(1)
Input low voltage	V <sub>IL</sub>	–	0.2 * L1VDD	V	(1)
Input current (LV <sub>IN</sub> = 0V or LV <sub>IN</sub> = LV <sub>DD</sub> )	I <sub>IN</sub>	–	±50	µA	(2)
Output high voltage (L1V <sub>DD</sub> = min, I <sub>OH</sub> = –2 mA)	V <sub>OH</sub>	2.4	–	V	–
Output low voltage (L1V <sub>DD</sub> = min, I <sub>OL</sub> = 2 mA)	V <sub>OL</sub>	–	0.4	V	–

- Notes:
1. The min V<sub>IL</sub> and max V<sub>IH</sub> values are based on the respective min and max L1V<sub>IN</sub> values found in [Table 3-2](#).
  2. The symbol LV<sub>IN</sub>, in this case, represents the L1V<sub>IN</sub> symbol referenced in [Recommended operating conditions](#)
  3. For recommended operating conditions, see [Table 3-2](#)

**Table 3-54.** Ethernet management interface 1 DC electrical characteristics (LV<sub>DD</sub> = 2.5V)<sup>(3)(4)</sup>

Parameters	Symbol	Min	Max	Unit	Notes
Input high voltage	V <sub>IH</sub>	0.7 * LVDD	–	V	(1)(4)
Input low voltage	V <sub>IL</sub>	–	0.2 * LVDD	V	(1)(4)
Input high current (V <sub>IN</sub> = LV <sub>DD</sub> )	I <sub>IH</sub>	–	50	µA	(2)(4)
Input low current (V <sub>IN</sub> = GND)	I <sub>IL</sub>	–50	–	µA	–
Output high voltage (LV <sub>DD</sub> = min, I <sub>OH</sub> = –1.0 mA)	V <sub>OH</sub>	2.00	–	V	–
Output low voltage (LV <sub>DD</sub> = min, I <sub>OL</sub> = 1.0 mA)	V <sub>OL</sub>	–	0.40	V	–

- Notes:
1. The min V<sub>IL</sub> and max V<sub>IH</sub> values are based on the respective min and max LV<sub>IN</sub>/L1V<sub>IN</sub> values found in [Table 3-2](#).
  2. The symbol V<sub>IN</sub>, in this case, represents the LV<sub>IN</sub>/L1V<sub>IN</sub> symbols referenced in [Recommended operating conditions](#).
  3. For recommended operating conditions, see [Table 3-2](#).
  4. The symbol LV<sub>DD</sub>, in this case, represents the LV<sub>DD</sub>/L1V<sub>DD</sub> symbols referenced in [Recommended operating conditions](#).

**Table 3-55.** Ethernet management interface 1 DC electrical characteristics(1.8V)<sup>(3)</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	V <sub>IH</sub>	0.7 * LVDD	–	V	(1)(4)
Input low voltage	V <sub>IL</sub>	–	0.2 * LVDD	V	(1)(4)
Input current (LV <sub>IN</sub> = 0V or LV <sub>IN</sub> = LV <sub>DD</sub> )	I <sub>IN</sub>	–	±50	µA	(2)(4)
Output high voltage (LV <sub>DD</sub> = min, I <sub>OH</sub> = –0.5 mA)	V <sub>OH</sub>	1.35	–	V	(4)
Output low voltage (LV <sub>DD</sub> = min, I <sub>OL</sub> = 0.5 mA)	V <sub>OL</sub>	–	0.4	V	(4)

- Notes:
1. The min V<sub>IL</sub> and max V<sub>IH</sub> values are based on the min and max LV<sub>IN</sub>/L1V<sub>IN</sub> respective values found in [Table 3-2](#).
  2. The symbol LV<sub>IN</sub> represents the LV<sub>IN</sub>/L1V<sub>IN</sub> symbols referenced in [Recommended operating conditions](#).
  3. For recommended operating conditions, see [Table 3-2](#).
  4. The symbol LV<sub>DD</sub>, in this case, represents the LV<sub>DD</sub> and L1V<sub>DD</sub> symbols referenced in [Recommended operating conditions](#).

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3.11.6.2 Ethernet management interface 1 AC electrical specifications

This table provides the Ethernet management interface 1 AC timing specifications.

Table 3-56. Ethernet management interface 1 AC timing specifications<sup>(5)</sup>

Parameter/Condition	Symbol <sup>(1)</sup>	Min	Typ	Max	Unit	Notes
MDC frequency	$f_{MDC}$	–	–	2.5	MHz	(2)
MDC clock pulse width high	$t_{MDCH}$	160	–	–	ns	–
MDC to MDIO delay	$t_{MDKHDX}$	$(5 \times t_{enet\_clk}) - 3$	–	$(5 \times t_{enet\_clk}) + 3$	ns	(3)(4)
MDIO to MDC setup time	$t_{MDDVKH}$	8	–	–	ns	–
MDIO to MDC hold time	$t_{MDDXKH}$	0	–	–	ns	–

- Notes:
- The symbols used for timing specifications follow the pattern of  $t_{(first\ two\ letters\ of\ functional\ block)(signal)(state)(reference)(state)}$  for inputs and  $t_{(first\ two\ letters\ of\ functional\ block)(reference)(state)(signal)(state)}$  for outputs. For example,  $t_{MDKHDX}$  symbolizes management data timing (MD) for the time  $t_{MDC}$  from clock reference (K) high (H) until data outputs (D) are invalid (X) or data hold time. Also,  $t_{MDDVKH}$  symbolizes management data timing (MD) with respect to the time data input signals (D) reach the valid state (V) relative to the  $t_{MDC}$  clock reference (K) going to the high (H) state or setup time.
  - This parameter is dependent on the Ethernet clock frequency (MDIO\_CFG [MDIO\_CLK\_DIV] field determines the clock frequency of the MgmtClk Clock EC\_MDC).
  - This parameter is dependent on the Ethernet clock frequency. The delay is equal to 5 Ethernet clock periods  $\pm$  3 ns. For example, with an Ethernet clock of 400 MHz, the min/max delay is 12.5 ns  $\pm$  3 ns.
  - $t_{enet\_clk}$  is the Ethernet clock period (Frame Manager clock period  $\times$  2).
  - For recommended operating conditions, see Table 3-2.

3.11.7 IEEE 1588 electrical specifications

3.11.7.1 IEEE 1588 DC electrical characteristics

This table shows IEEE 1588 DC electrical characteristics when operating at  $V_{DD} = 3.3V$  supply.

Table 3-57. IEEE 1588 DC electrical characteristics( $V_{DD} = 3.3V$ )<sup>(3)</sup>

Parameters	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	$0.7 * LV_{DD}$	–	V	(1)
Input low voltage	$V_{IL}$	–	$0.2 * LV_{DD}$	V	(1)
Input current ( $V_{IN} = 0V$ or $V_{IN} = LV_{DD}$ )	$I_{IH}$	–	$\pm 50$	$\mu A$	(2)
Output high voltage ( $V_{DD} = \min$ , $I_{OH} = -2.0\ mA$ )	$V_{OH}$	2.4	–	V	–
Output low voltage ( $V_{DD} = \min$ , $I_{OL} = 2.0\ mA$ )	$V_{OL}$	–	0.40	V	–

- Notes:
- The min  $V_{IL}$  and max  $V_{IH}$  values are based on the respective min and max  $V_{IN}$  values found in Table 3-2.
  - The symbol  $V_{IN}$ , in this case, represents the  $V_{IN}$  symbol referenced in Recommended operating conditions.
  - For recommended operating conditions, see Table 3-2.

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This table shows IEEE 1588 DC electrical characteristics when operating at LV<sub>DD</sub> = 2.5V supply.

**Table 3-58.** IEEE 1588 DC electrical characteristics(LV<sub>DD</sub> = 2.5V)<sup>(3)</sup>

Parameters	Symbol	Min	Max	Unit	Notes
Input high voltage	V <sub>IH</sub>	0.7 * LVDD	–	V	(1)
Input low voltage	V <sub>IL</sub>	–	0.2 * LVDD	V	(1)
Input current (LV <sub>IN</sub> = 0V or LV <sub>IN</sub> = LV <sub>DD</sub> )	I <sub>IH</sub>	–	±50	µA	(2)
Output high voltage (LV <sub>DD</sub> = min, I <sub>OH</sub> = –1.0 mA)	V <sub>OH</sub>	2.00	–	V	–
Output low voltage (LV <sub>DD</sub> = min, I <sub>OL</sub> = 1.0 mA)	V <sub>OL</sub>	–	0.40	V	–

Notes: 1. The min V<sub>IL</sub> and max V<sub>IH</sub> values are based on the respective min and max LV<sub>IN</sub> values found in Table 3-2.  
 2. The symbol LV<sub>IN</sub>, in this case, represents the LV<sub>IN</sub> symbol referenced in Recommended operating conditions.  
 3. For recommended operating conditions, see Table 3-2.

This table shows IEEE 1588 DC electrical characteristics when operating at LV<sub>DD</sub> = 1.8V supply.

**Table 3-59.** IEEE 1588 DC electrical characteristics(LV<sub>DD</sub> = 1.8V)<sup>(3)</sup>

Parameters	Symbol	Min	Max	Unit	Notes
Input high voltage	V <sub>IH</sub>	0.7 * LVDD	–	V	(1)
Input low voltage	V <sub>IL</sub>	–	0.2 * LVDD	V	(1)
Input current (LV <sub>IN</sub> = 0V or LV <sub>IN</sub> = LV <sub>DD</sub> )	I <sub>IH</sub>	–	±50	µA	(2)
Output high voltage (LV <sub>DD</sub> = min, I <sub>OH</sub> = –0.5 mA)	V <sub>OH</sub>	1.35	–	V	–
Output low voltage (LV <sub>DD</sub> = min, I <sub>OL</sub> = 0.5 mA)	V <sub>OL</sub>	–	0.40	V	–

Notes: 1. The min V<sub>IL</sub> and max V<sub>IH</sub> values are based on the respective min and max LV<sub>IN</sub> values found in Table 3-2.  
 2. The symbol LV<sub>IN</sub>, in this case, represents the LV<sub>IN</sub> symbol referenced in Recommended operating conditions.  
 3. For recommended operating conditions, see Table 3-2.

### 3.11.7.2 IEEE 1588 AC specifications

This table provides the IEEE 1588 AC timing specifications.

**Table 3-60.** IEEE 1588 AC timing specifications<sup>(5)</sup>

Parameter/Condition	Symbol	Min	Typ	Max	Unit	Notes
TSEC_1588_CLK_IN clock period	t <sub>T1588CLK</sub>	FM_CLK/2	–	T <sub>RX_CLK</sub> × 7	ns	(1)(3)(6)
TSEC_1588_CLK_IN duty cycle	t <sub>T1588CLKH</sub> / t <sub>T1588CLK</sub>	40	50	60	%	(2)
TSEC_1588_CLK_IN peak-to-peak jitter	t <sub>T1588CLKINJ</sub>	–	–	250	ps	–
Rise time TSEC_1588_CLK_IN (20%-80%)	t <sub>T1588CLKINR</sub>	1.0	–	2.0	ns	–
Fall time TSEC_1588_CLK_IN (80%-20%)	t <sub>T1588CLKINF</sub>	1.0	–	2.0	ns	–
TSEC_1588_CLK_OUT clock period	t <sub>T1588CLKOUT</sub>	5.0	–	–	ns	(4)
TSEC_1588_CLK_OUT duty cycle	t <sub>T1588CLKOTH</sub> / t <sub>T1588CLKOUT</sub>	30	50	70	%	–
TSEC_1588_PULSE_OUT1/2, TSEC_1588_ALARM_OUT1/2	t <sub>T1588OV</sub>	0.5	–	3.0	ns	–
TSEC_1588_TRIG_IN1/2 pulse width	t <sub>T1588TRIGH</sub>	2 × t <sub>T1588CLK_MAX</sub>	–	–	ns	(3)

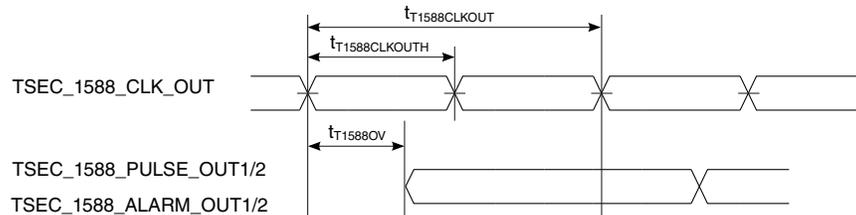
Notes: 1. T<sub>RX\_CLK</sub> is the maximum clock period of ethernet receiving clock selected by TMR\_CTRL[CKSEL]. See the chip reference manual for a description of TMR\_CTRL registers.

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2. It needs to be at least two times the clock period of the clock selected by TMR\_CTRL[CKSEL]. See the chip reference manual for a description of TMR\_CTRL registers.
3. The maximum value of  $t_{T1588CLK}$  is not only defined by the value of  $T_{RX\_CLK}$  but also defined by the recovered clock. For example, for 10/100/1000 Mbps modes, the maximum value of  $t_{T1588CLK}$  will be 2800, 280, and 56 ns, respectively.
4. There are 3 input clock sources for 1588 that is, TSEC\_1588\_CLK\_IN, RTC and MAC clock / 2. When using TSEC\_1588\_CLK\_IN, the minimum clock period is  $2 \times t_{T1588CLK}$ .
5. For recommended operating conditions, see [Table 3-2](#).
6. FM\_CLK = platform clock

This figure shows the data and command output AC timing diagram.

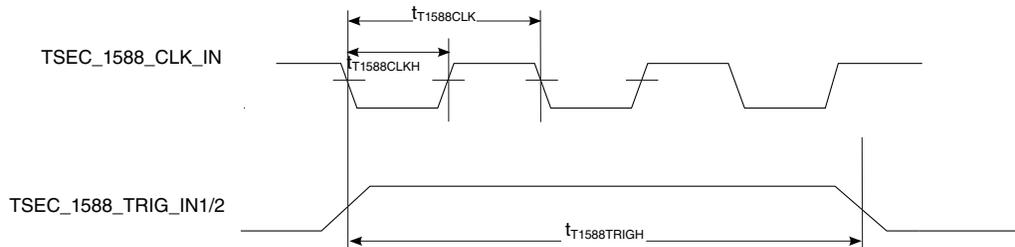
**Figure 3-21.** EEE 1588 output AC timing



Note: The output delay is counted starting at the rising edge if  $t_{T1588CLKOUT}$  is non-inverting. Otherwise, it is counted starting at the falling edge.

This figure shows the data and command input AC timing diagram.

**Figure 3-22.** IEEE 1588 input AC timing



### 3.12 QUICC Engine Specifications

#### 3.12.1 HDLC, Transparent, and Synchronous UART interfaces

This section describes the DC and AC electrical specifications for the high level data link control HDLC, transparent and synchronous UART.

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## 3.12.1.1 HDLC, Transparent and Synchronous UART DC electrical characteristics

This table provides the DC electrical characteristics for the HDLC, Transparent and Synchronous UART protocols.

**Table 3-61.** HDLC, Transparent and Synchronous UART DC electrical characteristics (DVDD=3.3V)<sup>(3)</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	0.7 * DVDD	–	V	(1)
Input low voltage	$V_{IL}$	–	0.2 * DVDD	V	(1)
Input current ( $V_{IN} = 0V$ or $V_{IN} = DV_{DD}$ )	$I_{IN}$	–	±50	µA	(2)
Output high voltage ( $DV_{DD} = \text{min}$ , $I_{OH} = -2 \text{ mA}$ )	$V_{OH}$	2.4	–	V	–
Output low voltage ( $DV_{DD} = \text{min}$ , $I_{OH} = 2 \text{ mA}$ )	$V_{OL}$	–	0.4	V	–

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the respective min and max  $DV_{IN}$  values found in [Table 3-2](#)
  2. The symbol  $V_{IN}$ , in this case, represents the input voltage of the supply. It is referenced in [Recommended operating conditions](#).
  3. For recommended operating conditions, see [Table 3-2](#).

This table provides the DC electrical characteristics for the HDLC, Transparent and Synchronous UART protocols.

**Table 3-62.** HDLC, Transparent and Synchronous UART DC electrical characteristics (DVDD=2.5V)<sup>3</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	0.7 * DVDD	–	V	1
Input low voltage	$V_{IL}$	–	0.2 * DVDD	V	1
Input current ( $V_{IN} = 0V$ or $V_{IN} = DV_{DD}$ )	$I_{IN}$	–	±50	µA	2
Output high voltage ( $DV_{DD} = \text{min}$ , $I_{OH} = -1 \text{ mA}$ )	$V_{OH}$	2.0	–	V	–
Output low voltage ( $DV_{DD} = \text{min}$ , $I_{OH} = 1 \text{ mA}$ )	$V_{OL}$	–	0.4	V	–

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the respective min and max  $DV_{IN}$  values found in [Table 3-2](#)
  2. The symbol  $V_{IN}$ , in this case, represents the input voltage of the supply. It is referenced in [Recommended operating conditions](#).
  3. For recommended operating conditions, see [Table 3-2](#).

3.12.1.2 HDLC, Transparent and Synchronous UART AC timing specifications

This table provides the input and output AC timing specifications for HDLC, and Transparent and Synchronous UART protocols.

**Table 3-63.** HDLC, Transparent AC timing specifications

Parameter	Symbol	Min	Max	Unit	Notes
Outputs-Internal clock delay	$t_{HIKHOV}$	0	5.5	ns	1
Outputs-External clock delay	$t_{HEKHOV}$	1	8.5	ns	1
Outputs-Internal clock High Impedance	$t_{HIKHOX}$	0	5.5	ns	1
Outputs-External clock High Impedance	$t_{HEKHOX}$	1	8.2	ns	1
Inputs-Internal clock input setup time	$t_{HIIVKH}$	8.0	–	ns	–
Inputs-External clock input setup time	$t_{HEIVKH}$	4	–	ns	–
Inputs-Internal clock input Hold time	$t_{HIIXKH}$	0	–	ns	–
Inputs-External clock input hold time	$t_{HEIXKH}$	1	–	ns	–

- Notes:
1. Output specifications are measured from the 50% level of the rising edge of CLKIN to the 50% level of the signal. Timings are measured at the pin.
  2. For recommended operating conditions, see [Table 3-2](#).
  3. The Maximum frequency of operation is 50MHz

This table provides the input and output AC timing specifications for the synchronous UART protocols.

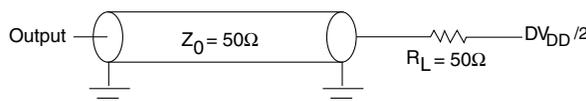
**Table 3-64.** Synchronous UART AC timing specifications

Parameter	Symbol	Min	Max	Unit	Notes
Outputs-Internal clock delay	$t_{HIKHOV}$	0	11	ns	1
Outputs-External clock delay	$t_{HEKHOV}$	1	14	ns	1
Outputs-Internal clock High Impedance	$t_{HIKHOX}$	0	11	ns	1
Outputs-External clock High Impedance	$t_{HEKHOX}$	1	14	ns	1
Inputs-Internal clock input setup time	$t_{HIIVKH}$	10	–	ns	–
Inputs-External clock input setup time	$t_{HEIVKH}$	8	–	ns	–
Inputs-Internal clock input Hold time	$t_{HIIXKH}$	0	–	ns	–
Inputs-External clock input hold time	$t_{HEIXKH}$	1	–	ns	–

- Notes:
1. Output specifications are measured from the 50% level of the rising edge of CLKIN to the 50% level of the signal. Timings are measured at the pin.
  2. For recommended operating conditions, see [Table 3-2](#).

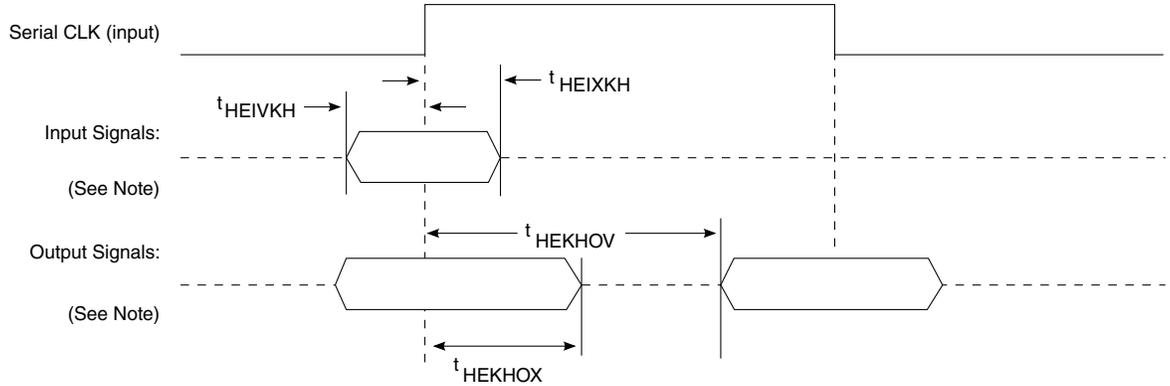
This figure provides the AC test load.

**Figure 3-23.** AC test load



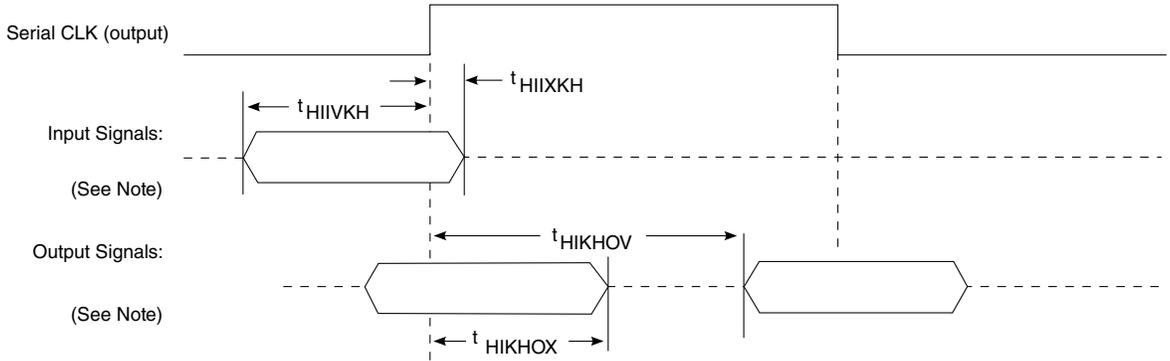
These figures represent the AC timing from [Table 3-63 on page 101](#) and [Table 3-64](#). Note that although the specifications generally reference the rising edge of the clock, these AC timing diagrams also apply when the falling edge is the active edge. This figure shows the timing with external clock.

**Figure 3-24.** AC timing (external clock) diagram



This figure shows the timing with internal clock.

**Figure 3-25.** AC timing (internal clock) diagram



Note: The clock edge is selectable

### 3.12.2 TDM/SI

This section describes the DC and AC electrical specifications for the time-division- multiplexed and serial interface (TDM/SI).

3.12.2.1 TDM/SI DC electrical characteristics

This table provides the TDM/SI DC electrical characteristics.

**Table 3-65.** TDM/SI DC electrical characteristics (DVDD=3.3V)<sup>3</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	V <sub>IH</sub>	0.7 * DVDD	–	V	1
Input low voltage	V <sub>IL</sub>	–	0.2 * DVDD	V	1
Input current (V <sub>IN</sub> = 0V or V <sub>IN</sub> = DV <sub>DD</sub> )	I <sub>IN</sub>	–	±50	µA	2
Output high voltage (DV <sub>DD</sub> = min, I <sub>OH</sub> = –2 mA)	V <sub>OH</sub>	2.4	–	V	–
Output low voltage (DV <sub>DD</sub> = min, I <sub>OH</sub> = 2 mA)	V <sub>OL</sub>	–	0.4	V	–

- Notes:
1. The min V<sub>IL</sub> and max V<sub>IH</sub> values are based on the respective min and max DV<sub>IN</sub> values found in [Table 3-2 on page 56](#)
  2. The symbol V<sub>IN</sub>, in this case, represents the input voltage of the supply. It is referenced in [Recommended operating conditions](#).
  3. For recommended operating conditions, see [Table 3-2](#).

**Table 3-66.** TDM/SI DC electrical characteristics (DVDD=2.5V)<sup>3</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	V <sub>IH</sub>	0.7 * DVDD	–	V	1
Input low voltage	V <sub>IL</sub>	–	0.2 * DVDD	V	1
Input current (V <sub>IN</sub> = 0V or V <sub>IN</sub> = DV <sub>DD</sub> )	I <sub>IN</sub>	–	±50	µA	2
Output high voltage (DV <sub>DD</sub> = min, I <sub>OH</sub> = –1 mA)	V <sub>OH</sub>	2.0	–	V	–
Output low voltage (DV <sub>DD</sub> = min, I <sub>OH</sub> = 1 mA)	V <sub>OL</sub>	–	0.4	V	–

- Notes:
1. The min V<sub>IL</sub> and max V<sub>IH</sub> values are based on the respective min and max DV<sub>IN</sub> values found in [Table 3-2](#)
  2. The symbol V<sub>IN</sub>, in this case, represents the input voltage of the supply. It is referenced in [Recommended operating conditions](#).
  3. For recommended operating conditions, see [Table 3-2](#).

3.12.2.2 TDM/SI AC timing specifications

This table provides the TDM/SI input and output AC timing specifications.

**Table 3-67.** TDM/SI AC timing specifications 1

Parameter	Symbol <sup>1</sup>	Min	Max	Unit
TDM/SI outputs-External clock delay	t <sub>SEKHOV</sub>	2	11	ns
TDM/SI outputs-External clock High Impedance	t <sub>SEKHOX</sub>	2	10	ns
TDM/SI inputs-External clock input setup time	t <sub>SEIVKH</sub>	5	–	ns
TDM/SI inputs-External clock input hold time	t <sub>SEIXKH</sub>	2	–	ns

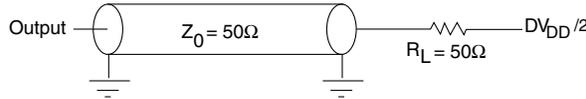
- Notes:
1. Output specifications are measured from the 50% level of the rising edge of CLKIN to the 50% level of the signal. Timings are measured at the pin.
  2. For recommended operating conditions, see [Table 3-2](#).

**NOTE**

The rise/fall time on QUICC Engine block input pins should not exceed 5 ns. This should be enforced especially on clock signals. Rise time refers to signal transitions from 10% to 90% of  $DV_{DD}$ ; fall time refers to transitions from 90% to 10% of  $DV_{DD}$

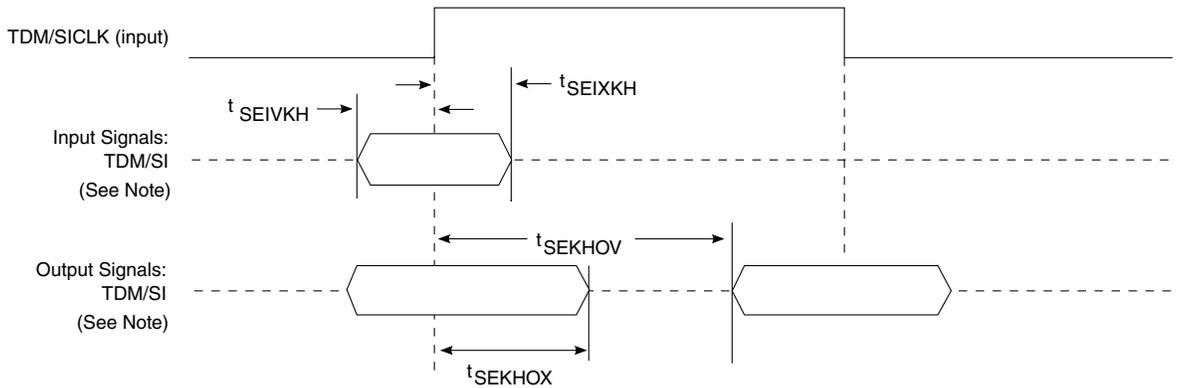
This figure provides the AC test load for the TDM/SI.

**Figure 3-26.** TDM/SI AC test load



This figure represents the AC timing from Table 3-65. Note that although the specifications generally reference the rising edge of the clock, these AC timing diagrams also apply when the falling edge is the active edge. This figure shows the TDM/SI timing with external clock.

**Figure 3-27.** TDM/SI AC timing (external clock) diagram



**3.13 USB interface**

This section provides the AC and DC electrical specifications for the USB interface.

**3.13.1 USB DC electrical characteristics**

This table provides the DC electrical characteristics for the USB interface at  $USB\_HV_{DD} = 3.3V$ .

**Table 3-68.** USB DC electrical characteristics ( $USB\_HV_{DD} = 3.3V$ )<sup>3</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	2.0	–	V	1
Input low voltage	$V_{IL}$	–	0.8	V	1
Input current ( $USB\_HV_{IN} = 0V$ or $USB\_HV_{IN} = USB\_HV_{DD}$ )	$I_{IN}$	–	$\pm 50$	$\mu A$	2
Output high voltage ( $USB\_HV_{DD} = \text{min}$ , $I_{OH} = -2 \text{ mA}$ )	$V_{OH}$	2.8	–	V	–
Output low voltage ( $USB\_HV_{DD} = \text{min}$ , $I_{OL} = 2 \text{ mA}$ )	$V_{OL}$	–	0.3	V	–

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the respective min and max  $USB\_HV_{IN}$  values found in Table 3-2.
  2. The symbol  $USB\_HV_{IN}$ , in this case, represents the  $USB\_HV_{IN}$  symbol referenced in Recommended operating conditions
  3. For recommended operating conditions, see Table 3-2

An Important Notice at the end of this datasheet addresses availability, warranty, changes, use in critical applications, intellectual property matters and other important disclaimers

This table provides the DC electrical characteristics for the USBCLK at  $O1V_{DD} = 1.8V$ .

**Table 3-69.** USBCLK DC electrical characteristics (1.8V)<sup>3</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	1.25	–	V	1
Input low voltage	$V_{IL}$	–	0.6	V	1
Input current ( $V_{IN} = 0V$ or $V_{IN} = O1V_{DD}$ )	$I_{IN}$	–	±50	µA	2

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the respective min and max  $O1V_{IN}$  values found in [Table 3-2](#).
  2. The symbol  $V_{IN}$ , in this case, represents the  $O1V_{IN}$  symbol referenced in [Recommended operating conditions](#).
  3. For recommended operating conditions, see [Table 3-2](#).

### 3.13.2 USB AC timing specifications

This section describes the AC timing specifications for the on-chip USB PHY. See Chapter 7 in the *Universal Serial Bus Revision 2.0 Specification* for more information.

This table provides the USB clock input (USBCLK) AC timing specifications.

**Table 3-70.** USBCLK AC timing specifications<sup>(1)</sup>

Parameter	Condition	Symbol	Min	Typ	Max	Unit	Notes
Frequency range	–	$f_{USB\_CLK\_I\_N}$	–	24	–	MHz	–
Rise/Fall time	Measured between 10% and 90%	$t_{USRF}$	–	–	6	ns	(2)
Clock frequency tolerance	–	$t_{CLK\_TOL}$	–0.005	0	0.005	%	–
Reference clock duty cycle	Measured at rising edge and/or falling edge at $O1V_{DD}/2$	$t_{CLK\_DUTY}$	40	50	60	%	–
Total input jitter/time interval error	RMS value measured with a second-order, band-pass filter of 500 kHz to 4 MHz bandwidth at $10^{-12}$ BER	$t_{CLK\_PJ}$	–	–	5	ps	–

- Notes:
1. For recommended operating conditions, see [Table 3-2](#)
  2. System/board must be designed to ensure the input requirement to the device is achieved. Proper device operation is guaranteed for inputs meeting this requirement by design, simulation, characterization, or functional testing.

## 3.14 Integrated flash controller

This section describes the DC and AC electrical specifications for the integrated flash controller.

### 3.14.1 Integrated flash controller DC electrical characteristics

This table provides the DC electrical characteristics for the integrated flash controller when operating at  $OV_{DD} = 1.8V$ .

**Table 3-71.** Integrated flash controller DC electrical characteristics (1.8V)<sup>3</sup>

Parameter	Symbol	Min	Max	Unit	Note
Input high voltage	$V_{IH}$	1.2	–	V	1
Input low voltage	$V_{IL}$	–	0.6	V	1
Input current ( $V_{IN} = 0V$ or $V_{IN} = OV_{DD}$ )	$I_{IN}$	–	±50	µA	2
Output high voltage ( $OV_{DD} = \text{min}$ , $I_{OH} = -0.5 \text{ mA}$ )	$V_{OH}$	1.35	–	V	–
Output low voltage ( $OV_{DD} = \text{min}$ , $I_{OL} = 0.5 \text{ mA}$ )	$V_{OL}$	–	0.32	V	–

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the respective min and max  $OV_{IN}$  values found in [Table 3-2](#).
  2. The symbol  $V_{IN}$ , in this case, represents the  $OV_{IN}$  symbol referenced in [Recommended operating conditions](#).
  3. For recommended operating conditions, see [Table 3-2](#).

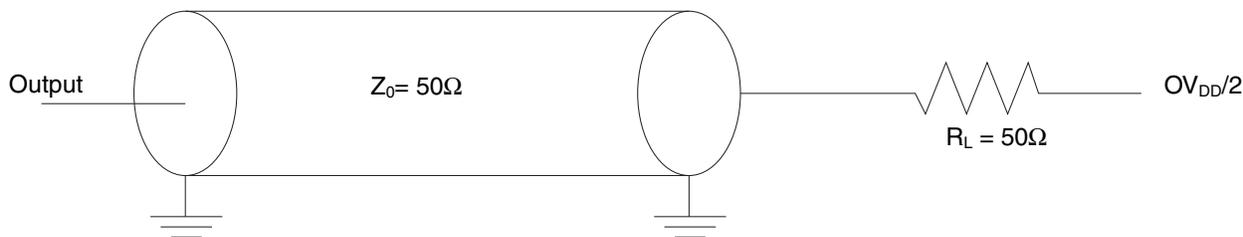
### 3.14.2 Integrated flash controller AC timing

This section describes the AC timing specifications for the integrated flash controller.

#### 3.14.2.1 Test condition

This figure provides the AC test load for the integrated flash controller.

**Figure 3-28.** Integrated flash controller AC test load



#### 3.14.2.2 Integrated flash controller Input AC timing specifications

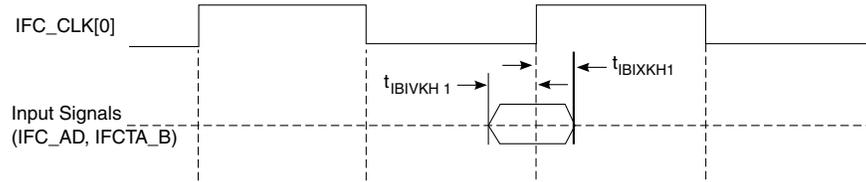
This table describes the input AC timing specifications of the IFC-GPCM and IFC- GASIC interface.

**Table 3-72.** Integrated Flash Controller input timing specifications for GPCM and GASIC mode ( $OV_{DD} = 1.8V$ )

Parameter	Symbol	Min	Max	Unit	Notes
Input setup	$t_{BIVKH1}$	4	–	ns	–
Input hold	$t_{BIXKH1}$	1	–	ns	–

This figure shows the input AC timing diagram for IFC-GPCM, IFC-GASIC interface.

**Figure 3-29.** IFC-GPCM, IFC-GASIC input AC timings



This table describes the input timing specifications of the IFC-NOR interface.

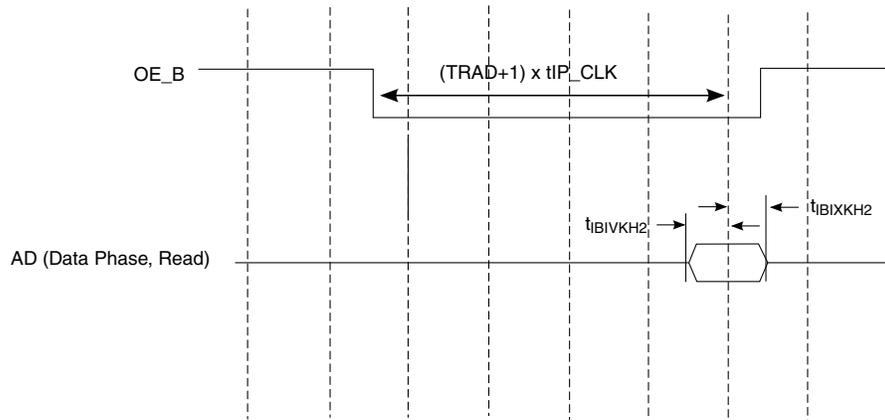
**Table 3-73.** Integrated Flash Controller Input timing specifications for NOR mode ( $OV_{DD} = 1.8V$ )

Parameter	Symbol	Min	Max	Unit	Notes
Input setup	$t_{IBIVKH2}$	$(2 \times t_{IP\_CLK}) + 2$	–	ns	1
Input hold	$t_{IBIXKH2}$	$1 \times t_{IP\_CLK}$	–	ns	1

- Notes:
- $t_{IP\_CLK}$  is the period of ip clock (not the IFC\_CLK) on which IFC is running.
  - For recommended operating conditions, see [Table 3-2](#)

This figure shows the AC input timing diagram for input signals of IFC-NOR interface. Here TRAD is a programmable delay parameter, refer to IFC section of QT1040 QorIQ Integrated Processor Reference Manual for more information.

**Figure 3-30.** IFC-NOR Interface input AC timings



$IP\_CLK$  is the internal clock on which IFC is running. It is not available on interface pins.

This table describes the input timing specifications of the IFC-NAND interface.

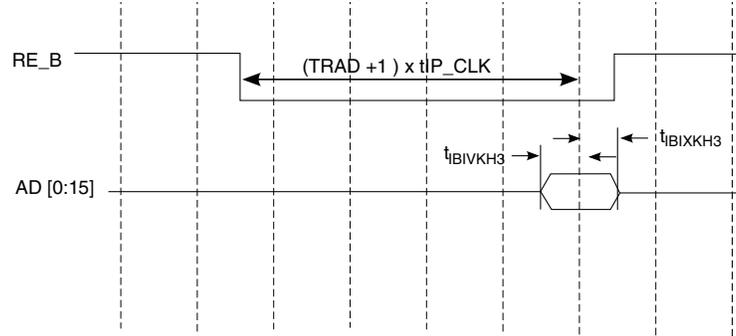
**Table 3-74.** Integrated Flash Controller input timing specifications for NAND mode ( $OV_{DD} = 1.8V$ )

Parameter	Symbol	Min	Max	Unit	Notes
Input setup	$t_{IBIVKH3}$	$(2 \times t_{IP\_CLK}) + 2$	–	ns	1
Input hold	$t_{IBIXKH3}$	$(1 \times t_{IP\_CLK})$	–	ns	1
IFC_RB_B pulse width	$t_{IBCH}$	2	–	$t_{IP\_CLK}$	1

- Notes:
- $t_{IP\_CLK}$  is the period of ip clock on which IFC is running.
  - For recommended operating conditions, see [Table 3-2](#)

This figure shows the AC input timing diagram for input signals of IFC-NAND interface. Here TRAD is a programmable delay parameter, refer to IFC section of QT1040 QorIQ Integrated Processor Reference Manual for more information.

**Figure 3-31.** IFC-NAND Interface input AC timings



$t_{IP\_CLK}$  is the period of ip clock (not the IFC\_CLK) on which IFC is running.

3.14.2.3 Integrated flash controller output AC timing specifications

This table describes the output AC timing specifications of IFC-GPCM and IFC-GASIC interface.

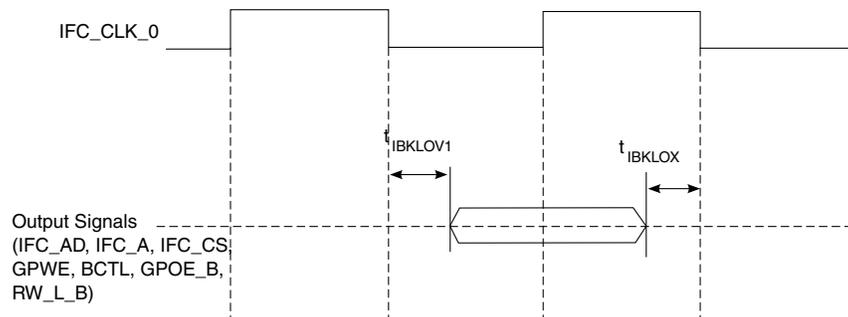
**Table 3-75.** Integrated Flash Controller IFC-GPCM and IFC-GASIC interface output timing specifications ( $OV_{DD} = 1.8V$ )

Parameter	Symbol	Min	Max	Unit	Notes
IFC_CLK cycle time	$t_{IBK}$	10	–	ns	–
IFC_CLK duty cycle	$t_{IBKH} / t_{IBK}$	45	55	%	–
Output delay	$t_{IBKLOV1}$	–	1.5	ns	–
Output hold	$t_{IBKLOX}$	–	–2	ns	1
IFC_CLK[0] to IFC_CLK[m] skew	$t_{IBKSKEW}$	0	$\pm 75$	ps	–

- Notes: 1. Output hold is negative. This means that output transition happens earlier than the falling edge of IFC\_CLK.  
 2. For recommended operating conditions, see [Table 3-2](#)

This figure shows the output AC timing diagram for IFC-GPCM, IFC-GASIC interface.

**Figure 3-32.** IFC-GPCM, IFC-GASIC Signals



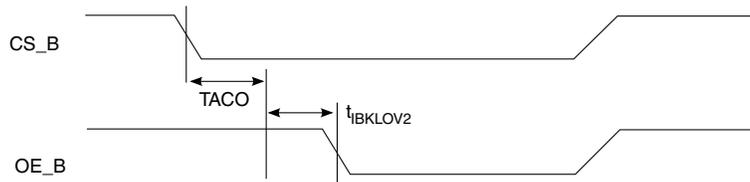
**Table 3-76.** Integrated Flash Controller IFC-NOR Interface output timing specifications ( $OV_{DD} = 1.8V$ )

Parameter	Symbol	Min	Max	Unit	Notes
Output delay	$t_{IBKLOV2}$	–	$\pm 1.5$	ns	1

- Notes:
1. This effectively means that a signal change may appear anywhere within  $\pm t_{IBKLOV2}$  (max) duration, from the point where it's expected to change.
  2. For recommended operating conditions, see [Table 3-2](#)

This figure shows the AC timing diagram for output signals of IFC-NOR interface. The timing specs have been illustrated here by taking timings between two signals, CS\_B and OE\_B as an example. OE\_B is suppose to change TACO (a programmable delay, refer to IFC section of QT1040 QorIQ Integrated Processor Reference Manual for more information) time after CS\_B. Because of skew between the signals, OE\_B may change anywhere within time window  $t_{IBKLOV2}$  (min) and  $t_{IBKLOV2}$  (max). This concept applies to other output signals of IFC-NOR interface as well. The diagram is an example to show the skew between any two chronological toggling signals as per the protocol. Here is the list of IFC-NOR output signals NRALE, NRAVD\_B, NRWE\_B, NROE\_B, CS\_B, AD(Address phase).

**Figure 3-33.** IFC-NOR Interface Output AC Timings



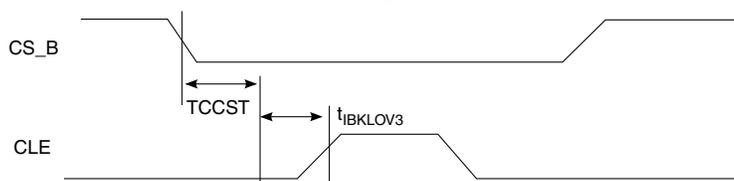
**Table 3-77.** Integrated Flash Controller IFC-NAND Interface output timing specifications ( $OV_{DD} = 1.8V$ )

Parameter	Symbol	Min	Max	Unit	Notes
Output delay	$t_{IBKLOV3}$	–	$\pm 1.5$	ns	1

- Notes:
1. This effectively means that a signal change may appear anywhere within  $t_{IBKLOV3}$  (min) to  $t_{IBKLOV3}$  (max) duration, from the point where it's expected to change.
  2. For recommended operating conditions, see [Table 3-2](#)

This figure shows the AC timing diagram for output signals of IFC-NAND interface. The timing specs have been illustrated here by taking timings between two signals, CS\_B and CLE as an example. CLE is suppose to change TCCST (a programmable delay, refer to IFC section of QT1040 QorIQ Integrated Processor Reference Manual for more information) time after CS\_B. Because of skew between the signals CLE may change anywhere within time window  $t_{IBKLOV3}$  (min) and  $t_{IBKLOV3}$  (max). This concept applies to other output signals of IFC-NAND interface as well. The diagram is an example to show the skew between any two chronological toggling signals as per the protocol. Here is the list of output signals NDWE\_B, NDRE\_B, NDALE, WP\_B, NDCLE, CS\_B, AD.

**Figure 3-34.** IFC-NAND Interface Output AC Timings



# QT1040/QT1020 4GB

## 3.14.2.4 Integrated flash controller NAND Source Synchronous Interface AC timing specifications

This table describes the AC timing specifications of IFC-NAND Source Synchronous interface.

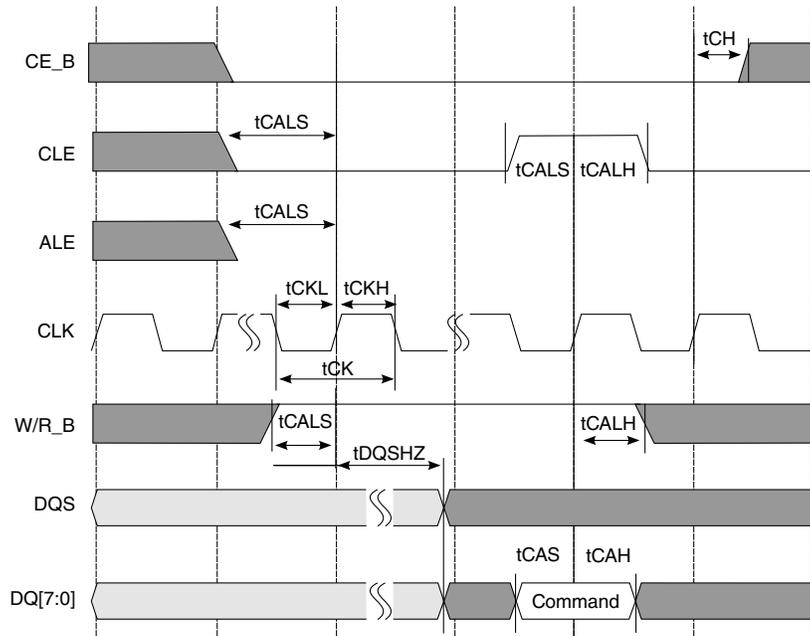
**Table 3-78.** Integrated Flash Controller IFC-NAND Source Synchronous Interface AC Timing Specifications ( $OV_{DD} = 1.8V$ )

Parameter	Symbol	I/O	Min	Max	Unit	Notes
Command/address DQ hold time	$t_{CAH}$	O	2.5	–	ns	–
CLE and ALE hold time	$t_{CALH}$	O	2.5	–	ns	–
CLE and ALE setup time	$t_{CALS}$	O	2.5	–	ns	–
Command/address DQ setup time	$t_{CAS}$	O	2.5	–	ns	–
CE# hold time	$t_{CH}$	O	2.5	–	ns	–
Data DQ setup time	$t_{DS}$	O	1	–	ns	–
Data DQ hold time	$t_{DH}$	O	1	–	ns	–
Average clock cycle time	$t_{CK}(avg)$ or $t_{CK}$	O	10	–	ns	(1)
Absolute clock period	$t_{CK}(abs)$	O	9.5	10.5	ns	–
Clock cycle high	$t_{CKH}(abs)$	O	0.44	0.56	$t_{CK}$	(2)
Clock cycle low	$t_{CKL}(abs)$	O	0.44	0.56	$t_{CK}$	–
DQS output high pulse width	$t_{DQSH}$	O	0.43	0.57	$t_{CK}$	(3)
DQS output low pulse width	$t_{DQSL}$	O	0.43	0.57	$t_{CK}$	(3)
DQS-DQ skew, DQS to last DQ valid, per access	$t_{DQSQ}$	I	–	1	ns	–
Data output to first DQS latching transition	$t_{DQSS}$	O	0.75+150(ps)	1.15	$t_{CK}$	–
DQS cycle time	$t_{DSC}$	O	10	–	ns	–
DQS falling edge to CLK rising – hold time	$t_{DSSH}$	O	0.228	–	$t_{CK}$	–
DQS falling edge to CLK rising – setup time	$t_{DSS}$	O	0.3	–	$t_{CK}$	–
Input data valid window	$t_{DVW}$	I	2.1	–	ns	–
Half-clock period	$t_{HP}$	O	4.4	–	ns	–
The deviation of a given $t_{CK}(abs)$ from $t_{CK}(avg)$	$t_{JIT}(per)$	O	–0.5	0.5	ns	–
DQ-DQS hold, DQS to first DQ to go non- valid, per access	$t_{QH}$	I	3.1	–	ns	–

- Notes:
1.  $t_{CK}(avg)$  is the average clock period over any consecutive 200 cycle window.
  2.  $t_{CKH}(abs)$  and  $t_{CKL}(abs)$  include static off set and duty cycle jitter.
  3.  $t_{DQSL}$  and  $t_{DQSH}$  are relative to  $t_{CK}$  when CLK is running. If CLK is stopped during data input, then  $t_{DQSL}$  and  $t_{DQSH}$  are relative to  $t_{DSC}$ .
  4. For recommended operating conditions, see [Table 3-2](#)

These figures show the AC timing diagram for IFC-NAND source synchronous interface.

**Figure 3-35. Command Cycle**



**Figure 3-36. Address Cycle**

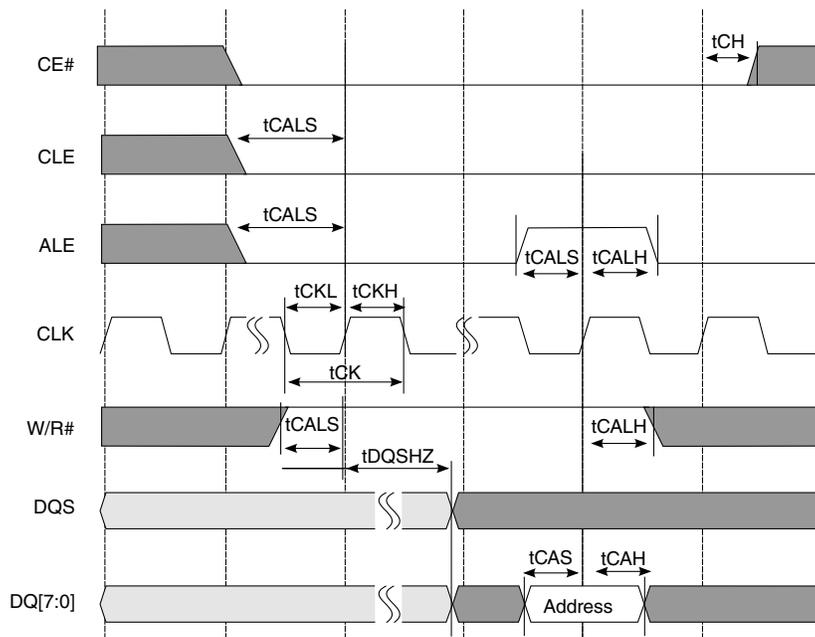


Figure 3-37. Write Cycle

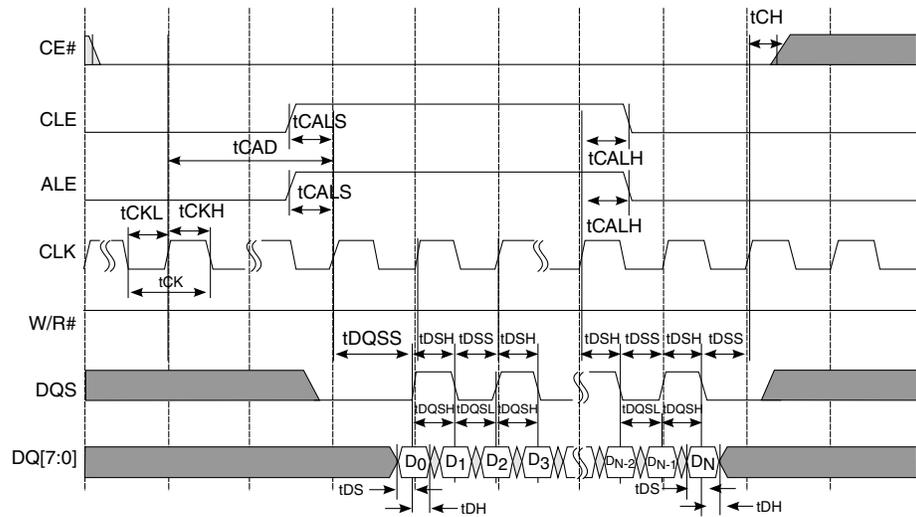
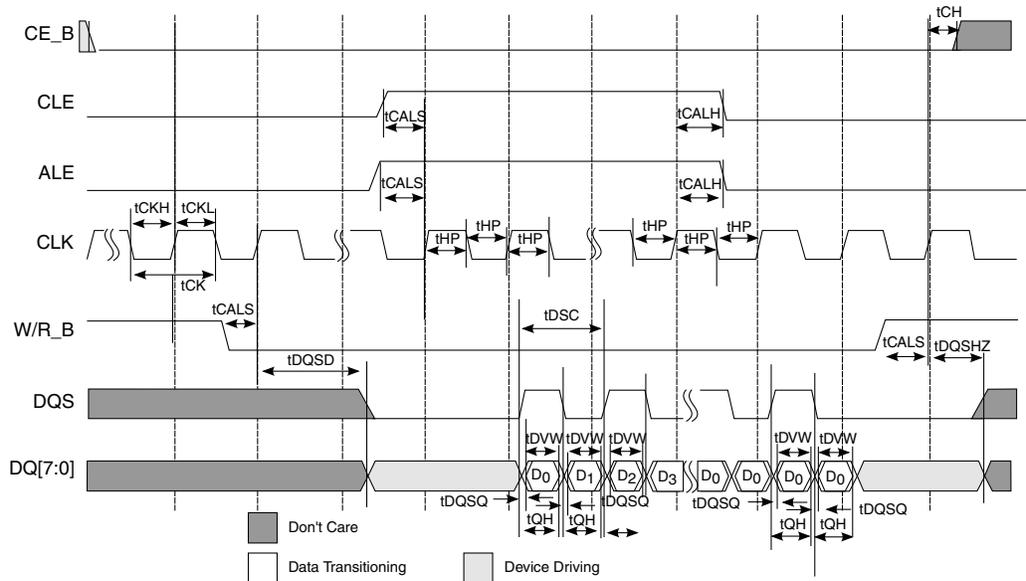


Figure 3-38. Read Cycle



### 3.15 Enhanced secure digital host controller (eSDHC)

This section describes the DC and AC electrical specifications for the eSDHC interface.

#### 3.15.1 eSDHC DC electrical characteristics

This table provides the DC electrical characteristics for the eSDHC interface.

**Table 3-79.** eSDHC interface DC electrical characteristics (dual-voltage cards)<sup>(3)</sup>

Characteristic	Symbol	Condition	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	–	$0.7 \times V_{DD}$	–	V	(1)
Input low voltage	$V_{IL}$	–	–	$0.2 \times V_{DD}$	V	(1)
Input/Output leakage current	$I_{IN}/I_{OZ}$	–	–50	50	$\mu A$	–
Output high voltage	$V_{OH}$	$I_{OH} = -100 \mu A$ at $V_{DD}$ min	$V_{DD} - 0.2V$	–	V	–
Output low voltage	$V_{OL}$	$I_{OL} = 100 \mu A$ at $V_{DD}$ min	–	0.2	V	–
Output high voltage	$V_{OH}$	$I_{OH} = -100 \mu A$	$V_{DD} - 0.2$	–	V	(2)
Output low voltage	$V_{OL}$	$I_{OL} = 2$ mA	–	0.3	V	(2)

Notes: 1. The min  $V_{IL}$  and  $V_{IH}$  values are based on the respective min and max  $V_{IN}$  values found in Table 3-2.

2. Open-drain mode is for MMC cards only.

3. For recommended operating conditions, see Table 3-2.

4. SDHC interface is powered by  $EV_{DD}$  and  $CV_{DD}$ . The  $V_{DD}$  and  $V_{IN}$  in the table above should be replaced by the respective IO power supply.

#### 3.15.2 eSDHC AC timing specifications

This table provides the eSDHC AC timing specifications as defined in Figure 3-39 and Figure 3-40 ( $EV_{DD}/CV_{DD} = 1.8V$  or  $3.3V$ ).

**Table 3-80.** eSDHC AC timing specifications (High Speed/Full Speed)<sup>6</sup>

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes	
SDHC_CLK clock frequency	SD/SDIO (full-speed/high-speed mode)	$f_{SCK}$	0	25/50	MHz	2, 4
	MMC full-speed/high-speed mode			20/52		
SDHC_CLK clock low time (full-speed/high-speed mode)	$t_{SCKL}$	10/7	–	ns	4	
SDHC_CLK clock high time (full-speed/high-speed mode)	$t_{SCKH}$	10/7	–	ns	4	
SDHC_CLK clock rise and fall times	$t_{SCKR}/t_{SCKF}$	–	3	ns	4	
Input setup times: SDHC_CMD, SDHC_DATx to SDHC_CLK	$t_{NIIVKH}$	2.5	–	ns	3, 4, 5	
Input hold times: SDHC_CMD, SDHC_DATx to SDHC_CLK	$t_{NIIKKH}$	2.5	–	ns	4, 5	
Output hold time: SDHC_CLK to SDHC_CMD, SDHC_DATx valid	$t_{NIKHOX}$	–3	–	ns	4, 5	
Output delay time: SDHC_CLK to SDHC_CMD, SDHC_DATx valid	$t_{NIKHOV}$	–	3	ns	4, 5	

Notes: 1. The symbols used for timing specifications herein follow the pattern of  $t_{(first\ three\ letters\ of\ functional\ block)(signal)(state)\ (reference)(state)}$  for inputs and  $t_{(first\ three\ letters\ of\ functional\ block)(reference)(state)(signal)(state)}$  for outputs. For example,  $t_{FHSKHOV}$  symbolizes eSDHC high-speed mode device timing (SHS) clock reference (K) going to the high (H) state, with respect to the output (O) reaching the invalid state (X) or output hold time. Note that in general, the clock reference symbol is based on five letters representing the clock of a particular functional. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).

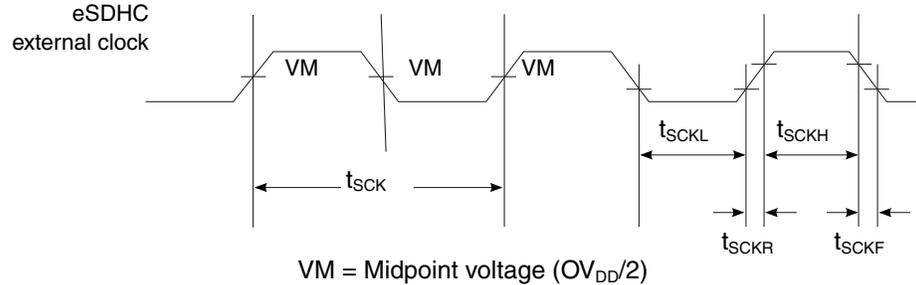
2. In full-speed mode, the clock frequency value can be 0-25 MHz for an SD/SDIO card and 0-20 MHz for an MMC card. In high-speed mode, the clock frequency value can be 0-50 MHz for an SD/SDIO card and 0-52 MHz for an MMC card.

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3. To satisfy setup timing, one-way board-routing delay between Host and Card, on SDHC\_CLK, SDHC\_CMD, and SDHC\_DATx should not exceed 1 ns for any high speed MMC card. For any high speed or default speed mode SD card, the one way board routing delay between Host and Card, on SDHC\_CLK, SDHC\_CMD, and SDHC\_DATx should not exceed 1.5ns.
4.  $C_{CARD} = 10 \text{ pF}$ , (1 card), and  $C_L = C_{BUS} + C_{HOST} + C_{CARD} = 40 \text{ pF}$ .
5. The parameter values apply to both full-speed and high-speed modes.
6. For recommended operating conditions, see [Table 3-2](#)

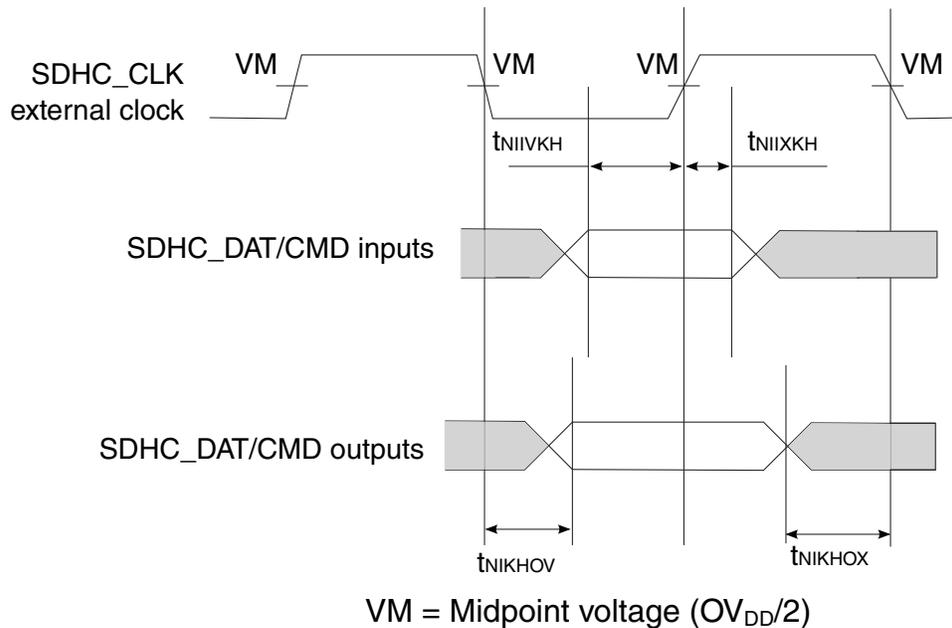
This figure provides the eSDHC clock input timing diagram.

**Figure 3-39.** eSDHC clock input timing diagram



This figure provides the data and command input/output timing diagram.

**Figure 3-40.** eSDHC data and command input/output timing diagram referenced to clock



This table provides the eSDHC AC timing specifications for SDR50 mode ( $E_{V_{DD}}/C_{V_{DD}} = 1.8V$ ).

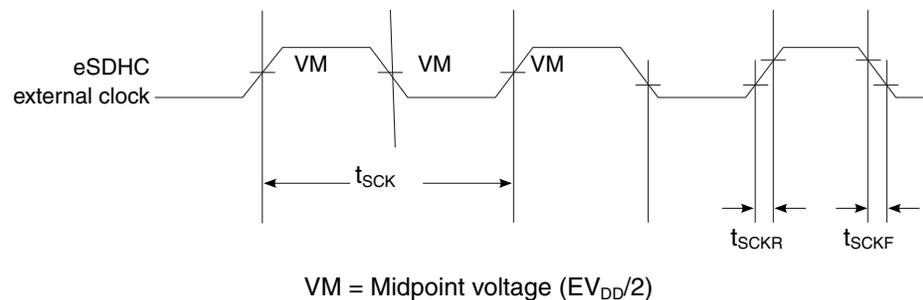
**Table 3-81.** eSDHC AC timing (SDR50)<sup>2</sup>

Parameter	Symbol	Min	Max	Unit	Notes
SDHC_CLK clock frequency:	$f_{SCK}$		100	MHz	
SDHC_CLK duty cycle		47	53	%	
SDHC_CLK clock rise and fall times	$t_{SCKR}/$ $t_{SCKF}$	–	2	ns	1
Skew between SDHC_CLK_SYNC_OUT and SDHC_CLK	–	–0.1	0.1	ns	–
Input setup times: SDHC_CMD, SDHC_DATx to SDHC_CLK_SYNC_IN	$t_{NIIVKH}$	2.1	–	ns	
Input hold times: SDHC_CMD, SDHC_DATx to SDHC_CLK_SYNC_IN	$t_{NIIXKH}$	0.9	–	ns	
Output hold time: SDHC_CLK to SDHC_CMD, SDHC_DATx valid, SDHC_DATx_DIR, SDHC_CMD_DIR	$t_{NIKHOX}$	2.4	–	ns	
Output delay time: SDHC_CLK to SDHC_CMD, SDHC_DATx valid, SDHC_DATx_DIR, SDHC_CMD_DIR	$t_{NIKHOV}$	–	6.3	ns	

Notes: 1.  $C_{CARD} = 10$  pF, (1 card), and  $C_L = C_{BUS} + C_{HOST} + C_{CARD} = 30$  pF.  
 2. For recommended operating conditions, see [Table 3-2](#).

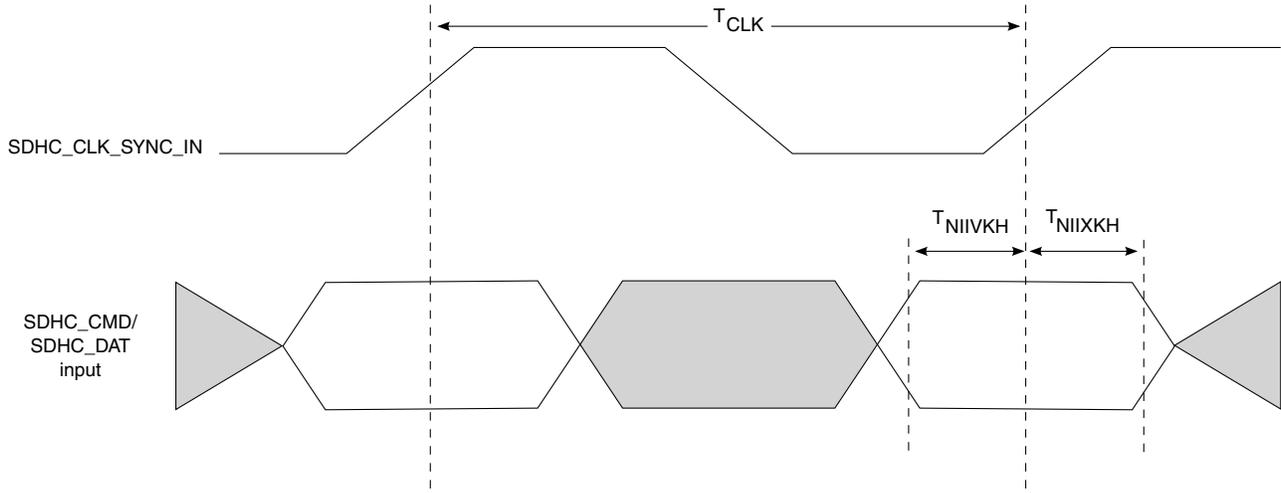
This figure provides the eSDHC clock input timing diagram for SDR50 mode.

**Figure 3-41.** eSDHC SDR50 mode clock input timing diagram



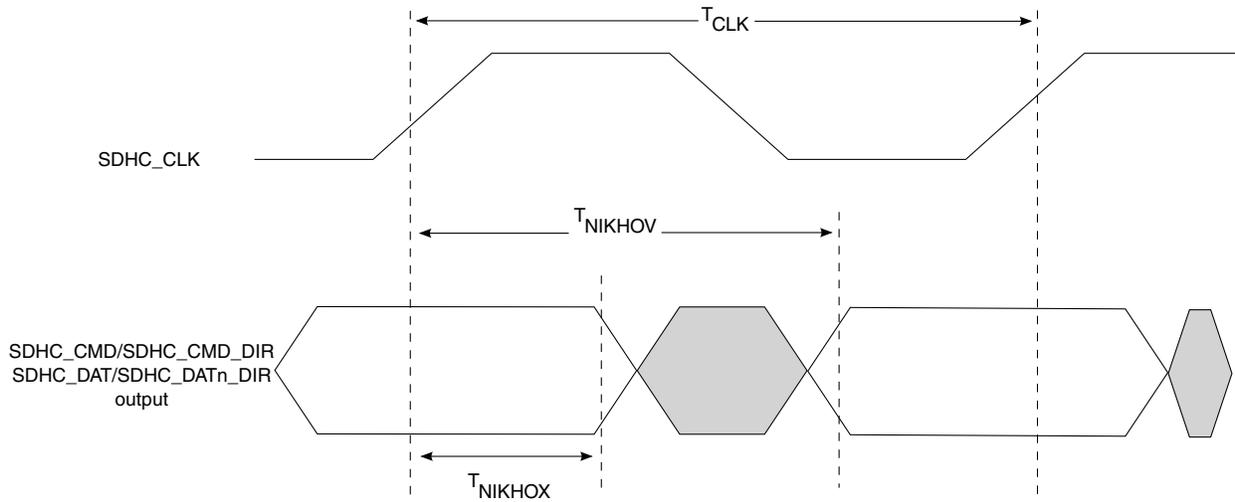
This figure shows the eSDHC input AC timing diagram for SDR50 mode.

**Figure 3-42.** eSDHC SDR50 mode input AC timing diagram



This figure shows the eSDHC output AC timing diagram for SDR50 mode.

**Figure 3-43.** eSDHC SDR50 mode output AC timing diagram



This table provides the eSDHC AC timing specifications for DDR50/eMMC DDR mode ( $EV_{DD}/CV_{DD} = 1.8V$ ).

**Table 3-82.** eSDHC AC timing (DDR50/eMMC DDR)<sup>3</sup>

Parameter		Symbol	Min	Max	Units	Notes
SDHC_CLK clock frequency	SD/SDIO DDR50 mode	$t_{SCK}$	–	50	MHz	–
	eMMC DDR mode			50		
SDHC_CLK duty cycle		–	47	53	%	–
Skew between SDHC_CLK_SYNC_OUT and SDHC_CLK		–	–0.1	0.1	ns	–
SDHC_CLK clock rise and fall times	SD/SDIO DDR50 mode	$t_{SCKR}/$ $t_{SCKF}$	–	4	ns	1
	eMMC DDR mode			2		2
Input setup times: SDHC_DATx to SDHC_CLK_SYNC_IN	SD/SDIO DDR50 mode	$t_{NDIVKH}$	0.5	–	ns	–
	eMMC DDR mode		0.6			
Input hold times: SDHC_DATx to SDHC_CLK_SYNC_IN	SD/SDIO DDR50 mode	$t_{NDIXKH}$	0.98	–	ns	–
	eMMC DDR mode		0.98			
Output hold time: SDHC_CLK to SDHC_DATx valid, SDHC_DATx_DIR	SD/SDIO DDR50 mode	$t_{NDKHOX}$	2.2	–	ns	–
	eMMC DDR mode		3.9			
Output delay time: SDHC_CLK to SDHC_DATx valid, SDHC_DATx_DIR	SD/SDIO DDR50 mode	$t_{NDKHOV}$	–	5.7	ns	–
	eMMC DDR mode			6.3		
Input setup times: SDHC_CMD to SDHC_CLK_SYNC_IN	SD/SDIO DDR50 mode	$t_{NIIVKH}$	3.3	–	ns	–
	eMMC DDR mode		2.7			
Input hold times: SDHC_CMD to SDHC_CLK_SYNC_IN	SD/SDIO DDR50 mode	$t_{NIIXKH}$	0.4	–	ns	–
	eMMC DDR mode		0.4			
Output hold time: SDHC_CLK to SDHC_CMD valid, SDHC_CMD_DIR	SD/SDIO DDR50 mode	$t_{NIKHOX}$	2.2	–	ns	–
	eMMC DDR mode		4.4			
Output delay time: SDHC_CLK to SDHC_CMD valid, SDHC_CMD_DIR	SD/SDIO DDR50 mode	$t_{NIKHOV}$	–	12.2	ns	–
	eMMC DDR mode			14.6		

- Notes: 1.  $C_{CARD} = 10$  pF, (1 card).  
 2.  $C_L = C_{BUS} + C_{HOST} + C_{CARD} = 20$  pF for MMC. 40pF for SD.  
 3. For recommended operating conditions, see [Table 3-2](#).

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This table provides the eSDHC AC timing specifications for eMMC DDR mode ( $EV_{DD}/CV_{DD} = 3.3V$ ).

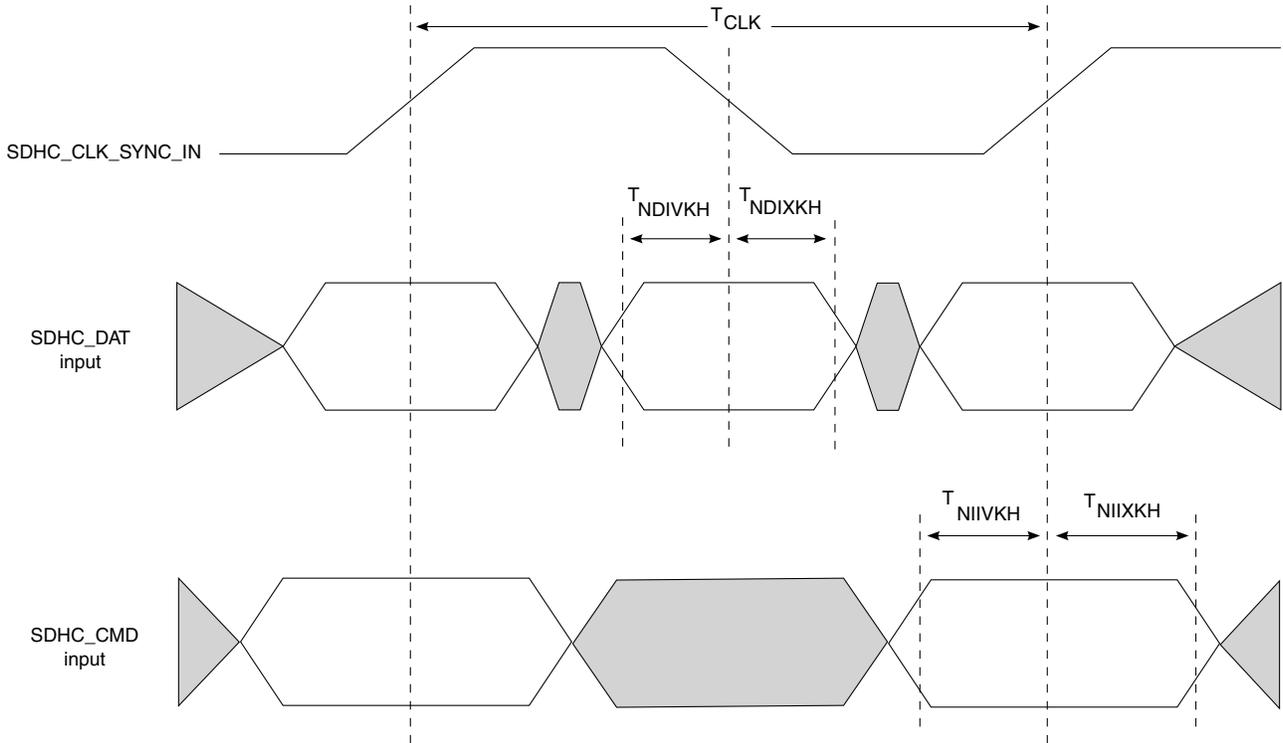
**Table 3-83.** eSDHC AC timing (eMMC DDR)<sup>3</sup>

Parameter		Symbol	Min	Max	Units	Notes
SDHC_CLK clock frequency	eMMC DDR mode	$f_{SCK}$	–	49	MHz	–
SDHC_CLK duty cycle		–	47	53	%	–
Skew between SDHC_CLK_SYNC_OUT and SDHC_CLK		–	–0.1	0.1	ns	–
SDHC_CLK clock rise and fall times	eMMC DDR mode	$t_{SCKR}^/$ $t_{SCKF}$	–	2	ns	2
Input setup times: SDHC_DATx to SDHC_CLK_SYNC_IN	eMMC DDR mode	$t_{NDIVKH}$	1.33	–	ns	–
Input hold times: SDHC_DATx to SDHC_CLK_SYNC_IN	eMMC DDR mode	$t_{NDIXKH}$	1.32	–	ns	4
Output hold time: SDHC_CLK to SDHC_DATx valid, SDHC_DATx_DIR	eMMC DDR mode	$t_{NDKHOX}$	3.9	–	ns	–
Output delay time: SDHC_CLK to SDHC_DATx valid, SDHC_DATx_DIR	eMMC DDR mode	$t_{NDKHOV}$	–	6.3	ns	–
Input setup times: SDHC_CMD to SDHC_CLK_SYNC_IN	eMMC DDR mode	$t_{NIIVKH}$	2.7	–	ns	–
Input hold times: SDHC_CMD to SDHC_CLK_SYNC_IN	eMMC DDR mode	$t_{NIIXKH}$	0.4	–	ns	–
Output hold time: SDHC_CLK to SDHC_CMD valid, SDHC_CMD_DIR	eMMC DDR mode	$t_{NIKHOX}$	4.4	–	ns	–
Output delay time: SDHC_CLK to SDHC_CMD valid, SDHC_CMD_DIR	eMMC DDR mode	$t_{NIKHOV}$	–	14.6	ns	–

- Notes:
1.  $C_{CARD} = 10$  pF, (1 card).
  2.  $C_L = C_{BUS} + C_{HOST} + C_{CARD} = 20$  pF for MMC. 40pF for SD.
  3. For recommended operating conditions, see [Table 3-2](#).
  4. Refer eSDHC A-008936

This figure shows the eSDHC DDR50/eMMC DDR mode input AC timing diagram.

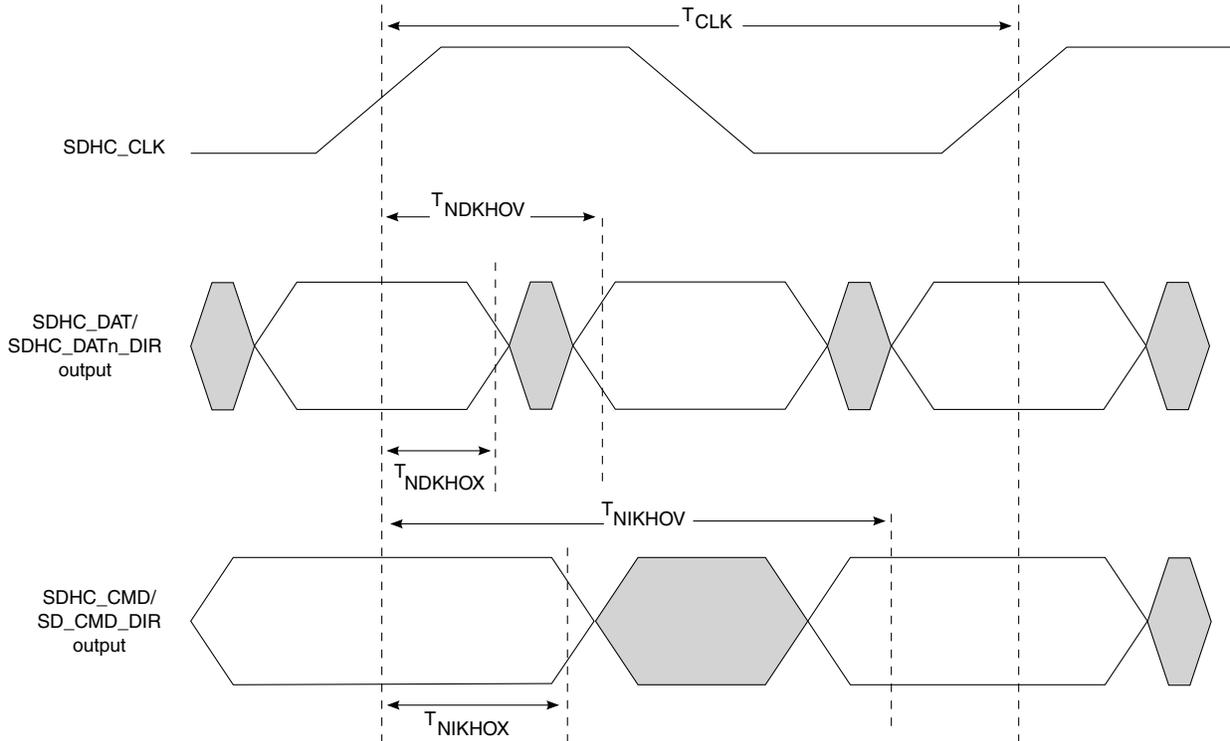
Figure 3-44. eSDHC DDR50/DDR mode input AC timing diagram



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This figure shows the DDR50/eMMC DDR mode output AC timing diagram.

**Figure 3-45.** eSDHC DDR50/DDR mode output AC timing diagram



This table provides the eSDHC AC timing specifications for SDR104/eMMC HS200 mode as defined in [Figure 3-46](#) ( $EV_{DD}/CV_{DD} = 1.8V$ ).

**Table 3-84.** eSDHC AC timing (SDR104/eMMC HS200)

Parameter		Symbol	Min	Max	Units	Notes
SDHC_CLK clock frequency	SD/SDIO SDR104 mode	$f_{SCK}$	–	165	MHz	–
	eMMC HS200 mode			175		
SDHC_CLK duty cycle		–	47	53	%	–
SDHC_CLK clock rise and fall times		$t_{SCKR}^t_{SCKF}$	–	1	ns	1
Output hold time: SDHC_CLK to SDHC_CMD, SDHC DATx valid, SDHC_CMD_DIR, SDHC_DATx_DIR	SD/SDIO SDR104 mode	$t_{NIKHOX}$	1.58	–	ns	–
	eMMC HS200 mode		1.6			
Output delay time: SDHC_CLK to SDHC_CMD, SDHC DATx valid, SDHC_CMD_DIR, SDHC_DATx_DIR	SD/SDIO SDR104	$t_{NIKHOV}$	–	4.15	ns	–
	eMMC HS200 mode			3.9		
Input data window (UI)	SD/SDIO SDR104 mode	$t_{IDV}$	0.5	–	Unit interval	–
	eMMC HS200 mode		0.475			

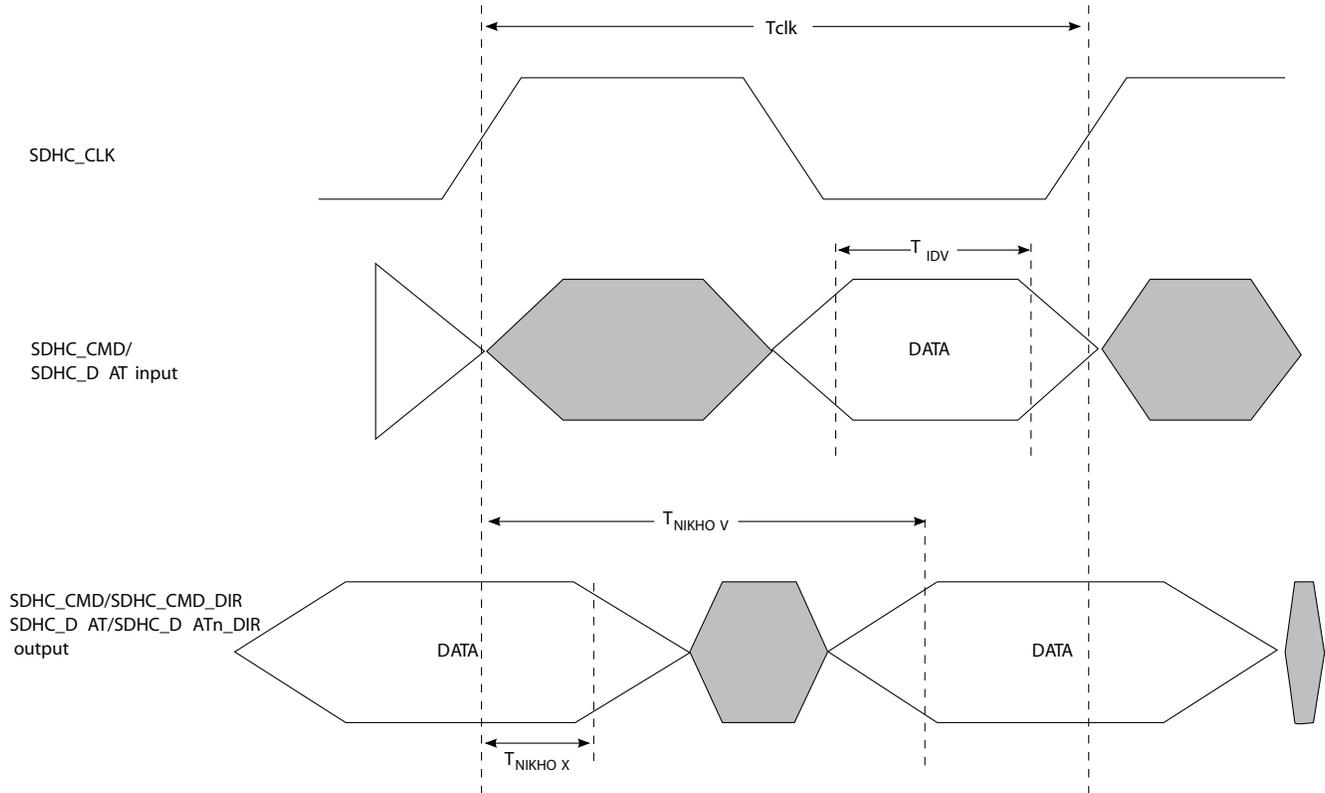
Notes: 1.  $C_L = C_{BUS} + C_{HOST} + C_{CARD} = 10$  pF.

2. For recommended operating conditions, see [Table 3-2](#).

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This figure provides the SDR104/HS200 mode timing diagram.

Figure 3-46. SDR104/eMMC HS200 mode timing diagram



### 3.16 Multicore programmable interrupt controller (MPIC)

This section describes the DC and AC electrical specifications for the multicore programmable interrupt controller.

#### 3.16.1 MPIC DC specifications

These tables provides the DC electrical characteristics for the MPIC interface. IRQ's pins are on L1VDD, O1VDD, DVDD and CVDD power supplies.

Table 3-85. MPIC DC electrical characteristics (O1V<sub>DD</sub> = 1.8V)<sup>3</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	V <sub>IH</sub>	1.2	–	V	1
Input low voltage	V <sub>IL</sub>	–	0.6	V	1
Input current (O1V <sub>IN</sub> = 0V or O1V <sub>IN</sub> = O1V <sub>DD</sub> )	I <sub>IN</sub>	–	±50	µA	2
Output high voltage (O1V <sub>DD</sub> = min, I <sub>OH</sub> = –0.5 mA)	V <sub>OH</sub>	1.35	–	V	–
Output low voltage (O1V <sub>DD</sub> = min, I <sub>OL</sub> = 0.5 mA)	V <sub>OL</sub>	–	0.4	V	–

- Notes:
1. The min V<sub>IL</sub> and max V<sub>IH</sub> values are based on the min and max DV<sub>IN</sub> respective values found in Table 3-2.
  2. The symbol O1V<sub>IN</sub>, in this case, represents the O1V<sub>IN</sub> symbol referenced in Table 3-2.
  3. For recommended operating conditions, see Table 3-2.

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**Table 3-86.** MPIC DC electrical characteristics ( $DV_{DD} = 1.8V$ )<sup>3</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	$0.7 * DV_{DD}$	–	V	1, 4
Input low voltage	$V_{IL}$	–	$0.2 * DV_{DD}$	V	1, 4
Input current ( $DV_{IN} = 0V$ or $DV_{IN} = DV_{DD}$ )	$I_{IN}$	–	$\pm 50$	$\mu A$	2
Output high voltage ( $DV_{DD} = \text{min}$ , $I_{OH} = -0.5 \text{ mA}$ )	$V_{OH}$	1.35	–	V	–
Output low voltage ( $DV_{DD} = \text{min}$ , $I_{OL} = 0.5 \text{ mA}$ )	$V_{OL}$	–	0.4	V	–

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the min and max  $DV_{IN}$  respective values found in [Table 3-2](#).
  2. The symbol  $DV_{IN}$ , in this case, represents the  $DV_{IN}$  symbol referenced in [Table 3-2](#).
  3. For recommended operating conditions, see [Table 3-2](#).
  4.  $DV_{DD}$  should be replaced by the respective IO power supply i.e. L1VDD, DVDD or CVDD.

**Table 3-87.** MPIC DC electrical characteristics ( $DV_{DD} = 2.5V$ )<sup>3</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	$0.7 * DV_{DD}$	–	V	1, 4
Input low voltage	$V_{IL}$	–	$0.2 * DV_{DD}$	V	1, 4
Input current ( $DV_{IN} = 0V$ or $DV_{IN} = DV_{DD}$ )	$I_{IN}$	–	$\pm 50$	$\mu A$	2
Output high voltage ( $DV_{DD} = \text{min}$ , $I_{OH} = -1 \text{ mA}$ )	$V_{OH}$	2.0	–	V	–
Output low voltage ( $DV_{DD} = \text{min}$ , $I_{OL} = 1 \text{ mA}$ )	$V_{OL}$	–	0.4	V	–

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the min and max  $DV_{IN}$  respective values found in [Table 3-2](#).
  2. The symbol  $DV_{IN}$ , in this case, represents the  $DV_{IN}$  symbol referenced in [Table 3-2](#).
  3. For recommended operating conditions, see [Table 3-2](#).
  4.  $DV_{DD}$  should be replaced by the respective IO power supply i.e. L1VDD, DVDD or CVDD.

**Table 3-88.** MPIC DC electrical characteristics ( $DV_{DD} = 3.3V$ )<sup>3</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	$0.7 * DV_{DD}$	–	V	1, 4
Input low voltage	$V_{IL}$	–	$0.2 * DV_{DD}$	V	1, 4
Input current ( $DV_{IN} = 0V$ or $DV_{IN} = DV_{DD}$ )	$I_{IN}$	–	$\pm 40$	$\mu A$	2
Output high voltage ( $DV_{DD} = \text{min}$ , $I_{OH} = -2 \text{ mA}$ )	$V_{OH}$	2.4	–	V	–
Output low voltage ( $DV_{DD} = \text{min}$ , $I_{OL} = 2 \text{ mA}$ )	$V_{OL}$	–	0.4	V	–

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the min and max  $DV_{IN}$  respective values found in [Table 3-2](#).
  2. The symbol  $DV_{IN}$ , in this case, represents the  $DV_{IN}$  symbol referenced in [Table 3-2](#).
  3. For recommended operating conditions, see [Table 3-2](#).
  4.  $DV_{DD}$  should be replaced by the respective IO power supply i.e. L1VDD, DVDD or CVDD.

### 3.16.2 MPIC AC timing specifications

This table provides the MPIC input and output AC timing specifications.

**Table 3-89.** MPIC Input AC timing specifications<sup>2</sup>

Characteristic	Symbol	Min	Max	Unit	Notes
MPIC inputs-minimum pulse width	$t_{PIWID}$	3	–	SYSCCLKs	1, 3

- Notes:
1. MPIC inputs and outputs are asynchronous to any visible clock. MPIC outputs must be synchronized before use by any external synchronous logic. MPIC inputs are required to be valid for at least  $t_{PIWID}$  ns to ensure proper operation when working in edge triggered mode.
  2. For recommended operating conditions, see [Table 3-2](#).
  3. Entry and exit from deep sleep respectively require a minimum pulse width  $t_{PIWID}$  of 25 SYSCCLK. See the Reference Manual for details on Entry and Exit from deep sleep.

### 3.17 JTAG controller

This section describes the DC and AC electrical specifications for the IEEE 1149.1 (JTAG) interface.

#### 3.17.1 JTAG DC electrical characteristics

This table provides the JTAG DC electrical characteristics.

**Table 3-90.** JTAG DC electrical characteristics ( $OV_{DD} = 1.8V$ )<sup>3</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	1.2	–	V	1
Input low voltage	$V_{IL}$	–	0.6	V	1
Input current ( $OV_{IN} = 0V$ or $OV_{IN} = OV_{DD}$ )	$I_{IN}$	–	$\pm 50$	$\mu A$	2
Output high voltage ( $OV_{DD} = \text{min}$ , $I_{OH} = -0.5 \text{ mA}$ )	$V_{OH}$	1.35	–	V	–
Output low voltage ( $OV_{DD} = \text{min}$ , $I_{OL} = 0.5 \text{ mA}$ )	$V_{OL}$	–	0.4	V	–

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the respective min and max  $OV_{IN}$  values found in [Table 3-2](#).
  2. The symbol  $V_{IN}$ , in this case, represents the  $OV_{IN}$  symbol found in [Table 3-2](#).
  3. For recommended operating conditions, see [Table 3-2](#).

## 3.17.2 JTAG AC timing specifications

This table provides the JTAG AC timing specifications as defined in [Figure 3-47](#) through [Figure 3-50](#).

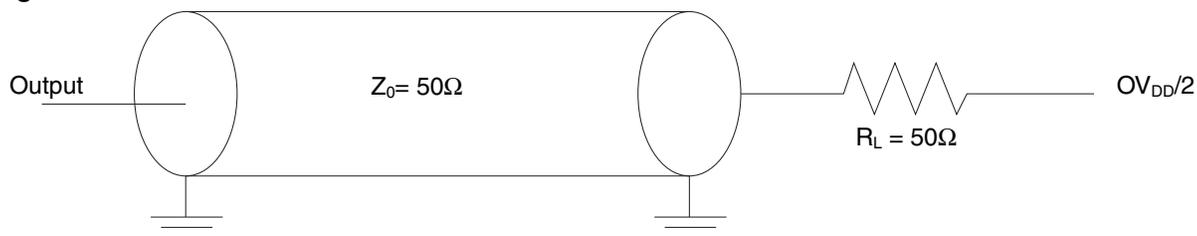
**Table 3-91.** JTAG AC timing specifications<sup>4</sup>

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
JTAG external clock frequency of operation	$f_{JTG}$	0	25	MHz	–
JTAG external clock cycle time	$t_{JTG}$	40	–	ns	–
JTAG external clock pulse width measured at 1.4V	$t_{JKHKL}$	15	–	ns	–
JTAG external clock rise and fall times	$t_{JGR}/t_{JGF}$	0	2	ns	–
TRST_B assert time	$t_{TRST}$	25	–	ns	2
Input setup times	$t_{JDVKH}$	7.5	–	ns	–
Input hold times	$t_{JDXKH}$	10	–	ns	–
Output valid times	$t_{JKLDV}$			ns	3
Boundary-scan data		–	15		
TDO		–	10		
Output hold times	$t_{JKLDX}$	0	–	ns	3

- Notes:
- The symbols used for timing specifications follow the pattern  $t_{(\text{first two letters of functional block})(\text{signal})(\text{state})(\text{reference})(\text{state})}$  for inputs and  $t_{(\text{first two letters of functional block})(\text{reference})(\text{state})(\text{signal})(\text{state})}$  for outputs. For example,  $t_{JDVKH}$  symbolizes JTAG device timing (JT) with respect to the time data input signals (D) reaching the valid state (V) relative to the  $t_{JTG}$  clock reference (K) going to the high (H) state or setup time. Also,  $t_{JDXKH}$  symbolizes JTAG timing (JT) with respect to the time data input signals (D) reaching the invalid state (X) relative to the  $t_{JTG}$  clock reference (K) going to the high (H) state. Note that in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
  - TRST\_B is an asynchronous level sensitive signal. The setup time is for test purposes only.
  - All outputs are measured from the midpoint voltage of the falling edge of  $t_{TCLK}$  to the midpoint of the signal in question. The output timings are measured at the pins. All output timings assume a purely resistive 50-Ω load. Time-of-flight delays must be added for trace lengths, vias, and connectors in the system.
  - For recommended operating conditions, see [Table 3-2](#).

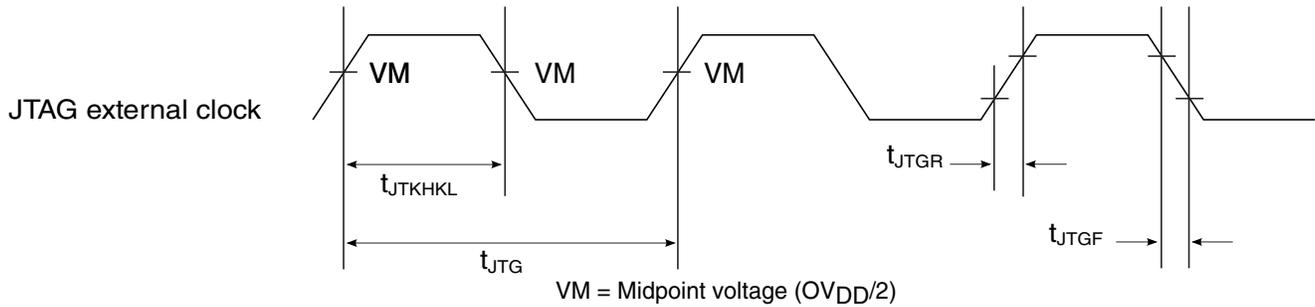
This figure provides the AC test load for TDO and the boundary-scan outputs of the device.

**Figure 3-47.** AC test load for the JTAG interface



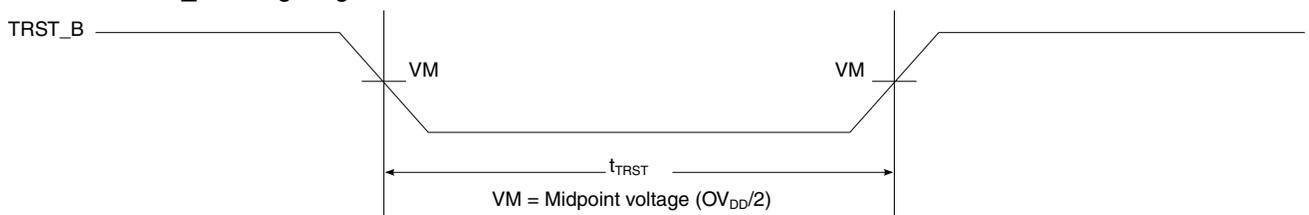
This figure provides the JTAG clock input timing diagram.

**Figure 3-48.** JTAG clock input timing diagram



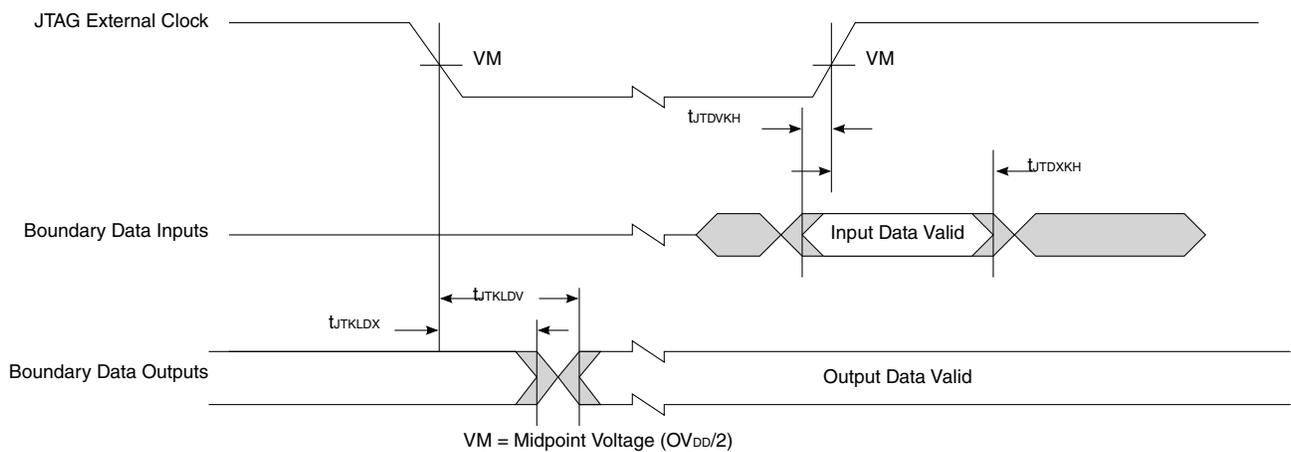
This figure provides the TRST\_B timing diagram.

**Figure 3-49.** TRST\_B timing diagram



This figure provides the boundary-scan timing diagram.

**Figure 3-50.** Boundary-scan timing diagram



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## 3.18 I<sup>2</sup>C interface

This section describes the DC and AC electrical characteristics for the I<sup>2</sup>C interface.

### 3.18.1 I<sup>2</sup>C DC electrical characteristics

This table provides the DC electrical characteristics for the I<sup>2</sup>C interfaces operating at 3.3V.

**Table 3-92.** I<sup>2</sup>C DC electrical characteristics (DV<sub>DD</sub> = 3.3V)<sup>5</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	V <sub>IH</sub>	0.7 * DVDD	–	V	1
Input low voltage	V <sub>IL</sub>	–	0.2 * DVDD	V	1
Output low voltage (I <sub>OL</sub> = 3.0 mA)	V <sub>OL</sub>	–	0.4	V	–
Pulse width of spikes which must be suppressed by the input filter	t <sub>I2KHKL</sub>	0	50	ns	3
Input current each I/O pin (input voltage is between 0.1 × DV <sub>DD</sub> and 0.9 × DV <sub>DD</sub> (max))	I <sub>I</sub>	–50	50	μA	4
Capacitance for each I/O pin	C <sub>I</sub>	–	10	pF	–

- Notes:
1. The min V<sub>IL</sub> and max V<sub>IH</sub> values are based on the respective min and max DV<sub>IN</sub> values found in [Table 3-2](#).
  2. See the chip reference manual for information about the digital filter used.
  3. I/O pins obstruct the SDA and SCL lines if DV<sub>DD</sub> is switched off.
  4. For recommended operating conditions, see [Table 3-2](#).

This table provides the DC electrical characteristics for the I<sup>2</sup>C interfaces operating at 2.5V.

**Table 3-93.** I<sup>2</sup>C DC electrical characteristics (DV<sub>DD</sub> = 2.5V)<sup>5</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	V <sub>IH</sub>	0.7 * DVDD	–	V	1
Input low voltage	V <sub>IL</sub>	–	0.2 * DVDD	V	1
Output low voltage (DV <sub>DD</sub> = min, I <sub>OL</sub> = 3 mA)	V <sub>OL</sub>	0	0.4	V	–
Pulse width of spikes which must be suppressed by the input filter	t <sub>I2KHKL</sub>	0	50	ns	3
Input current each I/O pin (input voltage is between 0.1 × DV <sub>DD</sub> and 0.9 × DV <sub>DD</sub> (max))	I <sub>I</sub>	–50	50	μA	4
Capacitance for each I/O pin	C <sub>I</sub>	–	10	pF	–

- Notes:
1. The min V<sub>IL</sub> and max V<sub>IH</sub> values are based on the respective min and max DV<sub>IN</sub> values found in [Table 3-2](#).
  2. See the chip reference manual for information about the digital filter used.
  3. I/O pins obstruct the SDA and SCL lines if DV<sub>DD</sub> is switched off.
  4. For recommended operating conditions, see [Table 3-2](#).

This table provides the DC electrical characteristics for the I<sup>2</sup>C interfaces operating at 1.8V.

**Table 3-94.** I<sup>2</sup>C DC electrical characteristics (DV<sub>DD</sub> = 1.8V)<sup>5</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	V <sub>IH</sub>	0.7 * DVDD	–	V	1
Input low voltage	V <sub>IL</sub>	–	0.2 * DVDD	V	1
Output low voltage (DV <sub>DD</sub> = min, I <sub>OL</sub> = 3 mA)	V <sub>OL</sub>	0	0.36	V	–
Pulse width of spikes which must be suppressed by the input filter	t <sub>12KHKL</sub>	0	50	ns	3
Input current each I/O pin (input voltage is between 0.1 × DV <sub>DD</sub> and 0.9 × DV <sub>DD</sub> (max))	I <sub>I</sub>	–50	50	μA	4
Capacitance for each I/O pin	C <sub>I</sub>	–	10	pF	–

Notes: 1. The min V<sub>IL</sub> and max V<sub>IH</sub> values are based on the respective min and max DV<sub>IN</sub> values found in Table 3-2.  
 2. See the chip reference manual for information about the digital filter used.  
 3. I/O pins obstruct the SDA and SCL lines if DV<sub>DD</sub> is switched off.  
 4. For recommended operating conditions, see Table 3-2.

### 3.18.2 I<sup>2</sup>C AC timing specifications

This table provides the AC timing parameters for the I<sup>2</sup>C interfaces.

**Table 3-95.** I<sup>2</sup>C AC timing specifications<sup>5</sup>

Parameter	Symbol <sup>1</sup>	Min	Max	Unit	Notes
SCL clock frequency	f <sub>12C</sub>	0	400	kHz	2
Low period of the SCL clock	t <sub>12CL</sub>	1.3	–	μs	–
High period of the SCL clock	t <sub>12CH</sub>	0.6	–	μs	–
Setup time for a repeated START condition	t <sub>12SVKH</sub>	0.6	–	μs	–
Hold time (repeated) START condition (after this period, the first clock pulse is generated)	t <sub>12SXKL</sub>	0.6	–	μs	–
Data setup time	t <sub>12DVKH</sub>	100	–	ns	–
Data input hold time:	t <sub>12DXKL</sub>			μs	3
CBUS compatible masters I <sup>2</sup> C bus devices		– 0	– –		
Data output delay time	t <sub>12OVKL</sub>	–	0.9	μs	4
Setup time for STOP condition	t <sub>12PVKH</sub>	0.6	–	μs	–
Bus free time between a STOP and START condition	t <sub>12KHDX</sub>	1.3	–	μs	–
Noise margin at the LOW level for each connected device (including hysteresis)	V <sub>NL</sub>	0.1 × OV <sub>DD</sub>	–	V	–
Noise margin at the HIGH level for each connected device (including hysteresis)	V <sub>NH</sub>	0.2 × OV <sub>DD</sub>	–	V	–
Capacitive load for each bus line	C <sub>b</sub>	–	400	pF	–

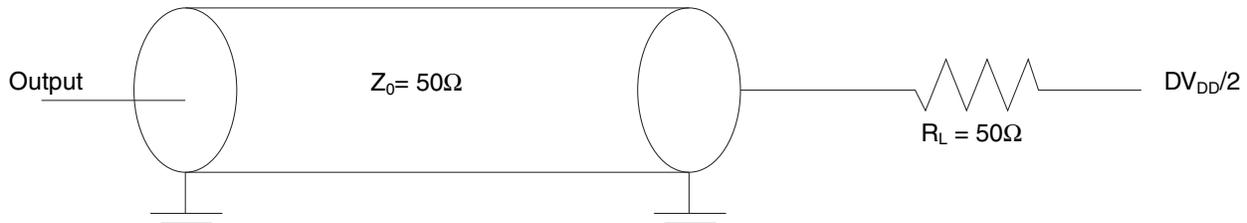
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- Notes:
1. The symbols used for timing specifications herein follow the pattern  $t_{(\text{first two letters of functional block})(\text{signal})(\text{state})(\text{reference})(\text{state})}$  for inputs and  $t_{(\text{first two letters of functional block})(\text{reference})(\text{state})(\text{signal})(\text{state})}$  for outputs. For example,  $t_{I2DVKH}$  symbolizes I<sup>2</sup>C timing (I2) with respect to the time data input signals (D) reaching the valid state (V) relative to the  $t_{I2C}$  clock reference (K) going to the high (H) state or setup time. Also,  $t_{I2SXKL}$  symbolizes I<sup>2</sup>C timing (I2) for the time that the data with respect to the START condition (S) went invalid (X) relative to the  $t_{I2C}$  clock reference (K) going to the low (L) state or hold time. Also,  $t_{I2PVKH}$  symbolizes I<sup>2</sup>C timing (I2) for the time that the data with respect to the STOP condition (P) reaches the valid state (V) relative to the  $t_{I2C}$  clock reference (K) going to the high (H) state or setup time.
  2. The requirements for I<sup>2</sup>C frequency calculation must be followed. See *Determining the I<sup>2</sup>C Frequency Divider Ratio for SCL* (AN2919).
  3. As a transmitter, the chip provides a delay time of at least 300 ns for the SDA signal (referred to the  $V_{IHmin}$  of the SCL signal) to bridge the undefined region of the falling edge of SCL to avoid unintended generation of a START or STOP condition. When the chip acts as the I<sup>2</sup>C bus master while transmitting, it drives both SCL and SDA. As long as the load on SCL and SDA are balanced, the chip does not generate an unintended START or STOP condition. Therefore, the 300 ns SDA output delay time is not a concern. If, under some rare condition, the 300 ns SDA output delay time is required for the chip as transmitter, see *Determining the I<sup>2</sup>C Frequency Divider Ratio for SCL* (AN2919).
  4. The maximum  $t_{I2OVKL}$  has to be met only if the device does not stretch the LOW period ( $t_{I2CL}$ ) of the SCL signal.
  5. For recommended operating conditions, see [Table 3-2](#).

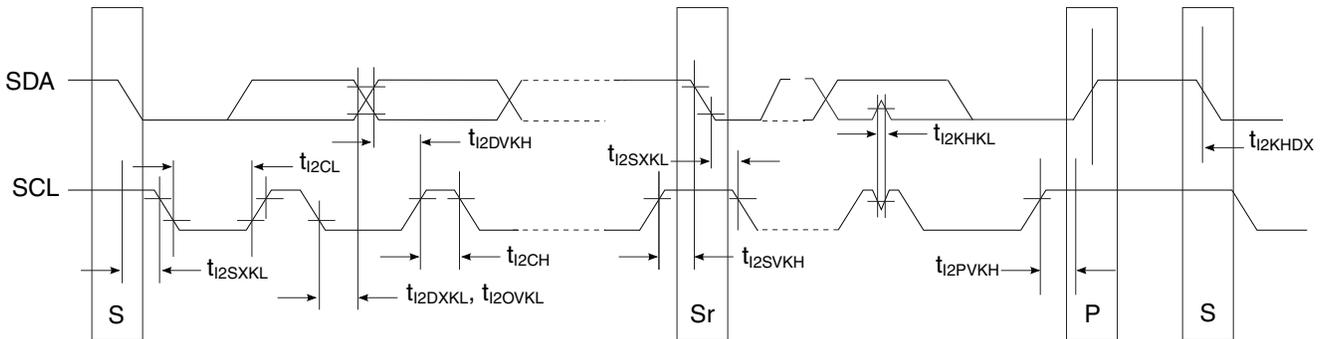
This figure provides the AC test load for the I<sup>2</sup>C.

**Figure 3-51.** I<sup>2</sup>C AC test load



This figure shows the AC timing diagram for the I<sup>2</sup>C bus.

**Figure 3-52.** I<sup>2</sup>C Bus AC timing diagram



### 3.19 GPIO interface

This section describes the DC and AC electrical characteristics for the GPIO interface. GPIO pins are on OVDD, O1VDD, DVDD, CVDD, EVDD, L1VDD and LVDD power supplies.

#### 3.19.1 GPIO DC electrical characteristics

This table provides the DC electrical characteristics for GPIO pins operating at 3.3V. GPIO pins on DVDD, CVDD, EVDD, L1VDD and LVDD power supplies.

**Table 3-96.** GPIO DC electrical characteristics (3.3V)<sup>3</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	0.7 * DVDD	–	V	1, 4
Input low voltage	$V_{IL}$	–	0.2 * DVDD	V	1, 4
Input current ( $V_{IN} = 0V$ or $V_{IN} = DV_{DD}$ )	$I_{IN}$	–	±50	µA	2
Output high voltage ( $DV_{DD} = \text{min}$ , $I_{OH} = -2 \text{ mA}$ )	$V_{OH}$	2.4	–	V	–
Output low voltage ( $DV_{DD} = \text{min}$ , $I_{OL} = 2 \text{ mA}$ )	$V_{OL}$	–	0.4	V	–

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the respective min and max  $DV_{IN}$  values found in [Table 3-2](#)
  2. The symbol  $V_{IN}$ , in this case, represents the  $DV_{IN}$  symbol referenced in [Recommended operating conditions](#).
  3. For recommended operating conditions, see [Table 3-2](#).
  4. DVDD should be replaced by the respective IO power supply i.e. L1VDD, LVDD, EVDD or CVDD.

This table provides the DC electrical characteristics for GPIO pins operating at 2.5V. GPIO pins on DVDD, CVDD, EVDD, L1VDD and LVDD power supplies.

**Table 3-97.** GPIO DC electrical characteristics (2.5V)<sup>3</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	0.7 * DVDD	–	V	1, 4
Input low voltage	$V_{IL}$	–	0.2 * DVDD	V	1, 4
Input current ( $V_{IN} = 0V$ or $V_{IN} = DV_{DD}$ )	$I_{IN}$	–	±50	µA	2
Output high voltage ( $DV_{DD} = \text{min}$ , $I_{OH} = -1 \text{ mA}$ )	$V_{OH}$	2.0	–	V	–
Output low voltage ( $DV_{DD} = \text{min}$ , $I_{OL} = 1 \text{ mA}$ )	$V_{OL}$	–	0.4	V	–

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the respective min and max  $LV_{IN}$  values found in [Table 3-2](#)
  2. The symbol  $V_{IN}$ , in this case, represents the  $LV_{IN}$  symbol referenced in [Recommended operating conditions](#).
  3. For recommended operating conditions, see [Table 3-2](#).
  4. DVDD should be replaced by the respective IO power supply i.e. L1VDD, LVDD, EVDD or CVDD.

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This table provides the DC electrical characteristics for GPIO pins operating at 1.8V. GPIO pins on DVDD, CVDD, EVDD, L1VDD and LVDD power supplies.

**Table 3-98.** GPIO DC electrical characteristics (1.8V)<sup>3</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	0.7 * DVDD	–	V	1, 4
Input low voltage	$V_{IL}$	–	0.2 * DVDD	V	1, 4
Input current ( $V_{IN} = 0V$ or $V_{IN} = DV_{DD}$ )	$I_{IN}$	–	±50	µA	2
Output high voltage ( $DV_{DD} = \text{min}$ , $I_{OH} = -0.5 \text{ mA}$ )	$V_{OH}$	1.35	–	V	–
Output low voltage ( $DV_{DD} = \text{min}$ , $I_{OL} = 0.5 \text{ mA}$ )	$V_{OL}$	–	0.4	V	–

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the respective min and max  $LV_{IN}$  values found in [Table 3-2](#).
  2. The symbol  $V_{IN}$ , in this case, represents the  $LV_{IN}$  symbol referenced in [Recommended operating conditions](#).
  3. For recommended operating conditions, see [Table 3-2](#).
  4. DVDD should be replaced by the respective IO power supply i.e. L1VDD, LVDD, EVDD or CVDD.

This table provides the DC electrical characteristics for GPIO pins operating at  $O1V_{DD}/OV_{DD} = 1.8V$ .

**Table 3-99.** GPIO DC electrical characteristics ( $OV_{DD}/O1V_{DD} = 1.8V$ )<sup>3</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	$V_{IH}$	1.2	–	V	1
Input low voltage	$V_{IL}$	–	0.6	V	1
Input current ( $V_{IN} = 0V$ or $V_{IN} = OV_{DD}$ )	$I_{IN}$	–	±50	µA	2
Output high voltage ( $OV_{DD}/O1V_{DD} = \text{min}$ , $I_{OH} = -0.5 \text{ mA}$ )	$V_{OH}$	1.35	–	V	–
Output low voltage ( $OV_{DD}/O1V_{DD} = \text{min}$ , $I_{OL} = 0.5 \text{ mA}$ )	$V_{OL}$	–	0.4	V	–

- Notes:
1. The min  $V_{IL}$  and max  $V_{IH}$  values are based on the respective min and max  $LV_{IN}$  values found in [Table 3-2](#).
  2. The symbol  $V_{IN}$ , in this case, represents the  $OV_{IN}/O1V_{IN}$  symbol referenced in [Recommended operating conditions](#).
  3. For recommended operating conditions, see [Table 3-2](#).

### 3.19.2 GPIO AC timing specifications

This table provides the GPIO input and output AC timing specifications.

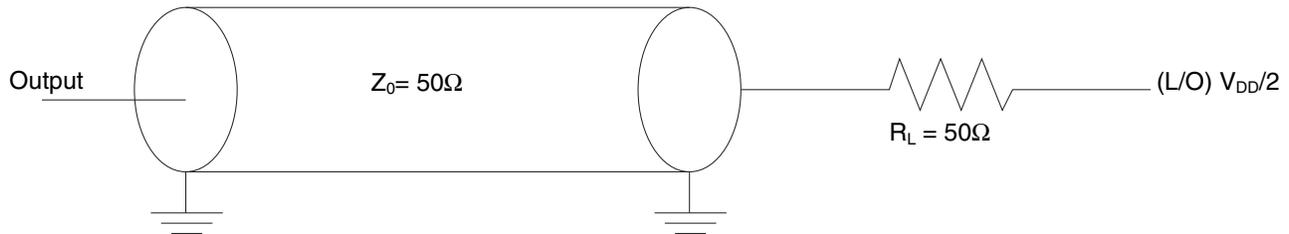
**Table 3-100.** GPIO input AC timing specifications<sup>2</sup>

Parameter	Symbol	Min	Unit	Notes
GPIO inputs–minimum pulse width	$t_{PIWID}$	20	ns	1, 3

- Notes:
1. GPIO inputs and outputs are asynchronous to any visible clock. GPIO outputs should be synchronized before use by any external synchronous logic. GPIO inputs are required to be valid for at least  $t_{PIWID}$  to ensure proper operation.
  2. For recommended operating conditions, see [Table 3-2](#).
  3. Entry and exit from deep sleep respectively require a minimum pulse width  $t_{PIWID}$  of 35 SYSCLK. See the Reference Manual for details on Entry and Exit from deep sleep.

This figure provides the AC test load for the GPIO.

Figure 3-53. GPIO AC test load



### 3.20 Display interface unit

This section describes the DIU DC and AC electrical characteristics.

#### 3.20.1 DIU DC electrical characteristics

This table provides the DIU DC electrical characteristics.

Table 3-101. DIU DC electrical characteristics (3.3V)<sup>1</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Output high voltage ( $DV_{DD} = \text{min}$ , $I_{OH} = -2 \text{ mA}$ )	$V_{OH}$	2.4	–	V	–
Output low voltage ( $DV_{DD} = \text{min}$ , $I_{OL} = 2 \text{ mA}$ )	$V_{OL}$	–	0.4	V	–

Note: 1. For recommended operating conditions, see Table 3-2.

#### 3.20.2 DIU AC timing specifications

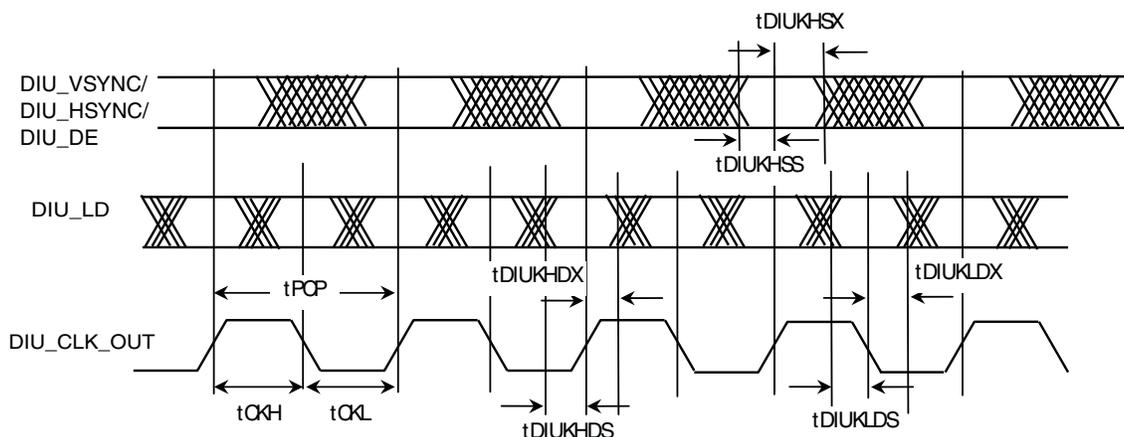
The table provides the output AC timing specifications for DIU interface.

Table 3-102. DIU interface timing parameters

Parameter	Symbol	Min	Typ	Max	Unit
Display pixel clock period	$t_{PCP}$	6.67	–	–	ns
Display pixel clock high time	$t_{CKH}$	$0.45 \times t_{PCP}$	$0.5 \times t_{PCP}$	$0.55 \times t_{PCP}$	ns
LCD interface pixel clock low time	$t_{CKL}$	$0.45 \times t_{PCP}$	$0.5 \times t_{PCP}$	$0.55 \times t_{PCP}$	ns
Pixel data output setup with respect to pixel clock	$t_{DIUKHDS}$ $t_{DIUKLDS}$	1.2	–	–	ns
Pixel data output hold with respect to pixel clock	$t_{DIUKHDX}$ $t_{DIUKLDX}$	1.2	–	–	ns
VSYNC/ HSYNC/ DE output setup respect to pixel clock	$t_{DIUKHSS}$	1.2	–	–	ns
VSYNC/ HSYNC/ DE output hold respect to pixel clock	$t_{DIUKHSX}$	3.8	–	–	ns

Note: 1. Display pixel clock frequency must be less than or equal to 1/4 of the platform clock.

Figure 3-54. DIU interface AC timing diagram



### 3.21 TDM interface

This section describes the DC and AC electrical specifications for the TDM interface.

#### 3.21.1 TDM DC Timing Specifications

This table provides the DC electrical characteristics for the TDM interface.

Table 3-103. TDM DC Electrical Characteristics (DV<sub>DD</sub> = 3.3V)<sup>3</sup>

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage	V <sub>IH</sub>	0.7 * DV <sub>DD</sub>	–	V	1
Input low voltage	V <sub>IL</sub>	–	0.2 * DV <sub>DD</sub>	V	1
Input current (DV <sub>IN</sub> = 0V or DV <sub>IN</sub> = DV <sub>DD</sub> )	I <sub>IN</sub>	–	±50	µA	2
Output high voltage (DV <sub>DD</sub> = min, I <sub>OH</sub> = –2 mA)	V <sub>OH</sub>	2.4	–	V	–
Output low voltage (DV <sub>DD</sub> = min, I <sub>OL</sub> = 2 mA)	V <sub>OL</sub>	–	0.4	V	–

- Notes:
1. Note that the min V<sub>IL</sub> and max V<sub>IH</sub> values are based on the respective min and max DV<sub>IN</sub> values found in [Table 3-2](#)
  2. Note that the symbol DV<sub>IN</sub> represents the input voltage of the supply. It is referenced in [Recommended operating conditions](#)
  3. For recommended operating conditions, see [Table 3-2](#)

3.21.2 TDM AC Timing Specifications

This table provides the input and output AC timing specifications for the TDM interface.

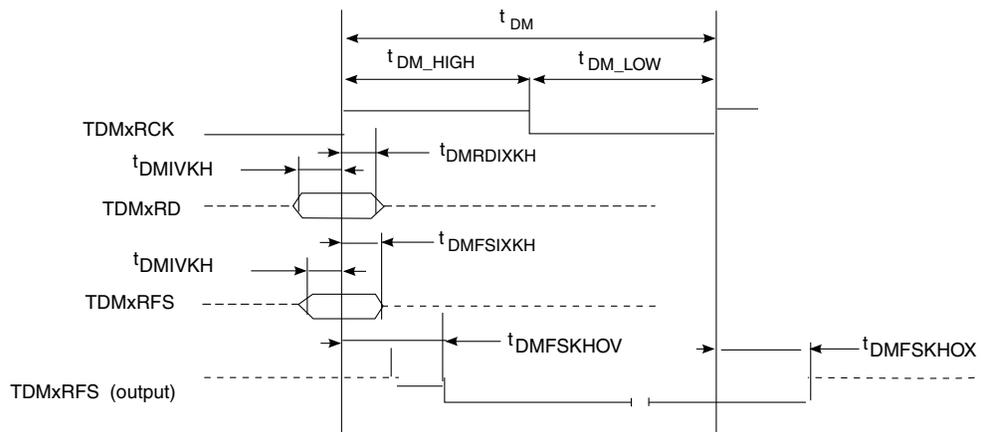
Table 3-104. TDM AC Timing Specifications for 50 MHz<sup>1</sup>

Characteristic	Symbol	Min	Max	Unit	Notes
TDM_RXCLK/TDM_TXCLK	$t_{DM}$	20.0	–	ns	–
TDM_RXCLK/TDM_TXCLK high pulse width	$t_{DM\_HIGH}$	8.0	–	ns	–
TDM_RXCLK/TDM_TXCLK low pulse width	$t_{DM\_LOW}$	8.0	–	ns	–
TDM all input setup time	$t_{DMIVKH}$	3.0	–	ns	2
TDM_RXD hold time	$t_{DMRDIXKH}$	3.5	–	ns	–
TDM_TFS/TDM_RFS input hold time	$t_{DMFSIXKH}$	2.0	–	ns	2
TDM_TXCLK high to TDM_TXD output active	$t_{DM\_OUTAC}$	4.0	–	ns	2, 3
TDM_TXCLK high to TDM_TXD output valid	$t_{DMTKHOV}$	–	14.0	ns	2, 3
TDM_TXD hold time	$t_{DMTKHOX}$	2.0	–	ns	–
TDM_TXCLK high to TDM_TXD output high impedance	$t_{DM\_OUTH}$	–	10.0	ns	–
TDM_TFS/TDM_RFS output valid	$t_{DMFSKHOV}$	–	13.5	ns	2
TDM_TFS/TDM_RFS output hold time	$t_{DMFSKHOX}$	2.5	–	ns	2

- Notes:
1. All values are based on a maximum TDM interface frequency of 50 MHz.
  2. The symbols used for timing specifications follow the pattern  $t_{(first\ two\ letters\ of\ functional\ block)(reference)(signal)(state)(reference)\ (state)}$  for inputs and  $t_{(first\ two\ letters\ of\ functional\ block)(reference)(state)(signal)(state)}$  for outputs. For example,  $t_{HIKHOX}$  symbolizes the outputs internal timing (HI) for the time  $t_{serial}$  memory clock reference (K) goes from the high state (H) until outputs (O) are invalid (X).
  3. Inputs are referenced to the sampling that the TDM is programmed to use. Outputs are referenced to the programming edge they are programmed to use. Use of the rising edge or falling edge as a reference is programmable.  $T_{DMxTCK}$  and  $T_{DMxRCK}$  are shown using the rising edge.
  4. Output values are based on 30 pF capacitive load.

This figure shows the TDM receive signal timing.

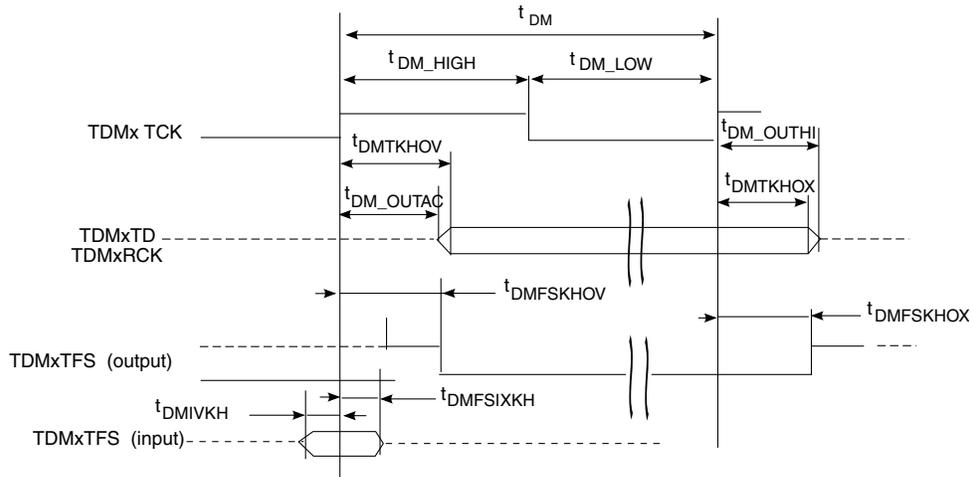
Figure 3-55. TDM Receive Signals



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This figure shows the TDM transmit signal timing.

Figure 3-56. TDM Transmit Signals



3.22 High-speed serial interfaces (HSSI)

The chip features a serializer/deserializer (SerDes) interface to be used for high-speed serial interconnect applications. The SerDes interface can be used for PCI Express, SATA, SGMII and QSGMII data transfers.

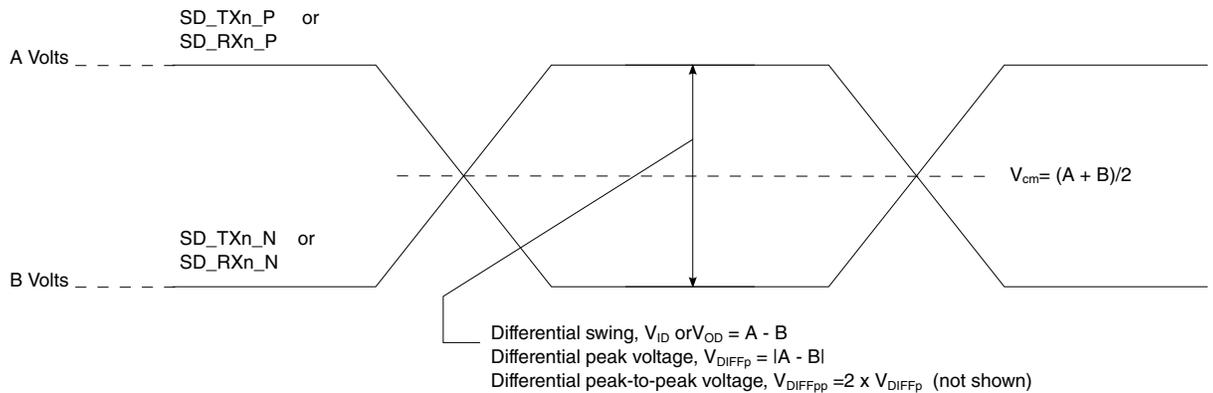
This section describes the common portion of SerDes DC electrical specifications: the DC requirement for SerDes reference clocks. The SerDes data lane's transmitter (Tx) and receiver (Rx) reference circuits are also shown.

3.22.1 Signal terms definition

The SerDes utilizes differential signaling to transfer data across the serial link. This section defines the terms that are used in the description and specification of differential signals.

This figure shows how the signals are defined. For illustration purposes only, one SerDes lane is used in the description. This figure shows the waveform for either a transmitter output (SD\_TXn\_P and SD\_TXn\_N) or a receiver input (SD\_RXn\_P and SD\_RXn\_N). Each signal swings between A volts and B volts where A > B.

Figure 3-57. Differential voltage definitions for transmitter or receiver



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Using this waveform, the definitions are as shown in the following list. To simplify the illustration, the definitions assume that the SerDes transmitter and receiver operate in a fully symmetrical differential signaling environment:

**Single-Ended Swing**

The transmitter output signals and the receiver input signals SD\_TXn\_P, SD\_TXn\_N, SD\_RXn\_P and SD\_RXn\_N each have a peak-to-peak swing of A - B volts. This is also referred as each signal wire's single-ended swing.

**Differential Output Voltage, V<sub>OD</sub> (or Differential Output Swing)**

The differential output voltage (or swing) of the transmitter, V<sub>OD</sub>, is defined as the difference of the two complimentary output voltages: V<sub>SD\_TXn\_P</sub> - V<sub>SD\_TXn\_N</sub>. The V<sub>OD</sub> value can be either positive or negative.

**Differential Input Voltage, V<sub>ID</sub> (or Differential Input Swing)**

The differential input voltage (or swing) of the receiver, V<sub>ID</sub>, is defined as the difference of the two complimentary input voltages: V<sub>SD\_RXn\_P</sub> - V<sub>SD\_RXn\_N</sub>. The V<sub>ID</sub> value can be either positive or negative.

**Differential Peak Voltage, V<sub>DIFFp</sub>**

The peak value of the differential transmitter output signal or the differential receiver input signal is defined as the differential peak voltage, V<sub>DIFFp</sub> = |A - B| volts.

**Differential Peak-to-Peak, V<sub>DIFFp-p</sub>**

Since the differential output signal of the transmitter and the differential input signal of the receiver each range from A - B to -(A - B) volts, the peak-to-peak value of the differential transmitter output signal or the differential receiver input signal is defined as differential peak-to-peak voltage, V<sub>DIFFp-p</sub> = 2 × V<sub>DIFFp</sub> = 2 × |(A - B)| volts, which is twice the differential swing in amplitude, or twice of the differential peak. For example, the output differential peak-to-peak voltage can also be calculated as V<sub>TX-DIFFp-p</sub> = 2 × |V<sub>OD</sub>|.

**Differential Waveform**

The differential waveform is constructed by subtracting the inverting signal (SD\_TXn\_N, for example) from the non-inverting signal (SD\_TXn\_P, for example) within a differential pair. There is only one signal trace curve in a differential waveform. The voltage represented in the differential waveform is not referenced to ground. See [Figure 3-62](#) as an example for differential waveform.

**Common Mode Voltage, V<sub>cm</sub>**

The common mode voltage is equal to half of the sum of the voltages between each conductor of a balanced interchange circuit and ground. In this example, for SerDes output, V<sub>cm\_out</sub> = (V<sub>SD\_TXn\_P</sub> + V<sub>SD\_TXn\_N</sub>) / 2 = (A + B) / 2, which is the arithmetic mean of the two complimentary output voltages within a differential pair. In a system, the common mode voltage may often differ from one component's output to the other's input. It may be different between the receiver input and driver output circuits within the same component. It is also referred to as the DC offset on some occasions.

To illustrate these definitions using real values, consider the example of a current mode logic (CML) transmitter that has a common mode voltage of 2.25V and outputs, TD and TD\_B. If these outputs have a swing from 2.0V to 2.5V, the peak-to-peak voltage swing of each signal (TD or TD\_B) is 500 mV p-p, which is referred to as the single-ended swing for each signal. Because the differential signaling environment is fully symmetrical in this example, the transmitter output's differential swing (V<sub>OD</sub>) has the same amplitude as each signal's single-ended swing. The differential output signal ranges between 500 mV and -500 mV. In other words, V<sub>OD</sub> is 500 mV in one phase and -500 mV in the other phase. The peak differential voltage (V<sub>DIFFp</sub>) is 500 mV. The peak-to-peak differential voltage (V<sub>DIFFp-p</sub>) is 1000 mV p-p.

## 3.22.2 SerDes reference clocks

The SerDes reference clock inputs are applied to an internal PLL whose output creates the clock used by the corresponding SerDes lanes. The SerDes reference clocks inputs are SD1\_REF\_CLK[1:2]\_P and SD1\_REF\_CLK[1:2]\_N.

SerDes may be used for various combinations of the following IP blocks based on the RCW Configuration field SRDS\_PRTCLn:

- SGMII (1.25 Gbaud), QSGMII (5 Gbps only)
- PEX1/2/3/4 (2.5 and 5Gbps)
- Aurora (2.5 and 5 Gbps)
- SATA1/2 (1.5 and 3.0 Gbps)

The following sections describe the SerDes reference clock requirements and provide application information.

### 3.22.2.1 SerDes spread-spectrum clock source recommendations

SDn\_REF\_CLKn\_P/SDn\_REF\_CLKn\_N are designed to work with spread-spectrum clock for PCI Express protocol only with the spreading specification defined in [Table 3-104](#). When using spread-spectrum clocking for PCI Express, both ends of the link partners should use the same reference clock. For best results, a source without significant unintended modulation must be used.

For SATA protocol, the SerDes transmitter does not support spread-spectrum clocking. The SerDes receiver does support spread-spectrum clocking on receive, which means the SerDes receiver can receive data correctly from a SATA serial link partner using spread-spectrum clocking.

The spread-spectrum clocking cannot be used if the same SerDes reference clock is shared with other non-spread-spectrum supported protocols. For example, if the spread-spectrum clocking is desired on a SerDes reference clock for PCI Express and the same reference clock is used for any other protocol such as SATA/SGMII/QSGMII due to the SerDes lane usage mapping option, spread-spectrum clocking cannot be used at all.

**Table 3-105.** SerDes spread-spectrum clock source recommendations 1

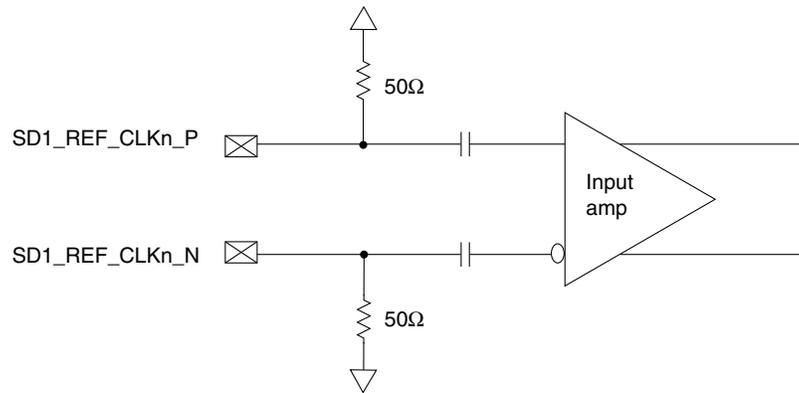
Parameter	Min	Max	Unit	Notes
Frequency modulation	30	33	kHz	–
Frequency spread	+0	–0.5	%	2

- Notes:
1. At recommended operating conditions. See [Table 3-2](#).
  2. Only down-spreading is allowed.

3.22.2.2 SerDes reference clock receiver characteristics

This figure shows a receiver reference diagram of the SerDes reference clocks.

**Figure 3-58.** Receiver of SerDes reference clocks



The characteristics of the clock signals are as follows:

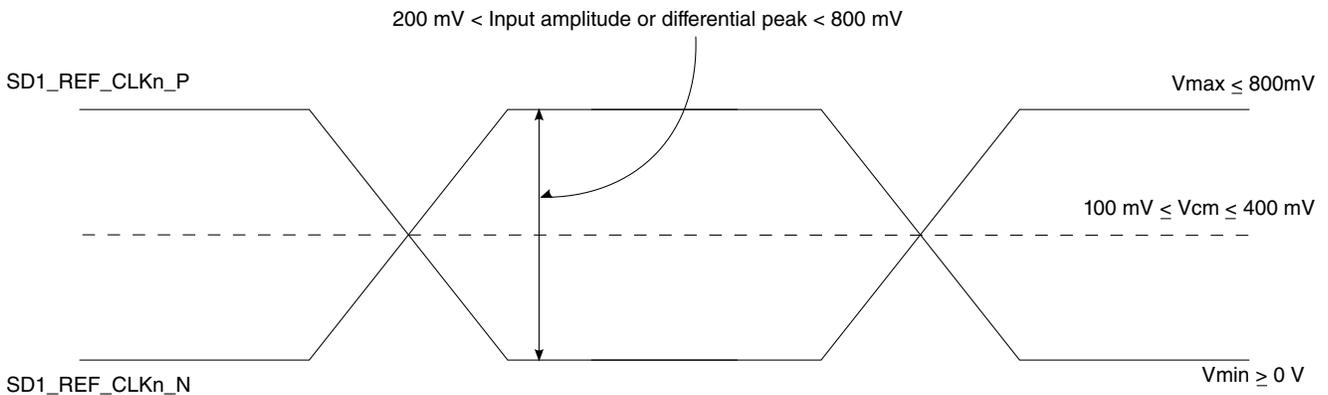
- The SerDes transceivers core power supply voltage requirements ( $S1V_{DD}$ ) are as specified in [Recommended operating conditions](#).
- The SerDes reference clock receiver reference circuit structure is as follows:
  - The SD1\_REF\_CLKn\_P and SD1\_REF\_CLKn\_N are internally AC-coupled differential inputs as shown in [Figure 3-58](#). Each differential clock input (SD1\_REF\_CLKn\_P or SD1\_REF\_CLKn\_N) has on-chip 50Ω termination to SGNDn followed by on-chip AC-coupling.
  - The external reference clock driver must be able to drive this termination.
  - The SerDes reference clock input can be either differential or single-ended. See the differential mode and single-ended mode descriptions below for detailed requirements.
- The maximum average current requirement also determines the common mode voltage range.
  - When the SerDes reference clock differential inputs are DC coupled externally with the clock driver chip, the maximum average current allowed for each input pin is 8 mA. In this case, the exact common mode input voltage is not critical as long as it is within the range allowed by the maximum average current of 8 mA because the input is AC-coupled on-chip.
  - This current limitation sets the maximum common mode input voltage to be less than 0.4V ( $0.4V \sim 50 = 8 \text{ mA}$ ) while the minimum common mode input level is 0.1V above SGNDn. For example, a clock with a 50/50 duty cycle can be produced by a clock driver with output driven by its current source from 0 mA to 16 mA (0-0.8V), such that each phase of the differential input has a single-ended swing from 0V to 800 mV with the common mode voltage at 400 mV.
  - If the device driving the SD1\_REF\_CLKn\_P and SD1\_REF\_CLKn\_N inputs cannot drive 50Ω to SGNDn DC or the drive strength of the clock driver chip exceeds the maximum input current limitations, it must be AC-coupled off-chip.
- The input amplitude requirement is described in detail in the following sections.

### 3.22.2.3 DC-level requirement for SerDes reference clocks

The DC level requirement for the SerDes reference clock inputs is different depending on the signaling mode used to connect the clock driver chip and SerDes reference clock inputs, as described below:

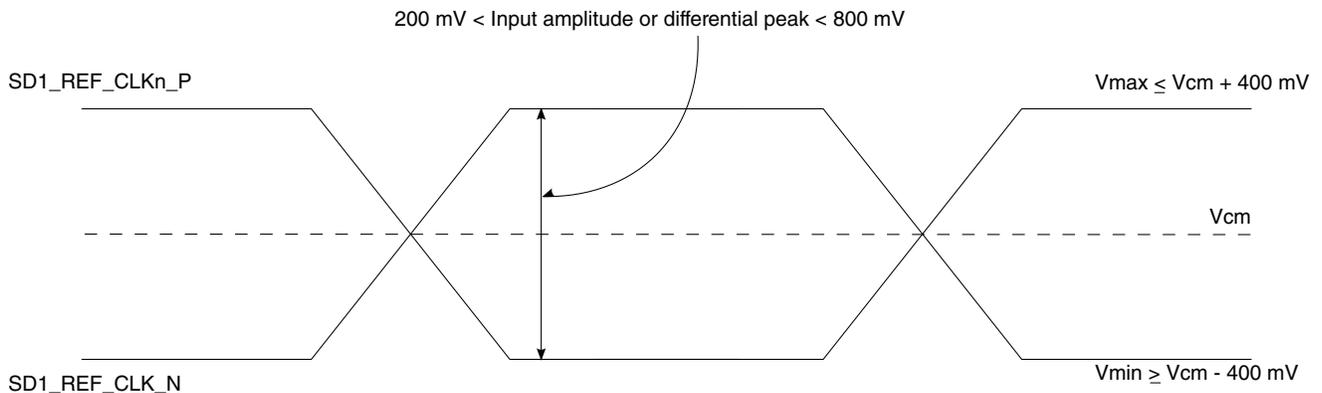
- Differential Mode
  - The input amplitude of the differential clock must be between 400 mV and 1600 mV differential peak-to-peak (or between 200 mV and 800 mV differential peak). In other words, each signal wire of the differential pair must have a single-ended swing of less than 800 mV and greater than 200 mV. This requirement is the same for both external DC-coupled or AC-coupled connection.
  - For an external DC-coupled connection, as described in [SerDes reference clock receiver characteristics](#), the maximum average current requirements sets the requirement for average voltage (common mode voltage) as between 100 mV and 400 mV. [Figure 3-59](#) shows the SerDes reference clock input requirement for DC-coupled connection scheme.

**Figure 3-59.** Differential reference clock input DC requirements (external DC-coupled)



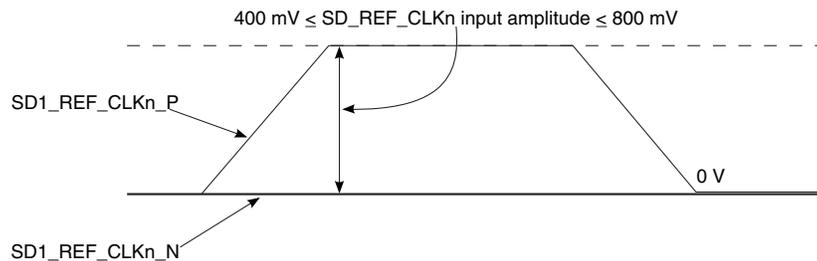
- For an external AC-coupled connection, there is no common mode voltage requirement for the clock driver. Because the external AC-coupling capacitor blocks the DC level, the clock driver and the SerDes reference clock receiver operate in different common mode voltages. The SerDes reference clock receiver in this connection scheme has its common mode voltage set to SGND<sub>n</sub>. Each signal wire of the differential inputs is allowed to swing below and above the common mode voltage (SGND<sub>n</sub>). [Figure 3-60](#) shows the SerDes reference clock input requirement for AC-coupled connection scheme.

**Figure 3-60.** Differential reference clock input DC requirements (external AC-coupled)



- Single-Ended Mode
  - The reference clock can also be single-ended. The SD1\_REF\_CLKn\_P input amplitude (single-ended swing) must be between 400 mV and 800 mV peak-to-peak (from  $V_{MIN}$  to  $V_{MAX}$ ) with SD1\_REF\_CLKn\_N either left unconnected or tied to ground.
  - The SD1\_REF\_CLKn input average voltage must be between 200 and 400 mV. Figure 3-61 shows the SerDes reference clock input requirement for single-ended signaling mode.
  - To meet the input amplitude requirement, the reference clock inputs may need to be DC- or AC-coupled externally. For the best noise performance, the reference of the clock could be DC- or AC-coupled into the unused phase (SD1\_REF\_CLKn\_N) through the same source impedance as the clock input (SD1\_REF\_CLKn) in use.

**Figure 3-61.** Single-ended reference clock input DC requirements



3.22.2.4 AC requirements for SerDes reference clocks

This table lists the AC requirements for SerDes reference clocks for protocols running at data rates up to 5 Gb/s.

This includes PCI Express (2.5, 5 GT/s), SGMII (1.25Gbps), QSGMII (5Gbps). SerDes reference clocks to be guaranteed by the customer's application design.

**Table 3-106.** SD1\_REF\_CLKn\_P and SD1\_REF\_CLKn\_N input clock requirements ( $S1V_{DDn} = 1.0V$ )<sup>(1)</sup>

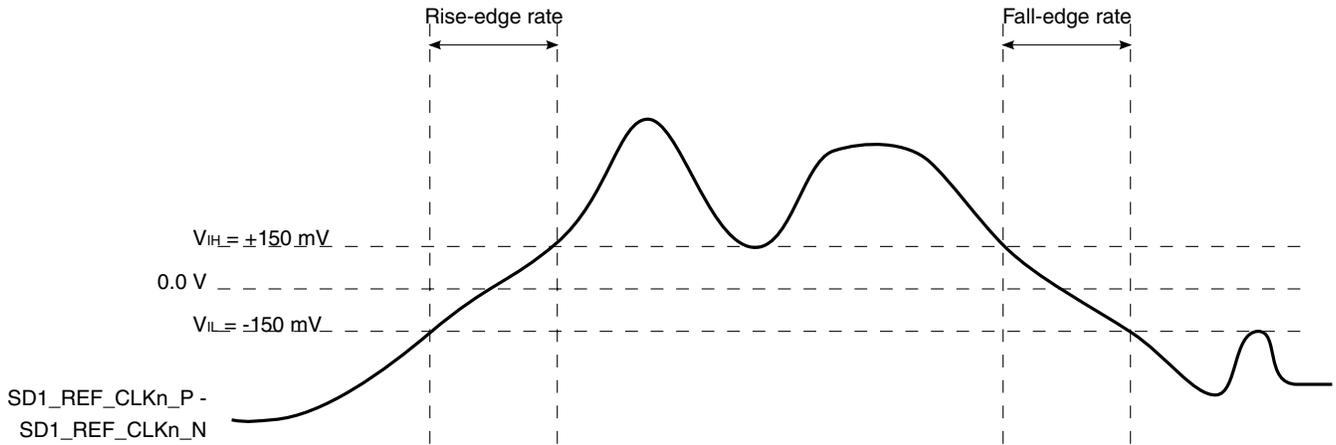
Parameter	Symbol	Min	Typ	Max	Unit	Notes
SD1_REF_CLKn_P/SD1_REF_CLKn_N frequency range	$t_{CLK\_REF}$	–	100/125	–	MHz	(2)
SD1_REF_CLKn_P/SD1_REF_CLKn_N clock frequency tolerance	$t_{CLK\_TOL}$	–300	–	300	ppm	(3)
SD1_REF_CLKn_P/SD1_REF_CLKn_N clock frequency tolerance	$t_{CLK\_TOL}$	–100	–	100	ppm	(4)
SD1_REF_CLKn_P/SD1_REF_CLKn_N reference clock duty cycle	$t_{CLK\_DUTY}$	40	50	60	%	(5)
SD1_REF_CLKn_P/SD1_REF_CLKn_N max deterministic peak-to-peak jitter at $10^{-6}$ BER	$t_{CLK\_DJ}$	–	–	42	ps	–
SD1_REF_CLKn_P/SD1_REF_CLKn_N total reference clock jitter at $10^{-6}$ BER (peak-to-peak jitter at refCLK input)	$t_{CLK\_TJ}$	–	–	86	ps	(6)
SD1_REF_CLKn_P/SD1_REF_CLKn_N 10 kHz to 1.5 MHz RMS jitter	$t_{REFCLK-LF-RMS}$	–	–	3	ps RMS	(7)
SD1_REF_CLKn_P/SD1_REF_CLKn_N > 1.5 MHz to Nyquist RMS jitter	$t_{REFCLK-HF-RMS}$	–	–	3.1	ps RMS	(7)
SD1_REF_CLKn_P/SD1_REF_CLKn_N rising/falling edge rate	$t_{CLKRRR}/t_{CLKFR}$	0.6	–	4	V/ns	(8)
Differential input high voltage	$V_{IH}$	150	–	–	mV	(5)
Differential input low voltage	$V_{IL}$	–	–	–150	mV	(5)
Rising edge rate (SD1REF_CLKn_P) to falling edge rate (SD1_REF_CLKn_N) matching	Rise-Fall Matching	–	–	20	%	(9)(10)

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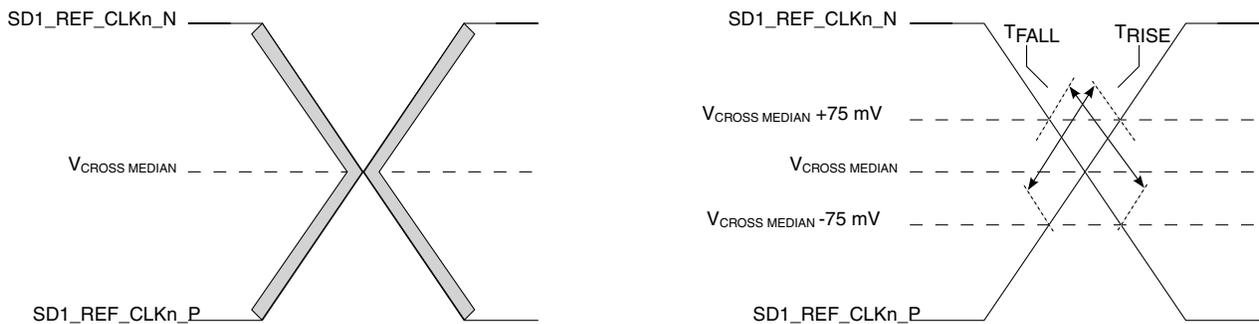
# QT1040/QT1020 4GB

- Notes:
1. For recommended operating conditions, see [Table 3-2](#).
  2. **Caution:** Only 100 and 125 have been tested. In-between values do not work correctly with the rest of the system.
  3. For PCI Express(2.5, 5 GT/s)
  4. For SGMII, QSGMII
  5. Measurement taken from differential waveform
  6. Limits from PCI Express CEM Rev 2.0
  7. For PCI Express-5 GT/s, per PCI Express base specification rev 3.0
  8. Measured from  $-150\text{ mV}$  to  $+150\text{ mV}$  on the differential waveform (derived from SD1\_REF\_CLKn\_P minus SD1\_REF\_CLKn\_N). The signal must be monotonic through the measurement region for rise and fall time. The  $300\text{ mV}$  measurement window is centered on the differential zero crossing. See [Figure 3-62](#).
  9. Measurement taken from single-ended waveform
  10. Matching applies to rising edge for SD1\_REF\_CLKn\_P and falling edge rate for SD1\_REF\_CLKn\_N. It is measured using a  $\pm 75\text{ mV}$  window centered on the median cross point where SD1\_REF\_CLKn\_P rising meets SD1\_REF\_CLKn\_N falling. The median cross point is used to calculate the voltage thresholds that the oscilloscope uses for the edge rate calculations. The rise edge rate of SD1\_REF\_CLKn\_P must be compared to the fall edge rate of SD1\_REF\_CLKn\_N, the maximum allowed difference should not exceed 20% of the slowest edge rate. See [Figure 3-63](#).

**Figure 3-62.** Differential measurement points for rise and fall time



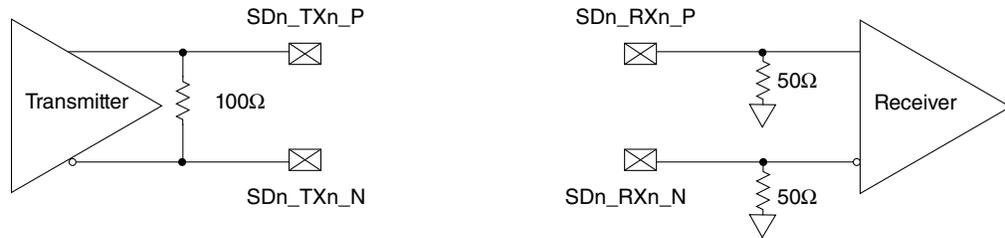
**Figure 3-63.** Single-ended measurement points for rise and fall time matching



**3.22.3 SerDes transmitter and receiver reference circuits**

This figure shows the reference circuits for SerDes data lane's transmitter and receiver.

**Figure 3-64.** SerDes transmitter and receiver reference circuits



The DC and AC specification of SerDes data lanes are defined in each interface protocol section below based on the application usage:

- PCI Express
- Aurora interface
- Serial ATA (SATA) interface
- SGMII interface
- QSGMII interface

Note that external AC-coupling capacitor is required for the above serial transmission protocols with the capacitor value defined in the specification of each protocol section.

**3.22.4 PCI Express**

This section describes the clocking dependencies, DC and AC electrical specifications for the PCI Express bus.

**3.22.4.1 Clocking dependencies**

The ports on the two ends of a link must transmit data at a rate that is within 600 parts per million (ppm) of each other at all times. This is specified to allow bit rate clock sources with a ±300 ppm tolerance.

# QT1040/QT1020 4GB

## 3.22.4.2 PCI Express DC physical layer specifications

This section contains the DC specifications for the physical layer of PCI Express on this chip.

### 3.22.4.2.1 PCI Express DC physical layer transmitter specifications

This section discusses the PCI Express DC physical layer transmitter specifications for 2.5 GT/s and 5 GT/s.

This table defines the PCI Express 2.0 (2.5 GT/s) DC specifications for the differential output at all transmitters. The parameters are specified at the component pins.

**Table 3-107.** PCI Express 2.0 (2.5 GT/s) differential transmitter output DC specifications ( $X1V_{DD} = 1.35V$ )<sup>1</sup>

Parameter	Symbol	Min	Typical	Max	Units	Notes
Differential peak-to-peak output voltage	$V_{TX-DIFFP-p}$	800	1000	1200	mV	$V_{TX-DIFFP-p} = 2 \times  V_{TX-D+} - V_{TX-D-} $
De-emphasized differential output voltage (ratio)	$V_{TX-DE-RATIO}$	3.0	3.5	4.0	dB	Ratio of the $V_{TX-DIFFP-p}$ of the second and following bits after a transition divided by the $V_{TX-DIFFP-p}$ of the first bit after a transition.
DC differential transmitter impedance	$Z_{TX-DIFF-DC}$	80	100	120	$\Omega$	Transmitter DC differential mode low Impedance
Transmitter DC impedance	$Z_{TX-DC}$	40	50	60	$\Omega$	Required transmitter D+ as well as D- DC Impedance during all states

Note: 1. For recommended operating conditions, see [Table 3-2](#).

This table defines the PCI Express 2.0 (5 GT/s) DC specifications for the differential output at all transmitters. The parameters are specified at the component pins.

**Table 3-108.** PCI Express 2.0 (5 GT/s) differential transmitter output DC specifications ( $X1V_{DD} = 1.35V$ )<sup>1</sup>

Parameter	Symbol	Min	Typical	Max	Units	Notes
Differential peak-to-peak output voltage	$V_{TX-DIFFP-p}$	800	1000	1200	mV	$V_{TX-DIFFP-p} = 2 \times  V_{TX-D+} - V_{TX-D-} $
Low power differential peak-to-peak output voltage	$V_{TX-DIFFP-p\_low}$	400	500	1200	mV	$V_{TX-DIFFP-p} = 2 \times  V_{TX-D+} - V_{TX-D-} $
De-emphasized differential output voltage (ratio)	$V_{TX-DE-RATIO-3.5dB}$	3.0	3.5	4.0	dB	Ratio of the $V_{TX-DIFFP-p}$ of the second and following bits after a transition divided by the $V_{TX-DIFFP-p}$ of the first bit after a transition.
De-emphasized differential output voltage (ratio)	$V_{TX-DE-RATIO-6.0dB}$	5.5	6.0	6.5	dB	Ratio of the $V_{TX-DIFFP-p}$ of the second and following bits after a transition divided by the $V_{TX-DIFFP-p}$ of the first bit after a transition.
DC differential transmitter impedance	$Z_{TX-DIFF-DC}$	80	100	120	$\Omega$	Transmitter DC differential mode low impedance
Transmitter DC Impedance	$Z_{TX-DC}$	40	50	60	$\Omega$	Required transmitter D+ as well as D- DC impedance during all states

Note: 1. For recommended operating conditions, see [Table 3-2](#).

3.22.4.3 PCI Express DC physical layer receiver specifications

This section discusses the PCI Express DC physical layer receiver specifications for 2.5 GT/s and 5 GT/s.

This table defines the DC specifications for the PCI Express 2.0 (2.5 GT/s) differential input at all receivers. The parameters are specified at the component pins.

**Table 3-109.** PCI Express 2.0 (2.5 GT/s) differential receiver input DC specifications ( $S_{V_{DD}} = 1.0V$ )<sup>4</sup>

Parameter	Symbol	Min	Typ	Max	Units	Notes
Differential input peak-to-peak voltage	$V_{RX-DIFFp-p}$	120	1000	1200	mV	$V_{RX-DIFFp-p} = 2 \times  V_{RX-D+} - V_{RX-D-} $ See Note 1.
DC differential input impedance	$Z_{RX-DIFF-DC}$	80	100	120	$\Omega$	Receiver DC differential mode impedance. See Note 2
DC input impedance	$Z_{RX-DC}$	40	50	60	$\Omega$	Required receiver D+ as well as D- DC Impedance ( $50 \pm 20\%$ tolerance). See Notes 1 and 2.
Powered down DC input impedance	$Z_{RX-HIGH-IMP-DC}$	50	–	–	k $\Omega$	Required receiver D+ as well as D- DC Impedance when the receiver terminations do not have power. See Note 3.
Electrical idle detect threshold	$V_{RX-IDLE-DET-DIFFp-p}$	65	–	175	mV	$V_{RX-IDLE-DET-DIFFp-p} = 2 \times  V_{RX-D+} - V_{RX-D-} $ Measured at the package pins of the receiver

- Notes:
1. Measured at the package pins with a test load of 50 $\Omega$  to GND on each pin.
  2. Impedance during all LTSSM states. When transitioning from a fundamental reset to detect (the initial state of the LTSSM) there is a 5 ms transition time before receiver termination values must be met on all unconfigured lanes of a port.
  3. The receiver DC common mode impedance that exists when no power is present or fundamental reset is asserted. This helps ensure that the receiver detect circuit does not falsely assume a receiver is powered on when it is not. This term must be measured at 300 mV above the receiver ground.
  4. For recommended operating conditions, see [Table 3-2](#).

This table defines the DC specifications for the PCI Express 2.0 (5 GT/s) differential input at all receivers. The parameters are specified at the component pins.

**Table 3-110.** PCI Express 2.0 (5 GT/s) differential receiver input DC specifications ( $S_{V_{DD}} = 1.0V$ )<sup>4</sup>

Parameter	Symbol	Min	Typ	Max	Units	Notes
Differential input peak-to-peak voltage	$V_{RX-DIFFp-p}$	120	1000	1200	mV	$V_{RX-DIFFp-p} = 2 \times  V_{RX-D+} - V_{RX-D-} $ See Note 1.
DC differential input impedance	$Z_{RX-DIFF-DC}$	80	100	120	$\Omega$	Receiver DC differential mode impedance. See Note 2
DC input impedance	$Z_{RX-DC}$	40	50	60	$\Omega$	Required receiver D+ as well as D- DC Impedance ( $50 \pm 20\%$ tolerance). See Notes 1 and 2.
Powered down DC input impedance	$Z_{RX-HIGH-IMP-DC}$	50	–	–	k $\Omega$	Required receiver D+ as well as D- DC Impedance when the receiver terminations do not have power. See Note 3.
Electrical idle detect threshold	$V_{RX-IDLE-DET-DIFFp-p}$	65	–	175	mV	$V_{RX-IDLE-DET-DIFFp-p} = 2 \times  V_{RX-D+} - V_{RX-D-} $ Measured at the package pins of the receiver

- Notes:
1. Measured at the package pins with a test load of 50  $\Omega$  to GND on each pin.
  2. Impedance during all LTSSM states. When transitioning from a fundamental reset to detect (the initial state of the LTSSM) there is a 5 ms transition time before receiver termination values must be met on all unconfigured lanes of a port.
  3. The receiver DC common mode impedance that exists when no power is present or fundamental reset is asserted. This helps ensure that the receiver detect circuit does not falsely assume a receiver is powered on when it is not. This term must be measured at 300 mV above the receiver ground.
  4. For recommended operating conditions, see [Table 3-2](#).

### 3.22.4.4 PCI Express AC physical layer specifications

This section contains the AC specifications for the physical layer of PCI Express on this device.

#### 3.22.4.4.1 PCI Express AC physical layer transmitter specifications

This section discusses the PCI Express AC physical layer transmitter specifications for 2.5 GT/s and 5 GT/s.

This table defines the PCI Express 2.0 (2.5 GT/s) AC specifications for the differential output at all transmitters. The parameters are specified at the component pins. The AC timing specifications do not include RefClk jitter.

**Table 3-111.** PCI Express 2.0 (2.5 GT/s) differential transmitter output AC specifications<sup>4</sup>

Parameter	Symbol	Min	Typ	Max	Units	Notes
Unit interval	UI	399.88	400	400.12	ps	Each UI is 400 ps ± 300 ppm. UI does not account for spread-spectrum clock dictated variations.
Minimum transmitter eye width	T <sub>TX-EYE</sub>	0.75	–	–	UI	The maximum transmitter jitter can be derived as T <sub>TX-MAX-JITTER</sub> = 1 - T <sub>TX-EYE</sub> = 0.25 UI. Does not include spread-spectrum or RefCLK jitter. Includes device random jitter at 10 <sup>-12</sup> . See Notes 1 and 2.
Maximum time between the jitter median and maximum deviation from the median	T <sub>TX-EYE-MEDIAN-to-MAX-JITTER</sub>	–	–	0.125	UI	Jitter is defined as the measurement variation of the crossing points (V <sub>TX-DIFFp-p</sub> = 0V) in relation to a recovered transmitter UI. A recovered transmitter UI is calculated over 3500 consecutive unit intervals of sample data. Jitter is measured using all edges of the 250 consecutive UI in the center of the 3500 UI used for calculating the transmitter UI. See Notes 1 and 2.
AC coupling capacitor	C <sub>TX</sub>	75	–	200	nF	All transmitters must be AC coupled. The AC coupling is required either within the media or within the transmitting component itself. See Note 3.

- Notes:
1. Specified at the measurement point into a timing and voltage test load as shown in [Figure 3-66](#) and measured over any 250 consecutive transmitter UIs.
  2. A T<sub>TX-EYE</sub> = 0.75 UI provides for a total sum of deterministic and random jitter budget of T<sub>TX-JITTER-MAX</sub> = 0.25 UI for the transmitter collected over any 250 consecutive transmitter UIs. The T<sub>TX-EYE-MEDIAN-to-MAX-JITTER</sub> median is less than half of the total transmitter jitter budget collected over any 250 consecutive transmitter UIs. It must be noted that the median is not the same as the mean. The jitter median describes the point in time where the number of jitter points on either side is approximately equal as opposed to the averaged time value.
  3. The chip's SerDes transmitter does not have C<sub>TX</sub> built-in. An external AC coupling capacitor is required.
  4. For recommended operating conditions, see [Table 3-2](#).

This table defines the PCI Express 2.0 (5 GT/s) AC specifications for the differential output at all transmitters. The parameters are specified at the component pins. The AC timing specifications do not include RefClk jitter.

**Table 3-112.** PCI Express 2.0 (5 GT/s) differential transmitter output AC specifications<sup>3</sup>

Parameter	Symbol	Min	Typ	Max	Units	Notes
Unit Interval	UI	199.94	200.00	200.06	ps	Each UI is 200 ps ± 300 ppm. UI does not account for spread-spectrum clock dictated variations.
Minimum transmitter eye width	T <sub>TX-EYE</sub>	0.75	–	–	UI	The maximum transmitter jitter can be derived as: T <sub>TX-MAX-JITTER</sub> = 1 - T <sub>TX-EYE</sub> = 0.25 UI. See Note 1.
Transmitter RMS deterministic jitter > 1.5 MHz	T <sub>TX-HF-DJ-DD</sub>	–	–	0.15	ps	–
Transmitter RMS deterministic jitter < 1.5 MHz	T <sub>TX-LF-RMS</sub>	–	3.0	–	ps	Reference input clock RMS jitter (< 1.5 MHz) at pin < 1 ps
AC coupling capacitor	C <sub>TX</sub>	75	–	200	nF	All transmitters must be AC coupled. The AC coupling is required either within the media or within the transmitting component itself. See Note 2.

- Notes:
1. Specified at the measurement point into a timing and voltage test load as shown in [Figure 3-66](#) and measured over any 250 consecutive transmitter UIs.
  2. The chip's SerDes transmitter does not have C<sub>TX</sub> built-in. An external AC coupling capacitor is required.
  3. For recommended operating conditions, see [Table 3-2](#).

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## 3.22.4.4.2 PCI Express AC physical layer receiver specifications

This section discusses the PCI Express AC physical layer receiver specifications for 2.5 GT/s and 5 GT/s.

This table defines the AC specifications for the PCI Express 2.0 (2.5 GT/s) differential input at all receivers. The parameters are specified at the component pins. The AC timing specifications do not include RefClk jitter.

**Table 3-113.** PCI Express 2.0 (2.5 GT/s) differential receiver input AC specifications<sup>4</sup>

Parameter	Symbol	Min	Typ	Max	Units	Notes
Unit Interval	UI	399.88	400.00	400.12	ps	Each UI is 400 ps ± 300 ppm. UI does not account for spread-spectrum clock dictated variations.
Minimum receiver eye width	$T_{RX-EYE}$	0.4	–	–	UI	The maximum interconnect media and transmitter jitter that can be tolerated by the receiver can be derived as $T_{RX-MAX-JITTER} = 1 - T_{RX-EYE} = 0.6$ UI. See Notes 1 and 2.
Maximum time between the jitter median and maximum deviation from the median.	$T_{RX-EYE-MEDIAN-to-MAX-JITTER}$	–	–	0.3	UI	Jitter is defined as the measurement variation of the crossing points ( $V_{RX-DIFFp-p} = 0V$ ) in relation to a recovered transmitter UI. A recovered transmitter UI is calculated over 3500 consecutive unit intervals of sample data. Jitter is measured using all edges of the 250 consecutive UI in the center of the 3500 UI used for calculating the transmitter UI. See Notes 1, 2 and 3.

- Notes:
1. Specified at the measurement point and measured over any 250 consecutive UIs. The test load in [Figure 3-66](#) must be used as the receiver device when taking measurements. If the clocks to the receiver and transmitter are not derived from the same reference clock, the transmitter UI recovered from 3500 consecutive UI must be used as a reference for the eye diagram.
  2. A  $T_{RX-EYE} = 0.40$  UI provides for a total sum of 0.60 UI deterministic and random jitter budget for the transmitter and interconnect collected any 250 consecutive UIs. The  $T_{RX-EYE-MEDIAN-to-MAX-JITTER}$  specification ensures a jitter distribution in which the median and the maximum deviation from the median is less than half of the total. UI jitter budget collected over any 250 consecutive transmitter UIs. It must be noted that the median is not the same as the mean. The jitter median describes the point in time where the number of jitter points on either side is approximately equal as opposed to the averaged time value. If the clocks to the receiver and transmitter are not derived from the same reference clock, the transmitter UI recovered from 3500 consecutive UI must be used as the reference for the eye diagram.
  3. It is recommended that the recovered transmitter UI is calculated using all edges in the 3500 consecutive UI interval with a fit algorithm using a minimization merit function. Least squares and median deviation fits have worked well with experimental and simulated data.
  4. For recommended operating conditions, see [Table 3-2](#).

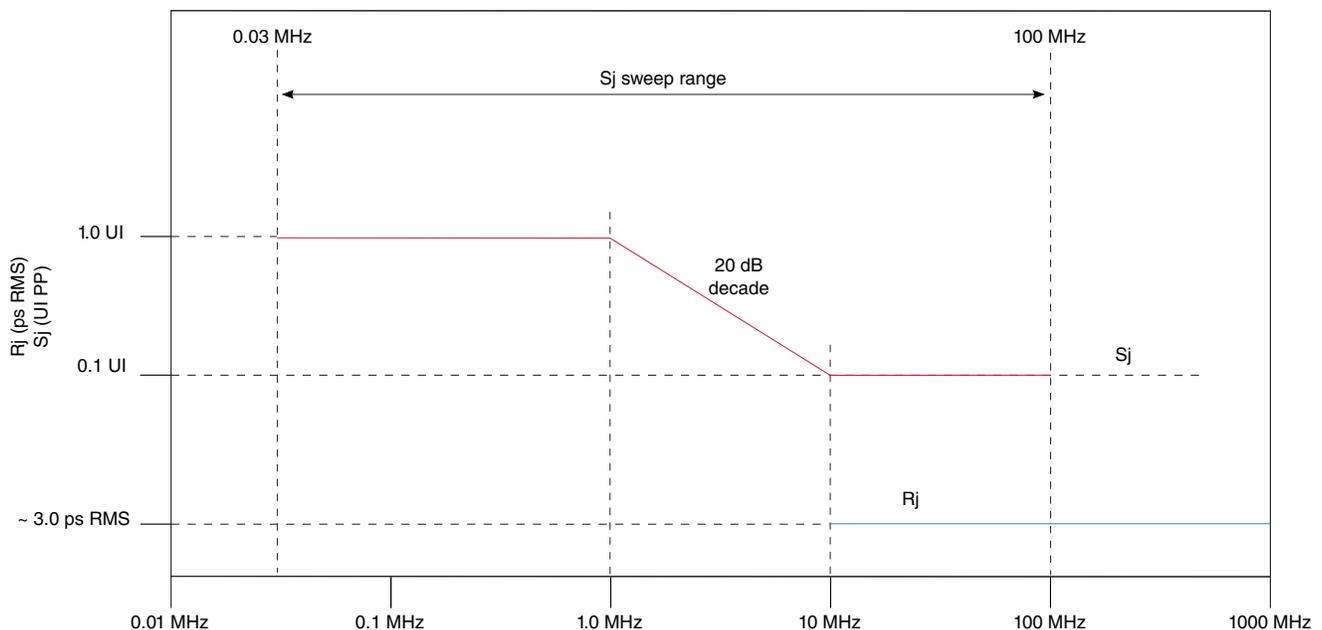
This table defines the AC specifications for the PCI Express 2.0 (5 GT/s) differential input at all receivers. The parameters are specified at the component pins. The AC timing specifications do not include RefClk jitter.

**Table 3-114.** PCI Express 2.0 (5 GT/s) differential receiver input AC specifications<sup>1</sup>

Parameter	Symbol	Min	Typ	Max	Units	Notes
Unit Interval	UI	199.40	200.00	200.06	ps	Each UI is 200 ps ± 300 ppm. UI does not account for spread-spectrum clock dictated variations.
Max receiver inherent timing error	$T_{RX-TJ-CC}$	–	–	0.4	UI	The maximum inherent total timing error for common RefClk receiver architecture
Max receiver inherent deterministic timing error	$T_{RX-DJ-DD-CC}$	–	–	0.30	UI	The maximum inherent deterministic timing error for common RefClk receiver architecture

Note: 1. For recommended operating conditions, see [Table 3-2](#).

**Figure 3-65.** Swept sinusoidal jitter mask



**3.22.4.5 Test and measurement load**

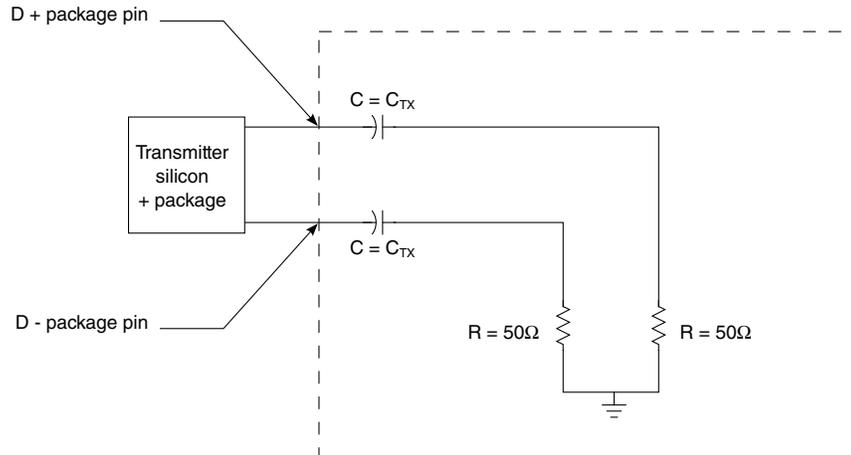
The AC timing and voltage parameters must be verified at the measurement point. The package pins of the device must be connected to the test/measurement load within 0.2 inches of that load, as shown in the following figure.

**NOTE**

The allowance of the measurement point to be within 0.2 inches of the package pins is meant to acknowledge that package/ board routing may benefit from D+ and D- not being exactly matched in length at the package pin boundary. If the vendor does not explicitly state where the measurement point is located, the measurement point is assumed to be the D+ and D- package pins.

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**Figure 3-66.** Test/measurement load



### 3.22.5 Aurora interface

This section describes the Aurora clocking requirements and its DC and AC electrical characteristics.

#### 3.22.5.1 Aurora clocking requirements for SD1\_REF\_CLKn\_P and SD1\_REF\_CLKn\_N

For more information on these specifications, see [SerDes reference clocks](#).

#### 3.22.5.2 Aurora DC electrical characteristics

This section describes the DC electrical characteristics for the Aurora interface.

##### 3.22.5.2.1 Aurora transmitter DC electrical characteristics

This table defines the Aurora transmitter DC electrical characteristics.

**Table 3-115.** Aurora transmitter DC electrical characteristics ( $XV_{DD} = 1.35V$ )<sup>1</sup>

Parameter	Symbol	Min	Typical	Max	Unit
Differential output voltage	$V_{DIFFPP}$	800	1000	1600	mV p-p
DC Differential transmitter impedance	$Z_{TX-DIFF-DC}$	80	100	120	$\Omega$

Note: 1. For recommended operating conditions, see [Table 3-2](#).

##### 3.22.5.2.2 Aurora receiver DC electrical characteristics

This table defines the Aurora receiver DC electrical characteristics for the Aurora interface.

**Table 3-116.** Aurora receiver DC electrical characteristics ( $SV_{DD} = 1.0V$ )<sup>1</sup>

Parameter	Symbol	Min	Typical	Max	Unit	Notes
Differential input voltage	$V_{IN}$	200	–	1600	mV p-p	2
DC Differential receiver impedance	$Z_{RX-DIFF-DC}$	80	100	120	$\Omega$	3

Notes: 1. For recommended operating conditions, see [Table 3-2](#).

2. Measured at receiver

3. DC Differential receiver impedance

3.22.5.3 Aurora AC timing specifications

This section describes the AC timing specifications for Aurora.

3.22.5.3.1 Aurora transmitter AC timing specifications

This table defines the Aurora transmitter AC timing specifications. RefClk jitter is not included.

Table 3-117. Aurora transmitter AC timing specifications<sup>1</sup>

Parameter	Symbol	Min	Typical	Max	Unit
Deterministic jitter	$J_D$	–	–	0.17	UI p-p
Total jitter	$J_T$	–	–	0.35	UI p-p
Unit interval: 2.5 GBaud	UI	400 – 100 ppm	400	400 + 100 ppm	ps
Unit interval: 5.0 GBaud	UI	200 – 100 ppm	200	200 + 100 ppm	ps

Note: 1. For recommended operating conditions, see Table 3-2.

3.22.5.3.2 Aurora receiver AC timing specifications

This table defines the Aurora receiver AC timing specifications. RefClk jitter is not included.

Table 3-118. Aurora receiver AC timing specifications<sup>3</sup>

Parameter	Symbol	Min	Typical	Max	Unit	Notes
Deterministic jitter tolerance	$J_D$	–	–	0.37	UI p-p	1
Combined deterministic and random jitter tolerance	$J_{DR}$	–	–	0.55	UI p-p	1
Total jitter tolerance	$J_T$	–	–	0.65	UI p-p	1, 2
Bit error rate	BER	–	–	$10^{-12}$	–	–
Unit Interval: 2.5 GBaud	UI	400 – 100 ppm	400	400 + 100 ppm	ps	–
Unit Interval: 5.0 GBaud	UI	200 – 100 ppm	200	200 + 100 ppm	ps	–

Notes: 1. Measured at receiver

- Total jitter is composed of three components: deterministic jitter, random jitter, and single frequency sinusoidal jitter. The sinusoidal jitter may have any amplitude and frequency in the unshaded region of Figure 3-15. The sinusoidal jitter component is included to ensure margin for low frequency jitter, wander, noise, crosstalk and other variable system effects.
- For recommended operating conditions, see Table 3-2.

## 3.22.6 Serial ATA (SATA) interface

This section describes the DC and AC electrical specifications for the serial ATA (SATA) interface.

### 3.22.6.1 SATA DC electrical characteristics

This section describes the DC electrical characteristics for SATA.

#### 3.22.6.1.1 SATA DC transmitter output characteristics

This table provides the differential transmitter output DC characteristics for the SATA interface at Gen1i/1m or 1.5 Gbits/s transmission.

**Table 3-119.** Gen1i/1m 1.5G transmitter DC specifications ( $X1V_{DD} = 1.35V$ )<sup>3</sup>

Parameter	Symbol	Min	Typ	Max	Units	Notes
Tx differential output voltage	$V_{SATA\_TXDIFF}$	400	500	600	mV p-p	1
Tx differential pair impedance	$Z_{SATA\_TXDIFFIM}$	85	100	115	$\Omega$	2

- Notes:
1. Terminated by 50 $\Omega$  load
  2. DC impedance
  3. For recommended operating conditions, see [Table 3-2](#).

This table provides the differential transmitter output DC characteristics for the SATA interface at Gen2i/2m or 3.0 Gbits/s transmission.

**Table 3-120.** Gen 2i/2m 3G transmitter DC specifications ( $X1V_{DD} = 1.35V$ )<sup>2</sup>

Parameter	Symbol	Min	Typ	Max	Units	Notes
Transmitter differential output voltage	$V_{SATA\_TXDIFF}$	400	–	700	mV p-p	1
Transmitter differential pair impedance	$Z_{SATA\_TXDIFFIM}$	85	100	115	$\Omega$	–

- Notes:
1. Terminated by 50  $\Omega$  load.
  2. For recommended operating conditions, see [Table 3-2](#).

#### 3.22.6.1.2 SATA DC receiver input characteristics

This table provides the Gen1i/1m or 1.5 Gbits/s differential receiver input DC characteristics for the SATA interface.

**Table 3-121.** Gen1i/1m 1.5 G receiver input DC specifications ( $SV_{DD} = 1.0V$ )<sup>3</sup>

Parameter	Symbol	Min	Typical	Max	Units	Notes
Differential input voltage	$V_{SATA\_RXDIFF}$	240	500	600	mV p-p	1
Differential receiver input impedance	$Z_{SATA\_RXSEIM}$	85	100	115	$\Omega$	2
OOB signal detection threshold	$V_{SATA\_OOB}$	50	120	240	mV p-p	–

- Notes:
1. Voltage relative to common of either signal comprising a differential pair
  2. DC impedance
  3. For recommended operating conditions, see [Table 3-2](#).

This table provides the Gen2i/2m or 3 Gbits/s differential receiver input DC characteristics for the SATA interface.

**Table 3-122.** Gen2i/2m 3 G receiver input DC specifications (SV<sub>DD</sub> = 1.0V)<sup>3</sup>

Parameter	Symbol	Min	Typical	Max	Units	Notes
Differential input voltage	V <sub>SATA_RXDIFF</sub>	240	–	750	mV p-p	1
Differential receiver input impedance	Z <sub>SATA_RXSEIM</sub>	85	100	115	Ω	2
OOB signal detection threshold	V <sub>SATA_OOB</sub>	75	120	240	mV p-p	2

- Notes:
1. Voltage relative to common of either signal comprising a differential pair
  2. DC impedance
  3. For recommended operating conditions, see [Table 3-2](#).

### 3.22.6.2 SATA AC timing specifications

This section discusses the SATA AC timing specifications.

#### 3.22.6.2.1 AC requirements for SATA REF\_CLK

The AC requirements for the SATA reference clock listed in this table are to be guaranteed by the customer's application design.

**Table 3-123.** SATA reference clock input requirements<sup>6</sup>

Parameter	Symbol	Min	Typ	Max	Unit	Notes
SD1_REF_CLKn_P/SD1_REF_CLKn_N frequency range	t <sub>CLK_REF</sub>	–	100/125	–	MHz	1
SD1_REF_CLKn_P/SD1_REF_CLKn_N clock frequency tolerance	t <sub>CLK_TOL</sub>	–350	–	+350	ppm	–
SD1_REF_CLKn_P/SD1_REF_CLKn_N reference clock duty cycle	t <sub>CLK_DUTY</sub>	40	50	60	%	5
SD1_REF_CLKn_P/SD1_REF_CLKn_N cycle- to-cycle clock jitter (period jitter)	t <sub>CLK_CJ</sub>	–	–	100	ps	2
SD1_REF_CLKn_P/SD1_REF_CLKn_N total reference clock jitter, phase jitter (peak-to-peak)	t <sub>CLK_PJ</sub>	–50	–	+50	ps	2, 3, 4

- Notes:
1. **Caution:** Only 100 and 125MHz have been tested. In-between values do not work correctly with the rest of the system.
  2. At RefClk input
  3. In a frequency band from 150 kHz to 15 MHz at BER of 10<sup>-12</sup>
  4. Total peak-to-peak deterministic jitter must be less than or equal to 50 ps.
  5. Measurement taken from differential waveform
  6. For recommended operating conditions, see [Table 3-2](#).

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## 3.22.6.3 AC transmitter output characteristics

This table provides the differential transmitter output AC characteristics for the SATA interface at Gen1i/1m or 1.5 Gbits/s transmission. The AC timing specifications do not include RefClk jitter.

**Table 3-124.** Gen1i/1m 1.5 G transmitter AC specifications<sup>2</sup>

Parameter	Symbol	Min	Typ	Max	Unit	Notes
Channel speed	$t_{CH\_SPEED}$	–	1.5	–	Gbps	–
Unit Interval	$T_{UI}$	666.4333	666.6667	670.2333	ps	–
Total jitter data-data 5 UI	$U_{SATA\_TXTJ5UI}$	–	–	0.355	UI p-p	1
Total jitter, data-data 250 UI	$U_{SATA\_TXTJ250UI}$	–	–	0.47	UI p-p	1
Deterministic jitter, data-data 5 UI	$U_{SATA\_TXDJ5UI}$	–	–	0.175	UI p-p	1
Deterministic jitter, data-data 250 UI	$U_{SATA\_TXDJ250UI}$	–	–	0.22	UI p-p	1

Notes: 1. Measured at transmitter output pins peak to peak phase variation, random data pattern  
2. For recommended operating conditions, see [Table 3-2](#).

This table provides the differential transmitter output AC characteristics for the SATA interface at Gen2i/2m or 3.0 Gbits/s transmission. The AC timing specifications do not include RefClk jitter.

**Table 3-125.** Gen 2i/2m 3 G transmitter AC specifications<sup>2</sup>

Parameter	Symbol	Min	Typ	Max	Unit	Notes
Channel speed	$t_{CH\_SPEED}$	–	3.0	–	Gbps	–
Unit Interval	$T_{UI}$	333.2167	333.3333	335.1167	ps	–
Total jitter $f_{C3dB} = f_{BAUD} \div 500$	$U_{SATA\_TXTJfB/500}$	–	–	0.37	UI p-p	1
Total jitter $f_{C3dB} = f_{BAUD} \div 1667$	$U_{SATA\_TXTJfB/1667}$	–	–	0.55	UI p-p	1
Deterministic jitter, $f_{C3dB} = f_{BAUD} \div 500$	$U_{SATA\_TXDJfB/500}$	–	–	0.19	UI p-p	1
Deterministic jitter, $f_{C3dB} = f_{BAUD} \div 1667$	$U_{SATA\_TXDJfB/1667}$	–	–	0.35	UI p-p	1

Notes: 1. Measured at transmitter output pins peak-to-peak phase variation, random data pattern  
2. For recommended operating conditions, see [Table 3-2](#).

3.22.6.4 AC differential receiver input characteristics

This table provides the Gen1i/1m or 1.5 Gbits/s differential receiver input AC characteristics for the SATA interface. The AC timing specifications do not include RefClk jitter.

Table 3-126. Gen 1i/1m 1.5G receiver AC specifications<sup>2</sup>

Parameter	Symbol	Min	Typ	Max	Unit	Notes
Unit Interval	$T_{UI}$	666.4333	666.6667	670.2333	ps	–
Total jitter data-data 5 UI	$U_{SATA\_RXTJ5UI}$	–	–	0.43	UI p-p	1
Total jitter, data-data 250 UI	$U_{SATA\_RXTJ250UI}$	–	–	0.60	UI p-p	1
Deterministic jitter, data-data 5 UI	$U_{SATA\_RXDJ5UI}$	–	–	0.25	UI p-p	1
Deterministic jitter, data-data 250 UI	$U_{SATA\_RXDJ250UI}$	–	–	0.35	UI p-p	1

Notes: 1. Measured at receiver.

2. For recommended operating conditions, see Table 3-2.

This table provides the differential receiver input AC characteristics for the SATA interface at Gen2i/2m or 3.0 Gbits/s transmission. The AC timing specifications do not include RefClk jitter.

Table 3-127. Gen 2i/2m 3G receiver AC specifications<sup>2</sup>

Parameter	Symbol	Min	Typical	Max	Unit	Notes
Unit Interval	$T_{UI}$	333.2167	333.3333	335.1167	ps	–
Total jitter $f_{C3dB} = f_{BAUD} \div 500$	$U_{SATA\_RXTJfB/500}$	–	–	0.60	UI p-p	1
Total jitter $f_{C3dB} = f_{BAUD} \div 1667$	$U_{SATA\_RXTJfB/1667}$	–	–	0.65	UI p-p	1
Deterministic jitter, $f_{C3dB} = f_{BAUD} \div 500$	$U_{SATA\_RXDJfB/500}$	–	–	0.42	UI p-p	1
Deterministic jitter, $f_{C3dB} = f_{BAUD} \div 1667$	$U_{SATA\_RXDJfB/1667}$	–	–	0.35	UI p-p	1

Notes: 1. Measured at receiver

2. For recommended operating conditions, see Table 3-2.

## 4. HARDWARE DESIGN CONSIDERATIONS

### 4.1 System clocking

This section describes the PLL configuration of the chip.

#### 4.1.1 PLL characteristics

Characteristics of the chip's PLLs include the following:

- There are two core cluster PLLs which generate a clock for each core cluster from the externally supplied SYSCLK input.
- Core cluster Group A PLL 1 and Core cluster group A PLL 2
- The frequency ratio between each of the core cluster PLLs and SYSCLK is selected using the configuration bits as described in [Core cluster to SYSCLK PLL ratio](#). The frequency for each core cluster is selected using the configuration bits as described in [Table 4-5](#).
- The platform PLL generates the platform clock from the externally supplied SYSCLK input. The frequency ratio between the platform and SYSCLK is selected using the platform PLL ratio configuration bits as described in [Platform to SYSCLK PLL ratio](#).
- Cluster group A generates an asynchronous clock for eSDHC SDR mode from CGA PLL1 or CGA PLL2. Described in [eSDHC SDR mode clock select](#).

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- The DDR block PLL generates an asynchronous DDR clock from the externally supplied DDRCLK input. The frequency ratio is selected using the Memory Controller Complex PLL multiplier/ratio configuration bits as described in [DDR controller PLL ratios](#).
- SerDes block has 2 PLLs which generate a core clock from their respective
- externally supplied SD1\_REF\_CLK<sub>n</sub>\_P/SD1\_REF\_CLK<sub>n</sub>\_N inputs. The frequency ratio is selected using the SerDes PLL RCW configuration bits as described in [SerDes PLL ratio](#).
- When using Single Oscillator Source clocking mode, a single onboard oscillator can provide the reference clock (100MHz) to all the PLL's that is, Platform PLL, Core Cluster PLL's, DDR PLL, USB PLL and Serdes PLL's.

## 4.1.2 Clock ranges

This table provides the clocking specifications for the processor core, platform, memory, and integrated flash controller.

**Table 4-1.** Processor, platform, and memory clocking specifications

Characteristic	Maximum processor core frequency						Unit	Notes
	1200 MHz		1400 MHz		1500 MHz			
	Min	Max	Min	Max	Min	Max		
Core cluster group PLL frequency	800	1200	800	1400	800	1500	MHz	1, 2
Core cluster frequency	400	1200	400	1400	400	1500	MHz	2
Platform clock frequency	300	500	300	600	300	600	MHz	1, 7
Memory bus clock frequency (DDR4)	625	800	625	800	625	800	MHz	1, 3, 4
IFC clock frequency	–	100	–	100	–	100	MHz	5
FMAN	300	500	300	600	300	600	MHz	6

- Notes:
1. **Caution:** The platform clock to SYSCLK ratio and core to SYSCLK ratio settings must be chosen such that the resulting SYSCLK frequency, core frequency, and platform clock frequency do not exceed their respective maximum or minimum operating frequencies
  2. The core cluster can run at cluster group PLL/1 and PLL/2. For the PLL/1 case, the minimum frequency is 800 MHz. With a minimum cluster group PLL frequency of 800 MHz, this results in a minimum allowable core cluster frequency of 400 MHz for PLL/2. Frequency provided to the e5500 cluster after any dividers must always be greater than or equal to the platform frequency. For the case of the minimum platform frequency = 400 MHz, the minimum core cluster frequency is 400 MHz.
  3. The memory bus clock speed is half the DDR4 data rate.
  4. The memory bus clock speed is dictated by its own PLL.
  5. The integrated flash controller (IFC) clock speed on IFC\_CLK[0:1] is determined by the IFC module input clock (platform clock / 2) divided by the IFC ratio programmed in CCR[CLKDIV].
  6. See the chip reference manual for more information.
  7. 1200MHz bin cannot support Gen2, x4 PCIe. The minimum platform frequency should meet the requirements in [Minimum platform frequency requirements for high-speed interfaces](#).
  8. "Single Oscillator Source" Reference clock mode supports differential reference clock pair frequency of 100MHz.

4.1.2.1 *DDR clock ranges*

The DDR memory controller can run only in asynchronous mode, where the memory bus is clocked with the clock provided on the DDRCLK input pin, which has its own dedicated PLL.

This table provides the clocking specifications for the memory bus.

**Table 4-2.** Memory bus clocking specifications

Characteristic		Min	Max	Unit	Notes
Memory bus clock frequency	DDR4	625	800		

- Notes:
- Caution:** The platform clock to SYSCLK ratio and core to SYSCLK clock ratio settings must be chosen such that the resulting SYSCLK frequency, core frequency, and platform frequency do not exceed their respective maximum or minimum operating frequencies. See [Platform to SYSCLK PLL ratio](#), and [Core cluster to SYSCLK PLL ratio](#), and [DDR controller PLL ratios](#), for ratio settings.
  - The memory bus clock refers to the chip's memory controllers' D1\_MCK[0:1] and D1\_MCK[0:1]\_B output clocks, running at half of the DDR data rate.
  - The memory bus clock speed is dictated by its own PLL. See [DDR controller PLL ratios](#).
  - Minimum Frequency supported by DDR4 is 1250MT/s

4.1.3 **Platform to SYSCLK PLL ratio**

This table lists the allowed platform clock to SYSCLK ratios.

Because the DDR operates asynchronously, the memory-bus clock-frequency is decoupled from the platform bus frequency.

For all valid platform frequencies supported on this chip, set the RCW Configuration field SYS\_PLL\_CFG = 0b00.

**Table 4-3.** Platform to SYSCLK PLL ratios

Binary Value of SYS_PLL_RAT	Platform:SYSCLK Ratio
0_0011	3:1
0_0100	4:1
0_0101	5:1
0_0110	6:1
0_0111	7:1
0_1000	8:1
0_1001	9:1
All Others	Reserved

4.1.4 **Core cluster to SYSCLK PLL ratio**

The clock ratio between SYSCLK and each of the core cluster PLLs is determined by the binary value of the RCW Configuration field CGA\_PLLn\_RAT. This table describes the supported ratios. For all valid core cluster frequencies supported on this chip, set the RCW Configuration field CGA\_PLLn\_CFG = 0b00.

This table lists the supported asynchronous core cluster to SYSCLK ratios.

**Table 4-4.** Core cluster PLL to SYSCLK ratios

Binary value of CGA_PLLn_RAT(n=1 or 2)	Core cluster:SYSCLK Ratio
00_0110	6:1
00_0111	7:1
00_1000	8:1
00_1001	9:1
00_1010	10:1
00_1011	11:1
00_1100	12:1
00_1101	13:1
00_1110	14:1
00_1111	15:1
01_0000	16:1
01_0010	18:1
01_0100	20:1
01_0110	22:1
01_1001	25:1
01_1010	26:1
01_1011	27:1
All others	Reserved

#### 4.1.5 Core complex PLL select

The clock frequency of each core cluster is determined by the binary value of the RCW Configuration field Cn\_PLL\_SEL. These tables describe the selections available to each core cluster, where each individual core cluster can select a frequency from their respective tables.

#### NOTE

There is a restriction that requires that the frequency provided to the e5500 core cluster after any dividers must always be greater than half of the platform frequency. Special care must be used when selecting the /2 outputs of a cluster PLL in which this restriction is observed.

**Table 4-5.** Core cluster PLL select

Binary Value of Cn_PLL_SEL for n=1-4	Core cluster ratio
0000	CGA PLL1 /1
0001	CGA PLL1 /2
0100	CGA PLL2 /1
0101	CGA PLL2 /2
All Others	Reserved

**4.1.6 DDR controller PLL ratios**

The DDR memory controller operates asynchronous to the platform.

In asynchronous DDR mode, the DDR data rate to DDRCLK ratios supported are listed in the following table. This ratio is determined by the binary value of the RCW Configuration field MEM\_PLL\_RAT (bits 10-15).

The RCW Configuration field MEM\_PLL\_CFG (bits 8-9) must be set to MEM\_PLL\_CFG = 0b00 for all valid DDR PLL reference clock frequencies supported on this chip.

**Table 4-6.** DDR clock ratio

Binary value of MEM_PLL_RAT	DDR data-rate:DDRCLK ratio	Maximum supported DDR data-rate (MT/s)
00_1000	8:1	1066
00_1010	10:1	1333
00_1011	11:1	1465
00_1100	12:1	1600
00_1101	13:1	1300
00_1110	14:1	1400
00_1111	15:1	1500
01_0000	16:1	1600
1_0100	20:1	1333
1_1000	24:1	1600
All Others	Reserved	–

**4.1.7 SerDes PLL ratio**

The clock ratio between each of the two SerDes PLLs and their respective externally supplied SD1\_REF\_CLKn\_P/SD1\_REF\_CLKn\_N inputs is determined by a set of RCW Configuration fields- SRDS\_PRTCL\_S1, SRDS\_PLL\_REF\_CLK\_SEL\_S1, and SRDS\_DIV\_\*\_S1 as shown in this table.

**Table 4-7.** Valid SerDes RCW encodings and reference clocks

SerDes protocol (given lane)	Valid reference clock frequency	Legal setting for SRDS_PRTCL_S1	Legal setting for SRDS_PLL_REF_CLK_SEL_S1	Legal setting for SRDS_DIV_*_S1	Notes
<b>High-speed serial interfaces</b>					
PCI Express 2.5 Gbps (doesn't negotiate upwards)	100 MHz	Any PCIe	0b0: 100 MHz	2b10: 2.5 G	1
	125 MHz		0b1: 125 MHz		1
PCI Express 5 Gbps (can negotiate up to 5 Gbps)	100 MHz	Any PCIe	0b0: 100 MHz	2b01: 5.0 G	1
	125 MHz		0b1: 125 MHz		1
SATA (1.5 or 3 Gbps)	100 MHz	Any SATA	0b0: 100 MHz	Don't care	2
	125 MHz		0b1: 125 MHz		
Debug (2.5 Gbps)	100 MHz	Aurora @ 2.5/5 Gbps	0b0: 100 MHz	0b1: 2.5 G	–
	125 MHz		0b1: 125 MHz		–

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**Table 4-7.** Valid SerDes RCW encodings and reference clocks (Continued)

SerDes protocol (given lane)	Valid reference clock frequency	Legal setting for SRDS_PRTCL_S1	Legal setting for SRDS_PLL_RE F_CLK_SEL_S1	Legal setting for SRDS_DIV_*_S1	Notes
Debug (5 Gbps)	100 MHz	Aurora @ 2.5/5 Gbps	0b0: 100 MHz	0b0: 5.0 G	–
	125 MHz		0b1: 125 MHz		–
<b>Networking interfaces</b>					
SGMII (1.25 Gbps)	100 MHz	SGMII @ 1.25 Gbps 1000Base-KX @ 1.25 Gbps	0b0: 100 MHz	Don't care	–
	125 MHz		0b1: 125 MHz		–
QSGMII (5.0 Gbps)	100 MHz	Any QSGMII	0b0: 100 MHz	0b0: 5.0 G	–
	125 MHz		0b1: 125 MHz		–

- Notes:
1. A spread-spectrum reference clock is permitted for PCI Express. However, if any other high-speed interface such as SATA, SGMII, QSGMII, 1000Base-KX, is used concurrently on the same SerDes PLL, spread-spectrum clocking is not permitted.
  2. SerDes lanes configured as SATA initially operate at 3.0 Gbps. 1.5 Gbps operation may later be enabled through the SATA IP itself. It is possible for software to set each SATA at different rate.

#### 4.1.8 eSDHC SDR mode clock select

The eSDHC SDR mode is asynchronous to the platform.

This table describes the clocking options that may be applied to the eSDHC SDR mode. The clock selection is determined by the binary value of the RCW Clocking Configuration field HWA\_CGA\_M1\_CLK\_SEL.

**Table 4-8.** eSDHC SDR mode clock select

Binary value of HWA_CGA_M1_CLK_SEL	eSDHC SDR mode frequency <sup>1</sup>
0b000	Reserved
0b001	Cluster group A PLL 1/1
0b010	Cluster group A PLL 1/2
0b011	Cluster group A PLL 1/3
0b100	Cluster group A PLL 1/4
0b101	Reserved
0b110	Cluster group A PLL 2/2
0b111	Cluster group A PLL 2/3

- Notes:
1. For asynchronous mode, max frequency, see table "Processor clocking specifications" in the chip reference manual.
  2. For SDR104 and HS200 modes, CGA1 PLL should be set to provide a minimum of 1200MHz.
  3. For SDR50 mode, Cluster PLL should be set to provide a minimum of 600MHz

**4.1.9 Frequency options**

This section discusses interface frequency options.

**4.1.9.1 SYSCLK and core cluster frequency options**

This table shows the expected frequency options for SYSCLK and core cluster frequencies.

**Table 4-9.** SYSCLK and core cluster frequency options

Core cluster: SYSCLK Ratio	SYSCLK (MHz)				
	64.00	66.67	100.00	125.00	133.33
	<b>Core cluster Frequency (MHz)<sub>1</sub></b>				
6:1					800
7:1				875	933
8:1			800	1000	1067
9:1			900	1125	1200
10:1			1000	1250	1333
11:1			1100	1375	
12:1		800	1200	1500	
13:1	832	867	1300		
14:1	896	933	1400		
15:1	960	1000	1500		
16:1	1024	1067			
18:1	1152	1200			
20:1	1280	1333			
21:1	1344	1400			

- Notes: 1. Core cluster frequency values are shown rounded up to the nearest whole number (decimal place accuracy removed)  
 2. When using Single Source clocking only 100MHz input is available.

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## 4.1.9.2 SYCLK and platform frequency options

This table shows the expected frequency options for SYCLK and platform frequencies.

**Table 4-10.** SYCLK and platform frequency options

Platform: SYCLK Ratio	SYCLK (MHz)				
	64.00	66.67	100.00	125.00	133.33
	Platform Frequency (MHz) <sup>(1)</sup>				
3:1			300	375	400
4:1			400	500	533
5:1	320	333	500		
6:1	384	400	600		
7:1	448	467			
8:1	512	533			
	Platform Frequency (MHz) <sup>(1)</sup>				
9:1	576	600			

- Notes:
1. Platform frequency values are shown rounded down to the nearest whole number (decimal place accuracy removed)
  2. When using Single source clocking, only 100MHz options are valid

## 4.1.9.3 DDRCLK and DDR data rate frequency options

This table shows the expected frequency options for DDRCLK and DDR data rate frequencies.

**Table 4-11.** DDRCLK and DDR data rate frequency options

DDR data rate: DDRCLK Ratio	DDRCLK (MHz)				
	64.00	66.67	100.00	125.00	133.33
	DDR Data Rate (MT/s) <sup>1</sup>				
8:1				1000	1066
10:1			1000	1250	1333
11:1			1100	1375	1465
12:1			1200	1500	1600
13:1			1300		
14:1			1400		
15:1		1000	1500		
16:1	1024	1067	1600		
20:1	1280	1333			
24:1	1536	1600			

- Notes:
1. DDR data rate values are shown rounded up to the nearest whole number (decimal place accuracy removed)
  2. When using Single Source clocking, only 100MHz options are available.
  3. Minimum Frequency supported by DDR4 is 1250MT/s

4.1.9.4 *SYSCLK and eSDHC High Speed modes frequency options*

These table shows the expected frequency options for SYSCLK and eSDHC High Speed modes.

**Table 4-12.** SYSCLK and eSDHC High Speed mode frequency options (clocked by CGA PLL1 /1)

Core cluster: SYSCLK Ratio	SYSCLK (MHz)				
		64.00	66.67	100.00	125.00
	Resultant Frequency (MHz) <sup>1</sup>				
9:1					1200
12:1			1200		
18:1	1152	1200			

- Notes: 1. Resultant frequency values are shown rounded up to the nearest whole number (decimal place accuracy removed)  
 2. For Low speed operation, eSDHC is clocked from Platform PLL and does not use CGA PLL.

4.1.9.5 *Minimum platform frequency requirements for high-speed interfaces*

The platform clock frequency must be considered for proper operation of high-speed interfaces as described below.

For proper PCI Express operation, the platform clock frequency must be greater than or equal to:

**Figure 4-1.** Gen 1 PEX minimum platform frequency

$$\frac{527 \text{ MHz} \times (\text{PCI Express link width})}{8}$$

**Figure 4-2.** Gen 2 PEX minimum platform frequency

$$\frac{527 \text{ MHz} \times (\text{PCI Express link width})}{4}$$

See section "Link Width," in the chip reference manual for PCI Express interface width details. Note that "PCI Express link width" in the above equation refers to the negotiated link width as the result of PCI Express link training, which may or may not be the same as the link width POR selection. It refers to the widest port in use, not the combined width of the number ports in use. For instance, if two x4 PCIe Gen2 ports are in use, 527MHz platform frequency is needed to support by using Gen 2 equation (527 × 4 / 4, not 527 × 4 × 2 / 4).

**NOTES**

1. Platform needs to run at a minimum frequency of 527MHz for PEX in Gen2 speed with x4 link width.
2. Platform needs to run at a minimum frequency of 400MHz for PEX in Gen2 speed.

## 4.2 Power supply design

### 4.2.1 Core and platform supply voltage filtering

The  $V_{DD}$ ,  $V_{DDC}$  supply is normally derived from a high current capacity linear or switching power supply which can regulate its output voltage very accurately despite changes in current demand from the chip within the regulator's relatively low bandwidth. Several bulk decoupling capacitors must be distributed around the PCB to supply transient current demand above the bandwidth of the voltage regulator.

These bulk capacitors should have a low ESR (equivalent series resistance) rating to ensure the quick response time necessary. They should also be connected to the power and ground planes through two vias to minimize inductance. However, customers should work directly with their power regulator vendor for best values and types of bulk capacitors.

As a guideline for customers and their power regulator vendors, Teledyne e2v recommends that these bulk capacitors be chosen to maintain the positive transient power surges to less than 1.0V+50 mV (negative transient undershoot should comply with specification of 1.0V-30mV) for current steps of up to 10A with a slew rate of 12 A/us.

These bulk decoupling capacitors will ideally supply a stable voltage for current transients into the megahertz range. Above that, see [Decoupling recommendations](#) for further decoupling recommendations.

### 4.2.2 PLL power supply filtering

Each of the PLLs described in [System clocking](#) is provided with power through independent power supply pins ( $AV_{DD\_PLAT}$ ,  $AV_{DD\_CGA1}$ ,  $AV_{DD\_CGA2}$ ,  $AV_{DD\_D1}$  and  $AV_{DD\_SD1\_PLLn}$ ).  $AV_{DD\_PLAT}$ ,  $AV_{DD\_CGA1}$ ,  $AV_{DD\_CGA2}$  and  $AV_{DD\_D1}$  voltages must be derived directly from a 1.8V voltage source through a low frequency filter scheme.  $AV_{DD\_SD1\_PLLn}$  voltages must be derived directly from the  $X1V_{DD}$  source through a low frequency filter scheme. The recommended solution for PLL filtering is to provide independent filter circuits per PLL power supply, as illustrated in [Figure 4-3](#), one for each of the  $AV_{DD}$  pins. By providing independent filters to each PLL, the opportunity to cause noise injection from one PLL to the other is reduced. This circuit is intended to filter noise in the PLL's resonant frequency range from a 500 kHz to 10 MHz range.

Each circuit should be placed as close as possible to the specific  $AV_{DD}$  pin being supplied to minimize noise coupled from nearby circuits. It should be possible to route directly from the capacitors to the  $AV_{DD}$  pin, which is on the periphery of the footprint, without the inductance of vias.

This figure shows the PLL power supply filter circuit. Where:

- $R = 5\Omega \pm 5\%$
- $C1 = 10 \mu F \pm 10\%$ , 0603, X5R, with  $ESL \leq 0.5 \text{ nH}$
- $C2 = 1.0 \mu F \pm 10\%$ , 0402, X5R, with  $ESL \leq 0.5 \text{ nH}$

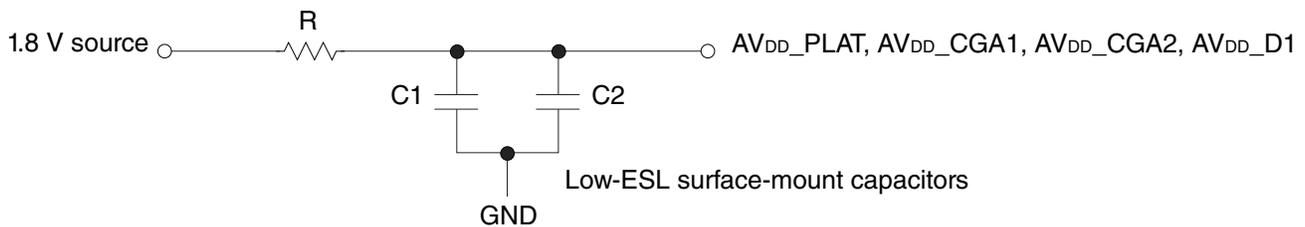
#### NOTE

A higher capacitance value for C2 may be used to improve the filter as long as the other C2 parameters do not change (0402 body, X5R,  $ESL \leq 0.5 \text{ nH}$ ).

#### NOTE

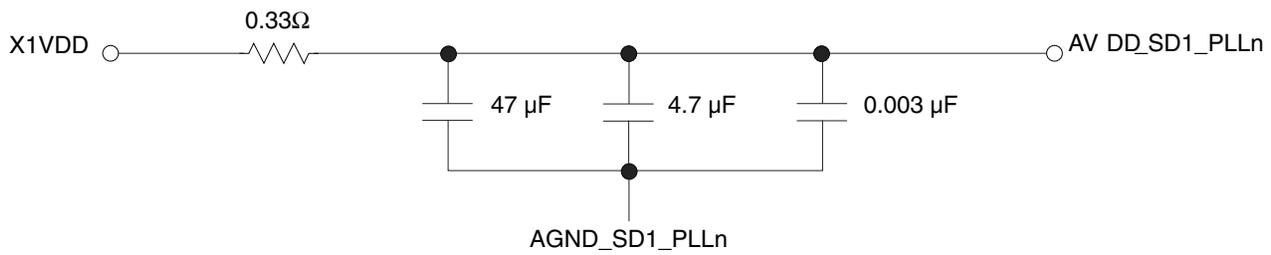
Voltage for AVDD is defined at the input of the PLL supply filter and not the pin of AVDD.

**Figure 4-3.** PLL power supply filter circuit



The AV<sub>DD</sub>\_SD1\_PLLn signals provides power for the analog portions of the SerDes PLL. To ensure stability of the internal clock, the power supplied to the PLL is filtered using a circuit similar to the one shown in following Figure 4-4. For maximum effectiveness, the filter circuit is placed as closely as possible to the AV<sub>DD</sub>\_SD1\_PLLn balls to ensure it filters out as much noise as possible. The ground connection should be near the AV<sub>DD</sub>\_SD1\_PLLn balls. The 0.003-μF capacitors closest to the balls, followed by a 4.7-μF and 47-μF capacitor, and finally the 0.33Ω resistor to the board supply plane. The capacitors are connected from AV<sub>DD</sub>\_SD1\_PLLn to the ground plane. Use ceramic chip capacitors with the highest possible self-resonant frequency. All traces should be kept short, wide, and direct.

**Figure 4-4.** SerDes PLL power supply filter circuit



Note the following:

- AV<sub>DD</sub>\_SDn\_PLLn should be a filtered version of XnV<sub>DD</sub>.
- Signals on the SerDes interface are fed from the X1V<sub>DD</sub> power plane.
- Voltage for AV<sub>DD</sub>\_SD1\_PLLn is defined at the PLL supply filter and not the pin of AV<sub>DD</sub>\_SD1\_PLLn.
- A 47-μF 0805 XR5 or XR7, 4.7-μF 0603, and 0.003-μF 0402 capacitor are recommended. The size and material type are important. A 0.33-Ω ± 1% resistor is recommended.
- There needs to be dedicated analog ground, AGND\_SD1\_PLLn for each AV<sub>DD</sub>\_SD1\_PLLn pin up to the physical local of the filters themselves.

### 4.2.3 S1V<sub>DD</sub> power supply filtering

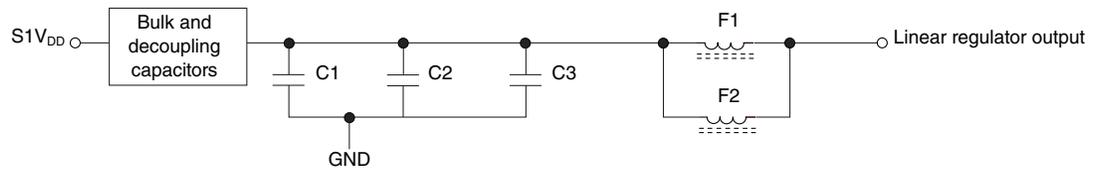
S1V<sub>DD</sub> should be supplied by a linear regulator.

An example solution for S1V<sub>DD</sub> filtering, is illustrated in Figure 4-5. The component values in this example filter are system dependent and are still under characterization, component values may need adjustment based on the system or environment noise.

Where:

- C1 = 0.003 μF ± 10%, X5R, with ESL ≤ .0.5 nH
- C2 and C3 = 2.2 μF ± 10%, X5R, with ESL ≤ .0.5 nH
- F1 and F2 = 120Ω at 100 MHz 2A 25% 0603 Ferrite (for example, Murata BLM18PG121SH1)
- Bulk and decoupling capacitors are added, as needed, per power supply design.

**Figure 4-5.**  $S1V_{DD}$  power supply filter circuit



Note the following:

- Refer to [Power-on ramp rate](#), for maximum  $S1V_{DD}$  power-up ramp rate.
- There needs to be enough output capacitance or a soft start feature to assure ramp rate requirement is met.
- The ferrite beads should be placed in parallel to reduce voltage droop.
- Besides a linear regulator, a low noise dedicated switching regulator can also be used. 10 mVp-p, 50kHz - 500MHz is the noise goal.

#### 4.2.4 $X1V_{DD}$ power supply filtering

$X1V_{DD}$  may be supplied by a linear regulator or sourced by a filtered  $G1V_{DD}$ . Systems may design in both options to allow flexibility to address system noise dependencies. However, for initial system bring-up, the linear regulator option is highly recommended.

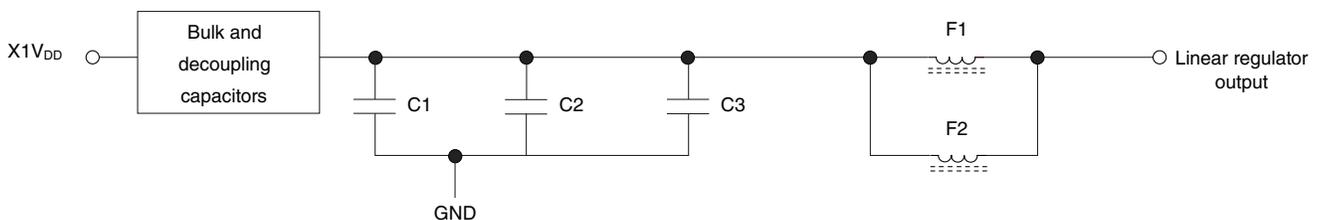
An example solution for  $X1V_{DD}$  filtering, where  $X1V_{DD}$  is sourced from a linear regulator, is illustrated in [Figure 4-6](#). The component values in this example filter are system dependent and are still under characterization, component values may need adjustment based on the system or environment noise.

Where:

- $C1 = 0.003 \mu\text{F} \pm 10\%$ , X5R, with  $\text{ESL} \leq .0.5 \text{ nH}$
- $C2$  and  $C3 = 2.2 \mu\text{F} \pm 10\%$ , X5R, with  $\text{ESL} \leq .0.5 \text{ nH}$
- $F1$  and  $F2 = 120\Omega$  at 100 MHz 2A 25% 0603 Ferrite (for example, Murata BLM18PG121SH1)
- Bulk and decoupling capacitors are added, as needed, per power supply design.

Note the following:

**Figure 4-6.**  $X1V_{DD}$  power supply filter circuit



- See [Power-on ramp rate](#) for maximum  $X1V_{DD}$  power-up ramp rate.
- There needs to be enough output capacitance or a soft-start feature to assure ramp rate requirement is met.
- The ferrite beads should be placed in parallel to reduce voltage droop.
- Besides a linear regulator, a low-noise, dedicated switching regulator can be used. 10 mVp-p, 50 kHz - 500 MHz is the noise goal.

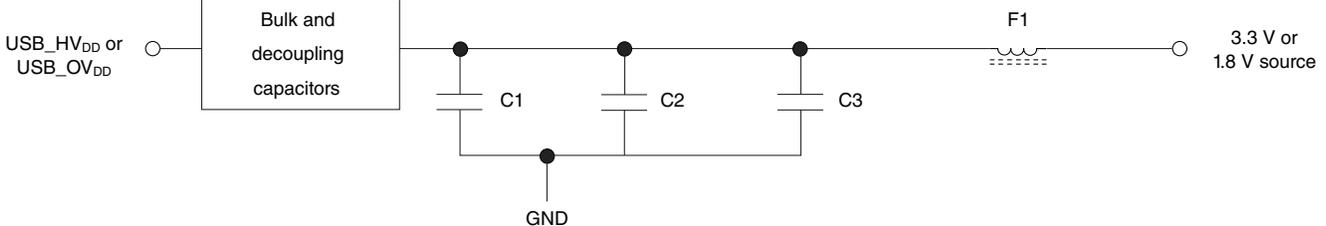
**4.2.5 USB\_HV<sub>DD</sub> and USB\_OV<sub>DD</sub> power supply filtering**

USB\_HV<sub>DD</sub> and USB\_OV<sub>DD</sub> must be sourced by a filtered 3.3V and 1.8V voltage source using a star connection. An example solution for USB\_HV<sub>DD</sub> and USB\_OV<sub>DD</sub> filtering, where USB\_HV<sub>DD</sub> and USB\_OV<sub>DD</sub> are sourced from a 3.3V and 1.8V voltage source, is illustrated in the following figure. The component values in this example filter is system dependent and are still under characterization, component values may need adjustment based on the system or environment noise.

Where:

- C1 = 0.003 μF ± 10%, X5R, with ESL ≤ 0.5 nH
- C2 and C3 = 2.2 μF ± 10%, X5R, with ESL ≤ 0.5 nH
- F1 = 120Ω at 100 MHz 2A 25% Ferrite (for example, Murata BLM18PG121SH1)
- Bulk and decoupling capacitors are added, as needed, per power supply design.

**Figure 4-7.** USB\_HV<sub>DD</sub> and USB\_OV<sub>DD</sub> power supply filter circuit



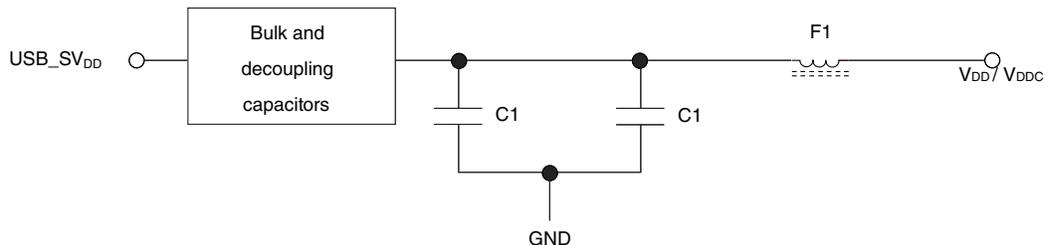
**4.2.6 USB\_SV<sub>DD</sub> power supply filtering**

USB\_SV<sub>DD</sub> must be sourced by a filtered V<sub>DD</sub> or V<sub>DDC</sub> using a star connection. An example solution for USB\_SV<sub>DD</sub> filtering, where USB\_SV<sub>DD</sub> is sourced from V<sub>DD</sub>, is illustrated in the following figure. The component values in this example filter is system dependent and are still under characterization, component values may need adjustment based on the system or environment noise.

Where:

- C1 = 2.2 μF ± 20%, X5R, with Low ESL (for example, Panasonic ECJ0EB0J225M)
- F1 = 120Ω at 100-MHz 2A 25% Ferrite (for example, Murata BLM18PG121SH1)
- Bulk and decoupling capacitors are added, as needed, per power supply design.

**Figure 4-8.** USB\_SV<sub>DD</sub> power supply filter circuit



## 4.3 Decoupling recommendations

Due to large address and data buses, and high operating frequencies, the device can generate transient power surges and high frequency noise in its power supply, especially while driving large capacitive loads. This noise must be prevented from reaching other components in the chip system, and the chip itself requires a clean, tightly regulated source of power. Therefore, it is recommended that the system designer place at least one decoupling capacitor at each  $V_{DD}$ ,  $V_{DDC}$ ,  $CV_{DD}$ ,  $OnV_{DD}$ ,  $DV_{DD}$ ,  $EV_{DD}$ ,  $GnV_{DD}$ , and  $LnV_{DD}$  pin of the device. These decoupling capacitors should receive their power from separate  $V_{DD}$ ,  $CV_{DD}$ ,  $OnV_{DD}$ ,  $DV_{DD}$ ,  $EV_{DD}$ ,  $GnV_{DD}$ ,  $LnV_{DD}$ , and GND power planes in the PCB, utilizing short traces to minimize inductance. Capacitors may be placed directly under the device using a standard escape pattern. Others may surround the part.

These capacitors should have a value of 0.1  $\mu\text{F}$ . Only ceramic SMT (surface mount technology) capacitors should be used to minimize lead inductance, preferably 0402 or 0201 sizes.

As presented in [Core and platform supply voltage filtering](#), it is recommended that there be several bulk storage capacitors distributed around the PCB, feeding the  $V_{DD}$ ,  $V_{DDC}$  and other planes (for example,  $CV_{DD}$ ,  $OnV_{DD}$ ,  $DV_{DD}$ ,  $EV_{DD}$ ,  $GnV_{DD}$ , and  $LnV_{DD}$ ), to enable quick recharging of the smaller chip capacitors.

## 4.4 SerDes block power supply decoupling recommendations

The SerDes block requires a clean, tightly regulated source of power ( $S1V_{DD}$  and  $X1V_{DD}$ ) to ensure low jitter on transmit and reliable recovery of data in the receiver. An appropriate decoupling scheme is outlined below.

### NOTE

Only SMT capacitors should be used to minimize inductance. Connections from all capacitors to power and ground should be done with multiple vias to further reduce inductance.

1. The board should have at least  $1 \times 0.1\text{-}\mu\text{F}$  SMT ceramic chip capacitor placed as close as possible to each supply ball of the device. Where the board has blind vias, these capacitors should be placed directly below the chip supply and ground connections. Where the board does not have blind vias, these capacitors should be placed in a ring around the device as close to the supply and ground connections as possible.
2. Between the device and any SerDes voltage regulator there should be a lower bulk capacitor for example a 10- $\mu\text{F}$ , low ESR SMT tantalum or ceramic and a higher bulk capacitor for example a 100 $\mu\text{F}$  - 300- $\mu\text{F}$  low ESR SMT tantalum or ceramic capacitor.

## 4.5 Connection recommendations

The following is a list of connection recommendations:

- To ensure reliable operation, it is highly recommended to connect unused inputs to an appropriate signal level. Unless otherwise noted in this document, all unused active low inputs should be tied to  $V_{DD}$ ,  $OnV_{DD}$ ,  $DV_{DD}$ ,  $GnV_{DD}$ ,  $EV_{DD}$ ,  $CV_{DD}$  and  $LnV_{DD}$  as required. All unused active high inputs should be connected to GND. All NC (no-connect) signals must remain unconnected. Power and ground connections must be made to all external  $V_{DD}$ ,  $OnV_{DD}$ ,  $DV_{DD}$ ,  $GnV_{DD}$ ,  $LnV_{DD}$ ,  $EV_{DD}$ ,  $CV_{DD}$  and GND pins of the device.
- The TEST\_SEL\_B pin must be pulled to  $O1V_{DD}$  through a 100- $\Omega$  to 1k- $\Omega$  resistor for QT1040 and tied to ground for 2 core QT1020.
- The chip has temperature diodes on the microprocessor that can be used in conjunction with other system temperature monitoring devices (such as Analog Devices, ADT7461A™). If a temperature diode monitoring device is not connected, these pins may be connected to test points or grounded.

#### 4.5.1 Legacy JTAG configuration signals

Correct operation of the JTAG interface requires configuration of a group of system control pins as demonstrated in [Figure 4-10](#). Care must be taken to ensure that these pins are maintained at a valid deasserted state under normal operating conditions as most have asynchronous behavior and spurious assertion will give unpredictable results.

Boundary-scan testing is enabled through the JTAG interface signals. The TRST\_B signal is optional in the IEEE Std 1149.1 specification, but it is provided on all processors built on Power Architecture technology. The device requires TRST\_B to be asserted during power-on reset flow to ensure that the JTAG boundary logic does not interfere with normal chip operation. While the TAP controller can be forced to the reset state using only the TCK and TMS signals, generally systems assert TRST\_B during the power-on reset flow. Simply tying TRST\_B to PORESET\_B is not practical because the JTAG interface is also used for accessing the common on-chip processor (COP), which implements the debug interface to the chip.

The COP function of these processors allow a remote computer system (typically, a PC with dedicated hardware and debugging software) to access and control the internal operations of the processor. The COP interface connects primarily through the JTAG port of the processor, with some additional status monitoring signals. The COP port requires the ability to independently assert PORESET\_B or TRST\_B in order to fully control the processor. If the target system has independent reset sources, such as voltage monitors, watchdog timers, power supply failures, or push-button switches, then the COP reset signals must be merged into these signals with logic.

The arrangement shown in [Figure 4-10](#) allows the COP port to independently assert PORESET\_B or TRST\_B, while ensuring that the target can drive PORESET\_B as well.

The COP interface has a standard header, shown in [Figure 4-9](#), for connection to the target system, and is based on the 0.025" square-post, 0.100" centered header assembly (often called a Berg header). The connector typically has pin 14 removed as a connector key.

The COP header adds many benefits such as breakpoints, watchpoints, register and memory examination/modification, and other standard debugger features. An inexpensive option can be to leave the COP header unpopulated until needed.

There is no standardized way to number the COP header; so emulator vendors have issued many different pin numbering schemes. Some COP headers are numbered top-to-bottom then left-to-right, while others use left-to-right then top-to-bottom. Still others number the pins counter-clockwise from pin 1 (as with an IC). Regardless of the numbering scheme, the signal placement recommended in [Figure 4-9](#) is common to all known emulators.

## 4.5.1.1 Termination of unused signals

If the JTAG interface and COP header will not be used, Teledyne e2v recommends the following connections:

- TRST\_B should be tied to PORESET\_B through a 0 kΩ isolation resistor so that it is asserted when the system reset signal (PORESET\_B) is asserted, ensuring that the JTAG scan chain is initialized during the power-on reset flow. Teledyne e2v recommends that the COP header be designed into the system as shown in [Figure 4-10](#). If this is not possible, the isolation resistor will allow future access to TRST\_B in case a JTAG interface may need to be wired onto the system in future debug situations.
- No pull-up/pull-down is required for TDI, TMS or TDO.

**Figure 4-9.** Legacy COP Connector Physical Pinout

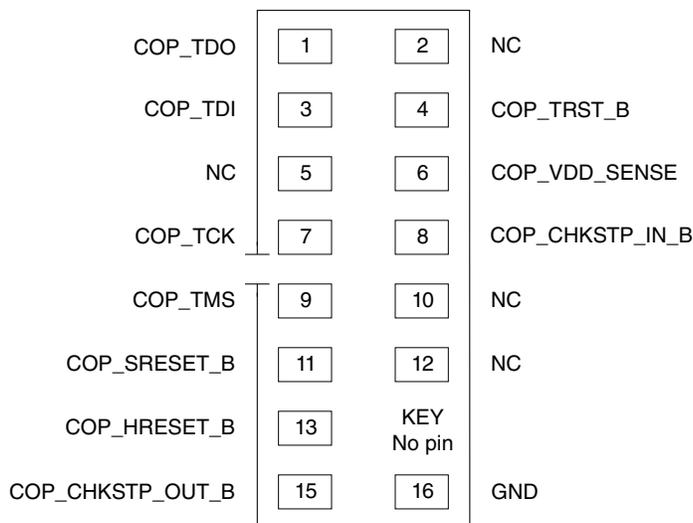
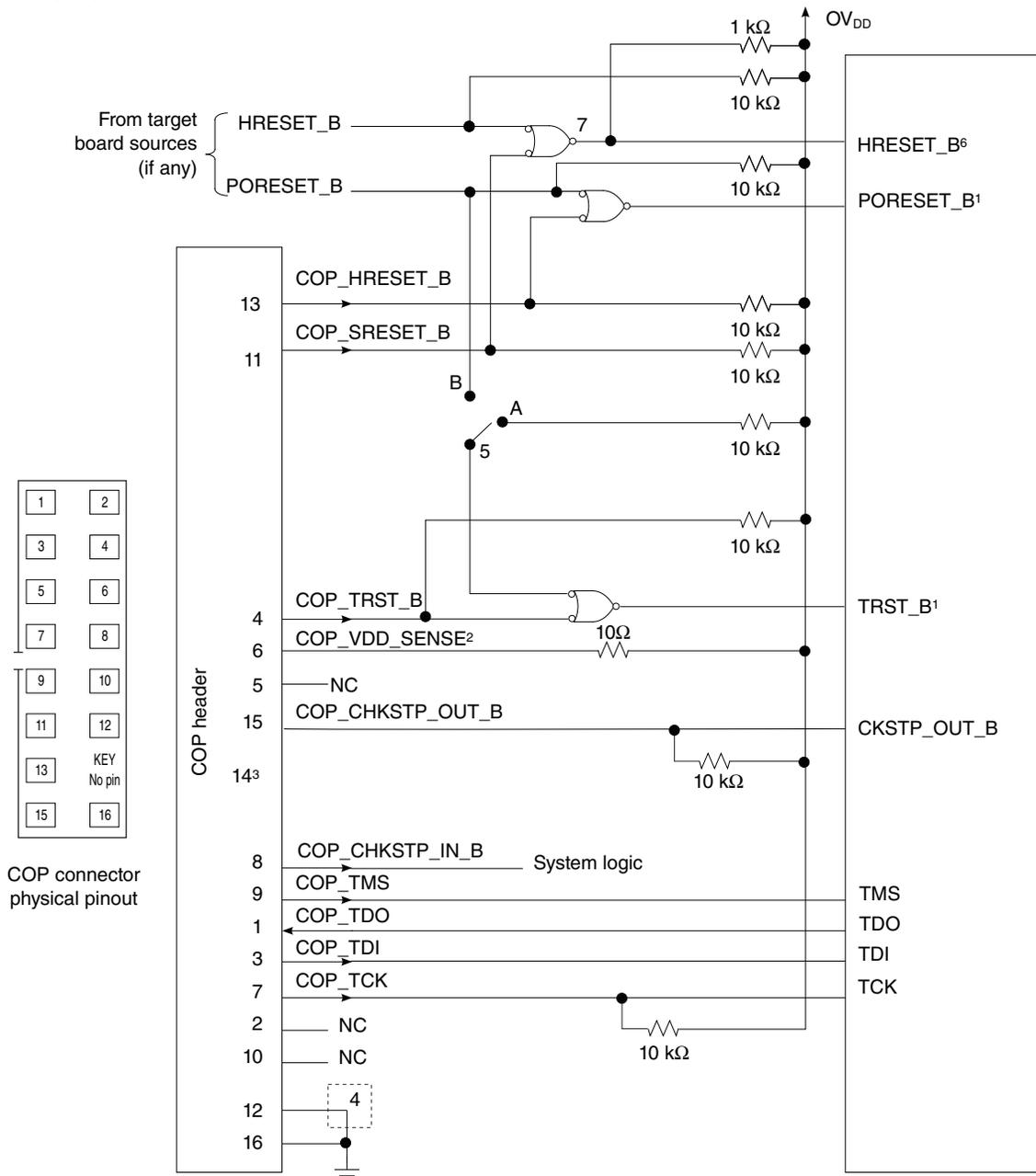


Figure 4-10. Legacy JTAG Interface Connection



- Notes:
1. The COP port and target board should be able to independently assert PORESET\_B and TRST\_B to the processor in order to fully control the processor as shown here.
  2. Populate this with a 10Ω resistor for short-circuit/current-limiting protection.
  3. The KEY location (pin 14) is not physically present on the COP header.
  4. Although pin 12 is defined as a no-connect, some debug tools may use pin 12 as an additional GND pin for improved signal integrity.
  5. This switch is included as a precaution for BSDL testing. The switch should be closed to position A during BSDL testing to avoid accidentally asserting the TRST\_B line. If BSDL testing is not being performed, this switch should be closed to position B.
  6. Asserting HRESET\_B causes a hard reset on the device
  7. This is an open-drain output gate.

## 4.5.2 Aurora configuration signals

Correct operation of the Aurora interface requires configuration of a group of system control pins as demonstrated in the figures below. Care must be taken to ensure that these pins are maintained at a valid deasserted state under normal operating conditions as most have asynchronous behavior and spurious assertion will give unpredictable results.

Teledyne e2v recommends that the Aurora 34 pin duplex connector be designed into the system as shown in [Figure 4-11](#) or the 70 pin duplex connector be designed into the system as shown in [Figure 4-12](#).

If the Aurora interface will not be used, Teledyne e2v recommends the legacy COP header be designed into the system as described in.

**Figure 4-11.** Aurora 34 pin connector duplex pinout

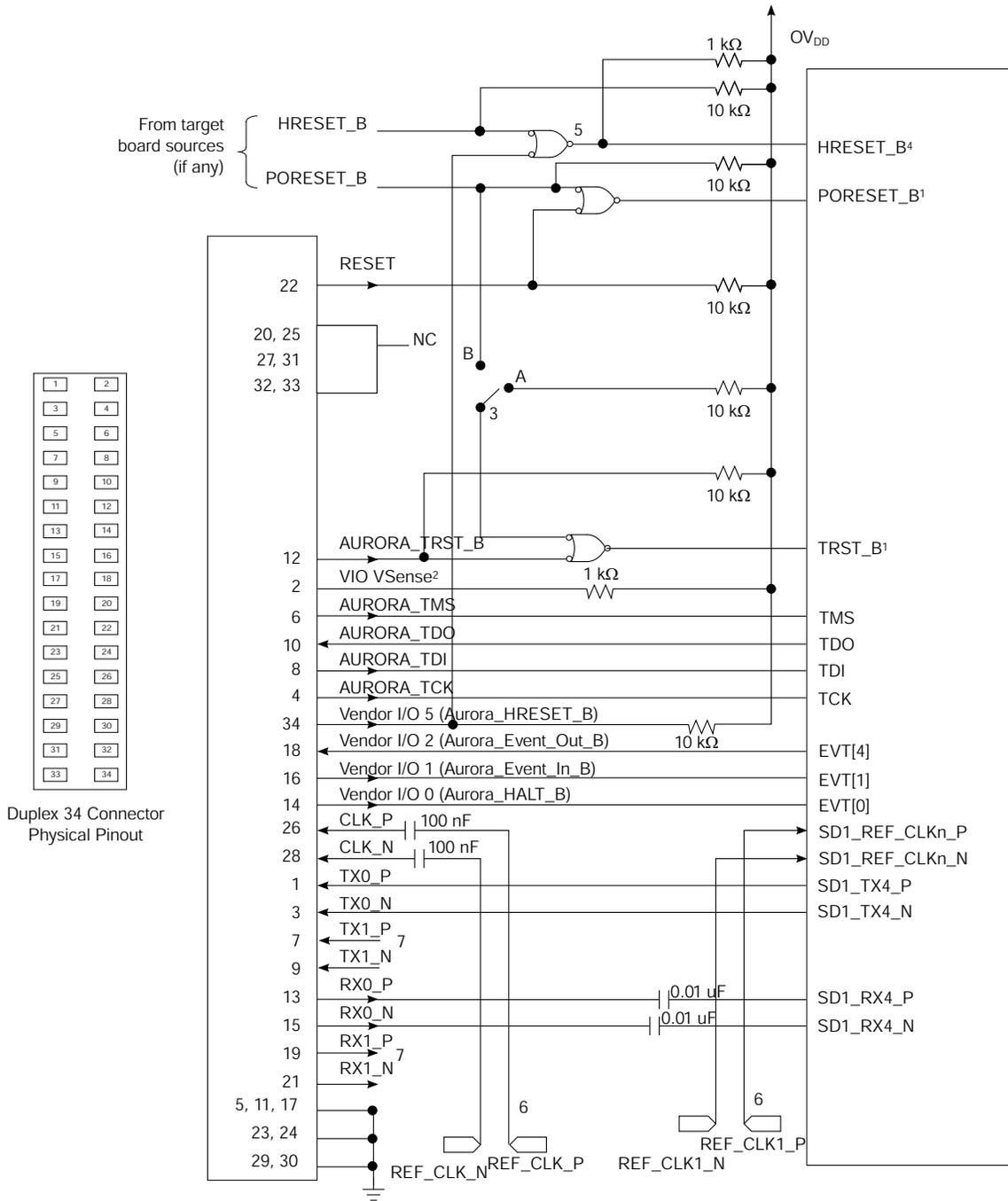
TX0_P	1	2	VIO (VSense)
TX0_N	3	4	TCK
GND	5	6	TMS
TX1_P	7	8	TDI
TX1_N	9	10	TDO
GND	11	12	TRST
RX0_P	13	14	Vendor I/O 0
RX0_N	15	16	Vendor I/O 1
GND	17	18	Vendor I/O 2
RX1_P	19	20	Vendor I/O 3
RX1_N	21	22	RESET
GND	23	24	GND
TX2_P	25	26	CLK_P
TX2_N	27	28	CLK_N
GND	29	30	GND
TX3_P	31	32	Vendor I/O 4
TX3_N	33	34	Vendor I/O 5

Figure 4-12. Aurora 70 pin connector duplex pinout

TX0_P	1	2	VIO (VSense)
TX0_N	3	4	TCK
GND	5	6	TMS
TX1_P	7	8	TDI
TX1_N	9	10	TDO
GND	11	12	TRST
RX0_P	13	14	Vendor I/O 0
RX0_N	15	16	Vendor I/O 1
GND	17	18	Vendor I/O 2
RX1_P	19	20	Vendor I/O 3
RX1_N	21	22	RESET
GND	23	24	GND
TX2_P	25	26	CLK_P
TX2_N	27	28	CLK_N
GND	29	30	GND
TX3_P	31	32	Vendor I/O 4
TX3_N	33	34	Vendor I/O 5
GND	35	36	GND
RX2_P	37	38	N/C
RX2_N	39	40	N/C
GND	41	42	GND
RX3_P	43	44	N/C
RX3_N	45	46	N/C
GND	47	48	GND
TX4_P	49	50	N/C
TX4_N	51	52	N/C
GND	53	54	GND
TX5_P	55	56	N/C
TX5_N	57	58	N/C
GND	59	60	GND
TX6_P	61	62	N/C
TX6_N	63	64	N/C
GND	65	66	GND
TX7_P	67	68	N/C
TX7_N	69	70	N/C

# QT1040/QT1020 4GB

Figure 4-13. Aurora 34 pin connector duplex interface connection

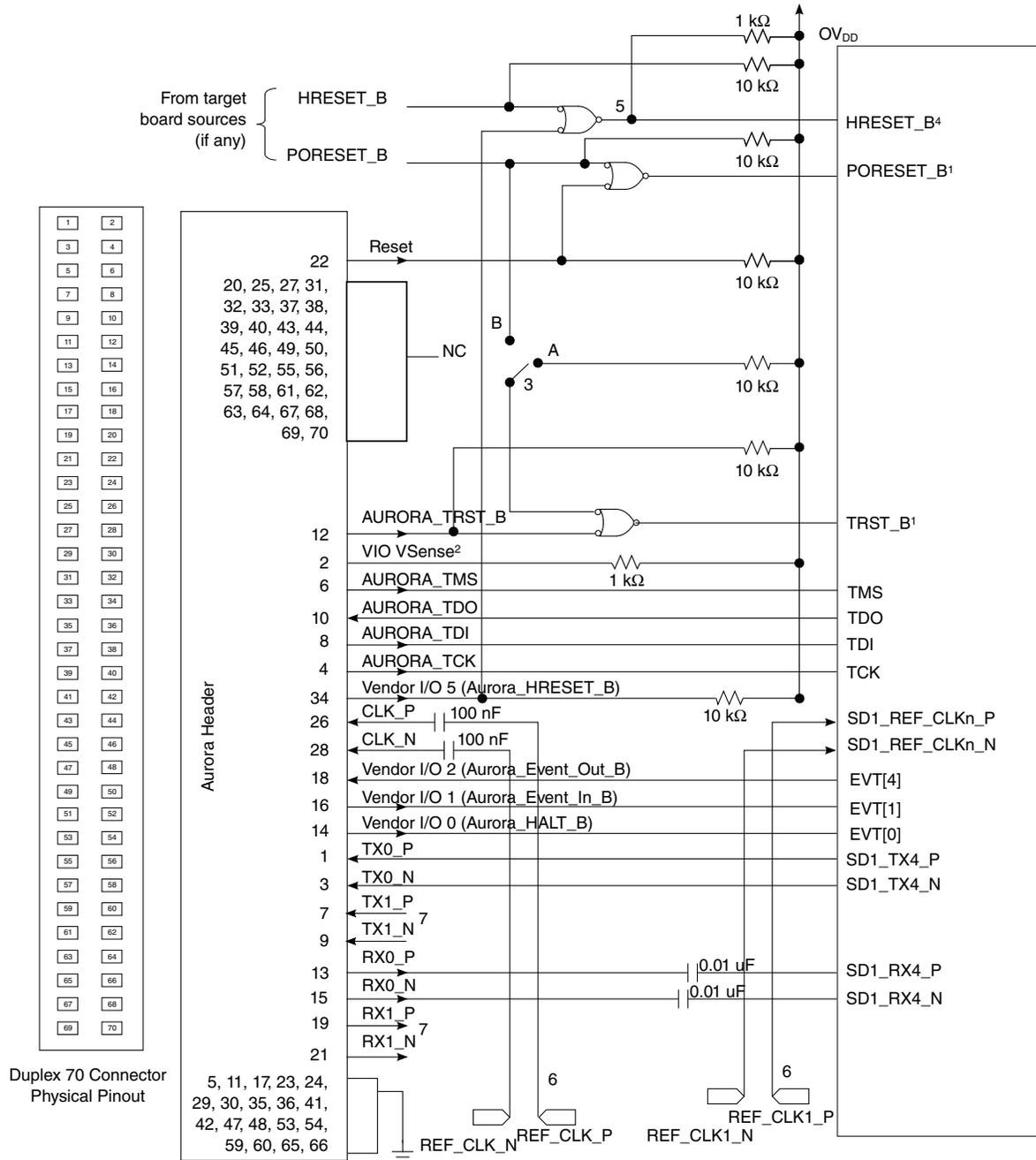


- Notes:
1. The Aurora port and target board should be able to independently assert PORESET\_B and TRST\_B to the processor in order to fully control the processor as shown here.
  2. Populate this with a 1 kΩ resistor for short-circuit/current-limiting protection.
  3. This switch is included as a precaution for BSDL testing. The switch should be closed to position A during BSDL testing to avoid accidentally asserting the TRST\_B line. If BSDL testing is not being performed, this switch should be closed to position B.
  4. Asserting HRESET\_B causes a hard reset on the device.
  5. This is an open-drain output gate.

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- 6. REF\_CLK\_P/REF\_CLK\_N and REF\_CLK1\_P/REFCLK1\_N are buffered clocks from the same common source.
- 7. RX1\_P/RX1\_N and TX1\_P/TX1\_N can be left floating at Aurora Header

Figure 4-14. Aurora 70 pin connector duplex interface connection



- Notes:
- 1. The Aurora port and target board should be able to independently assert PORESET\_B and TRST\_B to the processor in order to fully control the processor as shown here.
  - 2. Populate this with a 1 kΩ resistor for short-circuit/current-limiting protection.
  - 3. This switch is included as a precaution for BSDL testing. The switch should be closed to position A during BSDL testing to avoid accidentally asserting the TRST\_B line. If BSDL testing is not being performed, this switch should be closed to position B.

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4. Asserting HRESET\_B causes a hard reset on the device
5. This is an open-drain output gate.
6. REF\_CLK\_P/REF\_CLK\_N and REF\_CLK1\_P/REFCLK1\_N are buffered clocks from the same common source.
7. RX1\_P/RX1\_N and TX1\_P/TX1\_N can be left floating at Aurora Header

## 4.5.3 Guidelines for high-speed interface termination

### 4.5.3.1 SerDes interface entirely unused

If the high-speed SerDes interface is not used at all, the unused pin should be terminated as described in this section.

Note that S1V<sub>DD</sub>, X1V<sub>DD</sub> and AVDD\_SD1\_PLL1 must remain powered.

For AVDD\_SD1\_PLL1, it must be connected to X1V<sub>DD</sub> through a zero ohm resistor (instead of filter circuit shown in [Figure 4-4](#)).

The following pins must be left unconnected:

- SD1\_TX[7:0]\_P
- SD1\_TX[7:0]\_N
- SD1\_IMP\_CAL\_RX
- SD1\_IMP\_CAL\_TX

The following pins must be connected to S1GND:

- SD1\_REF\_CLK1\_P, SD1\_REF\_CLK2\_P
- SD1\_REF\_CLK1\_N, SD1\_REF\_CLK2\_N

It is recommended for the following pins to be connected to S1GND:

- SD1\_RX[7:0]\_P
- SD1\_RX[7:0]\_N

It is possible to disable SerDes module by disabling all PLLs associated with it. SerDes is disabled as follows:

- SRDS\_PLL\_PD\_S1 = 2'b11 (both PLLs configured as powered down, all data lanes selected by the protocols defined in SRDS\_PRTCL\_S1 associated to the PLLs are powered down as well)
- SRDS\_PLL\_REF\_CLK\_SEL\_S1 = 2'b00
- SRDS\_PRTCL\_S1 = 2 (no other values permitted when both PLLs are powered down)

### 4.5.3.2 SerDes interface partly unused

If only part of the high speed SerDes interface pins are used, the remaining high-speed serial I/O pins should be terminated as described in this section.

Note that both S1V<sub>DD</sub> and X1V<sub>DD</sub> must remain powered.

If any of the PLLs are un-used, the corresponding AVDD\_SD1\_PLL1 must be connected to X1V<sub>DD</sub> through a zero ohm resistor (instead of filter circuit shown in [Figure 4-4](#)).

The following unused pins must be left unconnected:

- SD1\_TX[7:0]\_P
- SD1\_TX[7:0]\_N

The following unused pins must be connected to S1GND:

- SD1\_REF\_CLK[1:2]\_P, SD1\_REF\_CLK[1:2]\_N (If entire SerDes unused) It is recommended for the following unused pins to be connected to S1GND:
- SD1\_RX[7:0]\_P
- SD1\_RX[7:0]\_N

In the RCW configuration field SRDS\_PLL\_PD\_S1, the respective bits for each unused PLL must be set to power it down. A module is disabled when both its PLLs are turned off.

Unused lanes must be powered down through the SRDSx Lane m General Control Register 0 (SRDSxLNmGCR0) as follows:

- SRDSxLNmGCR0[RRST] = 0
- SRDSxLNmGCR0[TRST] = 0
- SRDSxLNmGCR0[RX\_PD] = 1
- SRDSxLNmGCR0[TX\_PD] = 1

Note that in the case where the SerDes pins are connected to slots, it is acceptable to have these pins unterminated when unused.

#### 4.5.4 USB controller connections

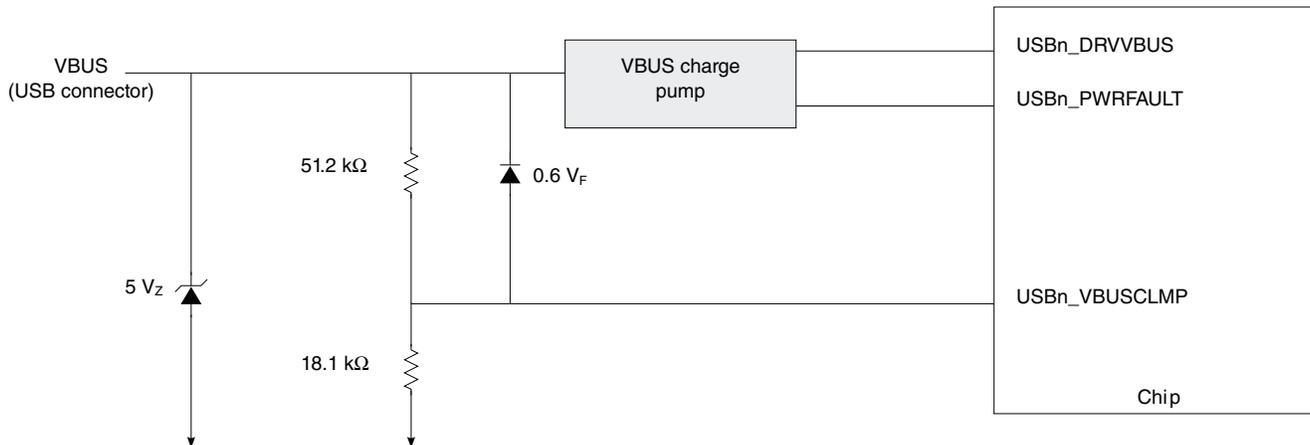
This section details the hardware connections required for the USB controllers.

##### 4.5.4.1 USB divider network

This figure shows the required divider network for the VBUS interface for the chip. Additional requirements for the external components are:

- Both resistors require 1% accuracy and a current capability of up to 1 mA. They must both have the same temperature coefficient and accuracy.
- The zener diode must have a value of 5V-5.25V.
- The 0.6V diode requires an  $I_F = 10\text{ mA}$ ,  $I_R < 500\text{ nA}$  and  $V_{F(Max)} = 0.8\text{V}$ . If the USB PHY does not support OTG mode, this diode can be removed from the schematic or made a DNP component.

Figure 4-15. Divider network at VBUS



## 4.6 Thermal

This table shows the thermal characteristics for the chip. Note that these numbers are based on design estimates and are preliminary.

**Table 4-13.** Package thermal characteristics<sup>(5)</sup>

Rating	Board	Symbol	Value	Unit	Notes
Junction to ambient, natural convection	Single-layer board (1s)	$R_{\theta JA}$	28	°C/W	(1)(2)
Junction to ambient, natural convection	Four-layer board (2s2p)	$R_{\theta JA}$	19	°C/W	(1)(3)
Junction to ambient (at 200 ft./min.)	Single-layer board (1s)	$R_{\theta JMA}$	22	°C/W	(1)(2)
Junction to ambient (at 200 ft./min.)	Four-layer board (2s2p)	$R_{\theta JMA}$	15	°C/W	(1)(2)
Junction to board	–	$R_{\theta JB}$	9	°C/W	(3)
Junction to case top	–	$R_{\theta JCTop}$	<0.1	°C/W	(4)

- Notes:
1. Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.
  2. Per JEDEC JESD51-3 and JESD51-6 with the board (JESD51-9) horizontal.
  3. Thermal resistance between the die and the printed-circuit board per JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.
  4. Junction-to-case-top at the top of the package determined using MIL-STD 883 Method 1012.1. The cold plate temperature is used for the case temperature. Reported value includes the thermal resistance of the interface layer.
  5. See [Thermal management information](#), for additional details.

This table provides the thermal resistance with heat sink in open flow

**Table 4-14.** Thermal Resistance with Heat Sink in Open Flow

Heat Sink with Thermal Grease	Air Flow	Thermal Resistance (°C/W)
53 × 53 × 25 mm Pin Fin	Natural Convection	6.6
	0.5 m/s	3.9
	1 m/s	2.9
	2 m/s	2.5
	4 m/s	2.2
35x31x23 mm Pin Fin	Natural Convection	8.7
	0.5 m/s	5.0
	1 m/s	4.2
	2 m/s	3.6
	4 m/s	3.1
30x30x9.4 mm Pin Fin	Natural Convection	12.1
	0.5 m/s	8.2
	1 m/s	6.4
	2 m/s	5.0
	4 m/s	4.1

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**Table 4-14.** Thermal Resistance with Heat Sink in Open Flow (Continued)

Heat Sink with Thermal Grease	Air Flow	Thermal Resistance (°C/W)
43x41x16.5 mm Pin Fin	Natural Convection	8.9
	0.5 m/s	5.4
	1 m/s	4.2
	2 m/s	3.3
	4 m/s	2.7

- Notes:
1. Simulations with heat sinks were done with the package mounted on the 2s2p thermal test board. The thermal interface material was a typical thermal grease such as Dow Corning 340 or Wakefield 120 grease.
  2. Simulation details:  
 Substrate metal thicknesses: 0.015, 0.025 mm  
 Substrate core thickness: 0.4 mm

**4.7 Recommended thermal model**

Information about Flotherm models of the package or thermal data not available in this document can be obtained from your local Teledyne e2v sales office.

**4.8 Temperature diode**

The chip has a temperature diode on the microprocessor that can be used in conjunction with other system temperature monitoring devices (such as Analog Devices, ADT7461A). These devices feature series resistance cancellation using 3 current measurements, where up to 1.5kΩ of resistance can be automatically cancelled from the temperature result, allowing noise filtering and a more accurate reading.

The following are the specifications of the chip's on-board temperature diode:

Operating range: 10 – 230 μA

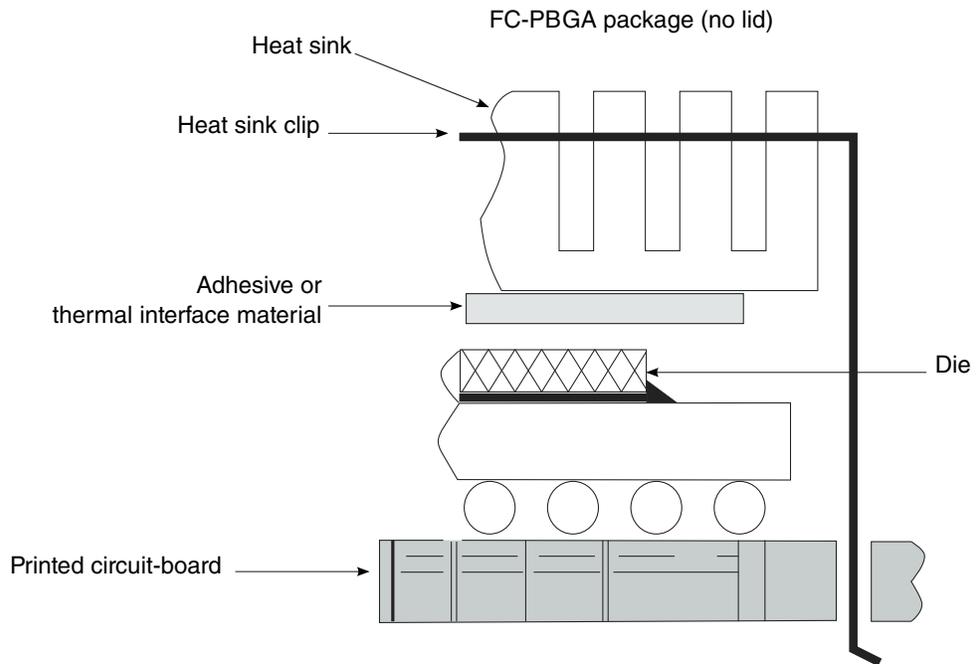
Ideality factor over 13.5 – 220 μA; Temperature range 80°C – 105°C: n = 1.004 ± 0.008

**4.9 Thermal management information**

This section provides thermal management information for the flip-chip, plastic-ball, grid array (FC-PBGA) package for air-cooled applications. Proper thermal control design is primarily dependent on the system-level design-the heat sink, airflow, and thermal interface material.

The recommended attachment method to the heat sink is illustrated in [Figure 4-16](#). The heat sink should be attached to the printed-circuit board with the spring force centered over the die. This spring force should not exceed 15 pounds force (65 Newton).

**Figure 4-16.** Package exploded, cross-sectional view-FC-PBGA (no lid)



The system board designer can choose between several types of heat sinks to place on the device. There are several commercially-available thermal interfaces to choose from in the industry. Ultimately, the final selection of an appropriate heat sink depends on many factors, such as thermal performance at a given air velocity, spatial volume, mass, attachment method, assembly, and cost.

For additional information regarding thermal management of lid-less flip-chip packages, refer to application note AN4871, "Assembly Handling and Thermal Solutions for Lidless Flip Chip Ball Grid Array Packages"

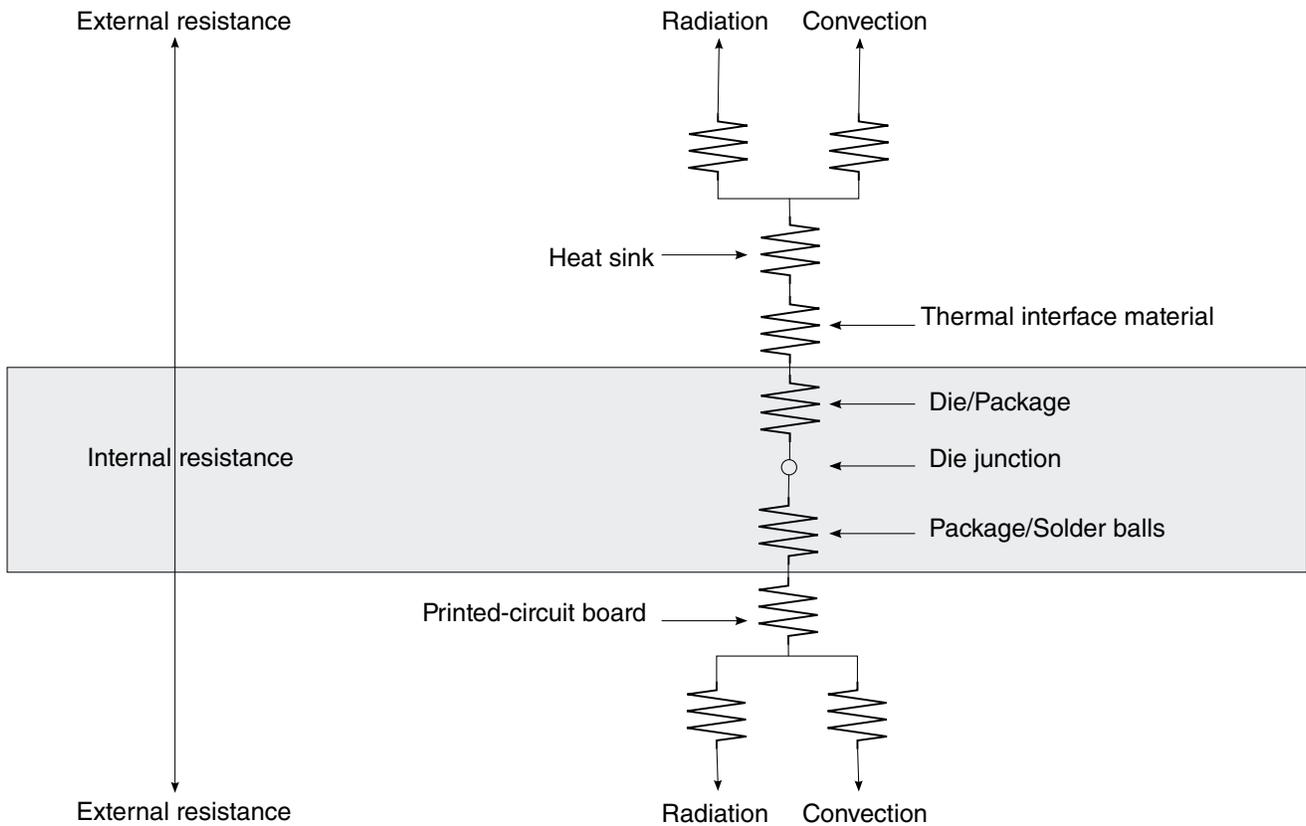
#### 4.9.1 Internal package conduction resistance

For the package, the intrinsic internal conduction thermal resistance paths are as follows:

- The die junction-to-case thermal resistance
- The die junction-to-board thermal resistance

This figure depicts the primary heat transfer path for a package with an attached heat sink mounted to a printed-circuit board.

Figure 4-17. Package with heat sink mounted to a printed-circuit board



(Note the internal versus external package resistance)

The heat sink removes most of the heat from the device. Heat generated on the active side of the chip is conducted through the silicon and through the heat sink attach material (or thermal interface material), and finally to the heat sink. The junction-to-case thermal resistance is low enough that the heat sink attach material and heat sink thermal resistance are the dominant terms.

**4.9.2 Thermal interface materials**

A thermal interface material is required at the package-to-heat sink interface to minimize the thermal contact resistance. The performance of thermal interface materials improves with increasing contact pressure; this performance characteristic chart is generally provided by the thermal interface vendor. The recommended method of mounting heat sinks on the package is by means of a spring clip attachment to the printed-circuit board (see [Figure 4-16](#)).

The system board designer can choose among several types of commercially-available thermal interface materials.

## 5. PACKAGE INFORMATION

### 5.1 Package parameters for the FC-PBGA

The package parameters are as provided in the following list. The package type is flip-chip, plastic-ball, grid array (FC-PBGA).

- Package outline - 26 × 44 mm
- Interconnects - 1415
- Ball Pitch - 0.8 mm
- Ball Diameter (typical): 0.525 mm (SnPb 63/37) , 0.55 mm (Sac305)
- Solder Balls - 96.5% Sn, 3% Ag, 0.5% Cu
- Solder Balls - 63% Sn, 37% Pb
- Module height: 3.32 mm typical



## 7. ORDERING INFORMATION

Contact your local Teledyne e2v sales office or regional marketing team for order information.

**Table 7-1.** Ordering Information

Generation	Platform	Number of virtual cores	Derivatives	Temperature range	Encryption	Package Type	CPU Speed	DDR Data Rate	Memory size	Memory type	Product Revision	Particular Specification
QT(X) = 28 nm Qormino	1	04 = 4 virtual cores	0 = First product	C = 0/70 B = 0/105 A = -40/105 F = -40/125	E = SEC present N = SEC not present	7 = MCM C4/C5 Pbfree 3 = SnPb	M = 1200 MHz P = 1400 MHz W = 1500 MHz	N = 1333 MT/s Q = 1600 MT/s	4 = 4GB	4 = DDR4	A = Rev 1.0 B = Rev 1.1 C = Rev 1.2 D = Rev 1.3	ZS3 <sup>(3)</sup>

- Notes:
1. For availability of the different versions, contact your local Teledyne e2v sales office.
  2. The letter x in the part number designates a "Prototype" product that has not been qualified by Teledyne e2v. Reliability of a PCX part-number is not guaranteed and such part-number shall not be used in Flight Hardware. Product changes may still occur while shipping prototypes.
  3. Reliability validated up to 700 AATC @ -55/125°C in F temperature range.

## 8. REVISION HISTORY

This table provides revision history for this document.

**Table 8-1.** Revision History

Rev. No	Date	Substantive Change(s)
1195J	03/2021	Added the particular specification ZS3 in the ordering information
1195I	10/2020	Removed "Preliminary" in the datasheet Updated <a href="#">Section 5.2 "Mechanical dimensions of the FC-PBGA" on page 181</a> : new diameter tolerances, replaced ±0.050 by ±0.075
1195H	04/2020	Updated <a href="#">Section 5.2 "Mechanical dimensions of the FC-PBGA" on page 181</a>
1195G	02/2020	Updated <a href="#">Section 5.2 "Mechanical dimensions of the FC-PBGA" on page 181</a> Updated <a href="#">Table 3-11</a> : added Iddinit current.
1195F	05/2019	<a href="#">Table 7-1, "Ordering Information," on page 182</a> added D = Rev 1.3
1195E	03/2019	New photo page 1 Updated <a href="#">Section 5.2</a> : Mechanical dimensions of the FC-PBGA
1195D	06/2018	Updated <a href="#">Table 7-1</a> : "Ordering Information" Updated <a href="#">Table 2-1</a> : added note 28 <a href="#">Table 3-1</a> : cancelled note 11
1195C	06/2018	<a href="#">Table 7-1</a> : added C = 0/70 in temperature range
1195B	03/2018	<a href="#">Table 7-1, "Ordering Information," on page 182</a> : Updated temperature range in ordering information, replaced C = 0/105 by C = 0/70 and added B = 0/105 Updated CPU Speed, added W = 1500MHz
1195A	10/2017	Initial revision

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